



SCOPE OF ACCREDITATION TO ISO/IEC 17025:2017
& ANSI/NCSL Z540-1-1994 & ANSI/NCSL Z540-3-2006

TECHNICAL MAINTENANCE, INC A TRUMETRIC FAMILY
12530 Telecom Drive
Temple Terrace, FL 33637
Scott Chamberlain Phone: 321-242-0890
Please Click Here to Access

[MICRO QUALITY CALIBRATION LLC A TruMetric Family or
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CALIBRATION

Valid To: [See Table Below](#)

Certificate Number: 2348.01

In recognition of the successful completion of the A2LA evaluation (including an assessment of the organization's compliance with A2LA's – R205 Calibration Program Requirements), accreditation is granted to this laboratory at the locations listed above as well as the branch laboratory location listed below to perform the following calibrations^{1, 8}:

I. Acoustical Quantities

Parameter/Range	Frequency	CMC ^{2, 9} (±)	Comment	Location ¹⁰
Sound Pressure Level – Measuring Equipment	114 dB @ 251.2 Hz	0.26 dB	Sound level calibrator	ATL
	94 dB @ 1 kHz	0.65 dB		HSV
	114 dB @ 1 kHz	0.97 dB		
Up to 150 dB, Measure & Measuring Equipment	(19 to 16 000) Hz	0.25 dB	Acoustics calibrator	RFD
	(16 000 to 20 000) Hz	0.32 dB		

II. Chemical Quantities

Parameter/Equipment	Range	CMC ² (±)	Comment	Location ¹⁰
pH Meters ³	4 pH	0.025 pH	pH buffer solutions	TPA, RDU, DFW
	7 pH	0.036 pH		
	10 pH	0.069 pH		
	4 pH	0.039 pH		ATL, SFL
	7 pH	0.03 pH		
	10 pH	0.035 pH		

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Parameter/Equipment	Range	CMC ² (±)	Comment	Location ¹⁰
pH Meters ³ (cont)	4 pH 7 pH 10 pH 4 pH 7 pH 10 pH	0.035 pH 0.025 pH 0.069 pH 0.018 pH 0.017 pH 0.03 pH	pH buffer solutions	RFD, HRT HSV, COS HLR, MEL
Conductivity Meters ³	2 µS/cm 100 µS/cm 1000 µS/cm 10 000 µS/cm 100 000 µS/cm 150 000 µS/cm 100 µS/cm 1413 µS/cm 10 000 µS/cm 100 µS/cm 1410 µS/cm 10 000 µS/cm 2 µS/cm 10 µS/cm 100 µS/cm 1000 µS/cm 1413 µS/cm 10 000 µS/cm 100 000 µS/cm 2 µS/cm 5 µS/cm 10 µS/cm 100 µS/cm 500 µS/cm 1000 µS/cm 10 000 µS/cm 100 000 µS/cm 84 µS/cm 1413 µS/cm 10 000 µS/cm	0.2 µS/cm 0.74 µS/cm 3.6 µS/cm 35 µS/cm 350 µS/cm 580 µS/cm 0.74 µS/cm 5.7 µS/cm 35 µS/cm 0.83 µS/cm 5.3 µS/cm 44 µS/cm 0.2 µS/cm 0.17 µS/cm 0.74 µS/cm 3.6 µS/cm 5.7 µS/cm 36 µS/cm 350 µS/cm 0.2 µS/cm 0.2 µS/cm 0.17 µS/cm 0.74 µS/cm 2.3 µS/cm 3.6 µS/cm 36 µS/cm 350 µS/cm 0.83 µS/cm 5.7 µS/cm 35 µS/cm	Conductivity solutions	TPA ATL HSV RFD, HLR, DFW SFL MEL

Parameter/Equipment	Range	CMC ² (±)	Comment	Location ¹⁰
Conductivity Meters	0.65 µS/cm 10 µS/cm 100 µS/cm 1000 µS/cm 10 000 µS/cm 100 000 µS/cm	0.33 µS/cm 0.64 µS/cm 2.1 µS/cm 5 µS/cm 44 µS/cm 400 µS/cm	Conductivity solutions	COS
	10 µS/cm 500 µS/cm 1000 µS/cm	0.17 µS/cm 2.2 µS/cm 3.6 µS/cm		RDU

III. Dimensional

Parameter/Equipment	Range	CMC ^{2, 4} (±)	Comment	Location ¹⁰
Gage Blocks – Length	Up to 10 in Up to 12 in	(3.3 + 2.2L) µin (4 + 2.3L) µin	Master gage blocks, P&W universal measuring machine	SFL ATL, HSV, HRT
	Up to 13 in Up to 13 in	(1.2 + 2.5L) µin (4 + 2.3L) µin		RFD HLR, MEL, COS, RDU, DFW
	Up to 20 in	(3.2 + 1.2L) µin		TPA
Micrometers ³	Up to 18 in	(26 + 4.7L) µin	Gage blocks (grade 2)	HRT
	Up to 40 in	(27 + 4.6L) µin		TPA, MEL, COS, RDU, DFW
	Up to 46 in	(9.3 + 7L) µin (29 + 4.4L) µin		HSV RFD, ATL, HLR, SFL
Micrometer Standards				
Length Rods	Up to 40 in Up to 40 in Up to 46 in (1 to 10) in Up to 13 in	(1.1 + 5.7L) µin (4.3 + 3.8L) µin (1 + 7.8L) µin (21 + 1.4L) µin (1.2 + 6.9L) µin	Gage blocks (grade 2), P&W universal measuring machine, dial comparator, bench micrometer	RFD TPA HSV, RDU HLR, COS, HRT, MEL, ATL, DFW

Parameter/Equipment	Range	CMC ^{2,4} (±)	Comment	Location ¹⁰
Laser Micrometer ³	Up to 1.5 in Up to 1.2 in Up to 10.5 mm	88 µin 72 µin 0.68 µm	Comparison to pin gages	HRT COS
Calipers ³	Up to 24 in (24 to 80) in Up to 40 in Up to 46 in Up to 80 in	(280 + 1.6L) µin (230 + 3.6L) µin (280 + 2L) µin (76 + 7L) µin (280 + 1.7L) µin (280 + 3.4L) µin	Gage blocks (grade 2)	HLR TPA, HRT, MEL, COS, RDU, DFW ATL RFD, SFL, RDU HSV
Dial Indicators ³ Resolution: ≥ 50 µin < 50 µin	Up to 10 in Up to 0.1 in	(26 + 3.9L) µin 7 µin 7.7 µin 8.3 µin 9.4 µin 10 µin	Gage blocks (grade 2)	TPA, ATL, HSV, RFD, HRT, HLR, SFL, MEL, COS, RDU, DFW RFD TPA ATL, COS, RDU, DFW HLR, SFL HSV, HRT, MEL
Spheres	Up to 2 in	30 µin	P&W Model C	HSV



Parameter/Equipment	Range	CMC ^{2,4} (±)	Comment	Location ¹⁰
Height Gages ³	Up to 40 in Up to 40 in Up to 46 in Up to 46 in Up to 46 in Up to 46 in Up to 46 in	(110 + 3.3L) μin (94 + 2.9L) μin (100 + 1.6L) μin (78 + 5.3L) μin (150 + 2.4L) μin (240 + 1.5L) μin (100 + 2.9L) μin	Gage blocks (grade 2)	TPA RFD, COS, HRT, MEL, RDU, DFW ATL HSV HLR SFL RDU
Protractors ³	(0 to 360) °	0.008 ° (29 arcsec) 0.015 ° (54 arcsec) 0.013 ° (47 arcsec)	Angle blocks, gage blocks, sine bar	TPA, HSV, RFD, MEL HRT ATL, SFL, COS, RDU, HLR, DFW
Rulers ³	Up to 48 in Up to 72 in	0.009 in 0.009 in	Gage blocks (grade 2)	TPA, ATL, HSV, HLR, SFL, MEL, COS, RDU, HRT, DFW RFD
Radius Gages	(0.016 to 1) in (0.016 to 1) in (0.01 to 1) in (0.01 to 1) in	220 μin 240 μin 290 μin 300 μin	Optical comparator	TPA, ATL, RFD, HLR, MEL, DFW, RDU
Tape Measures ³	Up to 100 ft Up to 150 ft Up to 100 ft	(0.000 26F + 0.026) in (0.000 28F + 0.024) in (0.000 28F + 0.024) in	Standard rule	MEL, RFD, SFL, TPA, HLR, COS, RDU, HSV, DFW HRT ATL
Feeler Gage	Up to 1 in Up to 1 in Up to 1 in Up to 1 in	31 μin 36 μin 45 μin 52 μin	Supermicrometer™ C	TPA, ATL, RFD, SFL, COS, RDU, DFW HSV HRT, MEL HLR



Parameter/Equipment	Range	CMC ^{2,4} (±)	Comment	Location ¹⁰
Bore Micrometers				
2 Point	Up to 8 in Up to 12 in Up to 12 in	(7 + 2 <i>L</i>) μin (22 + 3.9 <i>L</i>) μin (56 + 3.2 <i>L</i>) μin	Master gage blocks, P&W universal measuring machine	RFD TPA, ATL, HLR, MEL HSV, COS, RDU, DFW
3 Point	Up to 12 in Up to 12 in Up to 8 in Up to 3 in (0.125 to 3.5) in (0.25 to 3.2) in (0.125 to 2) in (0.625 to 3) in	(8.8 + 42 <i>L</i>) μin (64 + 3.1 <i>L</i>) μin (42 + 1.4 <i>L</i>) μin (57 + 2.8 <i>L</i>) μin (29 + 5.9 <i>L</i>) μin (23 + 26 <i>L</i>) μin (15 + 8.8 <i>L</i>) μin (57 + 14 <i>L</i>) μin	Master ring	TPA HSV RFD COS, DFW ATL HLR MEL RDU
Cylindrical Gages –				
Plain Rings	(0.125 to 14) in (0.125 to 14) in (0.04 to 14) in (0.125 to 8) in (0.04 to 8) in (0.125 to 13) in (0.04 to 10) in (0.04 to 12) in (0.04 to 14) in (0.125 to 14) in	(8.1 + 2.9 <i>D</i>) μin (9.8 + 3 <i>D</i>) μin (9.6 + 2.1 <i>D</i>) μin (11 + 2.2 <i>D</i>) μin (11 + 2.2 <i>D</i>) μin (9.4 + 2.4 <i>D</i>) μin (14 + 2 <i>D</i>) μin (8.1 + 2.1 <i>D</i>) μin (11 + 3.2 <i>D</i>) μin (11 + 3.2 <i>D</i>) μin	Master gage blocks, P&W universal measuring machine	TPA HSV RFD HRT DFW HLR SFL ATL COS, RDU MEL
Plain Pin, Plugs	Up to 13 in Up to 13 in Up to 13 in Up to 14 in Up to 8 in Up to 13 in Up to 10 in Up to 11 in (0.04 to 14) in (0.04 to 13) in	(6.8 + 3.3 <i>D</i>) μin (10 + 3.1 <i>D</i>) μin (11 + 2.5 <i>D</i>) μin (4.8 + 2.3 <i>D</i>) μin (10 + 3 <i>D</i>) μin (4.2 + 3.4 <i>D</i>) μin (10 + 2.9 <i>D</i>) μin (5.2 + 2.1 <i>D</i>) μin (14 + 2 <i>D</i>) μin (5.3 + 2.3 <i>D</i>) μin		RDU COS MEL HLR HRT, DFW RFD HSV SFL ATL TPA
NPT Thread Plugs				
Major Diameter Pitch Diameter	Up to 12 in Up to 12 in	55 μin 120 μin	Bench micrometer, Thread wire set, pipe taper sine block	TPA, RFD, MEL, COS, DFW, RDU
Parallelism & Straightness	Up to 0.01 in Up to 4 in	13 μin 110 μin	Gage amplifier, surface plate	RFD, RDU, HLR MEL, DFW

Parameter/Equipment	Range	CMC ^{2, 4} (±)	Comment	Location ¹⁰
Thread Plugs –				
Major Diameter	Up to 12 in	36 µin	B & S 599-246-00, thread wire set, gage blocks, Labmaster, Supermicrometer™	TPA
Pitch Diameter	Up to 12 in	92 µin		
Major Diameter	Up to 12 in	50 µin		ATL
Pitch Diameter	Up to 12 in	97 µin		
Major Diameter	Up to 12 in	40 µin		HSV
Pitch Diameter	Up to 12 in	92 µin		
Major Diameter	Up to 12 in	44 µin		RFD
Pitch Diameter	Up to 12 in	79 µin		
Major Diameter	Up to 12 in	65 µin		HLR
Pitch Diameter	Up to 12 in	110 µin		
Major Diameter	Up to 10 in	43 µin		HRT
Pitch Diameter	Up to 10 in	94 µin		
Major Diameter	Up to 12 in	62 µin		MEL
Pitch Diameter	Up to 12 in	99 µin		
Major Diameter	Up to 10 in	50 µin		SFL
Pitch Diameter	Up to 10 in	97 µin		
Major Diameter	Up to 10 in	44 µin		COS, DFW
Pitch Diameter	Up to 10 in	79 µin		
Major Diameter	Up to 10 in	53 µin		RDU
Pitch Diameter	Up to 10 in	98 µin		
Solid Thread Rings	(0.625 to 12) in	110 µin	Labmaster, measuring machine	RFD
Pitch Diameter	Up to 12 in	110 µin		TPA
	Up to 12 in	98 µin		COS, DFW
	Up to 12 in	120 µin		RDU
Adjustable Thread Rings				
Pitch Diameter (Tactile Fit)	Up to 12 in	(350 + 47D) µin	Thread setting plug gages	TPA, ATL, RFD, RDU, MEL, COS, HLR, DFW
Rotary Encoders – Angle ³	(0 to 360) °	24 arcsec	Rotary encoder	COS

Parameter/Equipment	Range ⁴	CMC ² (±)	Comment	Location ¹⁰
Thread Wires	Up to 0.5D Up to 0.5D	10 µin 11 µin	Master gage blocks, P&W universal measuring machine	TPA, RFD HSV, COS, RDU, DFW
Surface Plates ³ –				
Local Area Flatness	(-0.001 to 0.001) in (-0.001 to 0.001) in	72 µin 68 µin	Repeat-o-meter	RDU TPA, ATL, HSV, HLR, RFD, HRT, MEL, COS, DFW
Overall Flatness	(12 x 12) in to (6 x 12) ft (12 x 12) in to (6 x 12) ft	110 µin 130 µin	Planeator	MEL TPA
	(12 x 12) in to (6 x 12) ft	86 µin		COS, RDU, DFW
	(12 x 12) in to (6 x 12) ft	79 µin		HSV, RFD
	(12 x 12) in to (6 x 12) ft	79 µin	Leveling system	ATL, HLR
	(12 x 12) in to (6 x 12) ft	66 µin		HRT
Optical Comparators ³ –				
Angle Linearity Magnification	Up to 360 ° Up to 20 in (20 to 40) in 10x to 100x	0.0087 ° 210 µin 450 µin 340 µin	Gage blocks, angle blocks, glass scales, precision balls	TPA
Angle Linearity Magnification	Up to 360 ° Up to 20 in (20 to 40) in 10x to 100x	0.0087 ° 320 µin 630 µin 420 µin		HSV
Angle Linearity Magnification	Up to 360 ° Up to 20 in (20 to 40) in 10x to 100x	0.042 ° 320 µin 630 µin 420 µin		RFD, ATL
Angle Linearity Magnification	Up to 360 ° Up to 20 in (20 to 40) in 10x to 100x	0.016 ° 320 µin 630 µin 430 µin		COS, RDU, DFW
Angle Linearity Magnification	Up to 360 ° Up to 20 in (20 to 40) in (10 to 100) x	0.02 ° 190 µin 350 µin 250 µin		MEL

Parameter/Equipment	Range	CMC ^{2, 9} (±)	Comment	Location ¹⁰
Roughness – Measure	123 µin Ra 117 µin Ra 116 µin Ra 3 µm Ra	3.2 µin 2.5 µin 2.9 µin 0.06 µm	Mitutoyo SV-3200H4 surface measuring system & roughness specimens	RFD
Roughness Testers ³	117 µin Ra 370 µin Rmax	1.3 µin	Comparison to roughness specimen	HSV
Coating Thickness Gages ³ Eddy Current & Magnetic Induction	(0.737 to 100) mils (100 to 243) mils (14 to 202) mils (0.9 to 20) mils (0.49 to 38.9) mils	26 µin 240 µin 63 µin 62 µin 69 µin	Coating thickness standards, foils, Supermicrometers TM	TPA HLR MEL HSV
Ultrasonic Thickness Gauges ³	Up to 10 in Up to 10 in	110 µin 590 µin	Gage blocks	TPA, HSV MEL
Coating Thickness Shims	Up to 243 mils Up to 243 mils	57 µin 69 µin	Supermicrometer TM model C	TPA, HSV HLR, MEL, DFW, RDU
Crimp Tools ³	(0.011 to 1) in (0.011 to 0.5) in	150 µin 240 µin	Micrometer Pin gages	TPA, HLR, HSV, HRT, COS, MEL, DFW, RDU
Pi Tapes ³	Up to 3 in	450 µin	Comparison to plug gages	HRT
Microscopes	Up to 2 in Up to 1 in Up to 25 mm	100 µin 100 µin 2.6 µm	Comparison to stage micrometer	HRT, HSV COS

IV. Dimensional Testing⁵

Parameter/Equipment	Range	CMC ^{2, 4} ($\pm$)	Comment	Location ¹⁰
Length	X Axis (0.01 to 10) in Y Axis (0.01 to 6) in	160 μ in 120 μ in	Optical comparator	TPA, RFD, MEL, RDU
	X Axis (0.01 to 8) in Y Axis (0.01 to 4) in	160 μ in 120 μ in		ATL
	X Axis (0.01 to 8) in Y Axis (0.01 to 4) in	180 μ in 180 μ in		HLR
	Up to 480 in	(0.8 + 2.6L) μ in	Laser measurement system	COS
Angle	Up to 360°	0.006°	Optical comparator	TPA, RFD, HLR, RDU ATL, MEL, HSV
General Inspection				
X Axis	Up to 33 in Up to 838 mm	(80 + 3.6L) μ in (2.1 + 0.0036L) μ m	CMM	RFD
Y Axis	Up to 60 in Up to 1524 mm	(200 + 0.13L) μ in (5.1 + 0.000 13L) μ m		
Z Axis	Up to 20 in Up to 508 mm	(200 + 0.13L) μ in (5.1 + 0.000 13L) μ m		

V. Electrical – DC/Low Frequency

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
Phase Angle ³ – Generate	(-180 to 180) ° (10 to 65) Hz (65 to 500) Hz 500 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz	0.08° 0.19° 0.38° 1.9° 3.8° 7.6°	Fluke 5560A, 5522A multiproduct calibrator	TPA, ATL, RFD, HRT, MEL, COS, RDU, HSV, SFL, HLR, DFW
Phase Angle – Generate, 5 V Equal Amplitude 50 mV to 120 V Unequal Amplitude	(0 to 360)° 1 Hz to 1 kHz (1 to 6.25) kHz (6.25 to 50) kHz (50 to 200) kHz (0 to 360)° 1 Hz to 1 kHz (1 to 6.25) kHz (6.25 to 50) kHz (50 to 200) kHz	0.005° 0.01° 0.015° 0.04° 0.005° 0.01° 0.015° 0.04°	Clarke-Hess 5600, 5500-2 phase standard	TPA, RFD
Phase Angle – Measure 10 mV to 630 V	(0 to 360)° 5 Hz to 2 kHz (2 to 5) kHz (5 to 10) kHz (10 to 50) kHz (50 to 100) kHz (100 to 200) kHz	0.02° 0.03° 0.04° 0.05° 0.1° 0.2°	Clarke-Hess 6000A phase meter	TPA, RFD, COS
Phase Angle – Measure 50 mV to 120 V	(0 to 360)° 1 Hz to 1 kHz (1 to 50) kHz (1 to 50) kHz (50 to 200) kHz (5 to 50) kHz (50 to 200) kHz (5 to 50) kHz (50 to 200) kHz	0.001° 0.002° 0.002° 0.008° 0.002° 0.008° 0.002° 0.008°	Clarke-Hess 5002A phase bridge Clarke-Hess 5002B phase bridge Clarke-Hess 5002C phase bridge Clarke-Hess 5002D phase bridge	TPA, RFD



Parameter/Range	Range	CMC ^{2, 7} (±)	Comment	Location ¹⁰
DC Current – Generate ³	(1 to 1.2) nA (1.2 to 12) nA (12 to 120) nA (0.12 to 1.2) µA (1.2 to 10) µA	92 µA/A + 0.007 nA 92 µA/A + 0.007 nA 92 µA/A + 0.01 nA 36 µA/A + 0.1 nA 13 µA/A + 1 nA	Fluke 5730A multifunction calibrator & Fluke 5560A multiproduct calibrator	TPA, RFD, MEL, RDU, COS, DFW, HSV
	(1 to 1.2) nA (1.2 to 12) nA (12 to 120) nA (0.12 to 1.2) µA (1.2 to 10) µA	92 µA/A + 0.007 nA 92 µA/A + 0.007 nA 92 µA/A + 0.01 nA 36 µA/A + 0.1 nA 19 µA/A + 1 nA	Fluke 5720A multifunction calibrator & Fluke 5560A multiproduct calibrator	ATL
	(1 to 1.2) nA (1.2 to 12) nA (12 to 120) nA (0.12 to 1.2) µA (1.2 to 10) µA	99 µA/A + 0.007 nA 99 µA/A + 0.007 nA 99 µA/A + 0.01 nA 36 µA/A + 0.1 nA 19 µA/A + 1 nA	Fluke 5700A multifunction calibrator & Fluke 5560A multiproduct calibrator	HRT
	(1 to 2.2) nA (2.2 to 22) nA (22 to 220) nA (0.22 to 2.2) µA (2.2 to 10) µA	93 µA/A + 0.007 nA 92 µA/A + 0.007 nA 92 µA/A + 0.01 nA 36 µA/A + 0.1 nA 20 µA/A + 1 nA	Fluke 5720A multifunction calibrator & Fluke 5522A multiproduct calibrator	HLR, SFL
	(10 to 220) µA 220 µA to 2.2 mA (2.2 to 22) mA (22 to 100) mA (100 to 220) mA (0.22 to 1) A (1 to 2.2) A	38 µA/A + 5 nA 30 µA/A + 6 nA 30 µA/A + 38 nA 38 µA/A + 0.7 µA 39 µA/A + 0.7 µA 68 µA/A + 11 µA 78 µA/A + 11 µA	Fluke 5720A, 5730A multifunction calibrator	TPA, ATL, HSV, RFD, HLR, SFL, MEL, COS, RDU, DFW
	(10 to 220) µA 220 µA to 2.2 mA (2.2 to 22) mA (22 to 100) mA (100 to 220) mA (0.22 to 1) A (1 to 2.2) A	46 µA/A + 8 nA 46 µA/A + 8 nA 46 µA/A + 82 nA 53 µA/A + 0.9 µA 61 µA/A + 0.9 µA 72 µA/A + 23 µA 81 µA/A + 23 µA	Fluke 5700A multifunction calibrator	HRT

Parameter/Equipment	Range	CMC ^{2, 7} (±)	Comment	Location ¹⁰
DC Current – Generate ³	(2.2 to 11) A	270 µA/A + 370 µA	Fluke 5720A, 5730A multifunction calibrator w/5725A transconductance amplifier	HSV, HLR, SFL
	(11 to 20.5) A	760 µA/A + 580 µA	Fluke 5522A multiproduct calibrator	
	(2.2 to 3.1) A (3.1 to 12) A (12 to 30) A	230 µA/A + 110 µA 230 µA/A + 190 µA 760 µA/A + 390 µA	Fluke 5560A multiproduct calibrator	TPA, RFD, MEL, ATL, RDU, COS, HRT, HSV, DFW
	(12 to 20) A (20 to 100) A	76 µA/A + 0.76 mA 76 µA/A + 3.8 mA	Fluke 5560A /52120A amplifier	TPA, RFD, COS
DC Current – Clamp Meters ³	(1.2 to 200) A (6 to 1000) A	0.21 % of output + 0.008 A 0.21 % of output + 0.024 A	Fluke 5560A multiproduct calibrator w/9100- 200 x10/x50 coil	COS, HRT, HSV
	(1.2 to 200) A (6 to 1000) A	0.21 % of output + 0.028 A 0.21 % of output + 0.04 A	Fluke 5522A multiproduct calibrator w/9100- 200 x10/x50 coil	SFL, HLR
	(3.1 to 300.2) A	0.65 % of output + 0.014 A	Fluke 5560A multiproduct calibrator w/55xxA x1/x2/x10 coil	RDU
DC Current – Clamp Meters ³ Toroidal-Wound	(0.6 to 600) A (600 to 1000) A	0.19 % of output + 0.04 A 0.20 % of output + 0.04 A	Fluke 5560A multiproduct calibrator w/5500A coil x50	TPA, RFD, MEL, ATL, COS, HSV, DFW, RDU
	(0 to 1025) A	0.2 % of output + 0.05 A	Fluke 5522A multiproduct Calibrator w/5500A coil x50	HSV

Parameter/Equipment	Range	CMC ^{2, 7} (±)	Comment	Location ¹⁰
DC Current – Measure ³	(1 to 10) A (10 to 100) A	66 µA/A + 70 µA 66 µA/A + 0.01 mA	Agilent 3458A option 002 multimeter standard resistor Ohms Lab CSW-100	HSV
	(10 to 100) A	55 µA/A + 0.09 mA	Agilent 3458A option 002 multimeter standard resistor Ohms Lab CS-100	RDU
		44 µA/A + 0.09 mA		TPA
		49 µA/A + 0.09 mA		MEL
DC Current – Clamp Meters Other ³	(0.6 to 600) A (600 to 1000) A	0.38 % of output + 0.38 A 0.39 % of output + 0.38 A	Fluke 5560A multiproduct calibrator w/5500A coil x50	TPA, RFD, MEL, ATL, COS, HSV, DFW, RDU
	(0 to 1025) A	0.39 % of output + 0.38 A	Fluke 5522A multiproduct calibrator w/5500A coil x50	HSV
DC Current – Measure ³	(1 to 10) nA (10 to 100) nA (0.1 to 1) µA (1 to 10) µA (10 to 100) µA (0.1 to 1) mA (1 to 10) mA (10 to 100) mA	18 µA/A + 0.15 pA 6.0 µA/A + 1.5 pA 4.8 µA/A + 0.015 nA 4.4 µA/A + 0.015 nA 4.4 µA/A + 0.15 nA 4.4 µA/A + 0.0015 µA 4.4 µA/A + 0.015 µA 9.9 µA/A + 0.15 µA	Agilent 3458A multimeter option 002, Fluke 5450A resistance calibrator	TPA, RFD, COS
	(1 to 10) nA (10 to 100) nA (0.1 to 1) µA (1 to 10) µA	35 µA/A + 0.1 pA 12 µA/A + 1 pA 8.3 µA/A + 0.01 nA 6.9 µA/A + 0.1 nA	Fluke 5730A multifunction calibrator Agilent 3458A option 002 multimeter	MEL, HSV, DFW
	(1 to 10) nA (10 to 100) nA (0.1 to 1) µA (1 to 10) µA	35 µA/A + 0.1 pA 18 µA/A + 1 pA 10 µA/A + 0.01 nA 8.3 µA/A + 0.1 nA	Fluke 5720A multifunction calibrator, Agilent 3458A multimeter option 002	ATL, HLR, SFL
	(1 to 10) nA (10 to 100) nA (0.1 to 1) µA (1 to 10) µA	35 µA/A + 0.12 pA 18 µA/A + 1.2 pA 13 µA/A + 0.01 nA 12 µA/A + 0.12 nA	Fluke 5700A/03 multifunction calibrator Agilent 3458A option 002 multimeter	HRT

Parameter/Equipment	Range	CMC ^{2,7} (±)	Comment	Location ¹⁰
DC Current – Measure ³	(10 to 100) µA (0.1 to 1) mA (1 to 10) mA (10 to 100) mA (0.1 to 1) A	13 µA/A + 0.5 nA 13 µA/A + 3 nA 13 µA/A + 0.03 µA 23 µA/A + 0.3 µA 72 µA/A + 6.6 µA	Agilent 3458A multimeter	TPA, MEL, COS, HSV, HRT, HLR, SFL, RDU
	(0.1 to 20.2) µA (20.2 to 202) µA (0.202 to 2.02) mA (2.02 to 20.2) mA (20.2 to 202) mA (0.202 to 2.02) A (2.02 to 20.2) A (20.2 to 30.2) A	26 µA/A + 0.4 nA 9.9 µA/A + 0.4 nA 9.1 µA/A + 4 nA 14 µA/A + 0.04 µA 56 µA/A + 1.0 µA 130 µA/A + 0.2 mA 230 µA/A + 0.5 mA 540 µA/A + 4.3 mA	Fluke 8588A multimeter	RFD, ATL, DFW, COS
	(0.1 to 20.2) µA (20.2 to 202) µA (0.202 to 2.02) mA (2.02 to 20.2) mA (20.2 to 202) mA (0.202 to 2.02) A	30 µA/A + 0.4 nA 11 µA/A + 0.5 nA 11 µA/A + 5 nA 15 µA/A + 0.05 µA 58 µA/A + 1.5 µA 150 µA/A + 0.2 mA	Fluke 8558A multimeter	RDU
DC Current – Measure	(1 to 10) A (10 to 30) A (10 to 100) A	29 µA/A + 10 µA 25 µA/A + 1.2 µA 25 µA/A + 10 µA	Agilent 3458A option 002 multimeter standard resistor Guildline 9230A-30A 9230A-100A	COS
DC Current – Measure ³	(1 to 10) A (10 to 100) A (100 to 300) A	7.3 µA/A + 3.4 µA 7.3 µA/A + 34 µA 7.3 µA/A + 340 µA	Agilent 3458A multimeter option 002, MI 6311A current divider	TPA, COS
	(1 to 10) A (10 to 100) A	46 µA/A + 90 µA 47 µA/A + 0.09 mA	Agilent 3458A option 002 multimeter standard resistor L&N 4361 current shunt	ATL
	(1 to 10) A (10 to 100) A	35 µA/A + 85 µA 44 µA/A + 0.09 mA		RFD
	(1 to 10) A (10 to 100) A	34 µA/A + 90 µA 39 µA/A + 0.09 mA		MEL
	(1 to 3) A (3 to 10) A	760 µA/A + 460 µA 1.1 mA/A + 610 µA	Fluke 8845A multimeter	RDU, HSV, HRT
	(300 to 1 000) A	0.25 % of rdg + 8 mA	Agilent 3458A multimeter option 002, Empro current shunts	TPA
	(10 to 250) A	0.25 % of rdg + 0.02 A		RDU

Parameter/Equipment	Range	CMC ^{2, 7} (±)	Comment	Location ¹⁰
DC Current – Measure ³	(1 to 1000) A	0.25 % of rdg	Agilent 3458A multimeter option 002, Empo current shunts	MEL, COS, DFW
	(1 to 500) A	0.26 % of rdg		SFL
	(1 to 1000) A	0.26 % of rdg		HLR
	(10 to 100) A	0.25 % of rdg		HRT
	(1 to 1000) A	0.25 % of rdg		RFD
	(1 to 500) A	0.27 % of rdg		ATL
	(1 to 600) A	0.27 % of rdg		HSV
DC Voltage – Generate, Fixed Points	10 V	0.72 µV/V	Fluke 732B reference standard	COS
DC Voltage – Generate ³	(0 to 220) mV 220 mV to 2.2 V (2.2 to 11) V (11 to 22) V (22 to 220) V (220 to 1100) V	6.8 µV/V + 0.8 µV 4.6 µV/V + 0.9 µV 3 µV/V + 2.5 µV 3 µV/V + 3.9 µV 4.6 µV/V + 38 µV 6.1 µV/V + 390 µV	Fluke 5720A, 5730A multifunction calibrator	TPA, ATL, HSV, RFD, HLR, SFL, MEL, COS, RDU, DFW
	(0 to 220) mV 220 mV to 2.2 V (2.2 to 11) V (11 to 22) V (22 to 220) V (220 to 1000) V	6.8 µV/V + 0.9 µV 6.1 µV/V + 0.9 µV 6.1 µV/V + 3.2 µV 6.1 µV/V + 6.2 µV 6.8 µV/V + 76 µV 8.4 µV/V + 460 µV	Fluke 5700A multifunction calibrator	HRT
	(0 to 120) mV 120 mV to 1.2 V (1.2 to 12) V (12 to 120) V (120 to 1020) V	9.1 µV/V + 0.9 µV 6.3 µV/V + 1.0 µV 6.1 µV/V + 7.7 µV 8.4 µV/V + 76 µV 8.4 µV/V + 760 µV	Fluke 5560A multiproduct calibrator	COS, HRT, MEL, ATL RDU, TPA, RFD, HSV, DFW
High Voltage –Generate ³	(1 to 6) kV	2.4 % of output + 10 V	3565D tester high voltage	HLR

Parameter/Equipment	Range	CMC ^{2, 7} (±)	Comment	Location ¹⁰
DC Voltage – Measure ³	(0 to 100) mV 100 mV to 1 V (1 to 10) V (10 to 100) V (100 to 1000) V	3.3 $\mu\text{V/V} + 1 \mu\text{V}$ 2.6 $\mu\text{V/V} + 1 \mu\text{V}$ 2.6 $\mu\text{V/V} + 1.5 \mu\text{V}$ 3.9 $\mu\text{V/V} + 20 \mu\text{V}$ 3.9 $\mu\text{V/V} + 66 \mu\text{V} + 12 \mu\text{V/V}$ $\times (\text{Vin}/1000)^2$	Agilent 3458A multimeter option 002	TPA, ATL, HSV, RFD, HRT, HLR, MEL, COS, RDU, SFL, DFW
	(0 to 220) mV (0.202 to 2.02) V (2.02 to 20.2) V (20.2 to 202) V (202 to 1000) V	7.3 $\mu\text{V/V} + 0.7 \mu\text{V}$ 2.8 $\mu\text{V/V} + 0.8 \mu\text{V}$ 2.8 $\mu\text{V/V} + 0.8 \mu\text{V}$ 4.2 $\mu\text{V/V} + 30 \mu\text{V}$ 4.3 $\mu\text{V/V} + 0.49 \text{ mV}$	Fluke 8588A multimeter	ATL, RFD, DFW, COS
	(0 to 220) mV (0.202 to 2.02) V (2.02 to 20.2) V (20.2 to 202) V (202 to 1000)	6.3 $\mu\text{V/V} + 0.7 \mu\text{V}$ 4 $\mu\text{V/V} + 0.8 \mu\text{V}$ 4 $\mu\text{V/V} + 0.8 \mu\text{V}$ 6.5 $\mu\text{V/V} + 30 \mu\text{V}$ 6.5 $\mu\text{V/V} + 99 \mu\text{V}$	Fluke 8558A multimeter	RDU
	(1 to 60) kV	0.035 % of rdg	Ross VD60 HV divider, Agilent 3458A multimeter	TPA
	(12 to 120) kV	0.018 % of rdg	Ross VD120 HV divider, Agilent 3458A multimeter	
DC High Voltage – Measure ³	(0 to 1) kV (1 to 10) kV (10 to 70) kV	0.03 % of rdg + 0.000 032 kV 0.03 % of rdg + 0.000 12 kV + 1.5 $\mu\text{V/V} \times (\text{Vin}/1000)^2$ 0.04% of rdg + 0.001 kV + 0.14 $\mu\text{V/V} \times (\text{Vin}/1000)^2$	Vitretek 4700 digital HV meter Vitretek 4700 Digital HV Meter w/HVL-70 high voltage probe	DFW
	(1 to 60) kV	0.1 % of rdg	Ross VD60 HV divider, Agilent 34401A multimeter	ATL, HRT, HLR,RDU, MEL, COS
	(1 to 150) kV	0.1 % of rdg	Ross VD150 HV divider, Agilent 34401A multimeter	HSV, RDU
	(1 to 30) kV	0.1 % of rdg	Ross VD30 HV divider, Fluke 89 IV multimeter	HSV

Parameter/Equipment	Range	CMC ^{2, 7} (±)	Comment	Location ¹⁰
DC High Voltage – Measure ³	(1 to 30) kV	0.1 % of rdg	Ross VD30 HV divider, Fluke 287 multimeter	COS
	(0 to 1) kV	0.03 % of rdg + 0.000 032 kV	Vitretek 4700 digital HV meter	RFD
	(1 to 10) kV	0.03 % of rdg + 0.000 12 kV + 1.5 µV/V x (Vin/1000) ²		
	(1 to 60) kV	0.1 % of rdg	Ross VD60 HV divider, Agilent 34401A multimeter	
	(1 to 120) kV	0.1 % of rdg	Ross VD60, VD120 HV divider, Agilent 34401A multimeter	RFD, MEL
	(1 to 40) kV	2.3 % of rdg	Fluke 80k-40 HV probe, Agilent 34401A multimeter	SFL
DC Voltage – Measure Fixed Points	10 mV 100 mV 1 V 10 V 100 V 1000 V	31 µV/V 3.2 µV/V 0.79 µV/V 0.72 µV/V 0.72 µV/V 0.74 µV/V	Fluke 732C reference standard / Guildline 7520 voltage divider	COS
DC Voltage – Measure Fixed Points	100 mV 1 V 10 V 100 V 1000 V	3.1 µV/V 0.46 µV/V 0.3 µV/V 0.34 µV/V 0.48 µV/V	Fluke 732B reference standard, 752A voltage divider	TPA
	100 mV 1 V 10 V 100 V 1000 V	3.1 µV/V 0.61 µV/V 0.5 µV/V 0.52 µV/V 0.63 µV/V	Fluke 732A reference standard, 752A voltage divider	RFD
AC Voltage – Generate ³	(0.22 to 2.2) mV (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	230 µV/V + 3.9 µV 88 µV/V + 3.9 µV 76 µV/V + 3.9 µV 190 µV/V + 3.9 µV 460 µV/V + 4.6 µV 990 µV/V + 9.2 µV 1.3 mV/V + 19 µV 2.6 mV/V + 19 µV	Fluke 5720A, 5730A multifunction calibrator	TPA, MEL, HSV, RFD, COS, RDU, ATL, SFL, HLR, DFW

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
AC Voltage – Generate ³	(2.2 to 22) mV (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	230 µV/V + 3.9 µV 88 µV/V + 3.9 µV 76 µV/V + 3.9 µV 190 µV/V + 3.9 µV 460 µV/V + 4.6 µV 990 µV/V + 9.2 µV 1.3 mV/V + 19 µV 2.6 mV/V + 19 µV	Fluke 5720A, 5730A multifunction calibrator	TPA, MEL, HSV, RFD, COS, RDU, ATL, SFL, HLR, DFW
	(22 to 220) mV (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz 220 mV to 2.2 V (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	230 µV/V + 11.4 µV 88 µV/V + 6.1 µV 53 µV/V + 6.1 µV 110 µV/V + 6.1 µV 300 µV/V + 15 µV 610 µV/V + 19 µV 1.3 mV/V + 23 µV 2.5 mV/V + 46 µV 230 µV/V + 38 µV 84 µV/V + 15 µV 37 µV/V + 8 µV 61 µV/V + 9 µV 76 µV/V + 30 µV 300 µV/V + 76 µV 910 µV/V + 190 µV 1.5 mV/V + 300 µV	Fluke 5730A multifunction calibrator	TPA, MEL, HSV, RFD, COS, RDU, DFW
	(0.22 to 2.2) mV (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz (2.2 to 22) mV (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	230 µV/V + 3.9 µV 88 µV/V + 3.9 µV 76 µV/V + 3.9 µV 190 µV/V + 3.9 µV 460 µV/V + 4.6 µV 990 µV/V + 9.2 µV 1.3 mV/V + 19 µV 2.6 mV/V + 19 µV 230 µV/V + 3.9 µV 88 µV/V + 3.9 µV 76 µV/V + 3.9 µV 190 µV/V + 3.9 µV 460 µV/V + 4.6 µV 990 µV/V + 9.2 µV 1.3 mV/V + 19 µV 2.6 mV/V + 19 µV	Fluke 5720A, 5730A multifunction calibrator	TPA, MEL, HSV, RFD, COS, RDU, ATL, SFL, HLR, DFW

Parameter/Range	Frequency	CMC ^{2, 7} ($\pm$)	Comment	Location ¹⁰
AC Voltage – Generate ³	(22 to 220) mV (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	230 μ V/V + 11 μ V 88 μ V/V + 6.1 μ V 76 μ V/V + 6.1 μ V 190 μ V/V + 6.1 μ V 460 μ V/V + 15 μ V 840 μ V/V + 19 μ V 1.3 mV/V + 23 μ V 2.5 mV/V + 46 μ V	Fluke 5720A, multifunction calibrator	ATL, SFL HLR
	220 mV to 2.2 V (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	230 μ V/V + 38 μ V 84 μ V/V + 15 μ V 40 μ V/V + 8 μ V 68 μ V/V + 9 μ V 99 μ V/V + 30 μ V 380 μ V/V + 76 μ V 910 μ V/V + 190 μ V 1.5 mV/V + 300 μ V		
	(2.2 to 22) V (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	230 μ V/V + 380 μ V 84 μ V/V + 152 μ V 40 μ V/V + 54 μ V 68 μ V/V + 91 μ V 91 μ V/V + 190 μ V 250 μ V/V + 610 μ V 910 μ V/V + 1.9 mV 1.4 mV/V + 3 mV	Fluke 5730A multifunction calibrator	TPA, MEL, HSV, RFD COS, RDU, DFW
	(2.2 to 22) V (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	230 μ V/V + 380 μ V 84 μ V/V + 160 μ V 37 μ V/V + 54 μ V 61 μ V/V + 91 μ V 76 μ V/V + 190 μ V 250 μ V/V + 610 μ V 920 μ V/V + 1.9 mV 1.4 mV/V + 3 mV		
	(22 to 220) V (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz	230 μ V/V + 3.8 mV 84 μ V/V + 1.6 mV 49 μ V/V + 0.6 mV 76 μ V/V + 0.9 mV 140 μ V/V + 2.3 mV	Fluke 5720A, 5730A multifunction calibrator	TPA, MEL, HSV, RFD COS, RDU ATL, SFL HLR, DFW

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
AC Voltage – Generate ³	(220 to 750) V 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz	68 µV/V + 3 mV 130 µV/V + 5 mV 460 µV/V + 8 mV 1.8 mV/V + 34 mV	Fluke 5700A, 5720A, 5730A multifunction calibrator / Fluke 5725A amplifier	TPA, MEL, HSV, RFD COS, RDU ATL, SFL HLR, HRT, DFW
	(750 to 1000) V 40 Hz to 1 kHz (1 to 20) kHz (20 to 30) kHz	68 µV/V + 3 mV 130 µV/V + 5 mV 460 µV/V + 8 mV		
	(0.22 to 2.2) mV (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	460 µV/V + 3.9 µV 180 µV/V + 3.9 µV 91 µV/V + 3.9 µV 310 µV/V + 3.9 µV 720 µV/V + 6.1 µV 990 µV/V + 11 µV 1.4 mV/V + 23 µV 3.7 mV/V + 30 µV		
	(2.2 to 22) mV (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	460 µV/V + 4.6 µV 180 µV/V + 4.6 µV 91 µV/V + 4.6 µV 310 µV/V + 4.6 µV 720 µV/V + 6.1 µV 990 µV/V + 11 µV 1.4 mV/V + 23 µV 3.7 mV/V + 30 µV	Fluke 5700A multifunction calibrator	HRT
	(22 to 220) mV (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	460 µV/V + 12 µV 180 µV/V + 7.6 µV 84 µV/V + 7.6 µV 270 µV/V + 7.6 µV 690 µV/V + 23 µV 840 µV/V + 23 µV 1.4 mV/V + 30 µV 2.7 mV/V + 76 µV		
	220 mV to 2.2 V (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	460 µV/V + 8 µV 140 µV/V + 23 µV 65 µV/V + 5 µV 110 µV/V + 15 µV 210 µV/V + 61 µV 370 µV/V + 110 µV 910 µV/V + 300 µV 1.8 mV/V + 760 µV		



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
AC Voltage – Generate ³	(2.2 to 22) V (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	460 µV/V + 760 µV 140 µV/V + 230 µV 65 µV/V + 54 µV 110 µV/V + 150 µV 210 µV/V + 300 µV 460 µV/V + 1300 µV 1.1 mV/V + 3800 µV 2.3 mV/V + 6800 µV	Fluke 5700A multifunction calibrator	HRT
	(22 to 220) V (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz	457 µV/V + 7.6 mV 137 µV/V + 2.4 mV 68 µV/V + 1.0 mV 190 µV/V + 3.1 mV 460 µV/V + 7.6 mV		
AC Voltage – Generate ³	(1 to 12) mV (3 to 5) Hz (5 to 10) Hz 10 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz	0.19 % + 5.3 µV 0.067 % + 5.3 µV 0.011 % + 4.6 µV 0.029 % + 4.6 µV 0.11 % + 11 µV 0.61 % + 23 µV 0.61 % + 23 µV	Fluke 5560A multiproduct calibrator	COS, HRT, MEL, ATL RDU, TPA, RFD, HSV, DFW
	(12 to 120) mV (3 to 5) Hz (5 to 10) Hz 10 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz	0.19 % + 5.3 µV 0.067 % + 5.3 µV 0.011 % + 4.6 µV 0.027 % + 6.1 µV 0.061 % + 15 µV 0.15 % + 23 µV 0.15 % + 23 µV		
	(0.12 to 1.2) V (3 to 5) Hz (5 to 10) Hz (10 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz	0.19 % + 57 µV 0.067 % + 53 µV 0.011 % + 46 µV 0.011 % + 6 µV 0.023 % + 11 µV 0.053 % + 30 µV 0.15 % + 61 µV 0.15 % + 61 µV		
	(1.2 to 12) V (3 to 5) Hz (5 to 10) Hz (10 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz	0.19 % + 0.57 mV 0.067 % + 0.57 mV 0.011 % + 0.27 mV 0.011 % + 0.04 mV 0.023 % + 0.04 mV 0.053 % + 0.10 mV 0.15 % + 0.46 mV 0.15 % + 0.46 mV		

Parameter/Range	Frequency	CMC ^{2,7} (±)	Comment	Location ¹⁰
AC Voltage – Generate ³	(12 to 70) V (3 to 5) Hz (5 to 10) Hz (10 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz	0.19 % + 5.7 mV 0.067 % + 5.7 mV 0.011 % + 2.7 mV 0.011 % + 0.38 mV 0.023 % + 0.38 mV 0.053 % + 1.0 mV 0.15 % + 15 mV	Fluke 5560A multiproduct calibrator	COS, HRT, MEL, ATL RDU, TPA, RFD, HSV, DFW
	(70 to 120) V (3 to 5) Hz (5 to 10) Hz (10 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz	0.19 % + 5.7 mV 0.067 % + 5.7 mV 0.011 % + 2.7 mV 0.011 % + 0.38 mV 0.023 % + 0.38 mV 0.053 % + 1.0 mV		
	(120 to 330) V (3 to 5) Hz (5 to 10) Hz 10 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz	0.19 % + 57 mV 0.067 % + 57 mV 0.011 % + 6.1 mV 0.023 % + 6.1 mV 0.11 % + 9.5 mV		
	(330 to 1020) V (3 to 5) Hz (5 to 10) Hz 10 Hz to 10 kHz	0.19 % + 57 mV 0.067 % + 57 mV 0.011 % + 61 mV		
AC Voltage – Generate Wideband Absolute ³	(0.3 to 1.1) mV (10 to 30) Hz 30 Hz to 500 kHz (0.5 to 1.2) MHz (1.2 to 2) MHz (2 to 12) MHz (12 to 20) MHz (20 to 30) MHz	0.65 % of output + 1.5 µV 0.61 % of output + 1.5 µV 0.63 % of output + 3.8 µV 0.63 % of output + 3.8 µV 0.68 % of output + 3.8 µV 0.76 % of output + 3.8 µV 1.3 % of output + 13 µV	Fluke 5700A, 5720A, 5730A multifunction calibrator	TPA, ATL HSV, RFD, HRT, HLR, SFL, MEL, COS, RDU, DFW
	(1.1 to 3.3) mV (10 to 30) Hz 30 Hz to 500 kHz (0.5 to 1.2) MHz (1.2 to 2) MHz (2 to 12) MHz (12 to 20) MHz (20 to 30) MHz	0.58 % of output + 2.3 µV 0.53 % of output + 2.3 µV 0.54 % of output + 4.6 µV 0.54 % of output + 4.6 µV 0.58 % of output + 4.6 µV 0.65 % of output + 4.6 µV 1.3 % of output + 4.6 µV		



Parameter/Range	Frequency	CMC ^{2,7} (±)	Comment	Location ¹⁰
AC Voltage – Generate Wideband Absolute ³	(3.3 to 11) mV (10 to 30) Hz	0.58 % of output + 6.1 µV	Fluke 5700A, 5720A, 5730A multifunction calibrator	TPA, ATL, HSV, RFD, HRT, HLR, SFL, MEL, COS, RDU, DFW
	30 Hz to 500 kHz	0.53 % of output + 6.1 µV		
	(0.5 to 1.2) MHz	0.54 % of output + 8.4 µV		
	(1.2 to 2) MHz	0.54 % of output + 8.4 µV		
	(2 to 12) MHz	0.55 % of output + 8.4 µV		
	(12 to 20) MHz	0.61 % of output + 8.4 µV		
	(20 to 30) MHz	0.93 % of output + 8.4 µV		
	(11 to 33) mV (10 to 30) Hz	0.52 % of output + 12 µV		
	30 Hz to 500 kHz	0.46 % of output + 12 µV		
	(0.5 to 1.2) MHz	0.47 % of output + 14 µV		
	(1.2 to 2) MHz	0.47 % of output + 14 µV		
	(2 to 12) MHz	0.49 % of output + 14 µV		
	(12 to 20) MHz	0.55 % of output + 14 µV		
	(20 to 30) MHz	0.89 % of output + 14 µV		
	(33 to 110) mV (10 to 30) Hz	0.52 % of output + 30 µV		
	30 Hz to 500 kHz	0.46 % of output + 30 µV		
	(0.5 to 1.2) MHz	0.47 % of output + 33 µV		
	(1.2 to 2) MHz	0.47 % of output + 33 µV		
	(2 to 12) MHz	0.49 % of output + 33 µV		
	(12 to 20) MHz	0.55 % of output + 33 µV		
	(20 to 30) MHz	0.89 % of output + 33 µV		
	(110 to 330) mV (10 to 30) Hz	0.45 % of output + 0.1 mV		
	30 Hz to 500 kHz	0.38 % of output + 0.1 mV		
	(0.5 to 1.2) MHz	0.4 % of output + 0.1 mV		
	(1.2 to 2) MHz	0.4 % of output + 0.1 mV		
	(2 to 12) MHz	0.42 % of output + 0.1 mV		
	(12 to 20) MHz	0.49 % of output + 0.1 mV		
	(20 to 30) MHz	0.85 % of output + 0.1 mV		
	(0.33 to 1.1) V (10 to 30) Hz	0.45 % of output + 0.3 mV		
	30 Hz to 500 kHz	0.38 % of output + 0.3 mV		
	(0.5 to 1.2) MHz	0.4 % of output + 0.3 mV		
	(1.2 to 2) MHz	0.4 % of output + 0.3 mV		
	(2 to 12) MHz	0.42 % of output + 0.3 mV		
	(12 to 20) MHz	0.49 % of output + 0.3 mV		
	(20 to 30) MHz	0.85 % of output + 0.3 mV		
	(1.1 to 3.5) V (10 to 30) Hz	0.39 % of output + 0.4 mV		
	30 Hz to 500 kHz	0.3 % of output + 0.4 mV		
	(0.5 to 1.2) MHz	0.32 % of output + 0.4 mV		
	(1.2 to 2) MHz	0.32 % of output + 0.4 mV		
	(2 to 12) MHz	0.35 % of output + 0.4 mV		
	(12 to 20) MHz	0.44 % of output + 0.4 mV		
	(20 to 30) MHz	0.82 % of output + 0.4 mV		



Parameter/Range	Frequency	CMC ^{2,7} (±)	Comment	Location ¹⁰
AC Voltage – Measure ³	Up to 2.2 mV (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	1.3 mV/V + 1.2 µV 560 µV/V + 1.2 µV 320 µV/V + 1.2 µV 620 µV/V + 1.7 µV 910 µV/V + 2 µV 1.8 mV/V + 3.1 µV 1.8 mV/V + 6.1 µV 2.7 mV/V + 6.1 µV	Fluke 5790B AC/DC transfer standard	TPA, RFD, COS
	(2.2 to 7) mV (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	650 µV/V + 1.2 µV 280 µV/V + 1.2 µV 160 µV/V + 1.2 µV 300 µV/V + 1.7 µV 460 µV/V + 2 µV 910 µV/V + 3.1 µV 990 µV/V + 6.1 µV 1.8 mV/V + 6.1 µV		
AC Voltage – Measure ³	(7 to 22) mV (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	220 µV/V + 1.2 µV 150 µV/V + 1.2 µV 84 µV/V + 1.2 µV 160 µV/V + 1.7 µV 240 µV/V + 2 µV 620 µV/V + 3.1 µV 680 µV/V + 6.1 µV 1.3 mV/V + 6.1 µV	Fluke 5790B AC/DC transfer standard	TPA, RFD, COS
	(22 to 70) mV (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	180 µV/V + 1.3 µV 91 µV/V + 1.3 µV 49 µV/V + 1.3 µV 99 µV/V + 1.7 µV 200 µV/V + 2 µV 390 µV/V + 3.1 µV 510 µV/V + 6.1 µV 840 µV/V + 6.1 µV		
	(70 to 220) mV (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	160 µV/V + 1.3 µV 65 µV/V + 1.3 µV 29 µV/V + 1.3 µV 53 µV/V + 1.7 µV 120 µV/V + 2 µV 190 µV/V + 3.1 µV 290 µV/V + 6.1 µV 760 µV/V + 6.1 µV		

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
AC Voltage – Measure ³	(220 to 700) mV		Fluke 5790B AC/DC transfer standard	TPA, RFD, COS
	(10 to 20) Hz	160 µV/V + 1.3 µV		
	(20 to 40) Hz	58 µV/V + 1.3 µV		
	40 Hz to 20 kHz	25 µV/V + 1.3 µV		
	(20 to 50) kHz	39 µV/V + 1.7 µV		
	(50 to 100) kHz	60 µV/V + 2 µV		
	(100 to 300) kHz	140 µV/V + 3.1 µV		
	(300 to 500) kHz	230 µV/V + 6.1 µV		
	500 kHz to 1 MHz	730 µV/V + 6.1 µV		
	700 mV to 2.2 V			
	(10 to 20) Hz	150 µV/V + 0.7 µV		
	(20 to 40) Hz	50 µV/V + 0.7 µV		
	40 Hz to 20 kHz	18 µV/V + 0.7 µV		
	(20 to 50) kHz	35 µV/V + 0.7 µV		
	(50 to 100) kHz	54 µV/V + 0.7 µV		
	(100 to 300) kHz	120 µV/V + 0.7 µV		
	(300 to 500) kHz	200 µV/V + 0.7 µV		
	500 kHz to 1 MHz	690 µV/V + 0.7 µV		
	(2.2 to 7) V			
	(10 to 20) Hz	150 µV/V + 0.9 µV		
	(20 to 40) Hz	51 µV/V + 0.9 µV		
	40 Hz to 20 kHz	18 µV/V + 0.9 µV		
	(20 to 50) kHz	37 µV/V + 0.9 µV		
	(50 to 100) kHz	62 µV/V + 0.9 µV		
	(100 to 300) kHz	150 µV/V + 0.9 µV		
	(300 to 500) kHz	300 µV/V + 0.9 µV		
	500 kHz to 1 MHz	910 µV/V + 0.9 µV		
	(7 to 22) V			
	(10 to 20) Hz	150 µV/V + 0.9 µV		
	(20 to 40) Hz	51 µV/V + 0.9 µV		
	40 Hz to 20 kHz	21 µV/V + 0.9 µV		
	(20 to 50) kHz	37 µV/V + 0.9 µV		
	(50 to 100) kHz	62 µV/V + 0.9 µV		
	(100 to 300) kHz	150 µV/V + 0.9 µV		
	(300 to 500) kHz	300 µV/V + 0.9 µV		
	500 kHz to 1 MHz	910 µV/V + 0.9 µV		
	(22 to 70) V			
	(10 to 20) Hz	150 µV/V + 5.7 µV		
	(20 to 40) Hz	52 µV/V + 5.7 µV		
	40 Hz to 20 kHz	24 µV/V + 5.7 µV		
	(20 to 50) kHz	43 µV/V + 5.7 µV		
	(50 to 100) kHz	72 µV/V + 5.7 µV		
	(100 to 300) kHz	150 µV/V + 5.7 µV		
	(70 to 220) V			
	(10 to 20) Hz	150 µV/V + 5.7 µV		
	(20 to 40) Hz	52 µV/V + 5.7 µV		
	40 Hz to 20 kHz	24 µV/V + 5.7 µV		
	(20 to 50) kHz	53 µV/V + 5.7 µV		
	(50 to 100) kHz	75 µV/V + 5.7 µV		

Parameter/Range	Frequency	CMC ^{2,7} (±)	Comment	Location ¹⁰
AC Voltage – Measure ³	(220 to 700) V 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz	31 $\mu\text{V/V} + 57 \mu\text{V}$ 99 $\mu\text{V/V} + 57 \mu\text{V}$ 380 $\mu\text{V/V} + 57 \mu\text{V}$	Fluke 5790B AC/DC transfer standard	TPA, RFD, COS
	(700 to 1000) V 40 Hz to 20 kHz (20 to 30) kHz	29 $\mu\text{V/V} + 57 \mu\text{V}$ 99 $\mu\text{V/V} + 57 \mu\text{V}$		
AC High Voltage – Measure ³	60 Hz (1 to 10) kV (10 to 42) kV	0.5 % of rdg + 0.002 kV 0.5 % of rdg + 0.02 kV	Ross VD60 HV divider, Agilent 34401A multimeter	TPA, RFD ATL, HRT, HLR, MEL, COS, RDU
	60 Hz (1 to 10) kV (10 to 85) kV	0.5 % of rdg + 0.002 kV 0.5 % of rdg + 0.02 kV	Ross VD120 HV divider, Agilent 34401A multimeter	TPA, RFD, MEL
	60Hz (1 to 28) kV	5.8 % of rdg	Fluke 80k-40 HV probe, Agilent 34401A multimeter	SFL
	60Hz (1 to 5) kV (5 to 21) kV	0.5 % of rdg 0.5 % of rdg	Ross VD30 HV divider, Fluke 287 multimeter	COS
	(0 to 1) kV (30 to 200) Hz (200 to 450) Hz	0.12 % of rdg + 0.0001 kV 0.12 % of rdg + 0.000 15 kV + 0.14 $\mu\text{V/V} \times (\text{Vin}/1000)^2$	Vitretek 4700 Digital HV meter	DFW
	(1 to 10) kV (30 to 200) Hz (200 to 450) Hz	0.4 % of rdg + 0.0001 kV 0.4 % of rdg + 0.000 15 kV + 0.14 $\mu\text{V/V} \times (\text{Vin}/1000)^2$		
	(10 to 70) kV (30 to 100) Hz (100 to 200) Hz (200 to 450) Hz	0.12 % of rdg + 0.001 kV 0.6 % of rdg + 0.001 kV 2.5 % of rdg + 0.001 kV + + 0.14 $\mu\text{V/V} \times (\text{Vin}/1000)^2$	Vitretek 4700 Digital HV meter w/HVL-70 high voltage probe	
	(0 to 1) kV (30 to 200) Hz (200 to 450) Hz	0.12 % of rdg + 0.0001 kV 0.12 % of rdg + 0.000 15 kV + 1.5 $\mu\text{V/V} \times (\text{Vin}/1000)^2$	Vitretek 4700 HV meter	RFD
	(1 to 10) kV (30 to 200) Hz (200 to 450) Hz	0.4 % of rdg + 0.0001 kV 0.4 % of rdg + 0.000 15 kV + 1.5 $\mu\text{V/V} \times (\text{Vin}/1000)^2$		

Parameter/Range	Frequency	CMC ^{2, 7} ($\pm$)	Comment	Location ¹⁰
AC High Voltage – Measure ³	60 Hz (0 to 5) kV (5 to 21) kV	0.5 % of rdg 0.5 % of rdg	Ross VD30 HV divider, Agilent 34401A multimeter	RDU
	60 Hz (1 to 21) kV	0.5 % of rdg + 0.002 kV	Ross VD30 high voltage divider, Fluke 89 IV multimeter	HSV
	60 Hz (1 to 10) kV (10 to 100) kV	0.5 % of rdg + 0.002 kV 0.5 % of rdg + 0.02 kV	Ross VD150 high voltage divider, HP 34401A multimeter	HSV, RDU
AC Voltage – Measure ³	(1 to 10) mV (1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz 100 kHz to 1 MHz (1 to 4) MHz (4 to 8) MHz (10 to 100) mV (1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz (1 to 2) MHz (2 to 4) MHz (4 to 8) MHz (8 to 10) MHz (0.1 to 1) V (1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz (1 to 2) MHz (2 to 4) MHz (4 to 8) MHz (8 to 10) MHz	0.02 % of rdg + 2.0 μ V 0.013 % of rdg + 0.7 μ V 0.02 % of rdg + 0.7 μ V 0.065 % of rdg + 0.7 μ V 0.33 % of rdg + 0.7 μ V 0.78 % of rdg + 3.3 μ V 4.6 % of rdg + 4.6 μ V 13 % of rdg + 5.3 μ V 0.005 % of rdg + 2.6 μ V 0.005 % of rdg + 1.3 μ V 0.009 % of rdg + 1.3 μ V 0.02 % of rdg + 1.3 μ V 0.052 % of rdg + 1.3 μ V 0.20 % of rdg + 6.5 μ V 0.65 % of rdg + 6.5 μ V 0.98 % of rdg + 46 μ V 2.6 % of rdg + 46 μ V 2.6 % of rdg + 52 μ V 9.8 % of rdg + 65 μ V 0.005 % of rdg + 26 μ V 0.005 % of rdg + 13 μ V 0.009 % of rdg + 13 μ V 0.02 % of rdg + 13 μ V 0.052 % of rdg + 13 μ V 0.2 % of rdg + 65 μ V 0.65 % of rdg + 65 μ V 0.98 % of rdg + 0.5 mV 2.6 % of rdg + 0.5 mV 2.6 % of rdg + 0.5 mV 9.8 % of rdg + 0.7 mV	Agilent 3458A multimeter	TPA, ATL, HSV, RFD, HRT, HLR, MEL, COS, RDU, SFL, DFW



Parameter/Range	Frequency	CMC ^{2,7} (±)	Comment	Location ¹⁰
AC Voltage – Measure ³	(1 to 10) V (1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz (1 to 2) MHz (2 to 4) MHz (4 to 8) MHz (8 to 10) MHz	0.005 % of rdg + 0.3 mV 0.005 % of rdg + 0.1 mV 0.009 % of rdg + 0.1 mV 0.02 % of rdg + 0.1 mV 0.052 % of rdg + 0.1 mV 0.2 % of rdg + 0.7 mV 0.65 % of rdg + 0.7 mV 0.98 % of rdg + 4.6 mV 2.6 % of rdg + 4.6 mV 2.6 % of rdg + 5.2 mV 9.8 % of rdg + 6.5 mV	Agilent 3458A multimeter	TPA, ATL, HSV, RFD, HRT, HLR, MEL, COS, RDU, SFL, DFW
	(10 to 100) V (1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz	0.013 % of rdg + 2.6 mV 0.013 % of rdg + 1.3 mV 0.013 % of rdg + 1.3 mV 0.023 % of rdg + 1.3 mV 0.08 % of rdg + 1.3 mV 0.26 % of rdg + 6.5 mV 0.98 % of rdg + 6.5 mV		
	(100 to 700) V (1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz	0.026 % of rdg + 26 mV 0.026 % of rdg + 13 mV 0.039 % of rdg + 13 mV 0.078 % of rdg + 13 mV 0.20 % of rdg + 13 mV		
	(1.2 to 12.12) mV (1 to 2000) Hz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz (100 to 300) kHz (0.3 to 1) MHz (12.12 to 121.2) mV (1 to 2000) Hz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz (100 to 300) kHz (0.3 to 1 MHz) (1 to 2) MHz (2 to 4) MHz (4 to 8) MHz (8 to 10) MHz	0.028 % of rdg + 1.2 µV 0.036 % of rdg + 1.2 µV 0.037 % of rdg + 1.2 µV 0.30 % of rdg + 0.9 µV 0.99 % of rdg + 3.9 µV 2 % of rdg + 3.9 µV 0.009 % of rdg + 0.6 µV 0.013 % of rdg + 0.6 µV 0.023 % of rdg + 1.1 µV 0.052 % of rdg + 5.1 µV 0.21 % of rdg + 31 µV 0.99 % of rdg + 0.1 mV 1.5 % of rdg + 0.5 mV 4 % of rdg + 1.0 mV 8.2 % of rdg + 1.0 mV 15 % of rdg + 1.0 mV	Fluke 8588A multimeter	ATL, RFD, DFW, COS



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
AC Voltage – Measure ³	(0.1212 to 1.212) V		Fluke 8588A multimeter	ATL, RFD, DFW, COS
	(1 to 2000) Hz	0.007 % of rdg + 0.006 mV		
	(2 to 10) kHz	0.012 % of rdg + 0.006 mV		
	(10 to 30) kHz	0.023 % of rdg + 0.011 mV		
	(30 to 100) kHz	0.052 % of rdg + 0.05 mV		
	(100 to 300) kHz	0.21 % of rdg + 0.31 mV		
	(0.3 to 1) MHz	0.99 % of rdg + 0.99 mV		
	(1 to 2) MHz	1.5 % of rdg + 4.9 mV		
	(2 to 4) MHz	4 % of rdg + 9.8 mV		
	(4 to 8) MHz	8.1 % of rdg + 9.8 mV		
	(8 to 10) MHz	15 % of rdg + 9.8 mV		
	(1.212 to 12.12) V			
	(1 to 2000) Hz	0.007 % of rdg + 0.06 mV		
	(2 to 10) kHz	0.012 % of rdg + 0.06 mV		
	(10 to 30) kHz	0.023 % of rdg + 0.11 mV		
	(30 to 100) kHz	0.052 % of rdg + 0.52 mV		
	(100 to 300) kHz	0.21 % of rdg + 3.1 mV		
	(0.3 to 1) MHz	0.99 % of rdg + 9.9 mV		
	(1 to 2) MHz	1.5 % of rdg + 49 mV		
	(2 to 4) MHz	4 % of rdg + 98 mV		
	(4 to 8) MHz	8.1 % of rdg + 98 mV		
	(8 to 10) MHz	15 % of rdg + 98 mV		
	(12.12 to 121.2) V			
	(1 to 2000) Hz	0.009 % of rdg + 0.6 mV		
	(2 to 10) kHz	0.011 % of rdg + 0.6 mV		
	(10 to 30) kHz	0.023 % of rdg + 1.1 mV		
	(30 to 100) kHz	0.058 % of rdg + 5.1 mV		
	(100 to 200) kHz	0.37 % of rdg + 46 mV		
	(121.2 to 1050) V			
	(1 to 2000) Hz	0.011 % of rdg + 26 mV		
	(2 to 10) kHz	0.011 % of rdg + 26 mV		
	(10 to 30) kHz	0.023 % of rdg + 26 mV		
AC Voltage – Measure ³	(1.2 to 12.12) mV		Fluke 8558A multimeter	RDU
	(1 to 2000) Hz	0.06 % of rdg + 2.0 µV		
	(2 to 10) kHz	0.045 % of rdg + 2.0 µV		
	(10 to 30) kHz	0.046 % of rdg + 2.0 µV		
	(30 to 100) kHz	0.42 % of rdg + 2.0 µV		
	(100 to 300) kHz	1.6 % of rdg + 5.9 µV		
	(0.3 to 1) MHz	2.5 % of rdg + 5.9 µV		



Parameter/Range	Frequency	CMC ^{2,7} (±)	Comment	Location ¹⁰
AC Voltage – Measure ³	(12.12 to 121.2) mV			
	(1 to 2000) Hz	0.011 % of rdg + 1.0 µV		
	(2 to 10) kHz	0.015 % of rdg + 1.0 µV		
	(10 to 30) kHz	0.025 % of rdg + 2.0 µV		
	(30 to 100) kHz	0.057 % of rdg + 20 µV		
	(100 to 300) kHz	0.34 % of rdg + 50 µV		
	(0.3 to 1 MHz)	1.4 % of rdg + 0.2 mV		
	(1 to 2) MHz	1.6 % of rdg + 0.7 mV		
	(2 to 4) MHz	4.6 % of rdg + 1.2 mV		
	(4 to 8) MHz	9.2 % of rdg + 1.2 mV		
	(8 to 10) MHz	18 % of rdg + 1.2 mV		
	(0.1212 to 1.212) V			
	(1 to 2000) Hz	0.010 % of rdg + 0.01 mV		
	(2 to 10) kHz	0.014 % of rdg + 0.01 mV		
	(10 to 30) kHz	0.025 % of rdg + 0.02 mV		
	(30 to 100) kHz	0.057 % of rdg + 0.20 mV		
	(100 to 300) kHz	0.26 % of rdg + 0.5 mV		
	(0.3 to 1 MHz)	1.4 % of rdg + 2 mV		
	(1 to 2) MHz	1.6 % of rdg + 7 mV		
	(2 to 4) MHz	4.6 % of rdg + 12 mV		
	(4 to 8) MHz	9.1 % of rdg + 12 mV		
	(8 to 10) MHz	18 % of rdg + 12 mV		
	(1.212 to 12.12) V			
	(1 to 2000) Hz	0.010 % of rdg + 0.1 mV		
	(2 to 10) kHz	0.014 % of rdg + 0.1 mV		
	(10 to 30) kHz	0.025 % of rdg + 0.2 mV		
	(30 to 100) kHz	0.057 % of rdg + 2.0 mV		
	(100 to 300) kHz	0.26 % of rdg + 5.0 mV		
	(0.3 to 1 MHz)	1.38 % of rdg + 20 mV		
	(1 to 2) MHz	1.6 % of rdg + 70 mV		
	(2 to 4) MHz	4.6 % of rdg + 120 mV		
	(4 to 8) MHz	9.1 % of rdg + 120 mV		
	(8 to 10) MHz	18 % of rdg + 120 mV		
	(12.12 to 121.2) V			
	(1 to 2000) Hz	0.011 % of rdg + 1.0 mV		
	(2 to 10) kHz	0.015 % of rdg + 1.0 mV		
	(10 to 30) kHz	0.025 % of rdg + 2.0 mV		
	(30 to 100) kHz	0.063 % of rdg + 20 mV		
	(100 to 200) kHz	0.43 % of rdg + 100 mV		
	(121.2 to 1050) V			
	(1 to 1000) Hz	0.016 % of rdg + 30 mV		
	(2 to 10) kHz	0.018 % of rdg + 30 mV		
	(10 to 30) kHz	0.032 % of rdg + 30 mV		

Fluke 8558A
multimeter

RDU



Parameter/Range	Frequency	CMC ^{2,7} (±)	Comment	Location ¹⁰
AC Voltage Measure, Fixed Points	(22 to 2) mV			
	10 Hz	370 µV/V		
	20 Hz	370 µV/V		
	40 Hz	360 µV/V		
	100 Hz	360 µV/V		
	1 kHz	360 µV/V		
	10 kHz	360 µV/V		
	20 kHz	360 µV/V		
	50 kHz	360 µV/V		
	100 kHz	450 µV/V		
	300 kHz	540 µV/V		
	500 kHz	630 µV/V		
	800 kHz	730 µV/V		
	1 MHz	730 µV/V		
	(22 to 6) mV			
	10 Hz	220 µV/V		
	20 Hz	201 µV/V		
	40 Hz	180 µV/V		
	100 Hz	180 µV/V		
	1 kHz	180 µV/V		
	10 kHz	180 µV/V		
	20 kHz	180 µV/V		
	50 kHz	220 µV/V		
	100 kHz	290 µV/V		
	300 kHz	410 µV/V		
	500 kHz	470 µV/V		
	800 kHz	560 µV/V		
	1 MHz	600 µV/V		
	(22 to 10) mV			
	10 Hz	92 µV/V		
	20 Hz	83 µV/V		
	40 Hz	83 µV/V		
	100 Hz	83 µV/V		
	1 kHz	83 µV/V		
	10 kHz	83 µV/V		
	20 kHz	83 µV/V		
	50 kHz	92 µV/V		
	100 kHz	150 µV/V		
	300 kHz	220 µV/V		
	500 kHz	280 µV/V		
	800 kHz	320 µV/V		
	1 MHz	360 µV/V		
			Fluke 792A AC/DC transfer standard / 5730A multifunction calibrator / HP 3458A multimeter	COS

Parameter/Range	Frequency	CMC ^{2, 7} ($\pm$)	Comment	Location ¹⁰
AC Voltage Measure, Fixed Points	(22 to 20) mV			
	10 Hz	79 μ V/V		
	20 Hz	65 μ V/V		
	40 Hz	65 μ V/V		
	100 Hz	65 μ V/V		
	1 kHz	65 μ V/V		
	10 kHz	65 μ V/V		
	20 kHz	65 μ V/V		
	50 kHz	84 μ V/V		
	100 kHz	140 μ V/V		
	300 kHz	220 μ V/V		
	500 kHz	300 μ V/V		
	800 kHz	370 μ V/V		
	1 MHz	360 μ V/V		
	(220 to 20) mV			
	10 Hz	89 μ V/V		
	20 Hz	79 μ V/V		
	40 Hz	79 μ V/V		
	100 Hz	65 μ V/V		
	1 kHz	65 μ V/V		
	10 kHz	65 μ V/V		
	20 kHz	65 μ V/V		
	50 kHz	84 μ V/V		
	100 kHz	140 μ V/V		
	300 kHz	210 μ V/V		
	500 kHz	280 μ V/V		
	800 kHz	320 μ V/V		
	1 MHz	360 μ V/V		
	(220 to 60) mV			
	10 Hz	61 μ V/V		
	20 Hz	38 μ V/V		
	40 Hz	34 μ V/V		
	100 Hz	34 μ V/V		
	1 kHz	34 μ V/V		
	10 kHz	37 μ V/V		
	20 kHz	35 μ V/V		
	(220 to 60) mV			
	50 kHz	38 μ V/V		
	100 kHz	75 μ V/V		
	300 kHz	140 μ V/V		
	500 kHz	210 μ V/V		
	800 kHz	280 μ V/V		
	1 MHz	280 μ V/V		
			Fluke 792A AC/DC transfer standard / 5730A multifunction calibrator / HP 3458A multimeter	COS

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
AC Voltage Measure, Fixed Points	(220 to 100) mV			
	10 Hz	41 µV/V		
	20 Hz	27 µV/V		
	40 Hz	16 µV/V		
	100 Hz	16 µV/V		
	1 kHz	16 µV/V		
	10 kHz	16 µV/V		
	20 kHz	16 µV/V		
	50 kHz	26 µV/V		
	100 kHz	41 µV/V		
	300 kHz	81 µV/V		
	500 kHz	120 µV/V		
	800 kHz	180 µV/V		
	1 MHz	180 µV/V		
	(220 to 200) mV			
	10 Hz	26 µV/V		
	20 Hz	22 µV/V		
	40 Hz	13 µV/V		
	100 Hz	13 µV/V		
	1 kHz	13 µV/V		
	10 kHz	13 µV/V		
	20 kHz	13 µV/V		
	50 kHz	22 µV/V		
	100 kHz	41 µV/V		
	300 kHz	76 µV/V		
	500 kHz	110 µV/V		
	800 kHz	160 µV/V		
	1 MHz	180 µV/V		
	(700 to 200) mV			
	10 Hz	27 µV/V		
	20 Hz	22 µV/V		
	40 Hz	13 µV/V		
	100 Hz	13 µV/V		
	1 kHz	13 µV/V		
	10 kHz	13 µV/V		
	20 kHz	13 µV/V		
	50 kHz	22 µV/V		
	100 kHz	41 µV/V		
	300 kHz	76 µV/V		
	500 kHz	110 µV/V		
	800 kHz	160 µV/V		
	1 MHz	180 µV/V		
			Fluke 792A AC/DC transfer standard / 5730A multifunction calibrator / HP 3458A multimeter	COS



Parameter/Range	Frequency	CMC ^{2, 7} ($\pm$)	Comment	Location ¹⁰
AC Voltage Measure, Fixed Points	(700 to 600) mV			
	10 Hz	26 μ V/V		
	20 Hz	19 μ V/V		
	40 Hz	8 μ V/V		
	100 Hz	9 μ V/V		
	1 kHz	8 μ V/V		
	10 kHz	8 μ V/V		
	20 kHz	8 μ V/V		
	50 kHz	9 μ V/V		
	100 kHz	13 μ V/V		
	300 kHz	26 μ V/V		
	500 kHz	31 μ V/V		
	800 kHz	50 μ V/V		
	1 MHz	60 μ V/V		
	2.2 V to 600 mV			
	10 Hz	26 μ V/V		
	20 Hz	16 μ V/V		
	40 Hz	8 μ V/V		
	100 Hz	8 μ V/V		
	1 kHz	8 μ V/V		
	10 kHz	8 μ V/V		
	20 kHz	8 μ V/V		
	50 kHz	9 μ V/V		
	100 kHz	12 μ V/V		
	300 kHz	22 μ V/V		
	500 kHz	26 μ V/V		
	800 kHz	31 μ V/V		
	1 MHz	40 μ V/V		
	(2.2 to 1) V			
	10 Hz	26 μ V/V		
	20 Hz	16 μ V/V		
	40 Hz	7 μ V/V		
	100 Hz	7 μ V/V		
	1 kHz	7 μ V/V		
	10 kHz	7 μ V/V		
	20 kHz	7 μ V/V		
	50 kHz	9 μ V/V		
	100 kHz	11 μ V/V		
	300 kHz	21 μ V/V		
	500 kHz	26 μ V/V		
	800 kHz	30 μ V/V		
	1 MHz	40 μ V/V		
	(2.2 to 2) V			
	10 Hz	25 μ V/V		
	20 Hz	16 μ V/V		
	40 Hz	7 μ V/V		
	100 Hz	7 μ V/V		
	1 kHz	7 μ V/V		
	10 kHz	7 μ V/V		
	20 kHz	7 μ V/V		
			Fluke 792A AC/DC transfer standard / 5730A multifunction calibrator / HP 3458A multimeter	COS



Parameter/Range	Frequency	CMC ^{2, 7} ($\pm$)	Comment	Location ¹⁰
AC Voltage Measure, Fixed Points	(2.2 to 2) V			
	50 kHz	7 μ V/V		
	100 kHz	11 μ V/V		
	300 kHz	21 μ V/V		
	500 kHz	25 μ V/V		
	800 kHz	30 μ V/V		
	1 MHz	40 μ V/V		
	(7 to 2) V			
	10 Hz	26 μ V/V		
	20 Hz	16 μ V/V		
	40 Hz	9 μ V/V		
	100 Hz	7 μ V/V		
	1 kHz	7 μ V/V		
	10 kHz	7 μ V/V		
	20 kHz	7 μ V/V		
	50 kHz	8 μ V/V		
	100 kHz	11 μ V/V		
	300 kHz	21 μ V/V		
	500 kHz	26 μ V/V		
	800 kHz	30 μ V/V		
	1 MHz	40 μ V/V		
	(7 to 6) V			
	10 Hz	25 μ V/V		
	20 Hz	5 μ V/V		
	40 Hz	6 μ V/V		
	100 Hz	6 μ V/V		
	1 kHz	6 μ V/V		
	10 kHz	6 μ V/V		
	20 kHz	6 μ V/V		
	50 kHz	7 μ V/V		
	100 kHz	8 μ V/V		
	300 kHz	20 μ V/V		
	500 kHz	25 μ V/V		
	800 kHz	30 μ V/V		
	1 MHz	40 μ V/V		
	(22 to 6) V			
	10 Hz	25 μ V/V		
	20 Hz	15 μ V/V		
	40 Hz	6 μ V/V		
	100 Hz	6 μ V/V		
	1 kHz	6 μ V/V		
	10 kHz	6 μ V/V		
	20 kHz	6 μ V/V		
	50 kHz	7 μ V/V		
	100 kHz	8 μ V/V		
	300 kHz	20 μ V/V		
	500 kHz	25 μ V/V		
	800 kHz	30 μ V/V		
	1 MHz	40 μ V/V		
			Fluke 792A AC/DC transfer standard / 5730A multifunction calibrator / HP 3458A multimeter	COS



Parameter/Range	Frequency	CMC ^{2, 7} ($\pm$)	Comment	Location ¹⁰
AC Voltage Measure, Fixed Points	(22 to 10) V			
	10 Hz	25 μ V/V		
	20 Hz	15 μ V/V		
	40 Hz	6 μ V/V		
	100 Hz	6 μ V/V		
	1 kHz	6 μ V/V		
	10 kHz	6 μ V/V		
	20 kHz	6 μ V/V		
	50 kHz	7 μ V/V		
	100 kHz	9 μ V/V		
	300 kHz	20 μ V/V		
	500 kHz	25 μ V/V		
	800 kHz	30 μ V/V		
	1 MHz	40 μ V/V		
	(22 to 20) V			
	10 Hz	25 μ V/V		
	20 Hz	15 μ V/V		
	40 Hz	7 μ V/V		
	100 Hz	7 μ V/V		
	1 kHz	7 μ V/V		
	10 kHz	7 μ V/V		
	20 kHz	7 μ V/V		
	50 kHz	8 μ V/V		
	100 kHz	11 μ V/V		
	300 kHz	20 μ V/V		
	500 kHz	25 μ V/V		
	800 kHz	30 μ V/V		
	1 MHz	40 μ V/V		
	(70 to 20) V			
	10 Hz	25 μ V/V		
	20 Hz	15 μ V/V		
	40 Hz	7 μ V/V		
	100 Hz	7 μ V/V		
	1 kHz	7 μ V/V		
	10 kHz	7 μ V/V		
	20 kHz	7 μ V/V		
	50 kHz	8 μ V/V		
	100 kHz	11 μ V/V		
	300 kHz	25 μ V/V		
	(70 to 60) V			
	10 Hz	26 μ V/V		
	20 Hz	16 μ V/V		
	40 Hz	8 μ V/V		
	100 Hz	8 μ V/V		
	1 kHz	8 μ V/V		
	10 kHz	8 μ V/V		
	20 kHz	8 μ V/V		
	50 kHz	10 μ V/V		
	100 kHz	11 μ V/V		
	300 kHz	25 μ V/V		
			Fluke 792A AC/DC transfer standard / 5730A multifunction calibrator / HP 3458A multimeter	COS



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
AC Voltage Measure, Fixed Points	(220 to 60) V			
	10 Hz	26 µV/V		
	20 Hz	16 µV/V		
	40 Hz	8 µV/V		
	100 Hz	8 µV/V		
	1 kHz	8 µV/V		
	10 kHz	8 µV/V		
	20 kHz	8 µV/V		
	50 kHz	10 µV/V		
	100 kHz	11 µV/V		
	300 kHz	30 µV/V		
	(220 to 100) V			
	10 Hz	26 µV/V		
	20 Hz	16 µV/V		
	40 Hz	8 µV/V		
	100 Hz	8 µV/V		
	1 kHz	8 µV/V		
	10 kHz	8 µV/V		
	20 kHz	8 µV/V		
	50 kHz	9 µV/V		
	100 kHz	16 µV/V		
	(220 to 200) V			
	10 Hz	36 µV/V		
	20 Hz	16 µV/V		
	40 Hz	9 µV/V		
	100 Hz	9 µV/V		
	1 kHz	9 µV/V		
	10 kHz	9 µV/V		
	20 kHz	9 µV/V		
	50 kHz	11 µV/V		
	100 kHz	16 µV/V		
	(1000 to 200) V			
	10 Hz	40 µV/V		
	20 Hz	16 µV/V		
	40 Hz	10 µV/V		
	100 Hz	10 µV/V		
	1 kHz	10 µV/V		
	10 kHz	10 µV/V		
	20 kHz	10 µV/V		
	50 kHz	13 µV/V		
	100 kHz	30 µV/V		
	(1000 to 600) V			
	40 Hz	13 µV/V		
	100 Hz	13 µV/V		
	1 kHz	13 µV/V		
	10 kHz	13 µV/V		
	20 kHz	13 µV/V		
	50 kHz	17 µV/V		
	100 kHz	31 µV/V		
			Fluke 792A AC/DC transfer standard / 5730A multifunction calibrator / HP 3458A multimeter	COS



Parameter/Range	Frequency	CMC ^{2, 7} ($\pm$)	Comment	Location ¹⁰
AC Voltage Measure, Fixed Points	(1000 to 10 000) V 40 Hz 100 Hz 1 kHz 10 kHz 20 kHz 30 kHz	13 μ V/V 13 μ V/V 13 μ V/V 13 μ V/V 13 μ V/V 13 μ V/V	Fluke 792A AC/DC transfer standard /5730A multifunction calibrator / HP 3458A multimeter	COS
AC Voltage – Measure Wideband Flatness Relative to 1 kHz ³	(0.6 to 2.2) mV (10 to 30) Hz 30 Hz to 120 kHz 120 kHz 2 MHz (2 to 10) MHz (10 to 20) MHz (20 to 30) MHz (2.2 to 7) mV (10 to 30) Hz 30 Hz to 120 kHz 120 kHz 2 MHz (2 to 10) MHz (10 to 20) MHz (20 to 30) MHz	0.08 % of rdg + 0.1 μ V 0.04 % of rdg + 0.1 μ V 0.05 % of rdg + 0.8 μ V 0.13 % of rdg + 0.8 μ V 0.23 % of rdg + 0.8 μ V 0.53 % of rdg + 1.6 μ V 0.08 % of rdg + 0.1 μ V 0.04 % of rdg + 0.1 μ V 0.05 % of rdg + 0.8 μ V 0.08 % of rdg + 0.8 μ V 0.13 % of rdg + 0.8 μ V 0.28 % of rdg + 0.8 μ V	Fluke 5790B AC/DC transfer standard	TPA, RFD, COS



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
AC Voltage – Measure Wideband Flatness Relative to 1 kHz ³	(7 to 22) mV			
	(10 to 30) Hz	0.08 % of rdg + 0.1 µV		
	30 Hz to 120 kHz	0.04 % of rdg + 0.1 µV		
	120 kHz to 2 MHz	0.05 % of rdg + 0.1 µV		
	(2 to 10) MHz	0.08 % of rdg + 0.1 µV		
	(10 to 20) MHz	0.13 % of rdg + 0.1 µV		
	(20 to 30) MHz	0.28 % of rdg + 0.1 µV		
	(22 to 70) mV			
	(10 to 30) Hz	0.08 % of rdg + 0.6 µV		
	30 Hz to 2 MHz	0.04 % of rdg + 0.6 µV		
	(2 to 10) MHz	0.08 % of rdg + 0.6 µV		
	(10 to 20) MHz	0.11 % of rdg + 0.6 µV		
	(20 to 30) MHz	0.27 % of rdg + 0.6 µV		
	(70 to 220) mV			
	(10 to 30) Hz	0.08 % of rdg		
	30 Hz to 500 kHz	0.03 % of rdg		
	500 kHz to 2 MHz	0.04 % of rdg		
	(2 to 10) MHz	0.08 % of rdg		
	(10 to 20) MHz	0.11 % of rdg		
	(20 to 30) MHz	0.27 % of rdg		
	(220 to 700) mV			
	(10 to 30) Hz	0.08 % of rdg		
	30 Hz to 500 kHz	0.02 % of rdg		
	500 kHz to 2 MHz	0.04 % of rdg		
	(2 to 10) MHz	0.08 % of rdg		
	(10 to 20) MHz	0.11 % of rdg		
	(20 to 30 MHz)	0.27 % of rdg		
	(0.7 to 2) V			
	(10 to 30) Hz	0.08 % of rdg		
	30 Hz to 500 kHz	0.02 % of rdg		
	500 kHz to 2 MHz	0.04 % of rdg		
	(2 to 10) MHz	0.08 % of rdg		
	(10 to 20) MHz	0.11 % of rdg		
	(20 to 30) MHz	0.27 % of rdg		
	(2.2 to 7) V			
	(10 to 30) Hz	0.08 % of rdg		
	30 Hz to 500 kHz	0.02 % of rdg		
	500 kHz to 2 MHz	0.04 % of rdg		
	(2 to 10) MHz	0.08 % of rdg		
	(10 to 20) MHz	0.11 % of rdg		
	(20 to 30) MHz	0.27 % of rdg		
			Fluke 5790B AC/DC transfer standard	TPA, RFD, COS



Parameter/Range	Frequency	CMC ^{2, 6, 7} (±)	Comment	Location ¹⁰
AC Voltage – Fixed Point Generate, Wideband Flatness Relative to 1 kHz	1 mV			
	10 Hz	410 µV/V		
	20 Hz	410 µV/V		
	50 Hz	160 µV/V		
	100 Hz	160 µV/V		
	200 Hz	160 µV/V		
	2 kHz	160 µV/V		
	10 kHz	160 µV/V		
	20 kHz	160 µV/V		
	50 kHz	160 µV/V		
	100 kHz	160 µV/V		
	200 kHz	160 µV/V		
	500 kHz	160 µV/V		
	700 kHz	250 µV/V		
	1 MHz	250 µV/V		
	1.2 MHz	250 µV/V		
	2 MHz	390 µV/V		
	3 MHz	540 µV/V		
	4 MHz	540 µV/V		
	6 MHz	570 µV/V		
	8 MHz	590 µV/V		
	9 MHz	590 µV/V		
	10 MHz	590 µV/V		
	12 MHz	840 µV/V		
	15 MHz	840 µV/V		
	17 MHz	860 µV/V		
	20 MHz	0.10 %		
	23 MHz	0.12 %		
	26 MHz	0.15 %		
	28 MHz	0.18 %		
	30 MHz	0.18 %		
	35 MHz	0.21 %		
	40 MHz	0.23 %		
	45 MHz	0.25 %		
	50 MHz	0.27 %		
	3.2 mV			
	10 Hz	340 µV/V		
	20 Hz	340 µV/V		
	50 Hz	130 µV/V		
	100 Hz	130 µV/V		
	200 Hz	130 µV/V		
	2 kHz	130 µV/V		
	10 kHz	130 µV/V		
	20 kHz	130 µV/V		
	50 kHz	130 µV/V		
	100 kHz	130 µV/V		
	200 kHz	130 µV/V		
	500 kHz	130 µV/V		
	700 kHz	200 µV/V		
	1 MHz	200 µV/V		
			5730A/05 multifunction calibrator / PM EL1100 TVC / JFW 50HFI-0x0 N attenuators	COS



Parameter/Range	Frequency	CMC ^{2, 6, 7} ($\pm$)	Comment	Location ¹⁰
AC Voltage – Fixed Point Generate, Wideband Flatness Relative to 1 kHz	3.2 mV			
	1.2 MHz	200 μ V/V		
	2 MHz	360 μ V/V		
	3 MHz	490 μ V/V		
	4 MHz	490 μ V/V		
	6 MHz	500 μ V/V		
	8 MHz	510 μ V/V		
	9 MHz	510 μ V/V		
	10 MHz	510 μ V/V		
	12 MHz	720 μ V/V		
	15 MHz	720 μ V/V		
	17 MHz	750 μ V/V		
	20 MHz	860 μ V/V		
	23 MHz	0.11 %		
	26 MHz	0.13 %		
	28 MHz	0.15 %		
	30 MHz	0.16 %		
	35 MHz	0.18 %		
	40 MHz	0.19 %		
	45 MHz	0.21 %		
	50 MHz	0.23 %		
	10 mV			
	10 Hz	310 μ V/V		
	20 Hz	310 μ V/V		
	50 Hz	120 μ V/V		
	100 Hz	120 μ V/V		
	200 Hz	120 μ V/V		
	2 kHz	120 μ V/V		
	10 kHz	120 μ V/V		
	20 kHz	120 μ V/V		
	50 kHz	120 μ V/V		
	100 kHz	120 μ V/V		
	200 kHz	120 μ V/V		
	500 kHz	120 μ V/V		
	700 kHz	190 μ V/V		
	1 MHz	190 μ V/V		
	1.2 MHz	190 μ V/V		
	2 MHz	350 μ V/V		
	3 MHz	450 μ V/V		
	4 MHz	450 μ V/V		
	6 MHz	480 μ V/V		
	8 MHz	500 μ V/V		
	9 MHz	500 μ V/V		
	10 MHz	500 μ V/V		
	12 MHz	680 μ V/V		
	15 MHz	680 μ V/V		
	17 MHz	710 μ V/V		
	20 MHz	820 μ V/V		
	23 MHz	0.10 %		
	26 MHz	0.12 %		
			5730A/05 multifunction calibrator / PM EL1100 TVC / JFW 50HFI-0x0 N attenuators	COS

Parameter/Range	Frequency	CMC ^{2, 6, 7} (±)	Comment	Location ¹⁰
AC Voltage – Fixed Point Generate, Wideband Flatness Relative to 1 kHz	10 mV			
	28 MHz	0.14 %		
	30 MHz	0.15 %		
	35 MHz	0.17 %		
	40 MHz	0.19 %		
	45 MHz	0.21 %		
	50 MHz	0.22 %		
	32 mV			
	10 Hz	230 µV/V		
	20 Hz	230 µV/V		
	50 Hz	98 µV/V		
	100 Hz	98 µV/V		
	200 Hz	98 µV/V		
	2 kHz	98 µV/V		
	10 kHz	98 µV/V		
	20 kHz	98 µV/V		
	50 kHz	98 µV/V		
	100 kHz	98 µV/V		
	200 kHz	98 µV/V		
	500 kHz	98 µV/V		
	700 kHz	150 µV/V		
	1 MHz	150 µV/V		
	1.2 MHz	150 µV/V		
	2 MHz	330 µV/V		
	3 MHz	410 µV/V		
	4 MHz	410 µV/V		
	6 MHz	420 µV/V		
	8 MHz	430 µV/V		
	9 MHz	430 µV/V		
	10 MHz	430 µV/V		
	12 MHz	580 µV/V		
	15 MHz	580 µV/V		
	17 MHz	620 µV/V		
	20 MHz	680 µV/V		
	23 MHz	890 µV/V		
	26 MHz	0.11 %		
	28 MHz	0.12 %		
	30 MHz	0.13 %		
	35 MHz	0.14 %		
	40 MHz	0.16 %		
	45 MHz	0.17 %		
	50 MHz	0.19 %		
	100 mV			
	10 Hz	200 µV/V		
	20 Hz	200 µV/V		
	50 Hz	86 µV/V		
	100 Hz	86 µV/V		
	200 Hz	86 µV/V		
	2 kHz	86 µV/V		
			5730A/05 multifunction calibrator / PM EL1100 TVC / JFW 50HFI-0x0 N attenuators	COS

Parameter/Range	Frequency	CMC ^{2, 6, 7} (±)	Comment	Location ¹⁰
AC Voltage – Fixed Point Generate, Wideband Flatness Relative to 1 kHz	10 kHz	86 µV/V	5730A/05 multifunction calibrator / PM EL1100 TVC / JFW 50HFI-0x0 N attenuators	COS
	20 kHz	86 µV/V		
	50 kHz	86 µV/V		
	100 kHz	86 µV/V		
	200 kHz	86 µV/V		
	500 kHz	86 µV/V		
	700 kHz	140 µV/V		
	1 MHz	140 µV/V		
	1.2 MHz	140 µV/V		
	2 MHz	320 µV/V		
	3 MHz	380 µV/V		
	4 MHz	380 µV/V		
	6 MHz	410 µV/V		
	8 MHz	420 µV/V		
	9 MHz	420 µV/V		
	10 MHz	420 µV/V		
	12 MHz	550 µV/V		
	15 MHz	550 µV/V		
	17 MHz	590 µV/V		
	20 MHz	650 µV/V		
	23 MHz	850 µV/V		
	26 MHz	0.10 %		
	28 MHz	0.12 %		
	30 MHz	0.13 %		
	35 MHz	0.14 %		
	40 MHz	0.15 %		
	45 MHz	0.17 %		
	50 MHz	0.18 %		
	320 mV			
	10 Hz	120 µV/V		
	20 Hz	120 µV/V		
	50 Hz	69 µV/V		
	100 Hz	69 µV/V		
	200 Hz	69 µV/V		
	2 kHz	69 µV/V		
	10 kHz	69 µV/V		
	20 kHz	69 µV/V		
	50 kHz	69 µV/V		
	100 kHz	69 µV/V		
	200 kHz	69 µV/V		
	500 kHz	69 µV/V		
	700 kHz	110 µV/V		
	1 MHz	110 µV/V		
	1.2 MHz	110 µV/V		
	2 MHz	300 µV/V		
	3 MHz	350 µV/V		
	4 MHz	350 µV/V		
	6 MHz	360 µV/V		
	8 MHz	380 µV/V		
	9 MHz	380 µV/V		



Parameter/Range	Frequency	CMC ^{2, 6, 7} ($\pm$)	Comment	Location ¹⁰
AC Voltage – Fixed Point Generate, Wideband Flatness Relative to 1 kHz	320 mV			
	10 MHz	380 μ V/V		
	12 MHz	480 μ V/V		
	15 MHz	480 μ V/V		
	17 MHz	520 μ V/V		
	20 MHz	550 μ V/V		
	23 MHz	760 μ V/V		
	26 MHz	910 μ V/V		
	28 MHz	0.10 %		
	30 MHz	0.11 %		
	35 MHz	0.12 %		
	40 MHz	0.13 %		
	45 MHz	0.14 %		
	50 MHz	0.15 %		
	1.0 V			
	10 Hz	98 μ V/V		
	20 Hz	98 μ V/V		
	50 Hz	62 μ V/V		
	100 Hz	62 μ V/V		
	200 Hz	62 μ V/V		
	2 kHz	62 μ V/V		
	10 kHz	62 μ V/V		
	20 kHz	62 μ V/V		
	50 kHz	62 μ V/V		
	100 kHz	62 μ V/V		
	200 kHz	62 μ V/V		
	500 kHz	62 μ V/V		
	700 kHz	110 μ V/V		
	1 MHz	110 μ V/V		
	1.2 MHz	110 μ V/V		
	2 MHz	300 μ V/V		
	3 MHz	340 μ V/V		
	4 MHz	340 μ V/V		
	6 MHz	360 μ V/V		
	8 MHz	380 μ V/V		
	9 MHz	380 μ V/V		
	10 MHz	380 μ V/V		
	12 MHz	460 μ V/V		
	15 MHz	460 μ V/V		
	17 MHz	510 μ V/V		
	20 MHz	540 μ V/V		
	23 MHz	740 μ V/V		
	26 MHz	880 μ V/V		
	28 MHz	990 μ V/V		
	30 MHz	0.11 %		
	35 MHz	0.12 %		
	40 MHz	0.13 %		
	45 MHz	0.14 %		
	50 MHz	0.15 %		
			5730A/05 multifunction calibrator / PM EL1100 TVC / JFW 50HFI-0x0 N attenuators	COS

Parameter/Range	Frequency	CMC ^{2, 6, 7} ($\pm$)	Comment	Location ¹⁰
AC Voltage – Fixed Point Generate, Wideband Flatness Relative to 1 kHz	3.2 V			
	10 Hz	56 μ V/V		
	20 Hz	56 μ V/V		
	50 Hz	56 μ V/V		
	100 Hz	56 μ V/V		
	200 Hz	56 μ V/V		
	2 kHz	56 μ V/V		
	10 kHz	56 μ V/V		
	20 kHz	56 μ V/V		
	50 kHz	56 μ V/V		
	100 kHz	56 μ V/V		
	200 kHz	56 μ V/V		
	500 kHz	56 μ V/V		
	700 kHz	94 μ V/V		
	1 MHz	94 μ V/V		
	1.2 MHz	94 μ V/V		
	2 MHz	290 μ V/V		
	3 MHz	330 μ V/V		
	4 MHz	330 μ V/V		
	6 MHz	340 μ V/V		
	8 MHz	360 μ V/V		
	9 MHz	360 μ V/V		
	10 MHz	360 μ V/V		
	12 MHz	440 μ V/V		
	15 MHz	440 μ V/V		
	17 MHz	490 μ V/V		
	20 MHz	500 μ V/V		
	23 MHz	710 μ V/V		
	26 MHz	850 μ V/V		
	28 MHz	940 μ V/V		
	30 MHz	0.10 %		
	35 MHz	0.11 %		
	40 MHz	0.13 %		
	45 MHz	0.12 %		
	50 MHz	0.13 %		
			5730A/05 multifunction calibrator / PM EL1100 TVC / JFW 50HFI-0x0 N attenuators	COS

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
AC Current – Generate ³	(9 to 220) µA (10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (0.22 to 2.2) mA (10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (2.2 to 22) mA (10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (22 to 220) mA (10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	230 µA/A + 15 nA 150 µA/A + 10 nA 91 µA/A + 8 nA 270 µA/A + 12 nA 990 µA/A + 61 nA 230 µA/A + 39 nA 150 µA/A + 31 nA 91 µA/A + 31 nA 180 µA/A + 99 nA 990 µA/A + 610 nA 230 µA/A + 390 nA 150 µA/A + 310 nA 91 µA/A + 310 nA 180 µA/A + 540 nA 990 µA/A + 4.6 µA 230 µA/A + 4 µA 150 µA/A + 3 µA 91 µA/A + 2 µA 180 µA/A + 3 µA 990 µA/A + 9 µA	Fluke 5730A multifunction calibrator	TPA, HSV, RFD, MEL, COS, RDU, DFW
	(9 to 220) µA (10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (0.22 to 2.2) mA (10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (2.2 to 22) mA (10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	230 µA/A + 15 nA 150 µA/A + 10 nA 91 µA/A + 8 nA 270 µA/A + 12 nA 990 µA/A + 61 nA 230 µA/A + 39 nA 150 µA/A + 31 nA 110 µA/A + 31 nA 180 µA/A + 99 nA 990 µA/A + 610 nA 230 µA/A + 390 nA 150 µA/A + 310 nA 110 µA/A + 310 nA 180 µA/A + 540 nA 990 µA/A + 4.6 µA	Fluke 5720A multifunction calibrator	ATL, SFL HLR



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
AC Current – Generate ³	(22 to 220) mA (10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	230 µA/A + 4 µA 150 µA/A + 3 µA 110 µA/A + 2 µA 180 µA/A + 3 µA 990 µA/A + 9 µA	Fluke 5720A multifunction calibrator	ATL, SFL HLR
	(9 to 220) µA (10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (0.22 to 2.2) mA (10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (2.2 to 22) mA (10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (22 to 220) mA (10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	610 µA/A + 23 nA 320 µA/A + 19 nA 120 µA/A + 15 nA 530 µA/A + 38 nA 1400 µA/A + 760 nA 610 µA/A + 39 nA 320 µA/A + 31 nA 120 µA/A + 31 nA 530 µA/A + 380 nA 1400 µA/A + 760 nA 610 µA/A + 390 nA 320 µA/A + 310 nA 120 µA/A + 310 nA 530 µA/A + 3.8 µA 1400 µA/A + 7.6 µA 610 µA/A + 4 µA 320 µA/A + 3 µA 140 µA/A + 3 µA 530 µA/A + 38 µA 1400 µA/A + 76 µA	Fluke 5700A multifunction calibrator	HRT
	(0.22 to 1.2) A (3 to 45) Hz 45 to 1000 Hz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz (1.2 to 3.1) A (3 to 45) Hz 45 to 1000 Hz (1 to 5) kHz (5 to 10) kHz (3.1 to 12) A (3 to 45) Hz 45 to 1000 Hz (1 to 5) kHz (5 to 10) kHz	0.019 % of output + 0.08 mA 0.019 % of output + 0.04 mA 0.019 % of output + 0.06 mA 0.19 % of output + 0.23 mA 0.38 % of output + 0.23 mA 0.029 % of output + 0.4 mA 0.023 % of output + 0.27 mA 0.029 % of output + 0.27 mA 0.19 % of output + 0.40 mA 0.029 % of output + 0.8 mA 0.023 % of output + 0.4 mA 0.029 % of output + 0.6 mA 0.19 % of output + 0.8 mA	Fluke 5560A multiproduct calibrator	COS, HRT, MEL, ATL RDU, TPA, RFD, HSV, DFW



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
AC Current – Generate ³	(12 to 30.2) A (3 to 45) Hz 45 to 1000 Hz (1 to 5) kHz	0.076 % of output + 7.7 mA 0.053 % of output + 6.2 mA 0.038 % of output + 6.2 mA	Fluke 5560A multiproduct calibrator	COS, HRT, MEL, ATL RDU, TPA, RFD, HSV, DFW
	(30.2 to 120) A (10 to 65) Hz (65 to 300) Hz 300 Hz to 1 kHz (1 to 3) kHz (3 to 6) kHz (6 to 10) kHz	160 µA/A + 19 mA 250 µA/A + 28 mA 770 µA/A + 92 mA 0.23 % of output + 230 mA 0.76 % of output + 410 mA 3 % of output + 690 mA	Fluke 5560A multiproduct calibrator, 52120A transconductance amplifier	TPA, RFD, COS
	(0.22 to 2.2) A 20 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (2.2 to 11) A 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	250 µA/A + 31 µA 380 µA/A + 76 µA 6.1 mA/A + 150 µA 350 µA /A + 141 µA 720 µA /A + 300 µA 2.7 mA /A + 570 µA	Fluke 5720A, multifunction calibrator	SFL, HLR
	(11 to 20.5) A 45 Hz to 100 Hz 100 Hz to 1 kHz (1 to 5) kHz	0.09 % of output + 5 mA 0.11 % of output + 5 mA 2.3 % of output + 5 mA	Fluke 5522A multiproduct calibrator	
AC Current – Generate Clamp Meters ³	(3.1 to 300.2) A (3 to 440) Hz	0.65 % of output + 0.077 A	Fluke 5560A, w/55xxA, x1/2/10 coil	RDU
	(3.3 to 30) A (10 to 100) Hz (100 to 440) Hz (30 to 200) A 10 to 100 Hz (100 to 440) Hz	0.22 % of output + 0.028 A 0.3 % of output + 0.07 A 0.22 % of output + 0.032 A 0.79 % of output + 0.08 A	Fluke 5522A multiproduct, w/9100-200 x10 coil	HLR, SFL
	(6 to 150) A (10 to 100) Hz (100 to 440) Hz (150 to 1000) A (10 to 100) Hz (100 to 440) Hz	0.22 % of output + 0.029 A 0.3 % of output + 0.08 A 0.22 % of output + 0.81 A 0.79 % of output + 0.2 A	Fluke 5522A multiproduct, w/9100-200 x50 coil	

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
AC Current – Generate Clamp Meters ³	(1.2 to 30) A (10 to 440) Hz	0.2 % of output + 0.005 A	Fluke 5560A multiproduct calibrator / 9100- 200 x10 coil	HRT, COS, HSV, RDU
	(30 to 120) A (10 to 440) Hz	0.20 % of output + 0.008 A		
	(120 to 200) A 10 to 440 Hz	0.21 % of output + 0.076 A		
	(6 to 150) A (10 to 100) Hz	0.2 % of output + 0.02 A	Fluke 5560A multiproduct calibrator / 9100-200 x50 coil	
	(150 to 600) A (10 to 100) Hz	0.2 % of output + 0.04 A		
	(600 to 1000) A (10 to 100) Hz	0.21 % of output + 0.31 A		
AC Current Clamps – Toroidal-Wound ³	(0.6 to 600) A (45 to 65) Hz	0.21 % of output + 71 mA	Fluke 5560A multiproduct calibrator /x50 coil	TPA, RFD MEL, ATL, COS, DFW, HSV
	(600 to 1000) A (45 to 65) Hz	0.22 % of output + 0.31 A		
	(0.6 to 155) A (65 to 440) Hz	0.6 % of output + 77 mA		
AC Current Clamps – Other ³	(0.6 to 600) A (45 to 65) Hz	0.43 % of output + 0.53 A		
	(600 to 1000) A (45 to 65) Hz	0.43 % of output + 0.61 A		
	(0.6 to 155) A (65 to 440) Hz	0.76 % of output + 0.69 A		
AC Current – Generate ³ Clamps – Toroidal-Wound	(16.5 to 150) A (45 to 65) Hz	0.22 % of output + 69 mA	Fluke 5522A multiproduct calibrator, 5500A/coil x50	HSV
	(150 to 1 000) A (45 to 65) Hz	0.23 % of output + 0.2 A		
	(16.5 to 150) A (65 to 440) Hz	0.64 % of output + 0.085 A		
AC Current – Generate ³ Clamps – Other	(16.5 to 1025) A (45 to 65) Hz	0.44 % of output + 0.57 A		
	(16.5 to 150) A (65 to 440) Hz	0.79 % of output + 0.69 A		

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
AC Current Clamps – Rogowski ³	(10 to 100) A (10 to 1000) Hz (1 to 3) kHz	0.53 % of output + 0.011 A 0.61 % of output + 0.015 A	Fluke 5560A multiproduct calibrator, Fluke 52120A transconductance amplifier, coil 6KA current coil	TPA, RFD
	(100 to 1000) A (10 to 1000) Hz (1 to 3) kHz	0.53 % of output + 0.11 A 0.61 % of output + 0.15 A		
	(1000 to 6000) A (10 to 1000) Hz	0.53 % of output + 0.68 A		
	(1000 to 3500) A (1 to 3) kHz	0.61 % of output + 0.95 A		
AC Current – Measure ³	(2 to 200) µA 10 Hz to 10 kHz	0.047 % of rdg + 0.018 µA	Fluke 8508A multimeter	TPA
	200 µA to 2 mA 10 Hz to 10 kHz	0.028 % of rdg + 0.18 µA		
	(0.19 to 1) mA (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz	200 µA/A 200 µA/A 170 µA/A 280 µA/A	Agilent 3458A multimeter/ Fluke A40 current shunts	TPA
	(1 to 10) mA (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz	160 µA/A 70 µA/A 40 µA/A 65 µA/A		
	(10 to 50) mA (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz	170 µA/A 69 µA/A 39 µA/A 66 µA/A		
	(50 to 500) mA (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz	170 µA/A 70 µA/A 40 µA/A 72 µA/A		
	(0.5 to 2) A (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz	170 µA/A 77 µA/A 62 µA/A 110 µA/A		



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
AC Current - Measure	(0.06 to 1) mA			
	(10 to 20) Hz	170 µA/A		
	(20 to 40) Hz	84 µA/A		
	40 Hz to 20 kHz	79 µA/A		
	(20 to 50) kHz	160 µA/A		
	(50 to 100) kHz	220 µA/A		
	(1 to 10) mA			
	(10 to 20) Hz	160 µA/A		
	(20 to 40) Hz	69 µA/A		
	40 Hz to 20 kHz	39 µA/A		
	(20 to 50) kHz	68 µA/A		
	(50 to 100) kHz	160 µA/A		
	(10 to 20) mA			
	(10 to 20) Hz	160 µA/A		
	(20 to 40) Hz	62 µA/A		
	40 Hz to 20 kHz	35 µA/A		
	(20 to 50) kHz	51 µA/A		
	(50 to 100) kHz	79 µA/A		
	(20 to 100) mA			
	(10 to 20) Hz	160 µA/A		
	(20 to 40) Hz	67 µA/A		
	40 Hz to 20 kHz	37 µA/A		
	(20 to 50) kHz	61 µA/A		
	(50 to 100) kHz	160 µA/A		
	(100 to 200) mA			
	(10 to 20) Hz	160 µA/A		
	(20 to 40) Hz	62 µA/A		
	40 Hz to 20 kHz	34 µA/A		
	(20 to 50) kHz	50 µA/A		
	(50 to 100) kHz	81 µA/A		
	(0.2 to 1) A			
	(10 to 20) Hz	160 µA/A		
	(20 to 40) Hz	73 µA/A		
	40 Hz to 20 kHz	47 µA/A		
	(20 to 50) kHz	66 µA/A		
	(50 to 100) kHz	160 µA/A		
	(1 to 2 A)			
	(10 to 20) Hz	160 µA/A		
	(20 to 40) Hz	65 µA/A		
	40 Hz to 20 kHz	43 µA/A		
	(20 to 50) kHz	64 µA/A		
	(50 to 100) kHz	90 µA/A		
	(2 to 5 A)			
	(10 to 20) Hz	170 µA/A		
	(20 to 40) Hz	70 µA/A		
	40 Hz to 20 kHz	51 µA/A		
	(20 to 50) kHz	84 µA/A		
	(50 to 100) kHz	100 µA/A		
			Fluke 5790B AC/DC transfer standard / Fluke A40B current shunts	COS



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
AC Current - Measure	(5 to 10) A (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz	170 µA/A 86 µA/A 85 µA/A 120 µA/A 140 µA/A	Fluke 5790B AC/DC transfer standard / Fluke A40B current shunts	COS
	(10 to 20) A (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz	180 µA/A 96 µA/A 110 µA/A 170 µA/A 200 µA/A		
	(20 to 50) A (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz	200 µA/A 130 µA/A 130 µA/A 210 µA/A 220 µA/A		
	(50 to 100) A (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz	190 µA/A 120 µA/A 150 µA/A 320 µA/A 320 µA/A		
AC Current – Measure ³	(2 to 10) A (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz	180 µA/A 94 µA/A 79 µA/A 130 µA/A	Fluke 5790B AC/DC transfer standard / Fluke A40 current shunts	TPA
	(10 to 20) A (10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz	310 µA/A 310 µA/A 270 µA/A 380 µA/A	Agilent 3458A multimeter / Fluke Y5020 current shunt	TPA, RFD, ATL
	(1 to 10) A (10 to 1000) Hz	50 µA/A + 130 µA	Agilent 3458A multimeter, MI 6311A current divider	TPA, COS
	(10 to 100) A (10 to 1000) Hz	50 µA/A + 1.3 mA		
	(100 to 300) A (10 to 1000) Hz	50 µA/A + 13 mA		

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
AC Current – Measure ³	(0.22 to 10) mA (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (10 to 50) mA (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) mA (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (100 to 250) mA (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz	190 µA/A + 0.002 µA 90 µA/A + 0.002 µA 44 µA/A + 0.002 µA 76 µA/A + 0.002 µA 190 µA/A 87 µA/A 42 µA/A 71 µA/A 190 µA/A 88 µA/A 45 µA/A 77 µA/A 190 µA/A 91 µA/A 42 µA/A 82 µA/A	Fluke 5790A AC/DC transfer standard / Holt HCS-1 current shunts	RFD
	(10 to 100) A (40 to 1000) Hz	0.10 % + 0.5 mA	Agilent 3458A option 002 multimeter standard resistor Ohms Lab CS- 100	TPA, RDU, MEL

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
AC Current – Measure ³	(250 to 500) mA (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz	190 µA/A 91 µA/A 42 µA/A 82 µA/A	Fluke 5790A AC/DC transfer standard / Holt HCS-1 current shunts	RFD
	(0.5 to 1) A (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (1 to 2.5) A (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (2.5 to 5) A (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (5 to 10) A (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz	190 µA/A 92 µA/A 59 µA/A 120 µA/A 200 µA/A 110 µA/A 78 µA/A 130 µA/A 200 µA/A 110 µA/A 85 µA/A 180 µA/A 210 µA/A 130 µA/A 100 µA/A 150 µA/A		
	(5 to 100) µA (10 to 20) Hz (20 to 45) Hz 45 Hz to 1 kHz (0.1 to 1) mA (10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz (1 to 10) mA (10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz	0.26 % of rdg + 0.02 µA 0.1 % of rdg + 0.02 µA 0.04 % of rdg + 0.02 µA 0.26 % of rdg + 0.13 µA 0.1 % of rdg + 0.13 µA 0.04 % of rdg + 0.13 µA 0.02 % of rdg + 0.13 µA 0.26 % of rdg + 1.3 µA 0.1 % of rdg + 1.3 µA 0.04 % of rdg + 1.3 µA 0.02 % of rdg + 1.3 µA	Agilent 3458A multimeter	TPA, MEL ATL, RFD HSV, COS HRT, RDU SFL, HLR, DFW



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
AC Current – Measure ³	(10 to 100) mA (10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz (0.1 to 1) A (10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz	0.26 % of rdg + 13 µA 0.1 % of rdg + 13 µA 0.04 % of rdg + 13 µA 0.02 % of rdg + 13 µA 0.26 % of rdg + 0.13 mA 0.1 % of rdg + 0.13 mA 0.04 % of rdg + 0.13 mA 0.02 % of rdg + 0.13 mA	Agilent 3458A multimeter	TPA, MEL ATL, RFD HSV, COS HRT, RDU SFL, HLR, DFW
	(2.02 to 20.2) µA (1 to 2000) Hz (2 to 10) kHz (10 to 30) kHz (0.202 to 2.02) mA (1 to 2000) Hz (2 to 10) kHz (10 to 30) kHz 2.02 to 20.2) mA (1 to 2000) Hz (2 to 10) kHz (10 to 30) kHz (20.2 to 202) mA (1 to 2000) Hz (2 to 10) kHz (10 to 30) kHz	0.027 % of rdg + 2.5 nA 0.052 % of rdg + 2.5 nA 0.073 % of rdg + 2.5 nA 0.027 % of rdg + 49 nA 0.052 % of rdg + 49 nA 0.073 % of rdg + 49 nA 0.027 % of rdg + 0.49 µA 0.052 % of rdg + 0.49 µA 0.073 % of rdg + 0.49 µA 0.027 % of rdg + 4.9 µA 0.051 % of rdg + 4.9 µA 0.073 % of rdg + 4.9 µA	8588A multimeter	RFD, ATL, DFW, COS
	(0.202 to 2.02) A (1 to 2000) Hz (2 to 10) kHz (10 to 30) kHz (2.02 to 20.2) A (10 to 2000) Hz (2 to 10) kHz (20.2 to 30.2) A (10 to 2000) Hz (2 to 10) kHz	0.029 % of rdg + 98 µA 0.054 % of rdg + 98 µA 0.078 % of rdg + 98 µA 0.082 % of rdg + 0.49 mA 0.082 % of rdg + 0.49 mA 0.082 % of rdg + 12 mA 0.122 % of rdg + 12 mA	8588A multimeter	RFD, ATL, DFW, COS



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
AC Current – Measure ³	(2.02 to 20.2) µA (1 to 2000) Hz (2 to 10) kHz (10 to 30) kHz	0.38 % of rdg + 2.9 nA 0.38 % of rdg + 2.9 nA 0.38 % of rdg + 2.9 nA	Fluke 8558A multimeter	RDU
	(20.2 to 202) µA (1 to 2000) Hz (2 to 10) kHz (10 to 30) kHz	0.044 % of rdg + 9.8 nA 0.087 % of rdg + 9.8 nA 0.11 % of rdg + 9.8 nA		
	(0.202 to 2.02) mA (1 to 2000) Hz (2 to 10) kHz (10 to 30) kHz	0.044 % of rdg + 98 nA 0.087 % of rdg + 98 nA 0.11 % of rdg + 98 nA		
	(2.02 to 20.2) mA (1 to 2000) Hz (2 to 10) kHz (10 to 30) kHz	0.044 % of rdg + 0.98 µA 0.087 % of rdg + 0.98 µA 0.11 % of rdg + 0.98 µA		
	(20.2 to 202) mA (1 to 2 000) Hz (2 to 10) kHz (10 to 30) kHz	0.044 % of rdg + 9.8 µA 0.087 % of rdg + 9.8 µA 0.11 % of rdg + 9.8 µA		
	(0.202 to 2.02) A (1 to 2000) Hz (2 to 10) kHz (10 to 30) kHz	0.044 % of rdg + 148 µA 0.076 % of rdg + 148 µA 0.12 % of rdg + 148 µA		
	(1 to 3) A (3 to 5) Hz (5 to 10) Hz 10 Hz to 5 kHz	0.72 % of rdg + 1.2 mA 0.23 % of rdg + 1.2 mA 0.1 % of rdg + 1.2 mA	Agilent 34401A multimeter	MEL, ATL, SFL, HSV
	(1 to 3) A (3 to 5) Hz (5 to 10) Hz 10 Hz to 5 kHz (5 to 10) kHz (3 to 10) A (3 to 5) Hz (5 to 10) Hz 10 Hz to 5 kHz (5 to 10) kHz	0.84 % of rdg + 1.4 mA 0.27 % of rdg + 1.4 mA 0.11 % of rdg + 1.4 mA 0.27 % of rdg + 16 mA 0.84 % of rdg + 4.6 mA 0.27 % of rdg + 4.6 mA 0.11 % of rdg + 4.6 mA 0.27 % of rdg + 53 mA	Fluke 8845A, 8846A multimeter	RFD, HLR, RDU, HRT, TPA, COS, HSV, DFW



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
AC Current – Measure ³	(3 to 30) A 40 Hz to 1 kHz (1 to 5) kHz	0.3 % of rdg + 0.07 A 5 % of rdg + 0.14 A	Agilent 3458A multimeter, Keysight 34330A current shunt	ATL, HSV RFD, HLR SFL, MEL, RDU
	(10 to 100) A (50 to 1000) Hz (100 to 600) A (50 to 1000) Hz	2 % of rdg + 0.02 A 2 % of rdg + 0.2 A	Fluke 80i-600 clamp meter / Agilent 3458A multimeter	ATL
	(10 to 2 000) A 55 to 65 Hz (2 000 to 6000) A 55 to 65 Hz	1 % of rdg + 0.5A 1 % of rdg + 3.9 A	PEM CWT600B Rogowski coil / Agilent 34401A multimeter	ATL, TPA, RDU
	(10 to 1000) A (10 to 100) Hz (100 to 500) Hz	1.5 % of rdg + 0.5 A 1.9 % of rdg + 0.5 A	Fluke 376 clamp meter	TPA, MEL RFD, HRT, HSV, DFW
	(200 to 600) A (10 to 500) Hz (600 to 2500) A (10 to 500) Hz	2.3 % of rdg + 0.9 A 2.3 % of rdg + 6.6 A	Fluke 376 clamp meter i2500 flex probe	TPA, MEL HRT, HSV
	(30 to 600) A (10 to 100) Hz (100 to 400) Hz	1.5 % of rdg + 1.1 A 4.6 % of rdg + 1.1 A	Fluke 336 clamp meter	SFL
Resistance Generate Fixed Points	0.1 Ω 1 Ω 10 Ω 100 Ω 1 kΩ 10 kΩ 100 kΩ 1 MΩ 10 MΩ 100 MΩ 1 GΩ 10 GΩ	2.7 μΩ/Ω 0.22 μΩ/Ω 2.7 μΩ/Ω 2.7 μΩ/Ω 2.7 μΩ/Ω 1.0 μΩ/Ω 2.7 μΩ/Ω 3.2 μΩ/Ω 11 μΩ/Ω 20 μΩ/Ω 27 μΩ/Ω 45 μΩ/Ω	MI 9331R/9331G series standard resistors	COS

Parameter/Equipment	Range	CMC ^{2, 6, 7} ($\pm$)	Comment	Location ¹⁰
Resistance Generate Fixed Points	100 V 200 k Ω	1 % of output	TMI COLBOX resistance standard	COS
	(100 to 1000) V 500 k Ω 1 M Ω 2 M Ω 2.5 M Ω 5 M Ω 10 M Ω 1 G Ω 50 G Ω 100 G Ω 200 G Ω 500 G Ω 1 T Ω 2 T Ω	1 % of output 1 % of output 1 % of output 1 % of output 1 % of output 1 % of output 1 % of output 1.1 % of output 1.1 % of output 1.2 % of output 3.6 % of output 3.6 % of output 3.7 % of output		
Resistance Measure Fixed Points	(0.1 to 1) Ω (1 to 1) Ω (1 to 10) Ω (10 to 100) Ω (100 to 1000) Ω (1 to 10) k Ω	0.25 $\mu\Omega/\Omega$ 0.23 $\mu\Omega/\Omega$ 0.23 $\mu\Omega/\Omega$ 0.23 $\mu\Omega/\Omega$ 0.24 $\mu\Omega/\Omega$ 0.25 $\mu\Omega/\Omega$	MI 6020A primary resistance bridge / 9331R standard resistor	COS
	(10 to 10) k Ω (10 to 100) k Ω 100 k Ω to 1 M Ω (1 to 10) M Ω (10 to 100) M Ω 100 M Ω to 1 G Ω	1.4 $\mu\Omega/\Omega$ 1.4 $\mu\Omega/\Omega$ 2.9 $\mu\Omega/\Omega$ 3.4 $\mu\Omega/\Omega$ 11 $\mu\Omega/\Omega$ 21 $\mu\Omega/\Omega$		
Resistance – Generate, Fixed Points ³	1 m Ω 10 m Ω 100 m Ω	10 $\mu\Omega/\Omega$ 6.6 $\mu\Omega/\Omega$ 25 $\mu\Omega/\Omega$	LN 422x resistance standards	TPA, RFD
	100 $\mu\Omega$ 1 m Ω 10 m Ω 100 m Ω 1 Ω 10 Ω	0.053 % 0.039 % 0.016 % 0.014 % 0.009 % 0.008 %	Burster 1240 series resistance standards	HSV



Parameter/Equipment	Range	CMC ^{2, 7} (±)	Comment	Location ¹⁰
Resistance – Generate ³ Fixed Points	1 mΩ 10 mΩ 100 mΩ 1 GΩ	100 μΩ/Ω 100 μΩ/Ω 100 μΩ/Ω 220 ppm	Standard resistors	MEL
	1 Ω 10 Ω 100 Ω 1 kΩ 10 kΩ 100 kΩ 1 MΩ 10 MΩ 100 MΩ 1 GΩ	1 μΩ/Ω 2 μΩ/Ω 0.44 μΩ/Ω 0.67 μΩ/Ω 0.86 μΩ/Ω 1.2 μΩ/Ω 2 μΩ/Ω 2.5 μΩ/Ω 19 μΩ/Ω 84 μΩ/Ω	Fluke 742A, IET SRL resistance standards	TPA
	1 Ω 10 kΩ	2.6 μΩ/Ω 0.93 μΩ/Ω	Fluke 742A resistance standards	RFD
	100 V 100 kΩ (100 to 1000) V 1 MΩ 10 MΩ 100 MΩ 1 GΩ 10 GΩ	1 % of output 1 % of output 1 % of output 1 % of output 1 % of output 1.2 % of output	TMI RB resistance standard	TPA, HSV MEL, HLR HRT, SFL, COS, DFW, RDU
	(100 to 1000) V 100 GΩ	3.2 % of output		TPA, MEL HSV, DFW
	(1, 1.9) Ω (10, 19) Ω (100, 190) Ω (1, 1.9) kΩ (10, 19) kΩ 100 kΩ 190 kΩ 1 MΩ 1.9 MΩ 10 MΩ 19 MΩ 100 MΩ	84 μΩ/Ω + 0.1 μΩ 21 μΩ/Ω + 1 μΩ 9.1 μΩ/Ω + 6 μΩ 6.1 μΩ/Ω + 60 μΩ 6.1 μΩ/Ω + 0.6 mΩ 7.6 μΩ/Ω + 6 mΩ 9.1 μΩ/Ω + 6 mΩ 11 μΩ/Ω + 60 mΩ 16 μΩ/Ω + 60 mΩ 35 μΩ/Ω + 0.6 Ω 42 μΩ/Ω + 0.6 Ω 91 μΩ/Ω + 6 Ω	Fluke 5730A multifunction calibrator	COS, HSV MEL, RDU RFD, TPA, DFW



Parameter/Equipment	Range	CMC ^{2, 7} (±)	Comment	Location ¹⁰
Resistance – Generate ³ Fixed Points	(1, 1.9) Ω (10, 19) Ω (100, 190) Ω (1, 1.9) kΩ (10, 19) kΩ (100, 190) kΩ 1 MΩ 1.9 MΩ 10 MΩ 19 MΩ 100 MΩ	84 μΩ/Ω + 0.1 μΩ 21 μΩ/Ω + 1 μΩ 9.1 μΩ/Ω + 6 μΩ 7.6 μΩ/Ω + 60 μΩ 7.6 μΩ/Ω + 0.6 mΩ 9.9 μΩ/Ω + 6 mΩ 18 μΩ/Ω + 60 mΩ 18 μΩ/Ω + 60 mΩ 35 μΩ/Ω + 0.6 Ω 42 μΩ/Ω + 0.6 Ω 91 μΩ/Ω + 6 Ω	Fluke 5720A multifunction calibrator	HLR, SFL, ATL
	(1, 1.9) Ω (10, 19) Ω (100, 190) Ω (1, 1.9) kΩ (10, 19) kΩ (100, 190) kΩ 1 MΩ 1.9 MΩ 10 MΩ 19 MΩ 100 MΩ	84 μΩ/Ω + 0.1 μΩ 25 μΩ/Ω + 1 μΩ 15 μΩ/Ω + 6 μΩ 11 μΩ/Ω + 60 μΩ 11 μΩ/Ω + 0.6 mΩ 12 μΩ/Ω + 6 mΩ 18 μΩ/Ω + 60 mΩ 18 μΩ/Ω + 60 mΩ 35 μΩ/Ω + 0.6 Ω 42 μΩ/Ω + 0.6 Ω 99 μΩ/Ω + 6 Ω	Fluke 5700A multifunction calibrator	HRT
	1 Ω 1.9 Ω 10 Ω 19 Ω 100 Ω 190 Ω 1 kΩ 1.9 kΩ 10 kΩ 19 kΩ 100 kΩ 190 kΩ 1 MΩ 1.9 MΩ 10 MΩ 19 MΩ 100 MΩ	13 μΩ/Ω + 0.6 μΩ 8.7 μΩ/Ω + 0.6 μΩ 5.6 μΩ/Ω + 6 μΩ 6.7 μΩ/Ω + 6 μΩ 4.7 μΩ/Ω + 60 μΩ 4.5 μΩ/Ω + 60 μΩ 1.2 μΩ/Ω + 0.6 mΩ 1.1 μΩ/Ω + 0.6 mΩ 3 μΩ/Ω + 0.6 mΩ 2 μΩ/Ω + 6 mΩ 1.9 μΩ/Ω + 60 mΩ 1.7 μΩ/Ω + 60 mΩ 3.4 μΩ/Ω + 0.6 Ω 2.8 μΩ/Ω + 0.6 Ω 7.3 μΩ/Ω + 6 Ω 11 μΩ/Ω + 6 Ω 49 μΩ/Ω + 60 Ω	Fluke 5450A resistance calibrator	RFD

Parameter/Equipment	Range	CMC ^{2, 6, 7} ($\pm$)	Comment	Location ¹⁰
Resistance – Fixed Points ³	(0.01, 0.1, 1.0) Ω	34 $\mu\Omega/\Omega$	Leeds & Northrup resistor set	ATL
	0.001 Ω 0.01 Ω 0.01 Ω 1 Ω 10 Ω 100 Ω 1 k Ω 10 k Ω 100 k Ω	0.031 % 0.029 % 0.010 % 49 $\mu\Omega/\Omega$ 36 $\mu\Omega/\Omega$ 36 $\mu\Omega/\Omega$ 36 $\mu\Omega/\Omega$ 36 $\mu\Omega/\Omega$ 38 $\mu\Omega/\Omega$	Leeds & Northrup series standard resistors	RDU
	1 m Ω 10 m Ω 100 m Ω 1 Ω 10 Ω 100 Ω 1 k Ω 10 k Ω 100 k Ω	0.033 % of Output 0.019 % of Output 0.029 % of Output 0.014 % of Output 0.013 % of Output 0.013 % of Output 0.013 % of Output 0.013 % of Output 0.013 % of Output	Keysight 42030A resistor set fixed	COS
Resistance – Generate ³	Up to 12 Ω (12 to 120) Ω (0.12 to 1.20) k Ω (1.2 to 12.0) k Ω (12 to 120) k Ω (0.12 to 1.2) M Ω (1.2 to 12) M Ω (12 to 120) M Ω (120 to 1200) M Ω	19 $\mu\Omega/\Omega + 0.001 \Omega$ 19 $\mu\Omega/\Omega + 0.001 \Omega$ 19 $\mu\Omega/\Omega + 0.002 \Omega$ 19 $\mu\Omega/\Omega + 0.02 \Omega$ 19 $\mu\Omega/\Omega + 0.2 \Omega$ 19 $\mu\Omega/\Omega + 2 \Omega$ 27 $\mu\Omega/\Omega + 24 \Omega$ 330 $\mu\Omega/\Omega + 2 \text{ k}\Omega$ 3 m $\Omega/\Omega + 76 \Omega$	Fluke 5560A multiproduct calibrator	COS, HRT MEL, ATL RDU, RFD TPA, HSV, DFW
	(0 to 11) Ω (11 to 33) Ω (33 to 110) Ω (110 to 330) Ω (0.33 to 1.1) k Ω (1.1 to 3.3) k Ω (3.3 to 11) k Ω (11 to 33) k Ω (33 to 110) k Ω (110 to 330) k Ω 0.33 k Ω to 1.1 M Ω (1.1 to 3.3) M Ω (3.3 to 11) M Ω (11 to 33) M Ω (33 to 110) M Ω (110 to 330) M Ω 330 M Ω to 1.1 G Ω	30 $\mu\Omega/\Omega + 0.001 \Omega$ 23 $\mu\Omega/\Omega + 0.001 \Omega$ 21 $\mu\Omega/\Omega + 0.001 \Omega$ 21 $\mu\Omega/\Omega + 0.002 \Omega$ 21 $\mu\Omega/\Omega + 0.002 \Omega$ 21 $\mu\Omega/\Omega + 0.02 \Omega$ 21 $\mu\Omega/\Omega + 0.02 \Omega$ 21 $\mu\Omega/\Omega + 0.2 \Omega$ 21 $\mu\Omega/\Omega + 0.2 \Omega$ 24 $\mu\Omega/\Omega + 2 \Omega$ 24 $\mu\Omega/\Omega + 2 \Omega$ 46 $\mu\Omega/\Omega + 23 \Omega$ 99 $\mu\Omega/\Omega + 38 \Omega$ 190 $\mu\Omega/\Omega + 1.9 \text{ k}\Omega$ 380 $\mu\Omega/\Omega + 2.3 \text{ k}\Omega$ 0.23 % of setting + 76 k Ω 1.1 % of rdg + 380 k Ω	Fluke 5522A multiproduct calibrator	SFL, HLR HSV



Parameter/Equipment	Range	CMC ^{2, 7} (±)	Comment	Location ¹⁰
Resistance – Measure ³ Fixed Points	(1, 1.9) Ω (10, 19) Ω (100, 190) Ω (1, 1.9) kΩ (10, 19) kΩ (100, 190) kΩ (1, 1.9) MΩ (10, 19) MΩ 100 MΩ 1 GΩ	4.8 μΩ/Ω 2.6 μΩ/Ω 0.7 μΩ/Ω 0.9 μΩ/Ω 1 μΩ/Ω 1.3 μΩ/Ω 2.3 μΩ/Ω 2.9 μΩ/Ω 22 μΩ/Ω 120 μΩ/Ω	Fluke 8508A multimeter, Fluke 742A, IET SRL resistance standards	TPA
Resistance – Measure ³	Up to 2 Ω (2 to 20) Ω (20 to 200) Ω 200 Ω to 2 kΩ (2 to 20) kΩ (20 to 200) kΩ 200 kΩ to 2 MΩ (2 to 20) MΩ (20 to 200) MΩ 200 MΩ to 2 GΩ (2 to 20) GΩ	15 μΩ/Ω + 3.8 μΩ 8.8 μΩ/Ω + 14 μΩ 7.2 μΩ/Ω + 46 μΩ 7.2 μΩ/Ω + 457 μΩ 7.2 μΩ/Ω + 4.6 mΩ 7.2 μΩ/Ω + 46 mΩ 8 μΩ/Ω + 0.9 Ω 15 μΩ/Ω + 9 Ω 57 μΩ/Ω + 0.9 kΩ 150 μΩ/Ω + 91 kΩ 510 μΩ/Ω + 9.1 MΩ	Fluke 8508A multimeter	TPA
	Up to 2.02 Ω (2.02 to 20.2) Ω (20.2 to 202) Ω (0.202 to 2.02) kΩ (2.02 to 20.2) kΩ (20.2 to 202) kΩ (0.202 to 2.02) MΩ (2.02 to 20.2) MΩ (20.2 to 202) MΩ (0.202 to 2.02) GΩ (2.02 to 20.2) GΩ	16 μΩ/Ω + 4 μΩ 9.9 μΩ/Ω + 14 μΩ 9.0 μΩ/Ω + 48 μΩ 8.9 μΩ/Ω + 0.46 mΩ 9 μΩ/Ω + 4.6 mΩ 9.1 μΩ/Ω + 46 mΩ 10 μΩ/Ω + 1 Ω 17 μΩ/Ω + 9.8 Ω 67 μΩ/Ω + 0.98 kΩ 0.23 mΩ/Ω + 98 kΩ 1.3 mΩ/Ω + 9.8 MΩ	Fluke 8588A multimeter	RFD, ATL, DFW, COS
	Up to 2.02 Ω 2.02 to 20.2 Ω (20.2 to 202) Ω (0.202 to 2.02) kΩ (2.02 to 20.2) kΩ (20.2 to 202) kΩ (0.202 to 2.02) MΩ (2.02 to 20.2) MΩ (20.2 to 202) MΩ (0.202 to 2.02) GΩ (2.02 to 20.2) GΩ	21 μΩ/Ω + 4.4 μΩ 15 μΩ/Ω + 20 μΩ 12 μΩ/Ω + 53 μΩ 12 μΩ/Ω + 0.53 mΩ 12 μΩ/Ω + 5.3 mΩ 12 μΩ/Ω + 53 mΩ 13 μΩ/Ω + 1.0 Ω 17 μΩ/Ω + 9.8 Ω 67 μΩ/Ω + 0.98 kΩ 230 μΩ/Ω + 98 kΩ 1.3 mΩ/Ω + 9.8 MΩ	Fluke 8558A multimeter	RDU

Parameter/Equipment	Range	CMC ^{2, 7} (±)	Comment	Location ¹⁰
Resistance – Measure ³	40 V (0.2 to 2) MΩ (2 to 20) MΩ (20 to 200) MΩ (0.2 to 2) GΩ (2 to 20) GΩ (20 to 200) GΩ	0.13 % of rdg 0.13 % of rdg 0.15 % of rdg 0.23 % of rdg 0.23 % of rdg 0.35 % of rdg	Keithley 6517A electrometer	RFD
	400 V (0.2 to 2) TΩ (2 to 20) TΩ (20 to 200) TΩ	0.35 % of rdg 1.0 % of rdg 1.2 % of rdg		
Resistance – Measure ³	Up to 12 Ω (10 to 120) Ω (0.1 to 1.2) kΩ (1 to 12) kΩ (10 to 120) kΩ (0.1 to 1.2) MΩ (1 to 12) MΩ (10 to 120) MΩ (0.1 to 1.2) GΩ	9.8 μΩ/Ω + 38 μΩ 7.8 μΩ/Ω + 0.3 mΩ 6.5 μΩ/Ω + 0.4 mΩ 6.5 μΩ/Ω + 3.8 mΩ 6.5 μΩ/Ω + 38 mΩ 9.8 μΩ/Ω + 1.5 Ω 33 μΩ/Ω + 100 Ω 330 μΩ/Ω + 1 kΩ 0.33 % of rdg + 70 kΩ	Agilent 3458A multimeter	TPA, ATL, HSV, RFD, HLR, SFL, MEL, COS, RDU, HRT, DFW
	100 V 100 kΩ (100, 1000) V 1 MΩ 10 MΩ 100 MΩ 1 GΩ 10 GΩ (500, 1000) V 100 GΩ	0.53 % of rdg 0.5 % of rdg 0.5 % of rdg 0.5 % of rdg 0.5 % of rdg 0.52 % of rdg 0.59 % of rdg	Quadtech 1865 megohmmeter	TPA
	1000 V 1 TΩ 10 TΩ	0.7 % of rdg 2.5 % of rdg		
	50 Hz (1 to 10) Ω (10 to 100) Ω (100 to 1000) Ω (1 to 10) kΩ (10 to 100) kΩ (0.1 to 1) MΩ (1 to 10) MΩ	0.17 % of rdg 0.062 % of rdg 0.051 % of rdg 0.05 % of rdg 0.054 % of rdg 0.09 % of rdg 0.45 % of rdg	IET 1693 RLC meter	TPA, RFD COS, ATL

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
Resistance – Measure ³	100/120 Hz (1 to 10) Ω (10 to 100) Ω (100 to 1000) Ω (1 to 10) kΩ (10 to 100) kΩ (0.1 to 1) MΩ (1 to 10) MΩ	0.13 % of rdg 0.049 % of rdg 0.041 % of rdg 0.04 % of rdg 0.043 % of rdg 0.07 % of rdg 0.34 % of rdg	IET 1693 RLC meter	TPA, RFD COS, ATL
	1000 Hz (1 to 10) Ω (10 to 100) Ω (100 to 1000) Ω (1 to 10) kΩ (10 to 100) kΩ	0.05 % of rdg 0.02 % of rdg 0.02 % of rdg 0.02 % of rdg 0.02 % of rdg		
	1000 Hz (0.1 to 1) MΩ (1 to 10) MΩ	0.03 % of rdg 0.12 % of rdg		
	10 kHz (1 to 10) Ω (10 to 100) Ω (100 to 1000) Ω (1 to 10) kΩ (10 to 25.6) kΩ (25.6 to 100) kΩ (0.1 to 1) MΩ (1 to 10) MΩ	0.17 % of rdg 0.062 % of rdg 0.051 % of rdg 0.05 % of rdg 0.051 % of rdg 0.19 % of rdg 0.33 % of rdg 1.8 % of rdg		
	100 kHz (1 to 10) Ω (10 to 100) Ω (100 to 1000) Ω (1 to 10) kΩ (10 to 100) kΩ (0.1 to 1) MΩ	0.77 % of rdg 0.26 % of rdg 0.21 % of rdg 0.23 % of rdg 0.52 % of rdg 3.4 % of rdg		
Capacitance – Generate ³	(0.2 to 1.2) nF (1.2 to 12.0) nF (12 to 120.0) nF (0.12 to 1.2) μF (1.2 to 12.0) μF (12 to 120.0) μF (0.12 to 1.2) mF (1.2 to 12.0) mF (12 to 120.0) mF	0.09 % of output + 1.5 pF 0.09 % of output + 0.004 nF 0.10 % of output + 0.023 nF 0.10 % of output + 0.23 nF 0.10 % of output + 2.3 nF 0.11 % of output + 19 nF 0.19 % of output + 190 nF 0.19 % of output + 2.3 μF 0.38 % of output + 23 μF	Fluke 5560A multiproduct calibrator	COS, HRT MEL, ATL RDU, RFD TPA, HSV, DFW

Parameter/Equipment	Range	CMC ^{2, 7} (±)	Comment	Location ¹⁰
Capacitance – Generate ³	(220 to 400) pF (0.4 to 3.2999) nF (3.3 to 10.9999) nF (11 to 32.9999) nF (33 to 109.999) nF (110 to 329.999) nF (0.33 to 1.099 99) µF (1.1 to 3.299 99) µF (3.3 to 10.999 9) µF (11 to 32.999 9) µF (33 to 109.999) µF (110 to 329.999) µF (0.33 to 1.099 99) mF (1.1 to 3.299 99) mF (3.3 to 10.9999) mF (11 to 32.9999) mF (33 to 110) mF	0.38 % of output + 7.6 pF 0.38 % of output + 0.01 nF 0.19 % of output + 0.01 nF 0.19 % of output + 0.08 nF 0.19 % of output + 0.08 nF 0.19 % of output + 0.23 nF 0.19 % of output + 0.76 nF 0.19 % of output + 2.3 nF 0.19 % of output + 7.6 nF 0.3 % of output + 23 nF 0.34 % of output + 76 nF 0.34 % of output + 230 nF 0.34 % of output + 0.76 µF 0.34 % of output + 2.3 µF 0.34 % of output + 7.6 µF 0.57 % of output + 23 µF 0.84 % of output + 76 µF	Fluke 5522A multiproduct calibrator	HSV, SFL, HLR
Capacitance – Generate Fixed Point	1 nF 1 kHz	0.000 11 nF	Standard capacitor IET SCA-1.0nF-8588A	COS
	1.9 nF 1 kHz	0.000 21 nF	IET SCA-1.0nF-8588A	
	200 nF 1 kHz	0.10 nF	GR 1409-U	
	500 nF 1 kHz	0.25 nF	GR1409-X	
Capacitance – Generate ³ Fixed Points	1 pF 1 kHz 1 MHz 2 MHz 3 MHz 4 MHz 5 MHz 10 MHz 13 MHz	0.028 % of output 0.028 % of output 0.034 % of output 0.047 % of output 0.069 % of output 0.096 % of output 0.31 % of output 0.5 % of output	Agilent 16381A capacitor fixed	TPA, ATL
	10 pF 1 kHz 1 MHz 2 MHz 3 MHz 4 MHz 5 MHz 10 MHz 13 MHz	0.019 % of output 0.019 % of output 0.019 % of output 0.019 % of output 0.019 % of output 0.019 % of output 0.022 % of output 0.024 % of output	Agilent 16382A capacitor fixed	



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
Capacitance – Generate ³ Fixed Points	100 pF 1 kHz 1 MHz 2 MHz 3 MHz 4 MHz 5 MHz 10 MHz 13 MHz 1000 pF 1 kHz 1 MHz 2 MHz 3 MHz 4 MHz 5 MHz 10 MHz 13 MHz	0.017 % of output 0.017 % of output 0.018 % of output 0.018 % of output 0.02 % of output 0.024 % of output 0.053 % of output 0.083 % of output 0.018 % of output 0.019 % of output 0.024 % of output 0.035 % of output 0.051 % of output 0.069 % of output 0.22 % of output 0.32 % of output	Agilent 16384A standard air capacitor	TPA, ATL
	1 pF 1 kHz 1 MHz 2 MHz 3 MHz 4 MHz 5 MHz 10 MHz 13 MHz	0.038 % of output 0.038 % of output 0.044 % of output 0.055 % of output 0.073 % of output 0.096 % of output 0.25 % of output 0.37 % of output	Agilent 16381A capacitor fixed	RFD
	10 pF 1 kHz 1 MHz 2 MHz 3 MHz 4 MHz 5 MHz 10 MHz 13 MHz	0.035 % of output 0.035 % of output 0.035 % of output 0.035 % of output 0.035 % of output 0.035 % of output 0.036 % of output 0.038 % of output	Agilent 16382A capacitor fixed	
	100 pF 1 kHz 1 MHz 2 MHz 3 MHz 4 MHz 5 MHz 10 MHz 13 MHz	0.035 % of output 0.035 % of output 0.035 % of output 0.035 % of output 0.035 % of output 0.037 % of output 0.048 % of output 0.06 % of output	Agilent 16383A capacitor fixed	

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
Capacitance – Generate ³ Fixed Points	1000 pF 1 kHz 1 MHz 2 MHz 3 MHz 4 MHz 5 MHz 10 MHz 13 MHz	0.035 % of output 0.035 % of output 0.037 % of output 0.044 % of output 0.056 % of output 0.071 % of output 0.19 % of output 0.28 % of output	Agilent 16384A capacitor fixed	RFD, COS
	0.01 µF 0.12 kHz 1 kHz 10 kHz 100 kHz	0.02 % of output 0.02 % of output 0.02 % of output 0.02 % of output	Agilent 16385A capacitor fixed	
	0.1 µF 0.12 kHz 1 kHz 10 kHz 100 kHz	0.02 % of output 0.02 % of output 0.02 % of output 0.02 % of output	Agilent 16386A capacitor fixed	
	1 µF 0.12 kHz 1 kHz 10 kHz 100 kHz	0.021 % of output 0.02 % of output 0.02 % of output 0.021 % of output	Agilent 16387A capacitor fixed	
	1 pF 1 kHz 1 MHz 2 MHz 3 MHz 4 MHz 5 MHz 10 MHz 13 MHz	0.038 % of output 0.038 % of output 0.044 % of output 0.055 % of output 0.073 % of output 0.096 % of output 0.25 % of output 0.37 % of output	Agilent 16381A capacitor fixed	COS



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
Capacitance – Generate ³ Fixed Points	10 pF 1 kHz 1 MHz 2 MHz 3 MHz 4 MHz 5 MHz 10 MHz 13 MHz	0.035 % of output 0.035 % of output 0.035 % of output 0.035 % of output 0.035 % of output 0.035 % of output 0.036 % of output 0.038 % of output	Agilent 16382A capacitor fixed	COS
	1000 pF 1 kHz 1 MHz 2 MHz 3 MHz 4 MHz 5 MHz 10 MHz 13 MHz	0.035 % of output 0.035 % of output 0.037 % of output 0.044 % of output 0.056 % of output 0.071 % of output 0.19 % of output 0.28 % of output	Agilent 16384A, capacitor fixed	
	100 & 120 Hz 10 µF 100 µF 1000 µF 10 mF 100 mF 1 F 1 kHz 10 µF 100 µF 1000 µF 10 mF	0.35 % of output 0.35 % of output 0.35 % of output 0.35 % of output 0.36 % of output 0.43 % of output 0.35 % of output 0.35 % of output 0.36 % of output 0.4 % of output	Capacitance standard	
Capacitance – Generate	1 kHz 1 pF to 1.111 11 µF	0.05 % of output + 0.5 pF	GR 1413 decade capacitor	MEL, COS
Inductance – Generate ³	(13 to 120.0) µH (0.12 to 1.2) mH (1.2 to 12.0) mH (12 to 120.0) mH (0.12 to 1.2) H (1.2 to 12.0) H (12 to 120.0) H	0.15 % of output + 0.15 µH 0.09 % of output + 0.76 µH 0.09 % of output + 7.6 µH 0.09 % of output + 76 µH 0.11 % of output + 0.76 mH 0.15 % of output + 7.6 mH 0.19 % of output + 76 mH	Fluke 5560A multiproduct calibrator	COS, HRT MEL, ATL RDU, RFD, DFW, HSV

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
Inductance – Generate ³ Fixed Point	100 µH 10 kHz	0.25 µH	GR 1482-B standard inductor	RFD
	100 mH 100 Hz	0.047 mH	GR 1482-L standard inductor	RFD, RDU
	500 µH 1 kHz	0.35 µH	GR 1482-D standard inductor	ATL
	20 mH 1 kHz	0.008 mH	GR 1482-J standard Inductor	
	200 mH 100 Hz	0.11 mH	GR 1482-M standard inductor	
	2 H 100 Hz	0.8 mH	GR 1482-Q standard inductor	
	50 mH 100 Hz 1 kHz	0.028 mH 0.021 mH	GR 1482-K standard inductor	TPA
	100 mH 100 Hz 1 kHz	0.069 mH 0.063 mH	GR 1481-G standard inductor	
	200 mH 100 Hz 1 kHz	0.09 mH 0.06 mH	GR 1482-M standard inductor	
	500 mH 100 Hz 1 kHz	0.23 mH 0.15 mH	GR 1482-N standard inductor	
	5 H 100 Hz 1 kHz	0.021 H 0.021 H	GR 1482-R standard inductor	



Parameter/Range	Frequency	CMC ^{2, 6, 7} ($\pm$)	Comment	Location ¹⁰
Inductance – Generate Fixed Point	100 uH 1 kHz 10 kHz	0.078 μ H 0.078 μ H	GR 1693 LCR meter / standard inductors GR 1482-B	COS
	1 mH 1 kHz	0.000 28 mH	GR 1482-E	
	10 mH 110 Hz 1 kHz	0.0059 mH 0.0022 mH	GR 1482-H	
	100 mH 100 Hz	0.082 mH	IET LS-B-100mH-KAFB	
	1 H 12 Hz 100 Hz	0.0014 H 0.0008 H	GR 1482-P	
	10 H 12 Hz 100 Hz	0.013 H 0.0072 H	GR 1482-T	

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
Inductance – Generate ³ Fixed Point	1000 Hz 5 mH	0.0018 mH	GR 1482-G standard inductor	COS
	1kHz (1 to 10) mH (1 to 100) mH (100 to 1 000) mH (1 to 10) H	2 % of output 1 % of output 0.5 % of output 0.25 % of output	Bundy Electronics BEC-700-032 decade inductor	MEL
Capacitance – Measure ³	50 Hz (50 to 100) pF (100 to 400) pF (400 to 1000) pF (1 to 10) nF (10 to 100) nF (100 to 1000) nF (0.1 to 1) μF (1 to 10) μF (10 to 100) μF (100 to 1000) μF 100 Hz (20 to 100) pF (100 to 400) pF (400 to 1000) pF (1 to 10) nF (10 to 100) nF (100 to 1000) nF (0.1 to 1) μF (10 to 100) μF (100 to 1 000) μF 120 Hz (20 to 100) pF (100 to 400) pF (400 to 1000) pF (1 to 10) nF (10 to 100) nF (100 to 1000) nF (0.1 to 1) μF (1 to 10) μF (10 to 100) μF (100 to 1000) μF	2.6 % of rdg 1.3 % of rdg 0.37 % of rdg 0.18 % of rdg 0.063 % of rdg 0.051 % of rdg 0.051 % of rdg 0.05 % of rdg 0.054 % of rdg 0.09 % of rdg 2.4 % of rdg 0.52 % of rdg 0.16 % of rdg 0.088 % of rdg 0.045 % of rdg 0.041 % of rdg 0.041 % of rdg 0.046 % of rdg 0.1 % of rdg 2 % of rdg 0.44 % of rdg 0.14 % of rdg 0.08 % of rdg 0.044 % of rdg 0.04 % of rdg 0.04 % of rdg 0.041 % of rdg 0.047 % of rdg 0.11 % of rdg	IET 1693 LCR meter	TPA, RFD COS, ATL



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
Capacitance – Measure ³	1000 Hz (1 to 10) pF (10 to 20) pF (20 to 100) pF (100 to 400) pF (400 to 1000) pF (1 to 10) nF (10 to 100) nF (100 to 1000) nF (0.1 to 1) µF (1 to 10) µF (10 to 100) µF (100 to 1000) µF	1.6 % of rdg 0.18 % of rdg 0.1 % of rdg 0.036 % of rdg 0.024 % of rdg 0.022 % of rdg 0.02 % of rdg 0.02 % of rdg 0.02 % of rdg 0.022 % of rdg 0.04 % of rdg 0.22 % of rdg	IET 1693 LCR meter	TPA, RFD COS, ATL
	10 kHz (20 to 100) pF (100 to 622) pF (622 to 1000) pF (1 to 10) nF (10 to 100) nF (100 to 1000) nF (0.1 to 1) µF (1 to 10) µF (10 to 100) µF (100 to 500) µF	0.3 % of rdg 0.2 % of rdg 0.051 % of rdg 0.051 % of rdg 0.051 % of rdg 0.058 % of rdg 0.058 % of rdg 0.13 % of rdg 0.85 % of rdg 4.1 % of rdg		
	100 kHz (20 to 100) pF (100 to 400) pF (400 to 1000) pF (1 to 10) nF (10 to 100) nF (100 to 1000) nF (0.1 to 1) µF (1 to 10) µF	0.49 % of rdg 0.26 % of rdg 0.21 % of rdg 0.21 % of rdg 0.24 % of rdg 0.58 % of rdg 0.58 % of rdg 4 % of rdg		
Capacitance – Measure	1 KHz (0.1 to 1) pF (1 to 10) pF (10 to 100) pF (100 to 1000) pF 0.001 µF to 0.1 µF (0.01 to 0.1) µF (0.1 to 1) µF	14.1 µF/F + 0.06 aF 7.1 µF/F + 0.6 aF 7.1 µF/F + 6 aF 7.4 µF/F + 0.06 fF 11.5 µF/F + 0.6 fF 75.3 µF/F + 6 fF 733 µF/F + 0.06 nF	AH 2500A ultra precision capacitance bridge	RFD

Parameter/Range	Frequency	CMC ^{2,7} (±)	Comment	Location ¹⁰
Capacitance – Measure ³	100 Hz /120 Hz (16 to 400) pF	2 % of rdg + 0.3 pF	Agilent 4263B LCR meter	SFL, HSV
	(0.4 to 1) nF	0.17 % of rdg		
	(1 to 100) nF	0.13 % of rdg		
	(0.1 to 1) µF	0.12 % of rdg		
	(1 to 100) µF	0.18 % of rdg		
	(0.1 to 1) mF	0.20 % of rdg		
	1000 Hz (16 to 400) pF	0.43 % of rdg + 0.3 pF		
	(0.4 to 1) nF	0.1 % of rdg		
	(1 to 100) nF	0.08 % of rdg		
	(0.1 to 1) µF	0.07 % of rdg		
	(1 to 100) µF	0.13 % of rdg		
	(0.1 to 1) mF	0.45 % of rdg		
	10 kHz (16 to 400) pF	0.56 % of rdg + 0.3 pF		
	(0.4 to 1) nF	0.15 % of rdg		
	(1 to 100) nF	0.12 % of rdg		
	(0.1 to 1) µF	0.17 % of rdg		
	(1 to 100) µF	0.69 % of rdg		
	(0.1 to 1) mF	3.5 % of rdg		
	20 kHz (16 to 400) pF	2.1 % of rdg + 0.3 pF		
	(0.4 to 1) nF	0.62 % of rdg		
	(1 to 100) nF	0.62 % of rdg		
	(0.1 to 1) µF	0.43 % of rdg		
	(1 to 100) µF	1.7 % of rdg		
	100 kHz (16 to 400) pF	1.6 % of rdg + 0.3 pF		
	(0.4 to 1) nF	1 % of rdg		
	(1 to 100) nF	0.98 % of rdg		
	(0.1 to 1) µF	1.4 % of rdg		
	(1 to 10) µF	4.1 % of rdg		



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
Capacitance – Measure ³	(10 to 100) pF			
	(100 to 1000) Hz	10 % of rdg		
	(1 to 10) kHz	1 % of rdg		
	(10 to 100) kHz	0.3 % of rdg		
	(0.1 to 1) MHz	1 % of rdg		
	(1 to 2) MHz	1 % of rdg		
	(100 to 1000) pF			
	(20 to 100) Hz	10 % of rdg		
	(100 to 1000) Hz	1.2 % of rdg		
	(1 to 10) kHz	0.3 % of rdg		
	(10 to 100) kHz	0.3 % of rdg		
	(0.1 to 1) MHz	0.3 % of rdg		
	(1 to 2) MHz	1 % of rdg		
	(1 to 10) nF			
	(20 to 100) Hz	1.2 % of rdg		
	(100 to 1000) Hz	0.3 % of rdg		
	(1 to 10) kHz	0.1 % of rdg		
	(10 to 100) kHz	0.1 % of rdg		
	(0.1 to 1) MHz	0.3 % of rdg		
	(1 to 2) MHz	1 % of rdg		
	(10 to 100) nF			
	(20 to 100) Hz	0.3 % of rdg		
	(100 to 1000) Hz	0.1 % of rdg		
	(1 to 10) kHz	0.1 % of rdg		
	(10 to 100) kHz	0.1 % of rdg		
	(0.1 to 1) MHz	0.3 % of rdg		
	(1 to 2) MHz	1 % of rdg		
	(100 to 1000) nF			
	(20 to 100) Hz	0.3 % of rdg		
	(100 to 1000) Hz	0.1 % of rdg		
	(1 to 10) kHz	0.3 % of rdg		
	(10 to 100) kHz	0.3 % of rdg		
	(0.1 to 1) MHz	1 % of rdg		
	(1 to 2) MHz	1 % of rdg		
	(1 to 10) µF			
	(20 to 100) Hz	0.3 % of rdg		
	(100 to 1000) Hz	0.12 % of rdg		
	(1 to 10) kHz	0.3 % of rdg		
	(10 to 100) kHz	0.7 % of rdg		
	(0.1 to 1) MHz	5 % of rdg		
	(1 to 2) MHz	7 % of rdg		

Agilent
E4980A LCR
meter

MEL, TPA
RDU

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
Capacitance – Measure ³	(10 to 100) µF (20 to 100) Hz	0.3 % of rdg	Agilent E4980A LCR meter	MEL, TPA RDU
	(100 to 1000) Hz	0.3 % of rdg		
	(1 to 10) kHz	0.7 % of rdg		
	(10 to 100) kHz	5 % of rdg		
	(100 to 1000) µF (20 to 100) Hz	0.3 % of rdg		
	(100 to 1000) Hz	1 % of rdg		
	(1 to 10) kHz	5 % of rdg		
	(1 to 10) mF (20 to 100) Hz	1.2 % of rdg		
	(100 to 1000) Hz	10 % of rdg		
	(10 to 100) mF (20 to 100) Hz	10 % of rdg		
Inductance – Measure ³	100 Hz (40 to 100) µH	3.8 % of rdg	IET 1693 LCR meter	TPA, RFD COS, ATL
	(0.1 to 0.4) mH	1.6 % of rdg		
	(0.4 to 1) mH	0.42 % of rdg		
	(1 to 10) mH	0.19 % of rdg		
	(10 to 100) mH	0.056 % of rdg		
	(0.1 to 1) H	0.042 % of rdg		
	(1 to 10) H	0.041 % of rdg		
	(10 to 100) H	0.042 % of rdg		
	1000 Hz (4 to 10) µH	1.3 % of rdg		
	(10 to 40) µH	0.53 % of rdg		
	(40 to 100) µH	0.15 % of rdg		
	(0.1 to 0.4) mH	0.071 % of rdg		
	(0.4 to 1) mH	0.033 % of rdg		
	(1 to 10) mH	0.025 % of rdg		
	(10 to 100) mH	0.021 % of rdg		
	(0.1 to 1) H	0.02 % of rdg		
	(1 to 10) H	0.021 % of rdg		
	(10 to 100) H	0.026 % of rdg		
	10 kHz (1 to 4) µH	2.1 % of rdg		
	(4 to 10) µH	0.56 % of rdg		
	(10 to 40) µH	0.25 % of rdg		
	(40 to 100) µH	0.1 % of rdg		
	(0.1 to 0.4) mH	0.071 % of rdg		
	(0.4 to 1) mH	0.056 % of rdg		
	(1 to 10) mH	0.052 % of rdg		
	(10 to 100) mH	0.051 % of rdg		
	(0.1 to 0.407) H	0.051 % of rdg		
	(0.407 to 1) H	0.18 % of rdg		
	(1 to 10) H	0.27 % of rdg		
	(10 to 100) H	1.2 % of rdg		

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
Inductance – Measure ³	100 kHz (1 to 4) µH (4 to 10) µH (10 to 40) µH (40 to 100) µH (0.1 to 0.4) mH (0.4 to 1) mH (1 to 10) mH (10 to 100) mH (0.1 to 1) H	1.2 % of rdg 0.44 % of rdg 0.3 % of rdg 0.23 % of rdg 0.21 % of rdg 0.21 % of rdg 0.22 % of rdg 0.39 % of rdg 2.1 % of rdg	IET 1693 LCR meter	TPA, RFD COS, ATL
Inductance – Measure ³	100 Hz /120 Hz (4 to 10) µH (10 to 40) µH (40 to 100) µH (0.1 to 0.4) mH (0.4 to 1) mH (1 to 10) mH (10 to 100) mH (0.1 to 1) H (1 to 10) H 1000 Hz (1 to 4) µH (4 to 10) µH (10 to 40) µH (40 to 100) µH (0.1 to 0.4) mH (0.4 to 1) mH (1 to 10) mH (10 to 100) mH (0.1 to 1) H (1 to 10) H 10 kHz (1 to 4) µH (4 to 10) µH (10 to 40) µH (40 to 100) µH (0.1 to 0.4) mH (0.4 to 1) mH (1 to 10) mH (10 to 100) mH (0.1 to 1) H (1 to 10) H	3.4 % of rdg + 0.03 µH 1.5 % of rdg + 0.03 µH 0.57 % of rdg + 0.03 µH 0.4 % of rdg 0.32 % of rdg 0.28 % of rdg 0.23 % of rdg 0.18 % of rdg 0.22 % of rdg 1.0 % of rdg + 0.03 µH 0.46 % of rdg + 0.03 µH 0.49 % of rdg + 0.03 µH 0.35 % of rdg + 0.03 µH 0.30 % of rdg 0.11 % of rdg 0.12 % of rdg 0.10 % of rdg 0.10 % of rdg 0.12 % of rdg 0.62 % of rdg + 0.03 µH 0.40 % of rdg + 0.03 µH 0.32 % of rdg + 0.03 µH 0.18 % of rdg + 0.03 µH 0.20 % of rdg 0.14 % of rdg 0.17 % of rdg 0.20 % of rdg 0.20 % of rdg 0.44 % of rdg	Agilent 4263B LCR meter	SFL, HSV



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
Inductance – Measure ³	20 kHz (1 to 4) µH (4 to 10) µH (10 to 40) µH (40 to 100) µH (0.1 to 0.4) mH (0.4 to 1) mH (1 to 10) mH (10 to 100) mH (0.1 to 1) H (1 to 10) H	1.3 % of rdg + 0.03 µH 0.68 % of rdg + 0.03 µH 0.63 % of rdg + 0.03 µH 0.53 % of rdg + 0.03 µH 0.49 % of rdg 0.48 % of rdg 0.65 % of rdg 0.66 % of rdg 1.2 % of rdg 3.3 % of rdg	Agilent 4263B LCR meter	SFL, HSV
	100 kHz (1 to 4) µH (4 to 10) µH (10 to 40) µH (40 to 100) µH (0.1 to 0.4) mH (0.4 to 1) mH (1 to 10) mH (10 to 100) mH (0.1 to 1) H	1.8 % of rdg + 0.03 µH 0.86 % of rdg + 0.03 µH 1.20 % of rdg + 0.03 µH 0.68 % of rdg + 0.03 µH 0.90 % of rdg 1.1 % of rdg 1.3 % of rdg 1.4 % of rdg 6.3 % of rdg		
	(100 to 1000) nH (10 to 100) kHz (0.1 to 1) MHz (1 to 2) MHz (1 to 10) µH (2 to 10) kHz (10 to 100) kHz (0.1 to 1) MHz (1 to 2) MHz (10 to 100) µH (250 to 1000) Hz (1 to 2) kHz (2 to 10) kHz (10 to 100) kHz (0.1 to 1) MHz (1 to 2) MHz (100 to 1000) µH (50 to 100) Hz (100 to 250) Hz (250 to 1000) Hz (100 to 1000) µH (1 to 2) kHz (2 to 10) kHz (10 to 100) kHz (0.1 to 1) MHz (1 to 2) MHz	10 % of rdg 1 % of rdg 1 % of rdg 10 % of rdg 1 % of rdg 0.3 % of rdg 1 % of rdg 10 % of rdg 10 % of rdg 1 % of rdg 0.3 % of rdg 0.3 % of rdg 1 % of rdg 10 % of rdg 10 % of rdg 1 % of rdg 1 % of rdg 0.3 % of rdg 0.3 % of rdg 0.3 % of rdg 1 % of rdg	Agilent E4980A LCR meter	MEL, TPA RDU



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
Inductance – Measure ³	(1 to 10) mH (20 to 50) Hz (50 to 100) Hz (100 to 250) Hz (250 to 1000) Hz (1 to 2) kHz (2 to 10) kHz (10 to 100) kHz (0.1 to 1) MHz (1 to 2) MHz	10 % of rdg 1 % of rdg 1 % of rdg 0.3 % of rdg 0.3 % of rdg 0.1 % of rdg 0.1 % of rdg 0.3 % of rdg 1 % of rdg	Agilent E4980A LCR meter	MEL, TPA RDU
	(10 to 100) mH (20 to 50) Hz (50 to 100) Hz (100 to 250) Hz (250 to 1000) Hz (1 to 2) kHz (2 to 10) kHz (10 to 100) kHz (0.1 to 1) MHz (1 to 2) MHz	1 % of rdg 0.3 % of rdg 0.3 % of rdg 0.3 % of rdg 0.3 % of rdg 0.1 % of rdg 0.1 % of rdg 1 % of rdg 10 % of rdg		
	(100 to 1000) mH (20 to 50) Hz (50 to 100) Hz (100 to 250) Hz (250 to 1000) Hz (1 to 2) kHz (2 to 10) kHz (10 to 100) kHz (0.1 to 1) MHz	0.3 % of rdg 0.3 % of rdg 0.1 % of rdg 0.1 % of rdg 0.1 % of rdg 0.1 % of rdg 0.3 % of rdg 10 % of rdg		
	(1 to 10) H (20 to 50) Hz (50 to 100) Hz (100 to 250) Hz (250 to 1000) Hz (1 to 2) kHz (2 to 10) kHz (10 to 100) kHz	0.3 % of rdg 0.3 % of rdg 0.1 % of rdg 0.1 % of rdg 0.1 % of rdg 0.3 % of rdg 1 % of rdg		

Parameter/Equipment	Range	CMC ^{2, 7} (±)	Comment	Location ¹⁰
Oscilloscopes Calibration ³ – Generate				
Voltage DC – 50 Ω	(1 to 24.999) mV (25 to 109.99) mV 110 mV to 2.1999 V (2.2 to 6.6) V	0.19 % of Output + 31 μV 0.19 % of Output + 36 μV 0.19 % of Output + 87 μV 0.19 % of Output + 0.6 mV		
DC – 1 MΩ	(1 to 24.999) mV (25 to 109.99) mV 110 mV to 2.1999 V (2.2 to 10.999) V (11 to 130) V	0.019 % of rdg + 20 μV 0.019 % of rdg + 25 μV 0.019 % of rdg + 76 μV 0.019 % of rdg + 0.6 mV 0.019 % of rdg + 6.0 mV		
Square Wave 10 Hz to 10 kHz, 50 Ω	(1 to 24.999) mVpp (25 to 109.99) mVpp 110 mV to 2.1999 Vpp (2.2 to 6.6) Vpp	0.19 % of Output + 31 μV 0.19 % of Output + 36 μV 0.19 % of Output + 87 μV 0.19 % of Output + 0.6 mV		
Square Wave 10 Hz to 1 kHz, 1 MΩ	(1 to 24.999) mV (25 to 109.99) mV 110 mV to 2.1999 V (2.2 to 10.999) V (11 to 130) V	0.038 % of rdg + 4 μV 0.038 % of rdg + 9 μV 0.038 % of rdg + 60 μV 0.038 % of rdg + 0.6 mV 0.038 % of rdg + 6.0 mV		
Square Wave (1 to 10) kHz, 1 MΩ	(1 to 24.999) mV (25 to 109.99) mV 110 mV to 2.1999 V (2.2 to 10.999) V (11 to 130) V	0.19 % of rdg + 31 μV 0.19 % of rdg + 36 μV 0.19 % of rdg + 87 μV 0.19 % of rdg + 0.6 mV 0.19 % of rdg + 6.0 mV		
Leveled Sine Flatness ³ 50 kHz to 10 MHz Reference	3 dB Bandwidth (5 to 50) mVpp 50 kHz to 100 MHz (100 to 300) MHz (300 to 500) MHz (500 to 600) MHz (600 to 1600) MHz (1600 to 2100) MHz 50 mV to 3.5 Vpp 50 kHz to 100 MHz (100 to 300) MHz (300 to 500) MHz (500 to 600) MHz (600 to 1600) MHz (1600 to 2100) MHz	 0.34 dB 0.36 dB 0.42 dB 0.46 dB 0.5 dB 0.56 dB 0.24 dB 0.24 dB 0.32 dB 0.34 dB 0.4 dB 0.44 dB	Fluke 5820A oscilloscope calibrator w/ GHz option	COS, MEL ATL, TPA HSV, SFL, HLR



Parameter/Equipment	Range	CMC ^{2, 7} ($\pm$)	Comment	Location ¹⁰
Leveled Sine Flatness ³ 50 kHz to 10 MHz Reference	(3.5 to 5) Vpp 50 kHz to 100 MHz (100 to 300) MHz (300 to 500) MHz (500 to 600) MHz	0.24 dB 0.24 dB 0.32 dB 0.34 dB	Fluke 5820A oscilloscope calibrator w/ GHz option	COS, MEL ATL, TPA HSV, HRT SFL
Oscilloscope Calibration Generate ³ , Leveled Sine Flatness	3 dB Bandwidth 50 mV to 3.5 Vpp (1100 to 4000) MHz (4000 to 8000) MHz (8000 to 18 000) MHz	0.3 dB 0.38 dB 0.48 dB	Agilent EPM series power meter w/E9304A H18 power sensor	COS, MEL ATL, TPA HSV, HRT SFL, HLR RFD, RDU, DFW
Oscilloscope Calibration – Generate ³ Time Marker	 500 ps to 20 ms 50 ms to 5 s	 0.25 μ s/s 1.9 μ s/s + 3.8 μ Hz	Fluke 5820A oscilloscope calibrator w/ GHz option	COS, MEL ATL, TPA HSV, SFL, HLR
Oscilloscope Calibration – Measure ³ Resistance Leakage	 (40 to 60) Ω 500 k Ω to 1.5 M Ω (0 to 6.6) V (6.6 to 10) V	 0.08 % of rdg 0.08 % of rdg 0.038 % of rdg + 1.3 mV 0.038 % of rdg + 6.4 mV		
Oscilloscopes Calibration ³ – Generate Voltage DC – 50 Ω DC – 1 M Ω Square Wave 10 Hz to 10 kHz, 1 M Ω	 1 mV to 5 V 1 mV to 200 V 1 mV to 200 Vpp	 0.025 % of output + 25uV 0.025 % of output + 25uV 0.1 % of output + 10uV	Fluke 9500B w/ 9510 active head	COS, MEL ATL, TPA HSV, RFD
Oscilloscopes Calibration ³ – Generate Time Marker	 9 ns to 55 s	 0.25 μ s/s		
Oscilloscopes Calibration ³ – Measure Input Impedance Resistance	 (10 to 40) Ω (40 to 90) Ω (90 to 150) Ω (50 to 800) k Ω (0.8 to 1.2) M Ω (1.2 to 12) M Ω	 1 % of rdg 0.1 % of rdg 0.5 % of rdg 0.5 % of rdg 0.1 % of rdg 0.5 % of rdg		



Parameter/Equipment	Range	CMC ^{2, 7} (±)	Comment	Location ¹⁰
Oscilloscopes Calibration ³ – Generate Leveled Sine Flatness 50 kHz to 10 MHz Ref	(5 mV to 5 Vpp) 0.1 Hz to 300 MHz (300 to 550) MHz (5 mV to 3 Vpp) (550 to 1100) MHz	0.18 dB 0.22 dB 0.3 dB	Fluke 9500B w/ 9510 active head	COS, MEL ATL, TPA HSV, RFD
Oscilloscopes Calibration ³ – Generate Voltage DC – 50 Ω DC – 1 MΩ Square Wave 10 Hz to 10 kHz 50 Ω 50 Ω 1 MΩ 1 MΩ	1 mV to 5 V 1 mV to 200 V 40 μV to 1 mVpp 1 mV to 5 Vpp 40 μV to 1 mVpp 1 mV to 200 Vpp	0.025 % of output + 25uV 0.010 % of output + 10uV 1.0 % of output + 10uV 0.10 % of output + 10uV 1.0 % of output + 10uV 0.10 % of output + 10uV	Fluke 9500C w/9540C active head	RDU, ATL, DFW, HSV, HRT
Oscilloscopes Calibration ³ – Generate Leveled Sine Flatness 50 kHz Reference	(5 mV to 5 Vpp) (0.1 Hz to 100) MHz (100 to 500) MHz (500 to 1100) MHz (1100 to 2020) MHz (5 mV to 3 Vpp) (2020 to 3200) MHz (5 mV to 2 Vpp) (3200 to 4200) MHz	0.18 dB 0.24 dB 0.28 dB 0.34 dB 0.42 dB 0.52 dB		
Oscilloscopes Calibration ³ – Generate Time Marker	240 pS ns to 55 s	0.15 μs/s		
Oscilloscopes Calibration ³ – Measure Input Impedance Resistance	(10 to 40) Ω (40 to 90) Ω (0.09 to 800) kΩ (0.8 to 1.2) MΩ (1.2 to 12) MΩ	0.5 % of rdg 0.1 % of rdg 0.5 % of rdg 0.1 % of rdg 0.5 % of rdg		

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
AC Power – Generate ³ (12 to 120) mV Power Factor = 1	(1.2 to 12) mA (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.022 % of Output + 0.1 µW 0.022 % of Output + 0.1 µW 0.022 % of Output + 0.1 µW 0.12 % of Output + 0.1 µW	Fluke 5560A multiproduct calibrator	COS, HRT MEL, ATL RDU, RFD TPA, HSV, DFW
	(12 to 120) mA (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.022 % of Output + 1.1 µW 0.016 % of Output + 0.7 µW 0.022 % of Output + 0.9 µW 0.12 % of Output + 1.1 µW		
	(0.12 to 1.2) A (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.022 % of Output + 11 µW 0.022 % of Output + 7.2 µW 0.022 % of Output + 9.2 µW 0.19 % of Output + 28 µW		
	(1.2 to 3.1) A (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.03 % of Output + 48 µW 0.025 % of Output + 31 µW 0.03 % of Output + 31 µW 0.19 % of Output + 48 µW		
	(3.1 to 12) A (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.03 % of Output + 110 µW 0.025 % of Output + 72 µW 0.03 % of Output + 92 µW 0.19 % of Output + 110 µW		
AC Power – Generate ³ (0.12 to 1.2) V Power Factor = 1	(12 to 30.2) A (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz	0.077 % of Output + 0.92 mW 0.054 % of Output + 0.74 mW 0.38 % of Output + 0.74 mW		
	(1.2 to 12) mA (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.022 % of Output + 0.9 µW 0.022 % of Output + 0.9 µW 0.022 % of Output + 0.9 µW 0.12 % of Output + 0.9 µW		
	(12 to 120) mA (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.022 % of Output + 9.2 µW 0.016 % of Output + 4.7 µW 0.022 % of Output + 7.4 µW 0.12 % of Output + 9.2 µW		
	(0.12 to 1.2) A (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.022 % of Output + 92 µW 0.022 % of Output + 47 µW 0.022 % of Output + 74 µW 0.19 % of Output + 0.27 mW		



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
AC Power – Generate ³ (0.12 to 1.2) V Power Factor = 1	(1.2 to 3.1) A (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.03 % of Output + 0.46 mW 0.025 % of Output + 0.27 mW 0.03 % of Output + 0.27 mW 0.19 % of Output + 0.46 mW	Fluke 5560A multiproduct calibrator	COS, HRT MEL, ATL RDU, RFD TPA, HSV, DFW
	(3.1 to 12) A (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.03 % of Output + 0.92 mW 0.025 % of Output + 0.47 mW 0.030 % of Output + 0.74 mW 0.19 % of Output + 0.92 mW		
	(12 to 30.2) A (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz	0.077 % of Output + 9.1 mW 0.054 % of Output + 7.3 mW 0.38 % of Output + 7.3 mW		
AC Power – Generate ³ (1.2 to 12) V Power Factor = 1	(1.2 to 12) mA (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.022 % of Output + 9.2 µW 0.022 % of Output + 9.2 µW 0.022 % of Output + 9.2 µW 0.12 % of Output + 9.2 µW		
	(12 to 120) mA (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.022 % of Output + 92 µW 0.016 % of Output + 46 µW 0.022 % of Output + 74 µW 0.12 % of Output + 92 µW		
	(0.12 to 1.2) A (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.022 % of Output + 0.92 mW 0.022 % of Output + 0.46 mW 0.022 % of Output + 0.74 mW 0.19 % of Output + 2.7 mW		
	(1.2 to 3.1) A (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.03 % of Output + 4.6 mW 0.025 % of Output + 2.7 mW 0.03 % of Output + 2.7 mW 0.19 % of Output + 4.6 mW		
	(3.1 to 12) A (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.03 % of Output + 9.2 mW 0.025 % of Output + 4.6 mW 0.03 % of Output + 7.4 mW 0.19 % of Output + 9.2 mW		
	(12 to 30.2) A (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz	0.077 % of Output + 91 mW 0.054 % of Output + 73 mW 0.38 % of Output + 73 mW		



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
AC Power – Generate ³ (12 to 120) V Power Factor = 1	(1.2 to 12) mA (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.022 % of Output + 92 µW 0.022 % of Output + 92 µW 0.022 % of Output + 92 µW 0.12 % of Output + 92 µW	Fluke 5560A multiproduct calibrator	COS, HRT MEL, ATL RDU, RFD TPA, HSV, DFW
	(12 to 120) mA (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.022 % of Output + 0.92 mW 0.016 % of Output + 0.46 mW 0.022 % of Output + 0.74 mW 0.12 % of Output + 0.92 mW		
	(0.12 to 1.2) A (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.022 % of Output + 9.2 mW 0.022 % of Output + 4.6 mW 0.022 % of Output + 7.4 mW 0.19 % of Output + 27 mW		
	(1.2 to 3.1) A (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.03 % of Output + 46 mW 0.025 % of Output + 27 mW 0.03 % of Output + 27 mW 0.19 % of Output + 46 mW		
	(3.1 to 12) A (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.03 % of Output + 92 mW 0.025 % of Output + 46 mW 0.03 % of Output + 74 mW 0.19 % of Output + 92 mW		
	(12 to 30.2) A (10 to 40) Hz (40 to 1 000) Hz (1 to 5) kHz	0.077 % of Output + 0.91 W 0.054 % of Output + 0.73 W 0.38 % of Output + 0.73 W		
AC Power – Generate ³ (120 to 330) V Power Factor = 1	(1.2 to 12) mA (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.022 % of Output + 0.26 mW 0.022 % of Output + 0.26 mW 0.022 % of Output + 0.26 mW 0.12 % of Output + 0.26 mW		
	(12 to 120) mA (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.022 % of Output + 2.6 mW 0.016 % of Output + 1.5 mW 0.022 % of Output + 2.1 mW 0.12 % of Output + 2.6 mW		
	(0.12 to 1.2) A (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.022 % of Output + 26 mW 0.022 % of Output + 15 mW 0.022 % of Output + 21 mW 0.19 % of Output + 76 mW		

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
AC Power – Generate ³ (120 to 330) V Power Factor = 1	(1.2 to 3.1) A (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.03 % of Output + 0.13 W 0.025 % of Output + 0.08 W 0.030 % of Output + 0.08 W 0.19 % of Output + 0.13 W	Fluke 5560A multiproduct calibrator	COS, HRT MEL, ATL RDU, RFD TPA, HSV, DFW
	(3.1 to 12) A (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.03 % of Output + 0.26 W 0.025 % of Output + 0.15 W 0.03 % of Output + 0.21 W 0.19 % of Output + 0.26 W		
	(12 to 30.2) A (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz	0.077 % of Output + 2.5 W 0.054 % of Output + 2.0 W 0.38 % of Output + 2.0 W		
AC Power – Generate ³ (330 to 1020) V Power Factor = 1	(1.2 to 12) mA (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.022 % of Output + 1.1 mW 0.022 % of Output + 1.1 mW 0.022 % of Output + 1.1 mW 0.12 % of Output + 1.1 mW		
	(12 to 120) mA (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.022 % of Output + 11 mW 0.016 % of Output + 8.3 mW 0.022 % of Output + 9.6 mW 0.12 % of Output + 11 mW		
	(0.12 to 1.2) A (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.022 % of Output + 110 mW 0.022 % of Output + 83 mW 0.022 % of Output + 96 mW 0.19 % of Output + 240 mW		
	(1.2 to 3.1) A (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.03 % of Output + 0.43 W 0.025 % of Output + 0.30 W 0.03 % of Output + 0.30 W 0.19 % of Output + 0.43 W		
	(3.1 to 12) A (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz (5 to 10) kHz	0.03 % of Output + 1.1 W 0.025 % of Output + 0.8 W 0.03 % of Output + 1.0 W 0.19 % of Output + 1.1 W		
	(12 to 30.2) A (10 to 40) Hz (40 to 1000) Hz (1 to 5) kHz	0.077 % of Output + 8.0 W 0.054 % of Output + 6.5 W 0.38 % of Output + 6.5 W		



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
AC Power – Generate ³ (33 to 329.999) mV Power Factor = 1	(3.3 to 32.999 9) mA (20 to 45) Hz (45 to 1000) Hz	0.072 % of Output + 0.05 µW 0.032 % of Output + 0.05 µW	Fluke 5522A multiproduct	SFL, HLR HSV
	(33 to 329.999) mA (20 to 45) Hz (45 to 1000) Hz	0.072 % of Output + 0.5 µW 0.032 % of Output + 0.5 µW		
	(0.33 to 1.099 99) A (10 to 45) Hz (45 to 1000) Hz	0.14 % of Output + 2.6 µW 0.04 % of Output + 2.6 µW		
	(1.1 to 2.999 99) A (10 to 45) Hz (45 to 1000) Hz	0.14 % of Output + 3.1 µW 0.047 % of Output + 3.1 µW		
	(3 to 10.9999) A (45 to 100) Hz (100 to 1000) Hz	0.047 % of Output + 51 µW 0.077 % of Output + 51 µW		
AC Power – Generate ³ (0.33 to 3.299 99) V Power Factor = 1	(11 to 20.5) A (45 to 100) Hz (100 to 1000) Hz	0.092 % of Output + 0.13 mW 0.11 % of Output + 0.13 mW	Fluke 5522A multiproduct	SFL, HLR HSV
	(3.3 to 32.9999) mA (20 to 45) Hz (45 to 1000) Hz	0.072 % of Output + 0.52 µW 0.033 % of Output + 0.52 µW		
	(33 to 329.999) mA (20 to 45) Hz (45 to 1000) Hz	0.072 % of Output + 5.2 µW 0.033 % of Output + 5.2 µW		
	(0.33 to 1.09999) A (10 to 45) Hz (45 to 1000) Hz	0.14 % of Output + 26 µW 0.04 % of Output + 26 µW		
	(1.1 to 2.999 99) A (10 to 45) Hz (45 to 1000) Hz	0.14 % of Output + 0.28 µW 0.047 % of Output + 0.29 µW		
	(3 to 10.999 9) A (45 to 100) Hz (100 to 1000) Hz	0.047 % of Output + 0.51 mW 0.077 % of Output + 0.51 mW		
	(11 to 20.5) A (45 to 100) Hz (100 to 1000) Hz	0.092 % of Output + 1.3 mW 0.11 % of Output + 1.3 mW		



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
AC Power – Generate ³ (3.3 to 32.999 9) V Power Factor = 1	(3.3 to 32.999 9) mA (20 to 45) Hz (45 to 1000) Hz	0.072 % of Output + 5.3 µW 0.033 % of Output + 5.2 µW	Fluke 5522A multiproduct calibrator	SFL, HLR HSV
	(33 to 329.999) mA (20 to 45) Hz (45 to 1000) Hz	0.072 % of Output + 53 µW 0.033 % of Output + 52 µW		
	(0.33 to 1.099 99) A (10 to 45) Hz (45 to 1000) Hz	0.14 % of Output + 0.26 mW 0.04 % of Output + 0.26 mW		
	(1.1 to 2.999 99) A (10 to 45) Hz (45 to 1000) Hz	0.14 % of Output + 0.29 mW 0.047 % of Output + 0.29 mW		
	(3 to 10.9999) A (45 to 100) Hz (100 to 1000) Hz	0.047 % of Output + 5.1 mW 0.077 % of Output + 5.1 mW		
AC Power – Generate ³ (33 to 329.999) V Power Factor = 1	(11 to 20.5) A (45 to 100) Hz (100 to 1000) Hz	0.092 % of Output + 13 mW 0.11 % of Output + 13 mW		
	(3.3 to 32.999 9) mA (45 to 1000) Hz	0.034 % of Output + 51 µW		
	(33 to 329.999) mA (45 to 1000) Hz	0.034 % of Output + 0.51 mW		
	(0.33 to 1.099 99) A (45 to 1000) Hz	0.041 % of Output + 2.5 mW		
	(1.1 to 2.999 99) A (45 to 1000) Hz	0.048 % of Output + 2.6 mW		
	(3 to 10.9999) A (45 to 100) Hz (100 to 1000) Hz	0.048 % of Output + 50 mW 0.077 % of Output + 50 mW		
	(11 to 20.5) A (45 to 100) Hz (100 to 1000) Hz	0.092 % of Output + 0.13 W 0.12 % of Output + 0.13 W		



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
AC Power – Generate ³ (330 to 1 020) V Power Factor = 1	(3.3 to 32.999 9) mA (45 to 1000) Hz	0.036 % of Output + 0.16 mW	Fluke 5522A multiproduct calibrator	SFL, HLR HSV
	(33 to 329.999) mA (45 to 1000) Hz	0.036 % of Output + 1.6 mW		
	(0.33 to 1.099 99) A (45 to 1000) Hz	0.043 % of Output + 7.9 mW		
	(1.1 to 2.999 99) A (45 to 1000) Hz	0.049 % of Output + 8.3 mW		
	(3 to 10.999 9) A (45 to 100) Hz (100 to 1000) Hz	0.051 % of Output + 0.16 W 0.078 % of Output + 0.16 W		
	(11 to 20.5) A (45 to 100) Hz (100 to 1000) Hz	0.094 % of Output + 0.39 W 0.12 % of Output + 0.39 W		
Electrical Calibration of Thermocouple Indicators ³	Type B (600 to 800) °C (800 to 1550) °C (1550 to 1820) °C	0.27 °C 0.21 °C 0.17 °C	Fluke 7526A process calibrator	COS, MEL RDU, RFD TPA, SFL HSV, HLR, DFW
	Type BP (0 to 200) °C (200 to 600) °C (600 to 800) °C (800 to 1600) °C (1600 to 2000) °C (2000 to 2500) °C	0.14 °C 0.12 °C 0.13 °C 0.18 °C 0.21 °C 0.3 °C		
	Type C (0 to 1000) °C (1000 to 1800) °C (1800 to 2000) °C (2000 to 2316) °C	0.12 °C 0.18 °C 0.20 °C 0.27 °C		
	Type E (-250 to -200) °C (-200 to -100) °C (-100 to 0) °C (0 to 600) °C (600 to 1000) °C	0.19 °C 0.09 °C 0.07 °C 0.06 °C 0.08 °C		



Parameter/Equipment	Range	CMC ² (±)	Comment	Location ¹⁰
Electrical Calibration of Thermocouple Indicators ³	Type J (-210 to -100) °C	0.11 °C	Fluke 7526A process calibrator	COS, MEL RDU, RFD TPA, SFL HSV, HLR, DFW
	(-100 to 800) °C	0.07 °C		
	(800 to 1200) °C	0.08 °C		
	Type K (-250 to -200) °C	0.35 °C		
	(-200 to -100) °C	0.12 °C		
	(-100 to 800) °C	0.08 °C		
	(800 to 1372) °C	0.1 °C		
	Type XK (-250 to -100) °C	0.08 °C		
	(-100 to 0) °C	0.07 °C		
	(0 to 600) °C	0.06 °C		
	(600 to 800) °C	0.07 °C		
	Type L (-200 to -100) °C	0.08 °C		
	(-100 to 900) °C	0.07 °C		
	Type N (-250 to -200) °C	0.56 °C		
	(-200 to -100) °C	0.18 °C		
	(-100 to 0) °C	0.09 °C		
	(0 to 100) °C	0.08 °C		
	(100 to 800) °C	0.08 °C		
	(800 to 1300) °C	0.09 °C		
	Type R (-50 to -25) °C	0.42 °C		
	(-25 to 0) °C	0.34 °C		
	(0 to 100) °C	0.3 °C		
	(100 to 400) °C	0.21 °C		
	(400 to 600) °C	0.17 °C		
	(600 to 1000) °C	0.16 °C		
	(1000 to 1600) °C	0.14 °C		
	(1600 to 1767) °C	0.18 °C		
	Type S (-50 to -25) °C	0.39 °C		
	(-25 to 0) °C	0.33 °C		
	(0 to 100) °C	0.29 °C		
	(100 to 400) °C	0.22 °C		
	(400 to 600) °C	0.18 °C		
	(600 to 1600) °C	0.17 °C		
	(1600 to 1767) °C	0.20 °C		
	Type T (-250 to -200) °C	0.27 °C		
	(-200 to -100) °C	0.12 °C		
	(-100 to 0) °C	0.08 °C		
	(0 to 400) °C	0.07 °C		
	Type U (-200 to 0) °C	0.3 °C		
	(0 to 600) °C	0.08 °C		



Parameter/Equipment	Range	CMC ² (±)	Comment	Location ¹⁰
Electrical Calibration of RTD Indicating Devices ³	Pt 100 (385) (-200 to 800) °C	0.04 °C	Fluke 7526A process calibrator	COS, MEL RDU, RFD TPA, SFL HSV, HLR, DFW
	Pt 100 (3916) (-200 to 630) °C	0.04 °C		
	Pt 100 (3926) (-200 to 630) °C	0.04 °C		
	Pt 200 (385) (-200 to 400) °C (400 to 630) °C	0.30 °C 0.38 °C		
	Pt 500 (385) (-200 to 630) °C	0.13 °C		
	Pt 1000 (385) (-200 to 630) °C	0.07 °C		
	Cu 10 (427) (-100 to 260) °C	0.29 °C		
	Ni 120 (672) (-80 to 260) °C	0.29 °C		

Parameter/Equipment	Range	CMC ² (±)	Comment	Location ¹⁰
Electrical Calibration of Thermocouple Indicating Devices ³	Type B (600 to 800) °C	0.33 °C	Fluke 5560A multiproduct calibrator	HRT, ATL, TPA, HSV, RFD, MEL, COS, RDU, DFW
	(800 to 1000) °C	0.26 °C		
	(1000 to 1550) °C	0.23 °C		
	(1550 to 1820) °C	0.25 °C		
	Type C (0 to 150) °C	0.19 °C		
	(150 to 650) °C	0.16 °C		
	(650 to 1000) °C	0.2 °C		
	(1000 to 1800) °C	0.34 °C		
	(1800 to 2315) °C	0.60 °C		
	Type D (0 to 150) °C	0.19 °C		
	(150 to 650) °C	0.16 °C		
	(650 to 1000) °C	0.2 °C		
	(1000 to 1800) °C	0.33 °C		
	(1800 to 2315) °C	0.59 °C		
	Type E (-250 to -150) °C	0.3 °C		
	(-150 to -25) °C	0.11 °C		
	(-25 to 350) °C	0.08 °C		
	(350 to 650) °C	0.12 °C		
	(650 to 1000) °C	0.16 °C		
	Type G (0 to 150) °C	0.38 °C		
	(150 to 650) °C	0.25 °C		
	(650 to 1000) °C	0.2 °C		
	(1000 to 1800) °C	0.33 °C		
	(1800 to 2315) °C	0.59 °C		
	Type J (-210 to -100) °C	0.18 °C		
	(-100 to -30) °C	0.1 °C		
	(-30 to 150) °C	0.08 °C		
	(150 to 760) °C	0.11 °C		
	(760 to 1200) °C	0.15 °C		
	Type K (-200 to -100) °C	0.21 °C		
	(-100 to -25) °C	0.1 °C		
	(-25 to 120) °C	0.08 °C		
	(120 to 1000) °C	0.16 °C		
	(1000 to 1372) °C	0.27 °C		
	Type L (-200 to -100) °C	0.24 °C		
	(-100 to 800) °C	0.15 °C		
	(800 to 900) °C	0.08 °C		



Parameter/Equipment	Range	CMC ² (±)	Comment	Location ¹⁰
Electrical Calibration of Thermocouple Indicating Devices ³	Type N (-200 to -100) °C	0.25 °C	Fluke 5560A multiproduct calibrator	HRT, ATL, TPA, HSV, RFD, MEL, COS, RDU, DFW
	(-100 to -25) °C	0.11 °C		
	(-25 to 120) °C	0.09 °C		
	(120 to 410) °C	0.08 °C		
	(410 to 1300) °C	0.15 °C		
	Type R (0 to 250) °C	0.39 °C		
	(250 to 400) °C	0.22 °C		
	(400 to 1000) °C	0.21 °C		
	(1000 to 1767) °C	0.26 °C		
	Type S (0 to 250) °C	0.32 °C		
Electrical Calibration of RTD Indicators ³	(250 to 1000) °C	0.24 °C		
	(1000 to 1400) °C	0.24 °C		
	(1400 to 1767) °C	0.31 °C		
	Type T (-250 to -150) °C	0.46 °C		
	(-150 to 0) °C	0.16 °C		
	(0 to 120) °C	0.1 °C		
	(120 to 400) °C	0.08 °C		
	Type U (-200 to 0) °C	0.3 °C		
	(0 to 600) °C	0.08 °C		
	Type BP (0 to 1000) °C	0.3 °C		
	(1000 to 2000) °C	0.46 °C		
	(2000 to 2500) °C	0.61 °C		
	Type XK (-200 to 300) °C	0.15 °C		
	(300 to 800) °C	0.23 °C		
	Cu 10 (427) (-80 to 260) °C	0.23 °C		
	Cu 50 (428) (-180 to 200) °C	0.3 °C		
	Cu 100 (428) (-180 to 40) °C	0.3 °C		
	(40 to 200) °C	0.49 °C		
	Ni 120 (672) (-80 to 0) °C	0.06 °C		
	(0 to 100) °C	0.06 °C		
	(100 to 260) °C	0.11 °C		



Parameter/Equipment	Range	CMC ² (±)	Comment	Location ¹⁰
Electrical Calibration of RTD Indicators ³	Pt 100 (385)		Fluke 5560A multiproduct calibrator	HRT, ATL, TPA, HSV, RFD, MEL, COS, RDU, DFW
	(-200 to -80) °C	0.04 °C		
	(-80 to 0) °C	0.04 °C		
	(0 to 100) °C	0.05 °C		
	(100 to 300) °C	0.07 °C		
	(300 to 400) °C	0.08 °C		
	(400 to 630) °C	0.09 °C		
	(630 to 800) °C	0.18 °C		
	Pt 100 (3916)			
	(-200 to -190) °C	0.19 °C		
	(-190 to -80) °C	0.03 °C		
	(-80 to 0) °C	0.04 °C		
	(0 to 100) °C	0.05 °C		
	(100 to 260) °C	0.05 °C		
	(260 to 300) °C	0.06 °C		
	(300 to 400) °C	0.07 °C		
	(400 to 600) °C	0.08 °C		
	(600 to 630) °C	0.18 °C		
	Pt 100 (3926)			
	(-200 to -80) °C	0.04 °C		
	(-80 to 0) °C	0.04 °C		
	(0 to 100) °C	0.05 °C		
	(100 to 300) °C	0.07 °C		
	(300 to 400) °C	0.08 °C		
	(400 to 630) °C	0.09 °C		
	Pt 200 (385)			
	(-200 to -80) °C	0.03 °C		
	(-80 to 0) °C	0.03 °C		
	(0 to 100) °C	0.03 °C		
	(100 to 260) °C	0.04 °C		
	(260 to 300) °C	0.09 °C		
	(300 to 400) °C	0.1 °C		
	(400 to 600) °C	0.11 °C		
	(600 to 630) °C	0.12 °C		
	Pt 500 (385)			
	(-200 to -80) °C	0.03 °C		
	(-80 to 0) °C	0.04 °C		
	(0 to 100) °C	0.04 °C		
	(100 to 260) °C	0.05 °C		
	(260 to 300) °C	0.06 °C		
	(300 to 400) °C	0.06 °C		
	(400 to 600) °C	0.07 °C		
	(600 to 630) °C	0.08 °C		
	Pt 1000 (385)			
	(-200 to -80) °C	0.02 °C		
	(-80 to 0) °C	0.02 °C		
	(0 to 100) °C	0.03 °C		
	(100 to 260) °C	0.04 °C		
	(260 to 300) °C	0.05 °C		
	(300 to 400) °C	0.05 °C		
	(400 to 600) °C	0.05 °C		
	(600 to 630) °C	0.18 °C		



VI. Electrical – RF/Microwave

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
RF Flatness – Measure ³	9 kHz to 2000 MHz (20 to -10) dBm (-10 to -30) dBm (-30 to -40) dBm (-40 to -42) dBm	0.1 dB 0.1 dB 0.11 dB 0.12 dB	Agilent EPM series power meter w/E9304A H18 power sensor	COS, MEL RDU, RFD TPA, SFL HSV, HLR HRT, ATL, DFW
	(2 to 14) GHz (20 to -10) dBm (-10 to -30) dBm (-30 to -40) dBm (-40 to -42) dBm	0.10 dB 0.09 dB 0.1 dB 0.11 dB		
	(14 to 18) GHz (20 to -10) dBm (-10 to -30) dBm (-30 to -40) dBm (-40 to -42) dBm	0.11 dB 0.12 dB 0.12 dB 0.13 dB		
RF Power – Measure ³	9 kHz to 14 000 MHz (20 to 0) dB (0 to -40) dB (-40 to -50) dB (-50 to -55) dB	0.13 dB 0.15 dB 0.34 dB 0.93 dB		
	(14 000 to 18 000) MHz (20 to 0) dB (0 to -40) dB (-40 to -50) dB (-50 to -55) dB	0.12 dB 0.16 dB 0.35 dB 0.93 dB		

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
RF Power – Measure ³	(10 to 100) MHz (20 to 10) dB (10 to 0) dB (0 to -10) dB (-10 to -20) dB (-20 to -25) dB	0.07 dB 0.06 dB 0.06 dB 0.06 dB 0.11 dB	Agilent EPM series power meter RF power Keysight N8485A power	RFD, ATL, MEL
	(100 to 2000) MHz (20 to 10) dB (10 to 0) dB (0 to -10) dB (-10 to -20) dB (-20 to -25) dB	0.07 dB 0.07 dB 0.06 dB 0.07 dB 0.11 dB		
	(2000 to 12 400) MHz (20 to 10) dB (10 to 0) dB (0 to -10) dB (-10 to -20) dB (-20 to -25) dB	0.08 dB 0.08 dB 0.08 dB 0.08 dB 0.12 dB		
	(12 400 to 18 000) MHz (20 to 10) dB (10 to 0) dB (0 to -10) dB (-10 to -20) dB (-20 to -25) dB	0.09 dB 0.08 dB 0.08 dB 0.09 dB 0.12 dB		
	(18 000 to 26 500) MHz (20 to 10) dB (10 to 0) dB (0 to -10) dB (-10 to -20) dB (-20 to -25) dB	0.12 dB 0.12 dB 0.12 dB 0.12 dB 0.15 dB		
	(50 to 100) MHz (20 to 10) dB (10 to 0) dB (0 to -10) dB (-10 to -20) dB (-20 to -25) dB	0.08 dB 0.07 dB 0.07 dB 0.07 dB 0.11 dB	Agilent EPM series power meter N8487A power sensor	MEL, RFD TPA, HSV COS, RDU
	(100 to 6000) MHz (20 to 10) dB (10 to 0) dB (0 to -10) dB (-10 to -20) dB (-20 to -25) dB	0.08 dB 0.07 dB 0.07 dB 0.08 dB 0.11 dB		

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
RF Power – Measure ³	(6000 to 12 400) MHz			
	(20 to 10) dB	0.08 dB		
	(10 to 0) dB	0.08 dB		
	(0 to -10) dB	0.08 dB		
	(-10 to -20) dB	0.08 dB		
	(-20 to -25) dB	0.12 dB		
	(12 400 to 18 000) MHz			
	(20 to 10) dB	0.09 dB		
	(10 to 0) dB	0.09 dB		
	(0 to -10) dB	0.08 dB		
	(-10 to -20) dB	0.09 dB		
	(-20 to -25) dB	0.12 dB		
	(18 000 to 26 500) MHz			
	(20 to 10) dB	0.11 dB		
	(10 to 0) dB	0.11 dB		
	(0 to -10) dB	0.10 dB		
	(-10 to -20) dB	0.11 dB		
	(-20 to -25) dB	0.14 dB		
	(26 5000 to 33 000) MHz			
	(20 to 10) dB	0.12 dB		
	(10 to 0) dB	0.12 dB		
	(0 to -10) dB	0.12 dB		
	(-10 to -20) dB	0.12 dB		
	(-20 to -25) dB	0.15 dB		
	(33 000 to 40 000) MHz			
	(20 to 10) dB	0.13 dB		
	(10 to 0) dB	0.13 dB		
	(0 to -10) dB	0.12 dB		
	(-10 to -20) dB	0.13 dB		
	(-20 to -25) dB	0.15 dB		
	(40 000 to 50 000) MHz			
	(20 to 10) dB	0.19 dB		
	(10 to 0) dB	0.18 dB		
	(0 to -10) dB	0.18 dB		
	(-10 to -20) dB	0.19 dB		
	(-20 to -25) dB	0.2 dB		
			Agilent EPM series power meter N8487A power sensor	MEL, RFD TPA, HSV COS, RDU

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
RF Power – Measure ³	(100 to 2000) MHz			
	(20 to 10) dB	0.14 dB		
	(10 to 0) dB	0.06 dB		
	(0 to -10) dB	0.07 dB		
	(-10 to -20) dB	0.08 dB		
	(-20 to -25) dB	0.15 dB		
	(2000 to 12 400) MHz			
	(20 to 10) dB	0.15 dB		
	(10 to 0) dB	0.07 dB		
	(0 to -10) dB	0.07 dB		
	(-10 to -20) dB	0.08 dB		
	(-20 to -25) dB	0.15 dB		
	(12 400 to 18 000) MHz			
	(20 to 10) dB	0.15 dB		
	(10 to 0) dB	0.08 dB		
	(0 to -10) dB	0.08 dB		
	(-10 to -20) dB	0.09 dB		
	(-20 to -25) dB	0.15 dB		
	(18 000 to 26 500) MHz			
	(20 to 10) dB	0.16 dB		
	(10 to 0) dB	0.1 dB		
	(0 to -10) dB	0.1 dB		
	(-10 to -20) dB	0.11 dB		
	(-20 to -25) dB	0.16 dB		
	(26 5000 to 40 000) MHz			
	(20 to 10) dB	0.17 dB		
	(10 to 0) dB	0.12 dB		
	(0 to -10) dB	0.12 dB		
	(-10 to -20) dB	0.13 dB		
	(-20 to -25) dB	0.18 dB		
	(40 000 to 50 000) MHz			
	(20 to 10) dB	0.22 dB		
	(10 to 0) dB	0.19 dB		
	(0 to -10) dB	0.19 dB		
	(-10 to -20) dB	0.19 dB		
	(-20 to -25) dB	0.23 dB		
			Agilent EPM series power meter 8487A power sensor	ATL

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
RF Power – Measure ³	(50 to 26 500) MHz (20 to 10) dB (10 to -50) dB (-50 to -60) dB (-60 to -65) dB	0.25 dB 0.22 dB 0.37 dB 0.94 dB	Agilent EPM series power meter w/E4413A power sensor	MEL, TPA, COS
	100 kHz to 30 MHz (20 to 0) dB (0 to -58) dB (-58 to -78) dB (-78 to -110) dB (-110 to -115) dB (-115 to -120) dB (-120 to -125) dB	0.13 dB 0.13 dB 0.15 dB 0.2 dB 0.26 dB 0.39 dB 0.59 dB	Agilent N5531S measuring receiver N1912A w/E9304A power sensor	COS, MEL RDU, RFD TPA, SFL HSV, HLR HRT, ATL, DFW
	(30 to 2000) MHz (30 to 20) dB (20 to 0) dB (0 to -58) dB (-58 to -78) dB (-78 to -110) dB (-110 to -115) dB (-115 to -120) dB (-120 to -125) dB	0.36 dB 0.20 dB 0.22 dB 0.23 dB 0.25 dB 0.27 dB 0.33 dB 0.46 dB	Agilent N5531S measuring receiver w/N5532A Opt 526 power sensor	SFL, HLR, HRT
	(2000 to 3050) MHz (30 to 20) dB (20 to 0) dB (0 to -58) dB (-58 to -78) dB (-78 to -110) dB (-110 to -115) dB (-115 to -120) dB (-120 to -125) dB	0.42 dB 0.30 dB 0.31 dB 0.32 dB 0.34 dB 0.35 dB 0.40 dB 0.51 dB		
	(3050 to 6600) MHz (30 to 20) dB (20 to 0) dB (0 to -58) dB (-58 to -78) dB (-78 to -110) dB (-110 to -115) dB (-115 to -120) dB (-120 to -125) dB	0.42 dB 0.30 dB 0.31 dB 0.32 dB 0.34 dB 0.38 dB 0.48 dB 0.64 dB		

Parameter/Range	Frequency	CMC ^{2,7} (±)	Comment	Location ¹⁰
RF Power – Measure ³	(6600 to 13 200) MHz		Agilent N5531S measuring receiver w/N5532A Opt 526 power sensor	SFL, HLR, HRT
	(30 to 20) dB	0.42 dB		
	(20 to 0) dB	0.30 dB		
	(0 to -58) dB	0.31 dB		
	(-58 to -78) dB	0.32 dB		
	(-78 to -100) dB	0.34 dB		
	(-100 to -105) dB	0.37 dB		
	(-105 to -110) dB	0.45 dB		
	(-110 to -115) dB	0.60 dB		
	(-115 to -120) dB	0.82 dB		
	(13 200 to 18 000) MHz			
	(30 to 20) dB	0.42 dB		
	(20 to 0) dB	0.30 dB		
	(0 to -58) dB	0.31 dB		
	(-58 to -78) dB	0.32 dB		
	(-78 to -90) dB	0.33 dB		
	(-90 to -95) dB	0.35 dB		
	(-95 to -100) dB	0.41 dB		
	(-100 to -105) dB	0.53 dB		
	(-105 to -110) dB	0.72 dB		
	(18 000 to 19 200) MHz			
	(30 to 20) dB	0.48 dB		
	(20 to 0) dB	0.38 dB		
	(0 to -58) dB	0.39 dB		
	(-58 to -78) dB	0.40 dB		
	(-78 to -90) dB	0.41 dB		
	(-90 to -95) dB	0.42 dB		
	(-95 to -100) dB	0.47 dB		
	(-100 to -105) dB	0.58 dB		
	(-105 to -110) dB	0.75 dB		
	19 200 to 26 500) MHz			
	(30 to 20) dB	0.48 dB		
	(20 to 0) dB	0.38 dB		
	(0 to -58) dB	0.39 dB		
	(-58 to -78) dB	0.4 dB		
	(-78 to -90) dB	0.43 dB		
	(-90 to -95) dB	0.50 dB		
	(-95 to -100) dB	0.63 dB		
	(-100 to -105) dB	0.84 dB		
	(-105 to -110) dB	1.1 dB		



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
RF Power – Measure ³	(30 to 2000) MHz			
	(30 to 20) dB	0.36 dB		
	(20 to 0) dB	0.20 dB		
	(0 to -58) dB	0.22 dB		
	(-58 to -78) dB	0.23 dB		
	(-78 to -110) dB	0.25 dB		
	(-110 to -115) dB	0.27 dB		
	(-115 to -120) dB	0.33 dB		
	(-120 to -125) dB	0.70 dB		
	(2000 to 3050) MHz			
	(30 to 20) dB	0.37 dB		
	(20 to 0) dB	0.21 dB		
	(0 to -58) dB	0.23 dB		
	(-58 to -78) dB	0.24 dB		
	(-78 to -110) dB	0.26 dB		
	(-110 to -115) dB	0.28 dB		
	(-115 to -120) dB	0.34 dB		
	(-120 to -125) dB	0.70 dB		
	(3050 to 6600) MHz			
	(30 to 20) dB	0.37 dB		
	(20 to 0) dB	0.21 dB		
	(0 to -58) dB	0.23 dB		
	(-58 to -78) dB	0.24 dB		
	(-78 to -110) dB	0.29 dB		
	(-110 to -115) dB	0.38 dB		
	(-115 to -120) dB	0.53 dB		
	(6600 to 13 200) MHz			
	(30 to 20) dB	0.37 dB		
	(20 to 0) dB	0.21 dB		
	(0 to -58) dB	0.23 dB		
	(-58 to -78) dB	0.24 dB		
	(-78 to -110) dB	0.34 dB		
	(-110 to -115) dB	0.46 dB		
	(-115 to -120) dB	0.65 dB		
	(13 200 to 18 000) MHz			
	(30 to 20) dB	0.37 dB		
	(20 to 0) dB	0.21 dB		
	(0 to -58) dB	0.23 dB		
	(-58 to -78) dB	0.24 dB		
	(-78 to -90) dB	0.26 dB		
	(-90 to -95) dB	0.26 dB		
	(-95 to -100) dB	0.26 dB		
	(-100 to -105) dB	0.29 dB		
	(-105 to -110) dB	0.38 dB		
	(-110 to -115) dB	0.53 dB		
	(-115 to -120) dB	0.75 dB		
			Agilent N5531S measuring receiver w/N5532A/N5532B Opt 550 power sensor	MEL, RFD TPA, HSV COS, RDU ATL, DFW

Parameter/Range	Frequency	CMC ^{2,7} (±)	Comment	Location ¹⁰
RF Power – Measure ³	(18 000 to 19 200) MHz			
	(30 to 20) dB	0.39 dB		
	(20 to 0) dB	0.25 dB		
	(0 to -58) dB	0.24 dB		
	(-58 to -78) dB	0.25 dB		
	(-78 to -90) dB	0.27 dB		
	(-90 to -95) dB	0.27 dB		
	(-95 to -100) dB	0.27 dB		
	(-100 to -105) dB	0.30 dB		
	(-105 to -110) dB	0.38 dB		
	(-110 to -115) dB	0.53 dB		
	(-115 to -120) dB	0.75 dB		
	(19 200 to 26 500) MHz			
	(30 to 20) dB	0.39 dB		
	(20 to 0) dB	0.25 dB		
	(0 to -58) dB	0.24 dB		
	(-58 to -78) dB	0.25 dB		
	(-78 to -90) dB	0.28 dB		
	(-90 to -95) dB	0.33 dB		
	(-95 to -100) dB	0.43 dB		
	(-100 to -105) dB	0.61 dB		
	(-105 to -110) dB	0.85 dB		
	(-110 to -115) dB	1.20 dB		
	(-115 to -120) dB	1.50 dB		
	(26 500 to 31 150) MHz			
	(30 to 20) dB	0.42 dB		
	(20 to 0) dB	0.30 dB		
	(0 to -58) dB	0.34 dB		
	(-58 to -78) dB	0.34 dB		
	(-78 to -90) dB	0.36 dB		
	(-90 to -95) dB	0.39 dB		
	(-95 to -100) dB	0.46 dB		
	(-100 to -105) dB	0.61 dB		
	(-105 to -110) dB	0.82 dB		
	(-110 to -115) dB	1.1 dB		
	(31 150 to 41 000) MHz			
	(30 to 20) dB	0.42 dB		
	(20 to 0) dB	0.30 dB		
	(0 to -58) dB	0.34 dB		
	(-58 to -78) dB	0.35 dB		
	(-78 to -90) dB	0.48 dB		
	(-90 to -95) dB	0.64 dB		
	(-95 to -100) dB	0.87 dB		
	(-100 to -105) dB	1.2 dB		
	(-105 to -110) dB	1.5 dB		
			Agilent N5531S measuring receiver w/N5532A /N5532B Opt 550 power sensor	MEL, RFD TPA, HSV COS, RDU ATL, DFW

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
RF Power – Measure ³	(41 000 to 45 000) MHz		Agilent N5531S measuring receiver w/N5532A/N5532B Opt 550 power sensor	MEL, RFD TPA, HSV COS, RDU ATL, DFW
	(30 to 20) dB	0.42 dB		
	(20 to 0) dB	0.30 dB		
	(0 to -58) dB	0.34 dB		
	(-58 to -78) dB	0.38 dB		
	(-78 to -90) dB	0.68 dB		
	(-90 to -95) dB	0.93 dB		
	(-95 to -100) dB	1.2 dB		
	(-100 to -105) dB	1.6 dB		
	(45 000 to 50 000) MHz			
	(30 to 20) dB	0.42 dB		
	(20 to 0) dB	0.30 dB		
	(0 to -58) dB	0.34 dB		
	(-58 to -78) dB	0.67 dB		
	(-78 to -90) dB	1.4 dB		
	(10 to 100) MHz		Agilent EPM series power meter N8488A power sensor	COS, DFW
	(20 to 10) dB	0.09 dB		
	(10 to 0) dB	0.08 dB		
	(0 to -10) dB	0.08 dB		
	(-10 to -20) dB	0.09 dB		
	(-20 to -25) dB	0.12 dB		
	(-25 to -30) dB	0.29 dB		
	(-30 to -35) dB	0.82 dB		
	(100 to 2400) MHz			
	(20 to 10) dB	0.10 dB		
	(10 to 0) dB	0.10 dB		
	(0 to -10) dB	0.09 dB		
	(-10 to -20) dB	0.10 dB		
	(-20 to -25) dB	0.13 dB		
	(-25 to -30) dB	0.29 dB		
	(-30 to -35) dB	0.83 dB		
	(2400 to 12 400) MHz			
	(20 to 10) dB	0.10 dB		
	(10 to 0) dB	0.10 dB		
	(0 to -10) dB	0.09 dB		
	(-10 to -20) dB	0.10 dB		
	(2400 to 12 400) MHz			
	(-20 to -25) dB	0.13 dB		
	(-25 to -30) dB	0.29 dB		
	(-30 to -35) dB	0.83 dB		



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
RF Power – Measure ³	(12 400 to 18 000) MHz		Agilent EPM series power meter N8488A power sensor	COS, DFW
	(20 to 10) dB	0.10 dB		
	(10 to 0) dB	0.10 dB		
	(0 to -10) dB	0.10 dB		
	(-10 to -20) dB	0.10 dB		
	(-20 to -25) dB	0.13 dB		
	(-25 to -30) dB	0.29 dB		
	(-30 to -35) dB	0.83 dB		
	(18 000 to 26 500) MHz			
	(20 to 10) dB	0.12 dB		
	(10 to 0) dB	0.12 dB		
	(0 to -10) dB	0.12 dB		
	(-10 to -20) dB	0.12 dB		
	(-20 to -25) dB	0.15 dB		
	(-25 to -30) dB	0.30 dB		
	(-30 to -35) dB	0.83 dB		
	(26 500 to 40 000) MHz			
	(20 to 10) dB	0.15 dB		
	(10 to 0) dB	0.15 dB		
	(0 to -10) dB	0.15 dB		
	(-10 to -20) dB	0.15 dB		
	(-20 to -25) dB	0.17 dB		
	(-25 to -30) dB	0.31 dB		
	(-30 to -35) dB	0.83 dB		
	(40 000 to 67 000) MHz			
	(20 to 10) dB	0.22 dB		
	(10 to 0) dB	0.22 dB		
	(0 to -10) dB	0.22 dB		
	(-10 to -20) dB	0.22 dB		
	(-20 to -25) dB	0.24 dB		
	(-25 to -30) dB	0.35 dB		
	(-30 to -35) dB	0.85 dB		
	(67 000 to 70 000) MHz			
	(20 to 10) dB	0.25 dB		
	(10 to 0) dB	0.25 dB		
	(0 to -10) dB	0.25 dB		
	(-10 to -20) dB	0.25 dB		
	(-20 to -25) dB	0.26 dB		
	(-25 to -30) dB	0.37 dB		
	(-30 to -35) dB	0.85 dB		



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
RF Power – Measure ³	100 kHz to 2000 MHz (5 to 10) dB (10 to 20) dB (20 to 30) dB (30 to 35) dB (35 to 44) dB	0.15 dB 0.08 dB 0.07 dB 0.07 dB 0.18 dB	Agilent EPM series power meter RF power/ HP 8482A power sensor	TPA
	(2000 to 4200) MHz (5 to 10) dB (10 to 20) dB (20 to 30) dB (30 to 35) dB (35 to 44) dB	0.15 dB 0.08 dB 0.07 dB 0.07 dB 0.18 dB		
RF Power – Generate ³	10 Hz to 100 kHz (24 to -48) dBm	0.06 dB	Fluke 9640A-LPNX RF reference source	TPA, RFD
	100 kHz to 9.99 MHz (24 to -48) dBm (-48 to -74) dBm (-74 to -94) dBm	0.07 dB 0.16 dB 0.39 dB		
	(10 to 128) MHz (24 to -48) dBm (-48 to -84) dBm (-84 to -94) dBm (-94 to -124) dBm	0.07 dB 0.09 dB 0.24 dB 0.54 dB		
	(128 to 300) MHz (20 to -48) dBm (-48 to -74) dBm (-74 to -84) dBm (-84 to -94) dBm (-94 to -124) dBm	0.08 dB 0.09 dB 0.24 dB 0.39 dB 1.2 dB		
	(300 to 1400) MHz (20 to -48) dBm (-48 to -74) dBm (-74 to -84) dBm (-84 to -94) dBm (-94 to -124) dBm	0.16 dB 0.31 dB 0.39 dB 0.77 dB 1.2 dB		
	(1.4 to 3.0) GHz (14 to -48) dBm (-48 to -74) dBm (-74 to -94) dBm (-94 to -124) dBm	0.24 dB 0.39 dB 0.77 dB 1.2 dB		

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
RF Power Generate ³	(10 to 30) MHz (0 to -58) dB (-58 to -78) dB (-78 to -110) dB (-110 to -120) dB	0.23 dB 0.25 dB 0.27 dB 0.43 dB	Agilent N5531S measuring receiver N1912A w/E9304A power sensor, 83630B signal generator	SFL, HRT HLR, RDU
RF Power – Generate ³	(30 to 2000) MHz (20 to 0) dB (0 to -58) dB (-58 to -78) dB (-78 to -110) dB (-110 to -120) dB (2000 to 3050) MHz (20 to 0) dB (0 to -58) dB (-58 to -78) dB (-78 to -110) dB (-110 to -120) dB (3050 to 6600) MHz (20 to 0) dB (0 to -58) dB (-58 to -78) dB (-78 to -110) dB (-110 to -120) dB (6600 to 13 200) MHz (20 to 0) dB (0 to -58) dB (-58 to -78) dB (-78 to -110) dB (-110 to -120) dB (13 200 to 18 000) MHz (20 to 0) dB (0 to -58) dB (-58 to -78) dB (-78 to -110) dB (-110 to -120) dB (18 000 to 19 200) MHz (20 to 0) dB (0 to -58) dB (-58 to -78) dB (-78 to -110) dB (-110 to -120) dB	0.26 dB 0.28 dB 0.29 dB 0.3 dB 0.37 dB 0.37 dB 0.38 dB 0.38 dB 0.4 dB 0.52 dB 0.37 dB 0.38 dB 0.38 dB 0.4 dB 0.52 dB 0.37 dB 0.38 dB 0.38 dB 0.49 dB 0.84 dB 0.37 dB 0.38 dB 0.38 dB 0.75 dB 1.3 dB 0.49 dB 0.5 dB 0.5 dB 0.81 dB 1.4 dB	Agilent N5531S measuring receiver w/N5532A Opt 526 power sensor, 83630B signal generator	SFL, HRT HLR

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
RF Power – Generate ³	(19 200 to 26 500) MHz (20 to 0) dB (0 to -58) dB (-58 to -78) dB (-78 to -110) dB (-110 to -120) dB	0.49 dB 0.5 dB 0.5 dB 1.2 dB 1.9 dB	Agilent N5531S measuring receiver w/N5532A Opt 526 power sensor, 83630B signal generator	SFL, HRT HLR
RF Power – Generate ³	(30 to 2000) MHz (0 to -58) dB (-58 to -78) dB (-78 to -110) dB (2000 to 3050) MHz (0 to -58) dB (-58 to -78) dB (-78 to -110) dB (3050 to 6600) MHz (0 to -58) dB (-58 to -78) dB (-78 to -110) dB (6600 to 13 200) MHz (0 to -58) dB (-58 to -78) dB (-78 to -110) dB (13 200 to 18 000) MHz (0 to -58) dB (-58 to -78) dB (-78 to -110) dB (18 000 to 19 200) MHz (0 to -58) dB (-58 to -78) dB (-78 to -110) dB (19 200 to 26 500) MHz (0 to -58) dB (-58 to -78) dB (-78 to -110) dB (26 500 to 31 150) MHz (-3 to -58) dB (-58 to -78) dB (-78 to -110) dB (31 150 to 41 000) MHz (-6 to -58) dB (-58 to -78) dB (-78 to -100) dB	0.3 dB 0.31 dB 0.32 dB 0.35 dB 0.36 dB 0.37 dB 0.35 dB 0.36 dB 0.39 dB 0.35 dB 0.36 dB 0.42 dB 0.35 dB 0.36 dB 0.46 dB 0.41 dB 0.42 dB 0.5 dB 0.41 dB 0.42 dB 0.9 dB 0.63 dB 0.64 dB 0.96 dB 0.83 dB 0.84 dB 1.1 dB	Agilent N5531S measuring receiver w/N5532A Opt 550 power sensor, 83650B signal generator	RDU



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
RF Power – Generate ³	(41 000 to 45 000) MHz (-6 to -58) dB (-58 to -78) dB (-78 to -100) dB	0.83 dB 0.85 dB 1.4 dB	Agilent N5531S measuring receiver w/N5532A Opt 550 power sensor, 83650B signal generator	RDU
	(45 000 to 50 000) MHz (-6 to -58) dB (-58 to -78) dB (-78 to -90) dB	0.83 dB 1.0 dB 1.5 dB		
RF Power – Generate ³	(0.25 to 30) MHz (10 to 0) dB (0 to -58) dB (-58 to -78) dB (-78 to -110) dB (-110 to -120) dB	0.23 dB 0.23 dB 0.25 dB 0.27 dB 0.43 dB	Agilent N5531S measuring receiver N1912A w/E9304A power sensor, E8257D signal generator	MEL, TPA RFD, HSV ATL, COS SFL, DFW
	(30 to 2000) MHz (20 to 0) dB (0 to -58) dB (-58 to -78) dB (-78 to -110) dB	0.29 dB 0.30 dB 0.31 dB 0.32 dB		
	(2000 to 3050) MHz (20 to 0) dB (0 to -58) dB (-58 to -78) dB (-78 to -110) dB	0.34 dB 0.35 dB 0.36 dB 0.37 dB	Agilent N5531S measuring receiver w/N5532A/N5532B Opt 550 power sensor, E8752D signal generator	MEL, TPA RFD, HSV ATL, COS, DFW
	(3050 to 6600) MHz (20 to 0) dB (0 to -58) dB (-58 to -78) dB (-78 to -110) dB	0.34 dB 0.35 dB 0.36 dB 0.39 dB		
	(6600 to 13 200) MHz (20 to 0) dB (0 to -58) dB (-58 to -78) dB (-78 to -110) dB	0.34 dB 0.35 dB 0.36 dB 0.42 dB		
	(13 200 to 18 000) MHz (15 to 0) dB (0 to -58) dB (-58 to -78) dB (-78 to -110) dB	0.34 dB 0.35 dB 0.36 dB 0.46 dB		

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
RF Power – Generate ³	(18 000 to 19 200) MHz (15 to 0) dB (0 to -58) dB (-58 to -78) dB (-78 to -110) dB	0.41 dB 0.41 dB 0.42 dB 0.5 dB	Agilent N5531S measuring receiver w/N5532A/N5532B Opt 550 power sensor, E8257D signal generator	MEL, TPA RFD, HSV ATL, COS, DFW
	(19 200 to 26 500) MHz (15 to 0) dB (0 to -58) dB (-58 to -78) dB (-78 to -110) dB	0.41 dB 0.41 dB 0.42 dB 0.9 dB		
	(26 500 to 31 150) MHz (15 to 0) dB (0 to -58) dB (-58 to -78) dB (-78 to -110) dB	0.62 dB 0.63 dB 0.64 dB 0.96 dB		
	(31 150 to 41 000) MHz (10 to 0) dB (0 to -58) dB (-58 to -78) dB (-78 to -100) dB	0.82 dB 0.83 dB 0.84 dB 1.1 dB		
	(41 000 to 45 000) MHz (10 to 0) dB (0 to -58) dB (-58 to -78) dB (-78 to -100) dB	0.82 dB 0.83 dB 0.85 dB 1.4 dB		
	(45 000 to 50 000) MHz (10 to 0) dB (0 to -58) dB (-58 to -78) dB (-78 to -90) dB	0.82 dB 0.83 dB 1.0 dB 1.5 dB		
	(50 000 to 65 000) MHz (0 to -20) dB (-20 to -25) dB (-25 to -30) dB (-30 to -35) dB	0.86 dB 0.86 dB 0.89 dB 1.2 dB	Agilent EPM series power meter N8488A power sensor, E8257D Op 567 signal generator	COS, DFW
	(65 000 to 67 000) MHz (-2 to -20) dB (-20 to -25) dB (-25 to -30) dB (-30 to -35) dB	0.88 dB 0.88 dB 0.91 dB 1.2 dB		



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
Thermal Noise – Measure, ENR ³	5 dB, 15 dB, or 21 dB			
	0.1 GHz	0.21 dB		
	1 GHz	0.21 dB		
	2 GHz	0.22 dB		
	3 GHz	0.23 dB		
	4 GHz	0.24 dB		
	5 GHz	0.25 dB		
	6 GHz	0.26 dB		
	7 GHz	0.27 dB		
	8 GHz	0.28 dB		
	9 GHz	0.29 dB		
	10 GHz	0.30 dB		
	11 GHz	0.31 dB		
	12 GHz	0.32 dB		
	13 GHz	0.33 dB		
	14 GHz	0.34 dB		
	15 GHz	0.35 dB		
	16 GHz	0.36 dB		
	17 GHz	0.37 dB		
	18 GHz	0.38 dB		
	19 GHz	0.39 dB		
	20 GHz	0.40 dB		
	21 GHz	0.41 dB		
	22 GHz	0.42 dB		
	23 GHz	0.43 dB		
	24 GHz	0.44 dB		
	25 GHz	0.45 dB		
	26 GHz	0.46 dB		
	26.5 GHz	0.47 dB		
RF Attenuation – Measure ³	(30 to 3050) MHz			
	(0 to 10) dB	0.02 dB		
	(10 to 20) dB	0.025 dB		
	(20 to 30) dB	0.03 dB		
	(30 to 40) dB	0.035 dB		
	(40 to 50) dB	0.04 dB		
	(50 to 60) dB	0.076 dB		
	(60 to 70) dB	0.081 dB		
	(70 to 80) dB	0.12 dB		
	(80 to 90) dB	0.12 dB		
	(90 to 100) dB	0.13 dB		
	(100 to 110) dB	0.13 dB		
	(110 to 120) dB	0.26 dB		
			Agilent 346C noise source – option H13	TPA
			Agilent N5531S measuring receiver w/N5532A Opt 526 power sensor	SFL, HRT HLR



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
RF Attenuation – Measure ³	(3050 to 6600) MHz			
	(0 to 10) dB	0.02 dB		
	(10 to 20) dB	0.025 dB		
	(20 to 30) dB	0.03 dB		
	(30 to 40) dB	0.035 dB		
	(40 to 50) dB	0.04 dB		
	(50 to 60) dB	0.076 dB		
	(60 to 70) dB	0.081 dB		
	(70 to 80) dB	0.12 dB		
	(80 to 90) dB	0.12 dB		
	(90 to 100) dB	0.13 dB		
	(100 to 110) dB	0.15 dB		
	(110 to 120) dB	0.37 dB		
	(6600 to 13 200) MHz			
	(0 to 10) dB	0.02 dB		
	(10 to 20) dB	0.025 dB		
	(20 to 30) dB	0.03 dB		
	(30 to 40) dB	0.035 dB		
	(40 to 50) dB	0.04 dB		
	(50 to 60) dB	0.076 dB		
	(60 to 70) dB	0.081 dB		
	(70 to 80) dB	0.12 dB		
	(80 to 90) dB	0.12 dB		
	(90 to 100) dB	0.14 dB		
	(100 to 110) dB	0.34 dB		
	(110 to 120) dB	0.77 dB		
	(13 200 to 19 200) MHz			
	(0 to 10) dB	0.02 dB		
	(10 to 20) dB	0.025 dB		
	(20 to 30) dB	0.03 dB		
	(30 to 40) dB	0.035 dB		
	(40 to 50) dB	0.04 dB		
	(50 to 60) dB	0.076 dB		
	(60 to 70) dB	0.081 dB		
	(70 to 80) dB	0.12 dB		
	(80 to 90) dB	0.12 dB		
	(90 to 100) dB	0.27 dB		
	(100 to 110) dB	0.66 dB		
	(19 200 to 26 500) MHz			
	(0 to 10) dB	0.02 dB		
	(10 to 20) dB	0.025 dB		
	(20 to 30) dB	0.03 dB		
	(30 to 40) dB	0.035 dB		
	(40 to 50) dB	0.04 dB		
	(50 to 60) dB	0.076 dB		
	(60 to 70) dB	0.081 dB		
	(70 to 80) dB	0.12 dB		
	(80 to 90) dB	0.2 dB		
	(90 to 100) dB	0.5 dB		
	(100 to 110) dB	1.1 dB		
			Agilent N5531S measuring receiver w/N5532A Opt 526 power sensor	SFL, HRT HLR

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
RF Attenuation – Measure ³	(30 to 3050) MHz			
	(0 to 10) dB	0.02 dB		
	(10 to 20) dB	0.025 dB		
	(20 to 30) dB	0.03 dB		
	(30 to 40) dB	0.035 dB		
	(40 to 50) dB	0.04 dB		
	(50 to 60) dB	0.076 dB		
	(60 to 70) dB	0.081 dB		
	(70 to 80) dB	0.12 dB		
	(80 to 90) dB	0.12 dB		
	(90 to 100) dB	0.13 dB		
	(100 to 110) dB	0.13 dB		
	(3050 to 6600) MHz			
	(0 to 10) dB	0.02 dB		
	(10 to 20) dB	0.025 dB		
	(20 to 30) dB	0.03 dB		
	(30 to 40) dB	0.035 dB		
	(40 to 50) dB	0.04 dB		
	(50 to 60) dB	0.076 dB		
	(60 to 70) dB	0.081 dB		
	(70 to 80) dB	0.12 dB		
	(80 to 90) dB	0.12 dB		
	(90 to 100) dB	0.13 dB		
	(100 to 110) dB	0.19 dB		
	(6600 to 13 200) MHz			
	(0 to 10) dB	0.02 dB		
	(10 to 20) dB	0.025 dB		
	(20 to 30) dB	0.03 dB		
	(30 to 40) dB	0.035 dB		
	(40 to 50) dB	0.04 dB		
	(50 to 60) dB	0.076 dB		
	(60 to 70) dB	0.081 dB		
	(70 to 80) dB	0.12 dB		
	(80 to 90) dB	0.12 dB		
	(90 to 100) dB	0.13 dB		
	(100 to 110) dB	0.25 dB		
	(13 200 to 19 200) MHz			
	(0 to 10) dB	0.02 dB		
	(10 to 20) dB	0.025 dB		
	(20 to 30) dB	0.03 dB		
	(30 to 40) dB	0.035 dB		
	(40 to 50) dB	0.04 dB		
	(50 to 60) dB	0.076 dB		
	(60 to 70) dB	0.081 dB		
	(70 to 80) dB	0.12 dB		
	(80 to 90) dB	0.12 dB		
	(90 to 100) dB	0.13 dB		
	(100 to 110) dB	0.31 dB		
			Agilent N5531S measuring receiver w/N5532A/N5532B Opt 550 power sensor	MEL, RFD TPA, HSV COS, RDU, DFW, ATL

Parameter/Range	Frequency	CMC ^{2,7} (±)	Comment	Location ¹⁰
RF Attenuation – Measure ³	(19 200 to 26 500) MHz			
	(0 to 10) dB	0.02 dB		
	(10 to 20) dB	0.025 dB		
	(20 to 30) dB	0.03 dB		
	(30 to 40) dB	0.035 dB		
	(40 to 50) dB	0.04 dB		
	(50 to 60) dB	0.076 dB		
	(60 to 70) dB	0.081 dB		
	(70 to 80) dB	0.12 dB		
	(80 to 90) dB	0.14 dB		
	(90 to 100) dB	0.36 dB		
	(100 to 110) dB	0.82 dB		
	(26 500 to 31 150) MHz			
	(0 to 10) dB	0.02 dB		
	(10 to 20) dB	0.025 dB		
	(20 to 30) dB	0.03 dB		
	(30 to 40) dB	0.035 dB		
	(40 to 50) dB	0.04 dB		
	(50 to 60) dB	0.076 dB		
	(60 to 70) dB	0.081 dB		
	(70 to 80) dB	0.12 dB		
	(80 to 90) dB	0.13 dB		
	(90 to 100) dB	0.33 dB		
	(100 to 110) dB	0.77 dB		
	(31 150 to 41 000) MHz			
	(0 to 10) dB	0.02 dB	Agilent N5531S measuring receiver w/N5532A/N5532B Opt 550 power sensor	MEL, RFD TPA, HSV COS, RDU, DFW, ATL
	(10 to 20) dB	0.025 dB		
	(20 to 30) dB	0.03 dB		
	(30 to 40) dB	0.035 dB		
	(40 to 50) dB	0.04 dB		
	(50 to 60) dB	0.076 dB		
	(60 to 70) dB	0.081 dB		
	(70 to 80) dB	0.14 dB		
	(80 to 90) dB	0.36 dB		
	(41 000 to 45 000) MHz			
	(0 to 10) dB	0.02 dB		
	(10 to 20) dB	0.025 dB		
	(20 to 30) dB	0.03 dB		
	(30 to 40) dB	0.035 dB		
	(40 to 50) dB	0.04 dB		
	(50 to 60) dB	0.076 dB		
	(60 to 70) dB	0.11 dB		
	(70 to 80) dB	0.24 dB		
	(80 to 90) dB	0.6 dB		
	(45 000 to 50 000) MHz			
	(0 to 10) dB	0.02 dB		
	(10 to 20) dB	0.025 dB		
	(20 to 30) dB	0.03 dB		
	(30 to 40) dB	0.035 dB		
	(40 to 50) dB	0.04 dB		
	(50 to 60) dB	0.11 dB		
	(60 to 70) dB	0.29 dB		
	(70 to 80) dB	0.7 dB		
	(80 to 90) dB	1.4 dB		



Parameter/Range	Frequency	CMC ² (±)	Comment	Location ¹⁰
RF Power – Power Sensor (Cal Factor) <i>M</i> is the mismatch Uncertainty	Type-N (50 Ω) 0.1 MHz 0.3 MHz 0.5 MHz 1 MHz 3 MHz 5 MHz 10 MHz 30 MHz 50 MHz 100 MHz 300 MHz 500 MHz 1000 MHz 1500 MHz 2000 MHz 2500 MHz 3000 MHz 3500 MHz 3700 MHz 4000 MHz 4200 MHz 5000 MHz 6000 MHz	1.2 % of rdg + <i>M</i> 1 % of rdg + <i>M</i> 1 % of rdg + <i>M</i> 1 % of rdg + <i>M</i> 1 % of rdg + <i>M</i> 1 % of rdg + <i>M</i> 0.97 % of rdg + <i>M</i> 0.95 % of rdg + <i>M</i> 0.85 % of rdg + <i>M</i> 0.85 % of rdg + <i>M</i> 0.89 % of rdg + <i>M</i> 0.89 % of rdg + <i>M</i> 0.89 % of rdg + <i>M</i> 0.89 % of rdg + <i>M</i> 0.88 % of rdg + <i>M</i> 0.88 % of rdg + <i>M</i> 0.88 % of rdg + <i>M</i> 0.9 % of rdg + <i>M</i> 0.9 % of rdg + <i>M</i> 0.92 % of rdg + <i>M</i> 0.93 % of rdg + <i>M</i> 0.93 % of rdg + <i>M</i> 0.93 % of rdg + <i>M</i>	Agilent EPM series power meter w/Keysight N8482A H84 power sensor	RFD
	Type-N (50 Ω) 0.1 MHz 0.3 MHz 0.5 MHz 1 MHz 3 MHz 5 MHz 10 MHz 30 MHz 50 MHz 100 MHz 300 MHz 500 MHz 1000 MHz 1500 MHz 2000 MHz 2500 MHz 3000 MHz 3500 MHz 3700 MHz 4000 MHz 4200 MHz	1.1 % of rdg + <i>M</i> 0.94 % of rdg + <i>M</i> 0.93 % of rdg + <i>M</i> 0.93 % of rdg + <i>M</i> 0.9 % of rdg + <i>M</i> 0.9 % of rdg + <i>M</i> 0.89 % of rdg + <i>M</i> 0.89 % of rdg + <i>M</i> 0.89 % of rdg + <i>M</i> 0.91 % of rdg + <i>M</i> 0.89 % of rdg + <i>M</i> 0.94 % of rdg + <i>M</i> 0.94 % of rdg + <i>M</i> 0.94 % of rdg + <i>M</i> 0.96 % of rdg + <i>M</i> 0.96 % of rdg + <i>M</i> 0.96 % of rdg + <i>M</i> 1.1 % of rdg + <i>M</i> 1.2 % of rdg + <i>M</i> 1.2 % of rdg + <i>M</i> 1.2 % of rdg + <i>M</i> 1.4 % of rdg + <i>M</i> 1.4 % of rdg + <i>M</i>	Agilent EPM series power meter w/Keysight 8482A H84 power sensor	TPA

Parameter/Range	Frequency	CMC ² (±)	Comment	Location ¹⁰
RF Power – Power Sensor (Cal Factor) <i>M</i> is the mismatch Uncertainty	3.5 mm (50Ω) 50 MHz 100 MHz 300 MHz 500 MHz 1000 MHz 1500 MHz 2000 MHz 3000 MHz 4000 MHz 5000 MHz 6000 MHz 7000 MHz 8000 MHz 9000 MHz 10 000 MHz 11 000 MHz 12 000 MHz 12 400 MHz 13 000 MHz 14 000 MHz 15 000 MHz 16 000 MHz 17 000 MHz 18 000 MHz 19 000 MHz 20 000 MHz 21 000 MHz 22 000 MHz 23 000 MHz 24 000 MHz 25 000 MHz 26 000 MHz 26 500 MHz	0.3 % of rdg + <i>M</i> 1.2 % of rdg + <i>M</i> 1.2 % of rdg + <i>M</i> 1.3 % of rdg + <i>M</i> 1.3 % of rdg + <i>M</i> 1.3 % of rdg + <i>M</i> 1.2 % of rdg + <i>M</i> 1.3 % of rdg + <i>M</i> 1.3 % of rdg + <i>M</i> 1.3 % of rdg + <i>M</i> 1.4 % of rdg + <i>M</i> 1.4 % of rdg + <i>M</i> 1.5 % of rdg + <i>M</i> 1.6 % of rdg + <i>M</i> 1.6 % of rdg + <i>M</i> 1.5 % of rdg + <i>M</i> 1.5 % of rdg + <i>M</i> 1.6 % of rdg + <i>M</i> 1.6 % of rdg + <i>M</i> 1.9 % of rdg + <i>M</i> 1.7 % of rdg + <i>M</i> 1.6 % of rdg + <i>M</i> 1.8 % of rdg + <i>M</i> 1.7 % of rdg + <i>M</i> 2 % of rdg + <i>M</i> 2.2 % of rdg + <i>M</i> 2.1 % of rdg + <i>M</i> 2.5 % of rdg + <i>M</i> 2.7 % of rdg + <i>M</i> 2.3 % of rdg + <i>M</i> 2 % of rdg + <i>M</i> 2 % of rdg + <i>M</i> 2.3 % of rdg + <i>M</i>	Agilent EPM series power meter power w/Keysight 8485A H84 power sensor	TPA
	2.4 mm (50 Ω) 50 MHz 100 MHz 300 MHz 500 MHz 1000 MHz 2000 MHz 3000 MHz 4000 MHz 5000 MHz 6000 MHz 7000 MHz 8000 MHz 9000 MHz	1.1 % of rdg + <i>M</i> 1.1 % of rdg + <i>M</i> 1.1 % of rdg + <i>M</i> 1.2 % of rdg + <i>M</i> 1.2 % of rdg + <i>M</i> 1.2 % of rdg + <i>M</i> 1.2 % of rdg + <i>M</i> 1.2 % of rdg + <i>M</i> 1.2 % of rdg + <i>M</i> 1.3 % of rdg + <i>M</i> 1.3 % of rdg + <i>M</i> 1.3 % of rdg + <i>M</i> 1.3 % of rdg + <i>M</i> 1.4 % of rdg + <i>M</i> 1.5 % of rdg + <i>M</i>	Agilent EPM series power meter w/Keysight N8487A H84 power sensor	

Parameter/Range	Frequency	CMC ² (±)	Comment	Location ¹⁰
RF Power – Power Sensor (Cal Factor) <i>M</i> is the mismatch Uncertainty	2.4 mm (50 Ω)			
	10 000 MHz	1.5 % of rdg + <i>M</i>		
	11 000 MHz	1.5 % of rdg + <i>M</i>		
	12 000 MHz	1.5 % of rdg + <i>M</i>		
	13 000 MHz	1.5 % of rdg + <i>M</i>		
	14 000 MHz	1.6 % of rdg + <i>M</i>		
	15 000 MHz	1.6 % of rdg + <i>M</i>		
	16 000 MHz	1.7 % of rdg + <i>M</i>		
	17 000 MHz	1.7 % of rdg + <i>M</i>		
	18 000 MHz	1.7 % of rdg + <i>M</i>		
	19 000 MHz	1.9 % of rdg + <i>M</i>		
	20 000 MHz	1.9 % of rdg + <i>M</i>		
	21 000 MHz	1.9 % of rdg + <i>M</i>		
	22 000 MHz	1.9 % of rdg + <i>M</i>		
	23 000 MHz	1.9 % of rdg + <i>M</i>		
	24 000 MHz	1.9 % of rdg + <i>M</i>		
	25 000 MHz	1.9 % of rdg + <i>M</i>		
	26 000 MHz	1.9 % of rdg + <i>M</i>		
	27 000 MHz	2.4 % of rdg + <i>M</i>		
	28 000 MHz	2.4 % of rdg + <i>M</i>		
	29 000 MHz	2.4 % of rdg + <i>M</i>		
	30 000 MHz	2.4 % of rdg + <i>M</i>		
	31 000 MHz	2.4 % of rdg + <i>M</i>		
	32 000 MHz	2.4 % of rdg + <i>M</i>		
	33 000 MHz	2.4 % of rdg + <i>M</i>		
	34 000 MHz	2.5 % of rdg + <i>M</i>		
	34 500 MHz	2.5 % of rdg + <i>M</i>		
	35 000 MHz	2.5 % of rdg + <i>M</i>		
	36 000 MHz	2.6 % of rdg + <i>M</i>		
	37 000 MHz	2.6 % of rdg + <i>M</i>		
	38 000 MHz	2.6 % of rdg + <i>M</i>		
	39 000 MHz	2.9 % of rdg + <i>M</i>		
	40 000 MHz	3.0 % of rdg + <i>M</i>		
	41 000 MHz	3.2 % of rdg + <i>M</i>		
	42 000 MHz	3.2 % of rdg + <i>M</i>		
	43 000 MHz	3.2 % of rdg + <i>M</i>		
	44 000 MHz	3.2 % of rdg + <i>M</i>		
	45 000 MHz	3.2 % of rdg + <i>M</i>		
	46 000 MHz	3.2 % of rdg + <i>M</i>		
	47 000 MHz	3.2 % of rdg + <i>M</i>		
	48 000 MHz	3.3 % of rdg + <i>M</i>		
	49 000 MHz	3.4 % of rdg + <i>M</i>		
	50 000 MHz	3.4 % of rdg + <i>M</i>		
			Agilent EPM series power meter w/Keysight N8487A H84 power sensor	TPA

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
RF Power – Measure ³	50 MHz 1.0 mW	0.32 % of rdg	HP 432A PM w/478A Opt H76 thermistor mount	TPA, COS, HSV, DFW
Attenuation – Generate	30 MHz 10 dB 20 dB 30 dB 40 dB 50 dB	5.6 mdB 7.6 mdB 6.4 mdB 7.4 mdB 8.6 mdB	HP 11812A calibration kit	TPA, RFD
Phase Noise ³ Offset Frequency	5 MHz < f ≤ 18 GHz ≤ 100 kHz 100 kHz to 40 MHz	2.3 dB 4.6 dB	HP 3048A phase noise system w/866xA RF source	MEL, COS TPA
Total Harmonic Distortion (THD)	(0 to 65) dB 20 Hz to 20 kHz (0 to 40) dB (40 to 50) dB (50 to 60) dB (60 to 65) dB (20 to 50) kHz (0 to 40) dB (40 to 50) dB (50 to 60) dB (50 to 100) kHz (0 to 40) dB (40 to 50) dB	1.0 dB 1.0 dB 1.3 dB 1.7 dB 2.0 dB 2.1 dB 3.0 dB 2.0 dB 2.4 dB	HP 8903B audio analyzer	COS, HSV MEL, ATL RDU, RFD TPA, SFL HLR, HRT, DFW

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
Harmonics – Measure ³	(-80 to -10) dB 2nd through 5th Harmonic 1 kHz to 600 MHz (600 to 1320) MHz (1320 to 2200) MHz (2200 to 3000) MHz (3000 to 4400) MHz (4400 to 5300) MHz 2nd through 4th Harmonic (5300 to 6625) MHz 2nd through 3rd Harmonic (6625 to 8833) MHz 2nd Harmonic (8833 to 13 250) MHz	0.37 dB 1.1 dB 1.4 dB 1.4 dB 1.7 dB 1.9 dB 2.1 dB 2.1 dB 2.1 dB	Agilent E4440A measuring receiver	HLR, HRT SFL
	(-10 to -80) dB 2nd through 5th Harmonic 1 kHz to 600 MHz (600 to 1320) MHz (1320 to 2200) MHz (2200 to 3000) MHz (3000 to 4400) MHz (4400 to 5300) MHz (5300 to 10 000) MHz 2nd through 4th Harmonic (10 000 to 12 500) MHz 2nd through 3rd Harmonic (12 500 to 16 667) MHz 2nd Harmonic (16 667 to 25 000) MHz	0.37 dB 1.1 dB 1.4 dB 1.4 dB 1.7 dB 1.9 dB 2.1 dB 2.1 dB 2.1 dB 2.3 dB	Agilent E4448A measuring receiver	COS, HSV MEL, ATL RDU, RFD TPA, DFW
Amplitude Modulation – Measure ³	100 kHz to 10 MHz Rate 50 Hz to 10 kHz (5 to 99) % Depth 10 MHz to 3 GHz Rate 50 Hz to 100 kHz (5 to 20) % Depth (20 to 99) % Depth (3 to 26.5) GHz Rate 50 Hz to 100 kHz (5 to 20) % Depth (20 to 99) % Depth	0.75 % of rdg + 0.3 digits 2.5 % of rdg + 0.4 digits 1.5 % of rdg + 0.4 digits 4.5 % of rdg + 0.4 digits 1.5 % of rdg + 0.4 digits	Agilent N5531S measuring receiver	COS, HSV MEL, ATL RDU, RFD TPA, SFL HLR, HRT, DFW



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
Amplitude Modulation – Measure ³	(26.5 to 31.15) GHz Rate 50 Hz to 100 kHz (5 to 20) % Depth (20 to 99) % Depth (31.15 to 50) GHz Rate 50 Hz to 100 kHz (5 to 20) % Depth (20 to 99) % Depth	6.8 % of rdg + 0.4 digits 1.9 % of rdg + 0.4 digits 26 % of rdg + 0.4 digits 6 % of rdg + 0.4 digits	Agilent N5531S measuring receiver	COS, HSV MEL, ATL RDU, RFD TPA, DFW
AM Distortion – Measure ³ Rate 20 Hz to 1 kHz	(0.1 to 10) MHz AM Depth > 1% (0 to -20) dB (-20 to -30) dB AM Depth > 3% (0 to -20) dB (-20 to -30) dB (-30 to -40) dB 10 MHz to 26.5 GHz AM Depth > 1% (0 to -20) dB (-20 to -30) dB AM Depth > 3% (0 to -20) dB (-20 to -30) dB (-30 to -40) dB	1.2 dB 2.2 dB 1.0 dB 1.3 dB 2.4 dB 1.3 dB 2.5 dB 1.1 dB 1.4 dB 3.0 dB		COS, HSV MEL, ATL RDU, RFD TPA, SFL HLR, HRT, DFW
	(26.5 MHz to 50.0 GHz) AM Depth > 3 % (0 to -20) dB AM Depth > 5% (0 to -20) dB (-20 to -30) dB	1.8 dB 1.5 dB 3.5 dB		COS, HSV MEL, ATL RDU, RFD TPA, DFW

Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
Frequency Modulation – Measure ³ β = deviation / rate	250 kHz to 10 MHz Rates 20 Hz to 10 kHz Peak Dev 200 Hz to 40 kHz 10 MHz to 6.6 GHz Rates 50 Hz to 200 kHz Peak Dev 250 Hz to 400 kHz (6.6 to 13.2) GHz Rates 50 Hz to 200 kHz Peak Dev 250 Hz to 400 kHz (13.2 to 26.5) GHz Rates 50 Hz to 200 kHz Peak Dev 250 Hz to 400 kHz	$\beta > 0.2 - 1.5 \% \text{ of rdg} + 2 \text{ Hz}$ $\beta > 1.2 - 1 \% \text{ of rdg} + 2 \text{ Hz}$ $\beta > 0.20 - 1.5 \% \text{ of rdg} + 2 \text{ Hz}$ $\beta > 0.45 - 1 \% \text{ of rdg} + 2 \text{ Hz}$ $\beta > 0.2 - 2.5 \% \text{ of rdg} + 4 \text{ Hz}$ $\beta > 8.0 - 1 \% \text{ of rdg} + 4 \text{ Hz}$ $\beta > 0.2 - 3.8 \% \text{ of rdg} + 9 \text{ Hz}$ $\beta > 16 - 1 \% \text{ of rdg} + 9 \text{ Hz}$	Agilent N5531S measuring receiver	COS, HSV MEL, ATL RDU, RFD TPA, SFL HLR, HRT, DFW
	(26.5 to 31.15) GHz Rates 50 Hz to 200 kHz Peak Dev 250 Hz to 400 kHz (31.15 to 50) GHz Rates 50 Hz to 200 kHz Peak Dev 250 Hz to 400 kHz	$\beta > 0.2 - 3.8 \% \text{ of rdg} + 9 \text{ Hz}$ $\beta > 16 - 1 \% \text{ of rdg} + 9 \text{ Hz}$ $\beta > 0.2 - 8.5 \% \text{ of rdg} + 17 \text{ Hz}$ $\beta > 16 - 1 \% \text{ of rdg} + 17 \text{ Hz}$		COS, HSV MEL, ATL RDU, RFD TPA, DFW
FM Distortion – Measure ³ Rate 20 Hz to 1 kHz	(1 to 6 600) MHz Dev 500 Hz to 2 kHz (0 to -20) dB (-20 to -30) dB (-30 to -40) dB Dev > 2 kHz (0 to -20) dB (-20 to -30) dB (-30 to -40) dB (-40 to -50) dB (6.6 to 13.2) GHz Dev > 2.3 kHz (0 to -20) dB (-20 to -30) dB (-30 to -40) dB Dev > 4.5 K kHz (0 to -20) dB (-20 to -30) dB (-30 to -40) dB (-40 to -50) dB (13.2 to 26.5) GHz Dev > 2.7 kHz (0 to -20) dB (-20 to -30) dB (-30 to -40) dB	0.26 dB 0.79 dB 2.3 dB 0.09 dB 0.27 dB 0.83 dB 2.4 dB 0.26 dB 0.79 dB 2.3 dB 0.09 dB 0.27 dB 0.83 dB 2.4 dB 0.26 dB 0.79 dB 2.3 dB		COS, HSV MEL, ATL RDU, RFD TPA, SFL HLR, HRT, DFW



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
FM Distortion – Measure ³ Rate 20 Hz to 1 kHz	(13.2 to 26.5) GHz Dev > 6.0 kHz (0 to -20) dB (-20 to -30) dB (-30 to -40) dB (-40 to -50) dB	0.09 dB 0.27 dB 0.83 dB 2.4 dB	Agilent N5531S measuring receiver	COS, HSV MEL, ATL RDU, RFD TPA, SFL HLR, HRT, DFW
	(26.5 to 31.15) GHz Dev > 2.7 kHz (0 to -20) dB (-20 to -30) dB (-30 to -40) dB Dev > 6.0 kHz (0 to -20) dB (-20 to -30) dB (-30 to -40) dB (-40 to -50) dB	0.26 dB 0.79 dB 2.3 dB 0.09 dB 0.27 dB 0.83 dB 2.4 dB		COS, HSV MEL, ATL RDU, RFD TPA, DFW
	(31.15 to 50.0) GHz Dev > 4 kHz (0 to -20) dB (-20 to -30) dB (-30 to -40) dB Dev > 12 kHz (0 to -20) dB (-20 to -30) dB (-30 to -40) dB (-40 to -50) dB	0.26 dB 0.79 dB 2.3 dB 0.09 dB 0.27 dB 0.83 dB 2.4 dB		
Phase Modulation – Measure ³	100 kHz to 6.6 GHz Deviations > 0.3 rad Deviations > 0.7 rad	3 % of rdg + 0.002 rad 1 % of rdg + 0.002 rad		COS, HSV MEL, ATL RDU, RFD TPA, SFL HLR, HRT, DFW
	(6.6 to 13.2) GHz Deviations > 0.6 rad Deviations > 2.0 rad	3 % of rdg + 0.005 rad 1 % of rdg + 0.005 rad		
	(13.2 to 26.5) GHz Deviations: > 1.2 rad Deviations > 4.0 rad	3 % of rdg + 0.009 rad 1 % of rdg + 0.009 rad		
	(26.5 to 31.15) GHz Deviations: > 1.3 rad Deviations > 4.0 rad (31.15 to 50) GHz Deviations: > 2.4 rad Deviations > 8.0 rad	3 % of rdg + 0.009 rad 1 % of rdg + 0.009 rad 3 % of rdg + 0.018 rad 1 % of rdg + 0.018 rad		COS, HSV MEL, ATL RDU, RFD TPA, DFW



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
PM Distortion – Measure ³	(1 to 6 600) MHz			
	Rate (20 to 500) Hz			
	Dev > 0.8 rad			
	(0 to -20) dB	0.26 dB		
	(-20 to -30) dB	0.79 dB		
	(-30 to -40) dB	2.3 dB		
	Dev > 2.5 rad			
	(0 to -20) dB	0.09 dB		
	(-20 to -30) dB	0.27 dB		
	(-30 to -40) dB	0.83 dB		
	(-40 to -50) dB	2.4 dB		
	Rate (500 to 1 000) Hz			
	Dev > 0.4 rad			
	(0 to -20) dB	0.26 dB		
	(-20 to -30) dB	0.79 dB		
	(-30 to -40) dB	2.3 dB		
	Dev > 1.0 rad			
	(0 to -20) dB	0.09 dB		
	(-20 to -30) dB	0.27 dB		
	(-30 to -40) dB	0.83 dB		
	(-40 to -50) dB	2.4 dB		
	(6.6 to 13.2) GHz			
	Rate (20 to 500) Hz			
	Dev > 1.8 rad			
	(0 to -20) dB	0.26 dB		
	(-20 to -30) dB	0.79 dB		
	(-30 to -40) dB	2.3 dB		
	Dev > 5.5 rad			
	(0 to -20) dB	0.09 dB		
	(-20 to -30) dB	0.27 dB		
	(-30 to -40) dB	0.83 dB		
	(-40 to -50) dB	2.4 dB		
	Rate (500 to 1000) Hz			
	Dev > 0.8 rad			
	(0 to -20) dB	0.26 dB		
	(-20 to -30) dB	0.79 dB		
	(-30 to -40) dB	2.3 dB		
	Dev > 2.5 rad			
	(0 to -20) dB	0.09 dB		
	(-20 to -30) dB	0.27 dB		
	(-30 to -40) dB	0.83 dB		
	(-40 to -50) dB	2.4 dB		
			Agilent N5531S measuring receiver	COS, HSV MEL, ATL RDU, RFD TPA, SFL HLR, HRT, DFW



Parameter/Range	Frequency	CMC ^{2, 7} ($\pm$)	Comment	Location ¹⁰
PM Distortion – Measure ³	(13.2 to 26.5) GHz Rate (20 to 500) Hz Dev > 3.5 rad (0 to -20) dB (-20 to -30) dB (-30 to -40) dB Dev > 10.0 rad (0 to -20) dB (-20 to -30) dB (-30 to -40) dB (-40 to -50) dB Rate (500 to 1000) Hz Dev > 1.2 rad (0 to -20) dB (-20 to -30) dB (-30 to -40) dB Dev > 4.0 rad (0 to -20) dB (-20 to -30) dB (-30 to -40) dB (-40 to -50) dB	0.26 dB 0.79 dB 2.3 dB 0.09 dB 0.27 dB 0.83 dB 2.4 dB 0.26 dB 0.79 dB 2.3 dB 0.09 dB 0.27 dB 0.83 dB 2.4 dB	Agilent N5531S measuring receiver	COS, HSV MEL, ATL RDU, RFD TPA, SFL HLR, HRT, DFW
	(26.5 to 31.15) GHz Rate (20 to 500) Hz Dev > 3.5 rad (0 to -20) dB (-20 to -30) dB (-30 to -40) dB Dev > 10.0 rad (0 to -20) dB (-20 to -30) dB (-30 to -40) dB (-40 to -50) dB Rate (500 to 1000) Hz Dev > 1.2 rad (0 to -20) dB (-20 to -30) dB (-30 to -40) dB Dev > 4.0 rad (0 to -20) dB (-20 to -30) dB (-30 to -40) dB (-40 to -50) dB	0.26 dB 0.79 dB 2.3 dB 0.09 dB 0.27 dB 0.83 dB 2.4 dB 0.26 dB 0.79 dB 2.3 dB 0.09 dB 0.27 dB 0.83 dB 2.4 dB		MEL, RFD TPA, HSV COS, RDU, DFW



Parameter/Range	Frequency	CMC ^{2, 7} (±)	Comment	Location ¹⁰
PM Distortion – Measure ³	(31.15 to 50.0) GHz Rate (20 to 500) Hz Dev > 7.5 rad (0 to -20) dB (-20 to -30) dB (-30 to -40) dB Dev > 19.0 rad (0 to -20) dB (-20 to -30) dB (-30 to -40) dB (-40 to -50) dB (31.15 to 50.0) GHz Rate (500 to 1000) Hz Dev > 3.0 rad (0 to -20) dB (-20 to -30) dB (-30 to -40) dB Dev > 8.0 rad (0 to -20) dB (-20 to -30) dB (-30 to -40) dB (-40 to -50) dB	0.26 dB 0.79 dB 2.3 dB 0.09 dB 0.27 dB 0.83 dB 2.4 dB 0.26 dB 0.79 dB 2.3 dB 0.09 dB 0.27 dB 0.83 dB 2.4 dB	Agilent N5531S measuring receiver	MEL, RFD TPA, HSV COS, RDU, DFW
Return Loss (VSWR) @ 30 MHz 45 MHz to 50 GHz	(0 to 40) dB (0 to 40) dB	1.1 dB 0.41 dB	HP 8751A, HP 85107B network analyzers	TPA
ISN – Relative Amplitude (dB) Insertion Loss Impedance Magnitude (Ω) Impedance Phase ($^{\circ}$)	(0 to 120) dB 150 kHz to 80 MHz (0 to 1) kΩ 150 kHz to 80 MHz (-180 to 180)$^{\circ}$ 150 kHz to 80 MHz	0.59 dB 2 % of rdg 1.8 $^{\circ}$	CISPR 22, CISPR 32, CISPR 16-1-2 HP 8751A network analyzer & HP 87512A transmission/reflection test set, 85032B calibration kit	

Parameter/Range	Frequency	CMC ² (±)	Comment	Location ¹⁰
CDN's & Adapters – (50 to 150) Ω				TPA
Relative Amplitude (dB) Adapter Insertion Loss	(0 to 120) dB 10 kHz to 230 MHz	1.3 dB	IEC/EN 61000-4-6 CISPR 16-1-2 HP 8751A network analyzer & HP 87512A transmission/reflection test set, 85032B calibration kit	
Relative Amplitude (dB) Coupling Factor	(0 to 120) dB 10 kHz to 230 MHz	1.3 dB		
Impedance Magnitude (Ω)	(0 to 1) kΩ 10 kHz to 230 MHz	2 % rdg		
Relative Amplitude (dB) Voltage Division Factor	(0 to 120) dB 10 kHz to 230 MHz	0.59 dB		
LISN –				
Relative Amplitude (dB) Insertion Loss	(0 to 120) dB 9 kHz to 100 MHz (100 to 300) MHz (300 to 500) MHz	0.59 dB 1.3 dB 1.8 dB	ANSI C63.4, CISPR 25, CISPR 16-1-2 HP 8751A network analyzer & HP 87512A transmission/reflection test set, 85032B calibration kit	
Impedance Magnitude (Ω)	(0 to 1) kΩ 9 kHz to 500 MHz	2 % of rdg		
Impedance – Phase (°)	(-180 to 180)° 9 kHz to 500 MHz	1.8°		
Relative Amplitude (dB) Isolation	(0 to 120) dB 9 kHz to 100 MHz (100 to 300) MHz (300 to 500) MHz	0.59 dB 1.3 dB 1.8 dB		
Current Probes & Bulk Current Injection Probes Insertion Loss & Transfer Impedance Relative Amplitude (dB)	(0 to 120) dB 20 Hz to 100 MHz (100 to 300) MHz (300 to 500) MHz	0.59 dB 1.3 dB 1.8 dB	CISPR 16-1-2 IEC/EN 61000-4-6 HP 8751A network analyzer & HP 87512A transmission/reflection test set, 85032B calibration kit	
EFT/Burst Generator –				COS
Voltage (+/-) Risetime Impulse Duration Burst Duration Burst Period	10 V to 8 kV 5 ns +/- 30 % 50 ns +/- 30 % 15 ms +/- 20 % 300 ms +/- 20 %	2.6 % of rdg 0.003 % of rdg 0.003 % of rdg 0.003 % of rdg 0.003 % of rdg	IEC/EN 61000-4-4 Tektronix TDS784C oscilloscope, EFT attenuator set	



Parameter/Equipment	Range	CMC ² (±)	Comment	Location ¹⁰
Surge Generator – Front Time (+/-) Risetime Open/Short Circuit (+/-) Time to Half Value (+/-) Open Circuit Voltage (+/-) Short Circuit Voltage (+/-) Ring Wave Voltage Ring Wave Risetime	 (0.1 to 50) µs (0.1 to 50) µs (20 to 1500) µs 10 V to 8 kV (0.125 to 3) kA 1 kV +/- 10 % 1.5 µs +/- 0.5 µs	 0.008 % of rdg 0.008 % of rdg 0.008 % of rdg 2.9 % of rdg 2.9 % of rdg 2.9 % of rdg 0.008 % of rdg	 IEC/EN 61000-4-5 IEC/EN 61000-4-8 IEC/EN 61000-4-9 IEC/EN 61000-4-10 IEC/EN 61000-4-11 IEC/EN 61000-4-12 Tektronix TDS784C oscilloscope, Tektronix P5210 high voltage probe Pearson 411 current probe	COS
Source Errors for CISPR Bands A, B, C & D for Impulse Spectral Amplitude Absolute Amplitude Pulse Response & Relative Ratio	Band A (0 to 120) dB (10 to 150) kHz Band B (0 to 120) dB (0.15 to 30) MHz	 0.82 dB 0.82 dB	 IGUU 2918 pulse generator CISPR 16-1- 1 signal generator, Agilent 33250A waveform generator	
Source Errors for CISPR Bands A, B, C & D for Impulse Spectral Amplitude Absolute Amplitude Pulse Response & Relative Ratio	Band C & D (0 to 120) dB (30 to 1000) MHz (0 to 120) dB Band E (1 to 18) GHz	 1.5 dB 0.77 dB	 IGUU 2918 pulse generator CISPR 16-1- 1 signal generator, Agilent 33250A waveform generator	
Source Errors for Sinewave output for CISPR Checks (at 60 dBµV) Absolute Amplitude	60 dBµV Band A through D Band E	 0.58 dB 0.58 dB	 CISPR 16-1-1 Agilent E8257D signal generator, Agilent 33250A waveform generator	
QuasiPeak to Peak & Average Detector Response Relative Amplitude Ratio	(-60 to 60) dB Band A through D	 1.3 dB	 IGUU 2918 pulse generator	
Return Loss (VSWR) 30 kHz to 6 GHz 6 GHz to 18 GHz	 (0 to 80) dB (0 to 50) dB	 2.4 dB 0.32 dB	 Agilent 8753ES network analyzers, Wiltron 87A50 VSWR bridge	
ESD Simulators Contact Voltage (Positive & Negative) Risetime Peak Current 30 ns Current 60 ns Current	 (0 to 20) kV (20 to 30) kV (0 to 5) ns (0 to 60) A (0 to 60) A (0 to 60) A	 1.2 % of rdg + 2V 1.2 % of rdg + 20V 31.5 ps 2.1 % of rdg 2.9 % of rdg 6.3 % of rdg	 IEC 61000-4-2 ISO 10605 MIL STD 331 ESVM Agilent 54855A oscilloscope, IEC ESD target	

VII. Mechanical

Parameter/Equipment	Range	CMC ^{2, 4} (±)	Comment	Location ¹⁰
Accelerometers – (7 < 10) Hz (10 < 30) Hz (30 < 2000) Hz (2 to 10) kHz (5 < 10) Hz (10 < 30) Hz (30 < 2000) Hz (2 to 10) kHz (7 to 100) Hz (100 to 2500) Hz (2.5 to 10) kHz	(0.01 to 10) g (0.01 to 10) g (0.01 to 10) g	2 % of rdg 1.5 % of rdg 1 % of rdg 2.5 % of rdg 4 % of rdg 3 % of rdg 1.5 % of rdg 4 % of rdg 1.5 % of rdg 1.2 % of rdg 2.5 % of rdg	Accelerometer calibrator Portable vibration calibrator Accelerometer calibrator	TPA ATL, HRT, HLR, SFL, MEL, COS, DFW, RDU HSV
Accelerometers – (7 < 10) Hz (10 < 100) Hz (100 to 920) Hz (> 920 to 5000) Hz (> 5 to 10) kHz	(0.2 to 1) g	1.7 % of rdg 1.2 % of rdg 1 % of rdg 1.4 % of rdg 1.9 % of rdg	Accelerometer calibrator	RFD
Scales & Balances ³	1 mg to 5000 g (0.001 to 100) lb Up to 1 000 lb 1 g to 40 kg Up to 1100 lb Up to 500 kg 1 mg to 600 g 1 mg to 22 kg 10 mg to 40 kg (0.022 to 2000) lb 1 mg to 220 g Up to 1000 lb Up to 454 kg 500 mg to 15 kg Up to 28 kg Up to 1600 lb	(0.049 + 0.003X) mg (3.2 E ⁻⁶ + 3.1 E ⁻⁶ W) lb (0.0002 + 0.000 12W) lb (0.042 + 0.0045X) mg (0.0003 + 0.000 12W) lb (0.13 + 0.000 12X) g (0.014 + 0.0015X) mg (0.04 + 0.0031X) mg (7.7 + 0.12X) mg (0.000 04 + 0.000 12W) lb (0.048 + 0.003 1X) mg (0.000 12W) lb (0.000 12X) g (1 + 0.0042X) mg (8.5 + 0.12X) mg (0.005 + 0.000 13W) lb	Class 1 weights Class F weights Class 1 weights Class F weights Class 0 weights Class 1 weights Class F weights ASTM E617 Class 1 weights NIST Class F weights Class 1 & 2 weights Class F & 2 weights Class F weights	TPA, RFD ATL HSV HRT HLR

Parameter/Equipment	Range	CMC ^{2, 4} ($\pm$)	Comment	Location ¹⁰
Scales & Balances ³	0.01 g to 10 kg Up to 400 lb Up to 181 kg	(0.15 + 0.003X) mg 0.000 12W lb 0.000 12X g	Class 1 weights Class F weights	SFL, DFW SFL
	(1 to 400) g	(0.0015X + 0.019) mg	Class 0 weights	MEL
	(1 to 1000) g (1000 to 40 000) g	(0.0031X + 0.04) mg (0.0033X) mg	Class 1 weights	
	(1 to 9100) g	(0.12X + 9.3) mg	Class F weights	
	(0.002 to 1000) lb	(0.000 12W + 0.000 04) lb		
	1 mg to 420 g	(0.021 + 0.0034X) mg	Class 1 weights	COS, DFW
	Up to 100 kg Up to 1000 lb	(0.0017 + 0.000 12X) g (0.0021 + 0.000 12W) lb	Class F weights	
	500 g to 41 kg	(0.015 + 0.024X) mg	Class 1 weights	COS
	1 g to 11 kg (0.001 to 75) lb	(0.16 + 0.003X) mg (0.000 004 7W) lb	Class 6 weights	RDU
	1 g to 11 kg (0.001 to 531) lb	(0.75 + 0.12X) mg (0.000 12W) lb	Class 6 weights	
Banding Tools	Up to 180 lbf	1.2 lbf	Banding calibration fixture	MEL, COS

Parameter/Equipment	Range	CMC ^{2, 4} (±)	Comment	Location ¹⁰
Force				
Tension & Compression	(0.5 to 750) lbf	0.09 % of rdg	Class F weights	TPA
	(20 to 1000) lbf (200 to 10 000) lbf (10 000 to 25 000) lbf (25 000 to 50 000) lbf	The greater of: 0.012 % of rdg or 0.023 lbf 0.012 % of rdg or 0.24 lbf 0.012 % of rdg or 0.5 lbf 0.012 % of rdg or 0.77 lbf	Morehouse press with load cells	
	(5 to 300) lbf (40 to 2000) lbf	The greater of: 0.012 % of rdg or 0.006 lbf 0.012 % of rdg or 0.48 lbf	Morehouse press with load cells	RDU
	10 mgf to 540 lbf	0.061 % of rdg	Class 1 & Class F weights	ATL
	(0.01 to 500) lbf	0.063 % of rdg	Class F weights	RFD
	(50 to 2000) lbf (200 to 10 000) lbf (500 to 25 000) lbf	0.068 % of rdg 0.044 % of rdg 0.087 % of rdg	Morehouse press with load cells	
	Up to 10 kgf (0.1 to 300) lbf	(6.1 + 0.0029X) mg 0.086 % of rdg	Class 1 weights Class F weights	SFL
	(50 to 500) lbf	The greater of: 0.12 % of rdg or 0.06 lbf	Morehouse press with load cell	
	(0.5 to 500) lbf	0.06 % of rdg	Class F weights	MEL
	(0.5 to 500) lbf	0.02 % of rdg	Class F weights	COS, RDU, DFW
	(200 to 25 000) lbf	0.017 % of rdg	Morehouse load ³ cells	COS
Tension	(0.5 to 500) lbf 220 gf to 23 kgf	(0.000 06 + 0.000 12W) lbf (0.03 + 0.000 12M) g	Class F weights	HRT
	(1000 to 50 000) lbf	0.021 % of rdg	Morehouse load cells	HSV
	(10 to 200) mgf (0.2 to 1) gf (1 to 10) gf (10 to 500) gf (1 to 540) lbf	0.45 mgf 1.2 mgf 0.037 % of rdg 0.024 % of rdg 0.017 % of rdg	Class F weights	
Compression	(200 to 10 000) lbf (500 to 25 000) lbf (1000 to 50 000) lbf	0.014 % of rdg 0.018 % of rdg 0.034 % of rdg	Morehouse load cells	
Force Gages, Load Cells & Dynamometers				
Tension/Compression	10 g to 10 kg (0.5 to 500) lb	0.024 % of rdg 0.031 % of rdg	Class F weights	HLR

Parameter/Equipment	Range	CMC ^{2,9} (±)	Comment	Location ¹⁰
Pressure – Measuring Equipment ³	(0 to 24) inH ₂ O	0.0015 inH ₂ O	Dwyer 1425-25 hook gage	TPA
	(60 to 110) kPa (8.7 to 16) psia	0.027 kPa 0.004 psi	ADT783 pressure controller ADT151-BP	
	(-15 to 15) psi (> 15 to 30) psi	0.0018 psi 0.012 % of rdg	ADT783 pressure controller ADT151-01RD-CP30M	
	(-15 to 150) psi (> 150 to 300) psi	0.0018 psi 0.012 % of rdg	ADT783 pressure controller ADT151-01RD-CP300M	
	(-15 to 500) psi (> 500 to 1000) psi	0.059 psi 0.012 % of rdg	ADT783 pressure controller with ADT151-01RD-CP1KM	
	(10 to 16 000) psi	0.019 % of rdg	Fluke P3125-PSI dead weight tester	
	(16 000 to 40 000) psi	25 psi	Additel ADT672-10-GP40K pressure calibrator	
	(10 to 16 000) psi	0.019 % of rdg	Dead weight Fluke P3125	RFD
	(0 to 30) inH ₂ O	The greater of 0.0073 % of rdg or 0.000 55 inH ₂ O	Ruska 7250LP	ATL
	(0 to 23) psia (0 to 30) inHg	0.005 psi 0.01 inHg	Paroscientific 760-23A	
	(-15 to 300) psig (-15 to 1000) psig	0.07 psi 0.24 psi	Additel ADT761A-1K	
	(10 to 16 000) psi	The greater of 0.019 % of rdg or 0.0075 psi	Fluke P3125-PSI deadweight tester	
	(-14.75 to 1015) psig (0.75 to 1015) psia	0.002 % of rdg	Fluke PG7601 piston gauge, PC-7100/7600-1 PC-7200-2 & PC-7300-5 piston-cylinder	
	(60 to 13 000) psig (72 to 13 000) psia	0.0035 % of rdg		
	(145 to 29 000) psig (160 to 29 000) psia	0.0035 % of rdg		



Parameter/Equipment	Range	CMC ^{2,9} (±)	Comment	Location ¹⁰
Pressure – Measuring Equipment ³	(10 to 500) psi (200 to 10 000) psi	0.008 % of rdg 0.01 % of rdg	*Whichever is greater Fluke P3224-PSI	MEL
	(0.2 to 1000) psi	0.0022 % of rdg	Ruska 2468A deadweight tester	SFL
	Up to 2900 psig Up to 10 000 psig	0.37 psi 1.3 psi	ADT 762	COS
	(0.01 to 17.4) psia	*0.000 73 psi or 0.0084 % rdg	Fluke 6270A pressure controller & modules PM500-A120K	COS, DFW
	(-15 to 15) psi	0.000 88 psi	PM500-BG100K	
	(0 to 30) psi	*0.0012 psi or 0.0083 % rdg	PM500-G200K	
	(0 to 100) psi	*0.0043 psi or 0.0083 % rdg	PM500-G700K	
	(-15 to 600) psi	*0.025 psi or 0.0084 % rdg	PM500-BG4M	
	(-15 to 1500) psi	*0.062 psi or 0.0084 % rdg	PM500-BG10M	
	(0 to 6000) psi (0 to 15 000) psi	0.72 psi 2 psi	ADT793 w/ ADT151-01-GP15K	RDU
	(60 to 110) kPa (8.7 to 16) psia	0.027 kPa 0.004 psi	ADT783 w/ ADT151-BP	
	(-15 to 15) psi (> 15 to 100) psi	0.005 9 psi 0.012 % of rdg	ADT783 w/ ADT151-CP100M-PSI	
	(-15 to 150) psi (> 150 to 300) psi	0.018 psi 0.012 % of rdg	ADT783 w/ ADT151-CP300M-PSI	
	(-15 to 500) psi (> 500 to 1000) psi	0.059 psi 0.012 % of rdg	ADT783 w/ ADT151-CP1KM-PSI	
	(-15 to 1800) psi (> 1800 to 3600) psi	0.059 psi 0.012 % of rdg	ADT783 pressure controller w/ ADT151-CP3.6KM-PSI	



Parameter/Equipment	Range	CMC ^{2,9} (±)	Comment	Location ¹⁰
Pressure – Measure ³	(-150 to 150) inH ₂ O	0.07 inH ₂ O	Additel ADT686-DP150,	ATL
	(0 to 30) psig	0.007 psi	Additel ADT686-GP30	
	(0 to 50) psia	0.029 psi	Additel ADT681-05-AP50	ATL
	(0 to 150) psia	0.093 psi	Additel ADT681-05-AP150	
	(0 to 5000) psig	1.2 psi	Additel ADT686-GP5K,	ATL
	(0 to 10 000) psig	2.3 psi	Additel ADT686-GP10K	
	(0 to 30) psia	0.018 psi	Fluke 700GA5	HSV
	(0 to 61) inHg	0.037 inHg		
	(-15 to 15) psi	0.007 psi	Additel 681-GP15	HSV
	(0 to 30) psi	0.009 psi	Additel 681-GP30	
	(-15 to 100) psi	0.027 psi	Additel 681- GP100	HSV
	(0 to 300) psi	0.08 psi	Additel 681- GP300	
	(0 to 1000) psi	0.24 psi	Additel 681- GP1K	HSV
	(0 to 3000) psi	0.7 psi	Additel 681- GP3K	
	(0 to 10 000) psi	2.5 psi	Additel 681- GP10K	HSV
	(-150 to 150) inH ₂ O	0.094 inH ₂ O	Additel 681-DP150	
	(-20 to 20) inH ₂ O	0.013 inH ₂ O	Additel 681-DP20	RFD
	(-1 to 1) inH ₂ O	0.0015 inH ₂ O	ADT681-05-DP1-inH ₂ O	
	(-5 to 5) inH ₂ O	0.008 inH ₂ O	ADT681-05-DP5-inH ₂ O	RFD
	(-50 to 50) inH ₂ O	0.061 inH ₂ O	ADT681-05-DP50-inH ₂ O	
	(-15 to 0) psi	0.0089 psi	Fluke 2700G-BG100K	RFD
	(0 to 15) psi	0.004 psi	Fluke 2700G-BG100K	
	(0 to 30) psi	0.0078 psi	Additel ADT681-GP30	RFD
	(0 to 100) psi	0.028 psi	Fluke 2700G-BG700K	
	(0 to 300) psi	0.064 psi	Fluke 2700G-BG2M	RFD
	(0 to 1000) psi	0.23 psi	Fluke 2700G-BG7M	
	(0 to 3000) psi	0.97 psi	Additel ADT681-GP3K	RFD
	(0 to 10 000) psi	3.3 psi	Additel ADT681-GP10K	
	(-1 to 1) inH ₂ O	0.004 inH ₂ O	Additel ADT155-DPI-760	HRT
	(-15 to 100) psig	0.027 psi	ADT681-02-GP100-PSI	
	Up to 500 psig	0.12 psi	ADT681-02-GP500-PSI	HRT
	Up to 1000 psig	0.26 psi	ADT681-02-GP1K-PSI	
	Up to 10 000 psig	2.5 psi	ADT681-02-GP10K-PSI	HLR
	(0 to 15) psi	0.004 psi	ADT681-02-GP15-PSI	
	(-15 to 100) psi	0.03 psi	ADT681-02-CP100-PSI	HLR
	(0 to 500) psi	1.2 psi	ADT681-02-GP500-PSI	
	(0 to 1000) psi	0.27 psi	ADT685-02-GP1K-PS1	HLR
	(0 to 10 000) psi	2.3 psi	ADT681-02-GP10K-PS	



Parameter/Equipment	Range	CMC ^{2,9} (±)	Comment	Location ¹⁰
Pressure – Measure ³	(-1 to 1) inH ₂ O	0.0017 inH ₂ O	Additel ADT681-05-DP1	MEL
	(-50 to 50) inH ₂ O	0.058 inH ₂ O	Additel ADT681-05-DP50	
	(-30 to 0) inHg	0.022 inHg	Additel ADT681-02-CP30	
	(-15 to 30) psi	0.011 psi	Additel ADT681-02-CP30	
	(0 to 100) psi	0.032 psi	Additel ADT681-02-GP100	
	(0 to 300) psi	0.07 psi	Additel ADT681-02-GP300	
	(0 to 500) psi	0.12 psi	Additel ADT681-02-GP500	
	(0 to 1000) psi	0.3 psi	Additel ADT681-02-GP1K	
	(0 to 3000) psi	0.9 psi	Additel ADT681-02-GP3K	
	(0 to 5000) psi	1.5 psi	Additel ADT681-02-GP5K	
	(0 to 15 000) psi	8.7 psi	Additel ADT681-05-GP15K	
	(-15 to 100) psi	0.082 psi	Fluke 74x w/700PD6 pressure module	SFL
	(0 to 500) psi	0.31 psi	Fluke 700G07	
	(-150 to 150) inH ₂ O	0.07 inH ₂ O	ADT681-02-DP150	
	(0 to 15) psi	0.004 psi	ADT681-02-GP15	COS
	(0 to 100) psi	0.02 psi	ADT681-05-GP100	
	(0 to 1000) psi	0.6 psi	ADT681-02-GP1K	
	(0 to 10 000) psi	5.9 psi	ADT681-02-GP10K	
	(-150 to 150) inH ₂ O	0.07 inH ₂ O	ADT681-02-DP150	
	Up to 30 psia	0.035 psi	ADT681-10AP30	
	(-30 to 0) inHg	0.023 inHg	ADT681-02-CP30	
	(-15 to 30) psig	0.011 psi	ADT681-02-CP30	
	Up to 100 psig	0.025 psi	ADT681-02-GP100	
	(-15 to 300) psig	0.077 psi	ADT681-02-CP300	
	Up to 1000 psig	0.25 psi	ADT681-02-GP1K	
	Up to 5000 psig	1.5 psi	ADT681-02-GP5K	
	Up to 10 000 psig	3.1 psi	ADT681-02-GP10K	
	Up to 15 000 psig	3.6 psi	ADT681-05-GP15K	
	(-150 to 150) inH ₂ O	0.07 inH ₂ O	ADT681A-02-DP150	DFW
	(-30 to 0) inHg	0.023 inHg	ADT681-02-CP30	
	(-15 to 30) psig	0.011 psi	ADT681-02-CP30	
	Up to 100 psig	0.025 psi	ADT681-02-GP100	
	(-15 to 300) psig	0.077 psi	ADT681-02-CP300	
	Up to 1000 psig	0.25 psi	ADT681-02-GP1K	
	Up to 5000 psig	1.5 psi	ADT681-02-GP5K	
	Up to 10 000 psig	3.1 psi	ADT681-02-GP10K	
	Up to 15 000 psig	3.6 psi	ADT681-05-GP15K	
	(-1 to 1) inH ₂ O	0.002 inH ₂ O	ADT681A-05-DP1	RDU
	(-20 to 20) inH ₂ O	0.07 inH ₂ O	ADT681A-05-DP20	
	Up to 100 psig	0.025 psi	ADT681A-02-GP100	
	(-15 to 300) psig	0.07 psi	ADT681A-02-CP300	
	Up to 1000 psig	0.25 psi	ADT681A-02-GP1K	
	Up to 10000 psig	2.4 psi	ADT681A-02-GP10K	

Parameter/Equipment	Range	CMC ^{2,9} (±)	Comment	Location ¹⁰
Pressure – Measure	(-1 to 1) inH ₂ O (-20 to 20) inH ₂ O (-150 to 150) inH ₂ O (-30 to 0) inHg (-15 to 30) psig Up to 100 psig (-15 to 300) psig Up to 1000 psig Up to 5000 psig Up to 10 000 psig	0.0015 inH ₂ O 0.013 inH ₂ O 0.09 inH ₂ O 023 inHg 0.011 psi 0.025 psi 0.073 psi 0.26 psi 1.2 psi 2.3 psi	ADT681A-05-DP1 ADT681A-05-DP20 ADT681A-02-DP150 ADT681A-02-CP30 ADT681A-02-CP30 ADT681A-02-GP100 ADT681A-02-CP300 ADT681A-02-GP1K ADT681A-02-GP5K ADT681A-02-GP10K	TPA
Rotary Torque - Angle ³	(0 to 360) °	24 arcsec	Rotary encoder	COS
Vacuum Gages	(100 to 1000) torr (10 to 100) torr (1 to 10) torr (10 to 100) mtorr	0.084 % rdg + 0.25 torr 0.093 % rdg + 0.025 torr 0.094 % rdg + 0.0025 torr 0.29 % rdg + 0.025 mtorr	MKS 690A vacuum transducers	ATL
Pipette	(10 to 100) µL (100 to 1000) µL (1 to 10) mL	(0.58 + 0.004V) µL (0.6 + 0.001V) µL (2.6 + 0.0012V) µL	Mass balance	TPA, RDU, COS, DFW, SFL
Torque Tools ³	(10 to 100) ozf-in 64 ozf-in to 1000 lbf-ft	0.6 % of rdg 0.32 % of rdg	CDI 1001 torque tester CDI 5000 ST torque analyzer	TPA, RFD, HRT, HLR, SFL, MEL, COS
	64 ozf-in to 600 lbf-ft	0.32 % of rdg		RDU
	(15 to 200) ozf-in	0.33 % of rdg	CDI torque system	ATL
	(4 to 1000) lbf-in (25 to 1000) lbf-ft	0.33 % of rdg 0.33 % of rdg		ATL, DFW
	(10 to 100) ozf-in (5 to 1000) lbf-in (25 to 250) lbf-ft (250 to 2000) lbf-ft	0.59 % of rdg 0.35 % of rdg 0.35 % of rdg 0.6 % of rdg		HSV
	(0.5 to 2.5) ozf-in (2 to 10) ozf-in (6 to 43) ozf-in (30 to 215) ozf-in	0.18 % of rdg 0.18 % of rdg 0.18 % of rdg 0.18 % of rdg	Waters torque analyzer	RFD, COS, HLR
	(1 to 10) ozf-in	0.63 % of rdg	AWS QCMIO-10	MEL

Parameter/Equipment	Range	CMC ² (±)	Comment	Location ¹⁰
Torque Analyzers	1 lbf·in to 1000 lbf·ft	0.12 % of rdg	Torque arm/ Class F weights	TPA, SFL, HLR
	1 ozf·in to 250 lbf·ft	0.12 % of rdg		ATL, MEL
	(5 to 80) ozf·in (5 to 600) lbf·in (50 to 2000) lbf·ft	0.19 % of rdg 0.18 % of rdg 0.17 % of rdg		HSV
	0.4 ozf·in to 1000 lbf·ft	0.12 % of rdg		RFD, COS, RDU, DFW
Rockwell Hardness Testers ³	HBRW < 60 HBRW (≥ 60 to < 80) HBRW ≥ 80 HBRW	3 HBRW 3 HBRW 1.3 HBRW	Indirect verification per ASTM E18	TPA
	HRC < 35 HRC (≥ 35 to < 60) HRC ≥ 60 HRC	1.3 HRC 1.2 HRC 0.7 HRC		
	HREW < 84 HREW (≥ 84 to < 93) HREW ≥ 93 HREW	1.3 HREW 1.3 HREW 1.3 HREW		
	HR15TW < 81 HR15TW (≥ 81 to < 87) HR15TW > 87 HR15TW	1.8 HR15TW 1.3 HR15TW 1.3 HR15TW		
	HRA (20 to 69) HRA (70 to 79) HRA (80 to 86) HRA	0.62 HRA 0.52 HRA 0.33 HRA		ATL
	HRBW (0 to 59) HRBW (60 to 79) HRBW (80 to 100) HRBW	0.9 HRBW 0.62 HRBW 0.42 HRBW		
	HRC (20 to 39) HRC (40 to 59) HRC (60 to 70) HRC			

Parameter/Equipment	Range	CMC ² (±)	Comment	Location ¹⁰
Rockwell Hardness Testers ³	HRBW < 60 HRBW (≥ 60 to < 80) HRBW ≥ 80 HRBW	3 HRBW 3 HRBW 1.4 HRBW	Indirect verification per ASTM E18	RFD
	HRC < 35 HRC (≥ 35 to < 60) HRC ≥ 60 HRC	1.3 HRC 1.3 HRC 0.73 HRC		
	HR15TW < 81 HR15TW (≥ 81 to < 87) HR15TW > 87 HR15TW	1.8 HR15TW 1.3 HR15TW 1.3 HR15TW		
	HRBW < 60 HRBW (≥ 60 to < 80) HRBW	3.1 HRBW 3 HRBW		HSV
	HRC (≥ 35 to < 60) HRC ≥ 60 HRC	1.2 HRC 0.7 HRC		
	HA < 70 HA > 80 HA	1.4 HRA 0.7 HRA		
	HRA (20 to 65) HRA (70 to 78) HRA (80 to 84) HRA	0.53 HRA 0.36 HRA 0.29 HRA		HLR
	HRBW (40 to 59) HRBW (60 to 79) HRBW (80 to 100) HRBW	0.57 HRBW 0.61 HRBW 0.4 HRBW		
	HRC (20 to 30) HRC (35 to 55) HRC (56 to 65) HRC	0.42 HRC 0.26 HRC 0.23 HRC		
	HRBW (0 to 59) HRBW (60 to 79) HRBW (80 to 100) HRBW	0.82 HRBW 0.8 HRBW 0.55 HRBW		MEL
	HRC (20 to 39) HRC (40 to 59) HRC (60 to 70) HRC	0.47 HRC 0.45 HRC 0.39 HRC		

Parameter/Equipment	Range	CMC ² (±)	Comment	Location ¹⁰
Rockwell Hardness Testers ³	HRA (20 to 65) HRA (70 to 78) HRA (80 to 84) HRA	0.45 HRA 0.39 HRA 0.32 HRA	Indirect verification per ASTM E18	MEL
	HRBW < 60 HRBW (≥ 60 to < 80) HRBW ≥ 80 HRBW	0.8 HRBW 0.85 HRBW 0.69 HRBW		RDU
	HRC < 35 HRC (≥ 35 to < 60) HRC ≥ 60 HRC	0.58 HRC 0.54 HRC 0.39 HRC		
	HRBW < 60 HRBW (≥ 60 to < 80) HRBW ≥ 80 HRBW	3 HRBW 3 HRBW 1.3 HRBW		COS
	HRC < 35 HRC (≥ 35 to < 60) HRC ≥ 60 HRC	1.3 HRC 1.2 HRC 0.7 HRC		
	HRA < 70 HRA (≥ 70 to < 80) HRA ≥ 80 HRA	1.3 HRA 1.2 HRA 0.7 HRA		
Durometers Scale (Force) Accuracy			Direct verification	RFD
Types A, B, E, O,C, D, DO Type M Types OO, OOO Types CF & SL	(0 to 100) duros	0.06 duros 0.07 duros 0.08 duros 0.06 duros	Master balance	
Indenter Geometry Length Diameter Angle	0.1 in 0.05 in (30 to 35) °	130 μin 130 μin 0.085°	Optical comparator	
Types A, B, C, D, DO, O Type M Types O, OO	(0 to 100) duros	0.06 duros 0.07 duros 0.08 duros	Master balance	TPA, RDU
Indenter Geometry Length Diameter Angle	0.1 in 0.05 in (30 to 35) °	130 μin 130 μin 0.12°	Optical comparator	

Parameter/Equipment	Range	CMC ² (±)	Comment	Location ¹⁰
Durometers Scale (Force) Accuracy				
Types A, B, C, D, DO, E, O Type M, Types OO, OOO	(0 to 100) duros	0.06 duros 0.09 duros 0.07 duros	Master balance	ATL, HLR
Indenter Geometry Length Diameter Angle	0.1 in 0.05 in (30 to 35) °	180 µin 180 µin 0.006°	Optical comparator	
Types A, B, C, D, DO, E, O	(0 to 100) duros	0.06 duros	Master balance	HSV
Indenter Geometry Length Diameter Angle	0.1 in 0.05 in (30 to 35) °	140 µin 140 µin 0.13°	Optical comparator	
Mass – Fixed Points	(1, 2, 5, 10) mg (20, 50, 100, 500) mg (1, 2, 5) g 10 g 20 g 50 g 100 g 200 g 500 g 1 kg 5 kg (0.001, 0.002) lb (0.005, 0.01, 0.02) lb 0.05 lb 0.1 lb 0.2 lb (0.5, 1, 2) lb 5 lb 10 lb 25 lb 50 lb	0.027 mg 0.027 mg 0.08 mg 0.13 mg 0.11 mg 0.22 mg 0.36 mg 0.64 mg 29 mg 30 mg 31 mg 0.18 mg 0.19 mg 0.24 mg 0.29 mg 0.39 mg 27 mg 28 mg 28 mg 0.23 g 0.23 g	ASTM E617 Class 1 weights	TPA
	(1,2,5) g 10 g 20 g 50 g 100 g 200 g 500 g 1 kg 2 kg	0.07 mg 0.15 mg 0.19 mg 0.23 mg 0.45 mg 0.99 mg 6.5 mg 10 mg 14 mg	ASTM E617 Class 1 weights	ATL

Parameter/Equipment	Range	CMC ² (±)	Comment	Location ¹⁰
Mass – Fixed Points	5 kg	31 mg	ASTM E617 Class 4 weights	ATL
	10 kg	82 mg		
	20 kg	114 mg		
	200 g	0.73 mg	ASTM E617 Class 1 weights	RFD
	500 g	29 mg		
	1 kg	30 mg		
	5 kg	30 mg		
	(1, 2, 3, 5, 10) mg	0.013 mg		
	(20, 30, 50, 100) mg	0.013 mg		
	(200, 300, 500) mg	0.013 mg		
	(1, 2, 3, 5) g	0.049 mg		
	(10, 20, 30) g	0.068 mg		
	50 g	0.072 mg		
	100 g	0.23 mg		
	200 g	0.38 mg		
	500 g	5.8 mg	ASTM E617; Class 1 weights,	RDU
	(1, 2, 3) kg	58 mg		
	(5, 10, 20) kg	58 mg		
	(0.001, 0.002) lb	0.13 mg		
	(0.005, 0.01, 0.02) lb	0.14 mg		
	0.05 lb	0.2 mg		
	0.1 lb	0.3 mg		
	0.2 lb	0.34 mg		
	(0.5, 1, 2) lb	27 mg		
	(5, 10) lb	28 mg		
	50 lb	150 mg		
	(1, 2, 5) g	0.14 mg		
	10 g	0.19 mg		
	20g	0.18 mg		
	50 g	0.25 mg		
	100 g	0.45 mg		
	200 g	0.65 mg		
	500 g	29 mg		
	(1, 2, 5) kg	31 mg		
	10 kg	150 mg		



Parameter/Equipment	Range	CMC ² (±)	Comment	Location ¹⁰
Mass –	(1, 2, 3, 5, 10, 20, 30) mg (50, 100, 200) mg 300 mg 500 mg (1, 2, 5) g 10 g 20 g 50 g 100 g 200 g 500 g 1 kg 2 kg 5 kg 10 kg 20 kg 25 kg	1.8 µg 1.8 µg 2 µg 1.8 µg 5.2 µg 8.2 µg 10 µg 21 µg 41 µg 61 µg 0.16 mg 0.31 mg 0.61 mg 2.1 mg 3.1 mg 8.1 mg 8.1 mg	ASTM E617; Class 0 weights, OIML Class E2 weights precision mass comparators, balances	HLR
Arvoirdupois	(0.001, 0.002) lb 0.005 lb 0.01 lb 0.02 lb 0.05 lb 0.1 lb 0.2 lb (0.5, 1) lb 2 lb 5 lb 10 lb 20 lb 25 lb 50 lb	2.5 µg 6.1 µg 6.2 µg 7.3 µg 15 µg 20 µg 38 µg 0.25 mg 0.33 mg 1.2 mg 2.1 mg 4.1 mg 4.2 mg 14 mg	ASTM E617 Class 1 weights Precision mass comparators balances	
Class F	(5 to 225) g (0.5 to 10) lb (10 to 50) lb	1.2 mg 0.034 g 0.33 g	Master balances	ATL
	(0.5 to 10) lb (10 to 50) lb	0.03 g, (0.000 066) lb 0.27 g, (0.000 6) lb		HSV
	(1 to 220) g (220 to 6400) g (6 to 34) kg	0.42 mg 36 mg 0.31 g		MEL, HLR
	(1 to 200) g (200 to 2500) g (1 to 34) kg	0.69 mg 0.026 g 0.25 g	Precision balance	RFD



Parameter/Equipment	Range	CMC ² (±)	Comment	Location ¹⁰
Mass – Fixed Points Avoirdupois	5 lb 10 lb 20 lb 25 lb 50 lb 100 lb 500 lb 1000 lb	470 mg 470 mg 480 mg 490 mg 520 mg 1.0 g 4.5 g 9.1 g	ASTM E617 Class 3 & 4 weights	DFW
Gloss Meters	(20, 60, 85)° (0 to 100) GU	0.71 GU	Gloss standards	HLR

VIII. Fluid Quantities

Parameter/Equipment	Range	CMC ² (±)	Comment	Location ¹⁰
Gas Flow	(1 to 10 000) sccm (10 to 1000) slpm	0.2 % of rdg 0.26 % of rdg	Molbloc flow standards	TPA
	(1 to 50 000) sccm (15 to 100) slpm	0.2 % of reading 0.31 % of reading		DFW

IX. Thermodynamics

Parameter/Equipment	Range	CMC ^{2, 9} (±)	Comment	Location ¹⁰
Relative Humidity – Measuring Equipment	(10 to 95) % RH	0.5 % RH	Thunder Scientific 2500 humidity chamber	COS, RDU, TPA, RFD, HRT, HLR, SFL, MEL, ATL, DFW

Parameter/Equipment	Range	CMC ^{2,9} (±)	Comment	Location ¹⁰
Relative Humidity Measure ³	(0 to 90) % RH (90 to 100) % RH	1.2 % RH 2 % RH	Vaisala MI70/HMP76 humidity indicator & probe	COS, RDU, TPA, RFD, SFL, ATL, MEL
	(0 to 90) % RH	1.6 % RH	Vaisala M170/HMP75 humidity indicator & probe	HRT
	(0 to 90) % RH	1.2 % RH	Vaisala HM170/ HMP77B humidity indicator & probe	HSV
	(10 to 90) % RH	1.3 % RH	Comparison to Vaisala MI70 indicator & HMP77B probe	HLR
	(9 to 85) % RH	2.1 % RH	Vaisala HM46 humidity indicator & probe	DFW
	(0 to 90) % RH	0.64 % RH	Rotronic HP32/HC2A-SH	ATL
Temperature – Measure ³	(-196 to 230) °C (-321 to 446) °F (230 to 420) °C (446 to 788) °F (420 to 660) °C (788 to 1220) °F	0.023 °C 0.042 °F 0.04 °C 0.072 °F 0.056 °C 0.1 °F	Hart 1502A indicator with 5616 & 5609 PRT	TPA
	(800 to 1550) °C	2 °C	Type B thermocouple	
	(-196 to 230) °C (230 to 420) °C	0.017 °C 0.023 °C	Hart 1502 indicator with Fluke 5615 PRT	ATL
	(420 to 500) °C	0.069 °C	Hart 1502A indicator with 5616 PRT	
	(-200 to 420) °C	0.036 °C	Hart 1502A indicator with Burnes Engineering 12005 PRT	RFD
	(-196 to 200) °C (200 to 400) °C (400 to 660) °C	0.018 °C 0.03 °C 0.043 °C	PRT w/ Additel reference thermometer readout	HSV
	(-196 to 0.01) °C (0.01 to 660) °C	0.0043 °C (0.0043 + 0.000 0017) °C	Fluke 5699 SPRT & Fluke 1594A Super-Thermometer	RDU
	(-196 to 200) °C (200 to 420) °C	0.02 °C 0.3 °C	Hart 1502 indicator, Fluke 5618B	HLR
	(-200 to 300) °C	0.031 °C	Hart 1502 indicator with 5622 PRT	SFL

Parameter/Equipment	Range	CMC ^{2,9} (±)	Comment	Location ¹⁰
Temperature – Measure ³	(-196 to 232) °C (-321 to 450) °F (232 to 420) °C (450 to 788) °F	0.018 °C 0.032 °F 0.025 °C 0.044 °F	Comparison to Hart 1502A indicator with 5615 PRT	MEL
	(-200 to 400) °C (400 to 660) °C	0.024 °C 0.069 °C	Secondary PRT	COS
	(-196 to 0) °C (0 to 230) °C (230 to 420) °C (420 to 660) °C	0.015 °C 0.021 °C 0.029 °C 0.052 °C	Comparison to Hart 1502A indicator with 5615 PRT	HRT
	(-197 to 230) °C (230 to 420) °C (420 to 660) °C	0.015 °C 0.023 °C 0.035 °C	Secondary PRT w/ Additel reference thermometer readout	RDU, DFW
Temperature – Measuring Equipment ³	(-40 to 160) °C (160 to 420) °C	0.056 °C 0.067 °C	Hart 1502 indicator with Fluke 5615 PRT & Additel dry well	ATL
	(420 to 660) °C	0.31 °C	Additel dry well	
	(-40 to 155) °C (155 to 660) °C	0.037 °C 0.14 °C	PRT w/ Additel reference thermometer readout & dry block	HSV
	(-25 to 350) °C	0.087 °C	Hart 1502A indicator with Burnes Engineering 1200S PRT & dry block	RFD
	(-25 to 140) °C (140 to 300) °C	0.13 °C 0.42 °C	Hart 1502 indicator with 5622 PRT & dry block	SFL
	(-25 to 140) °C	0.08 °C	Hart 1502A w/ 5615 PRT Fluke 9103 dry block	MEL
	(140 to 375) °C (375 to 420) °C	0.19 °C 0.74 °C	Fluke 9100S dry block Techne FD8650SP dry block	
	(-5 to 125) °C	0.051 °C	Hart 1502A w/ 5615 PRT Fluke 7102 microbath	COS, DFW
	(-40 to 660) °C (-40 to 160) °C (33 to 700) °C	0.18 °C 0.13 °C (0.21 + 0.000 42T) °C	Dry well calibrators	RDU
Temperature – Measuring Equipment	(-196 to 300) °C (> 300 to 500) °C	0.014 °C 0.02 °C	Fluke 5699 SPRT, Fluke 1594A Superthermometer & temperature baths	RDU

Parameter/Equipment	Range	CMC ^{2,9} (±)	Comment	Location ¹⁰
Temperature – Measuring Equipment, Fixed Point	0.01 °C	0.0026 °C	Triple point of water	RDU
Temperature Uniformity Surveys ³				
Type J	(100 to 900) °F	1.8 °F	Datalogger & thermocouples	TPA
Type K	(100 to 1000) °F (1000 to 2000) °F (2000 to 2200) °F	2 °F 2.1 °F 2.7 °F		TPA, HSV, COS, SFL
Type T	(32 to 400) °F	1.6 °F		HSV
Infrared (IR) Thermometry ³	(50 to 100) °C (100 to 300) °C (300 to 420) °C (420 to 500) °C	1.5 °C 4.3 °C 6 °C 7.7 °C	Fluke 9132 infrared calibrator $\lambda = (8 \text{ to } 14) \mu\text{m}$, $\varepsilon = 0.95$	TPA, ATL, HSV, RFD, HLR, SFL, MEL, COS, RDU, HRT, DFW

X. Time & Frequency

Parameter/Equipment	Range	CMC ^{2,9} (±)	Comment	Location ¹⁰
Frequency – Measuring Equipment ³	10 MHz	$1 \times 10^{-9} \text{ Hz/Hz}$	HP Z3801A GPS receiver	HSV, HLR HRT
		$1 \times 10^{-12} \text{ Hz/Hz}$	HP 58503A, Z3805A GPS receiver	TPA, MEL RFD, COS SFL, ATL RDU, DFW
	(1 to 10) Hz (10 to 100) Hz (100 to 1000) Hz (1 to 10) kHz (10 to 100) kHz (0.1 to 1) MHz (1 to 10) MHz	$1 \times 10^{-9} \text{ Hz/Hz} + 0.57 \mu\text{Hz}$ $1 \times 10^{-9} \text{ Hz/Hz} + 5.7 \mu\text{Hz}$ $1 \times 10^{-9} \text{ Hz/Hz} + 57 \mu\text{Hz}$ $1 \times 10^{-9} \text{ Hz/Hz} + 0.57 \text{ mHz}$ $1 \times 10^{-9} \text{ Hz/Hz} + 5.7 \text{ mHz}$ $1 \times 10^{-9} \text{ Hz/Hz} + 57 \text{ mHz}$ $1 \times 10^{-9} \text{ Hz/Hz} + 0.57 \text{ Hz}$	Agilent 33250A function generator / HP Z3801A GPS receiver	HSV, HLR HRT
		$1 \times 10^{-12} \text{ Hz/Hz} + 0.57 \mu\text{Hz}$ $1 \times 10^{-12} \text{ Hz/Hz} + 5.7 \mu\text{Hz}$ $1 \times 10^{-12} \text{ Hz/Hz} + 57 \mu\text{Hz}$ $1 \times 10^{-12} \text{ Hz/Hz} + 0.57 \text{ mHz}$ $1 \times 10^{-12} \text{ Hz/Hz} + 5.7 \text{ mHz}$ $1 \times 10^{-12} \text{ Hz/Hz} + 57 \text{ mHz}$ $1 \times 10^{-12} \text{ Hz/Hz} + 0.57 \text{ Hz}$	Agilent 33250A function generator / HP 58503A, Z3805A GPS receiver	TPA, MEL RFD, COS SFL, ATL RDU, DFW



Parameter/Equipment	Range	CMC ^{2,9} (±)	Comment	Location ¹⁰
Frequency – Measuring Equipment ³	(10 to 20 000) MHz	1×10^{-12} Hz/Hz + 0.57 mHz	Agilent E8257D Opt 520 / HP 58503A GPS receiver	SFL
	(10 to 26 500) MHz	1×10^{-12} Hz/Hz + 0.57 Hz	HP 83630B Opt 008 / HP 58503A GPS receiver	
		1×10^{-9} Hz/Hz + 0.57 kHz	HP 83630B / HP Z3801A GPS receiver	HLR, HRT
	(10 to 50 000) MHz	1×10^{-12} Hz/Hz + 0.57 mHz	Agilent 83650B Opt 008 / HP 58503A GPS receiver	RDU
		1×10^{-9} Hz/Hz + 0.57mHz	Agilent E8257D Opt 550 / HP Z3801A GPS receiver	HSV
		1×10^{-12} Hz/Hz + 0.57mHz	Agilent E8257D Opt 550 / HP 58503A GPS receiver	TPA, COS, MEL, ATL, RFD, DFW
	(50 000 to 67 000) MHz	1×10^{-12} Hz/Hz + 0.57mHz	Agilent E8257D Opt 567 / HP 58503A GPS receiver	COS, DFW
	(1 to 10) Hz (10 to 100) Hz (100 to 1000) Hz (1 to 10) kHz (10 to 100) kHz (100 to 200) kHz (0.2 to 3000) MHz	5.2×10^{-9} Hz/Hz 2.5×10^{-9} Hz/Hz 1.6×10^{-9} Hz/Hz 1.3×10^{-9} Hz/Hz 1.2×10^{-9} Hz/Hz 1.2×10^{-9} Hz/Hz	Agilent 53131A Opt 030 frequency counter / HP Z3801A GPS receiver	HLR, HRT, HSV
		4.2×10^{-9} Hz/Hz 1.5×10^{-9} Hz/Hz 0.6×10^{-9} Hz/Hz 0.33×10^{-9} Hz/Hz 0.24×10^{-9} Hz/Hz 0.21×10^{-9} Hz/Hz 0.21×10^{-9} Hz/Hz	Agilent 53131A Opt 030 frequency counter / HP 58503A, Z3805A GPS receiver	SFL, RDU, ATL, DFW

Parameter/Equipment	Range	CMC ^{2,9} (±)	Comment	Location ¹⁰
Frequency – Measure ³	(1 to 10) Hz (10 to 100) Hz (100 to 1000) Hz (1 to 10) kHz (10 to 100) kHz (100 to 200) kHz (0.2 to 3000) MHz	1.8 x 1 ⁻⁹ Hz/Hz 0.59 x 1 ⁻⁹ Hz/Hz 0.20 x 1 ⁻⁹ Hz/Hz 74 x 1 ⁻¹² Hz/Hz 35 x 1 ⁻¹² Hz/Hz 23 x 1 ⁻¹² Hz/Hz 20 x 1 ⁻¹² Hz/Hz	Agilent 53132A Opt 030 frequency counter / HP 58503A GPS receiver	TPA, MEL RFD, COS
	(10 to 26 500) MHz	1 x 1 ⁻⁹ Hz/Hz + 0.1 Hz	Agilent E4440A spectrum analyzer / HP Z3801A GPS receiver	HRT, HLR
		1 x 1 ⁻¹² Hz/Hz + 0.1 Hz	Agilent E4440A spectrum analyzer / HP 58503A GPS receiver	SFL
	(500 to 46 000) MHz	1 x 1 ⁻⁹ Hz/Hz + 1.0 Hz	Agilent 5352B frequency counter / HP Z3801A GPS receiver	HSV
		1 x 1 ⁻¹² Hz/Hz + 1.6 Hz	Agilent 53152A frequency counter / HP 58503A GPS receiver	TPA
	(10 to 50 000) MHz	1 x 1 ⁻⁹ Hz/Hz + 0.1 Hz	Agilent E4448A spectrum analyzer / HP Z3801A GPS receiver	HSV
		1 x 1 ⁻¹² Hz/Hz + 0.1 Hz	Agilent E4448A spectrum analyzer / HP 58503A,Z3805A GPS receiver	TPA, RFD, MEL, COS, RDU, ATL, DFW
Time – Measuring Equipment	1 pps	1 x 1 ⁻¹² s/s + 750 ps	HP 58503A GPS receiver	TPA, MEL RFD, COS SFL, ATL, RDU, DFW



Parameter/Equipment	Range	CMC ^{2, 4, 9} ($\pm$)	Comment	Location ¹⁰
Timer - Stopwatch ³	10 s to 24 hr	34 ms	Totalize method with counter	SFL, HLR COS, RDU HRT, ATL, RFD, DFW
Type I (Digital) Timers ³	(0 to 19.99) sec/day (0 to 599) sec/month	0.031 sec/day 1.1 sec/month	Helmut Klein Timometer 4500	TPA, RFD MEL, HSV
Type II (Mechanical) Timers ³	(0 to 320) sec/day	0.6 sec/day		
Tachometers – RPM ³ Measuring Equipment	Up to 100 000 RPM	0.001 % of rdg + 0.6R	Comparison to HP 3325B, 33250A signal generator & LED	HRT, RDU HLR, TPA SFL, RFD ATL, MEL COS, HSV, DFW

¹ This laboratory offers commercial calibration service and field calibration service.

² Calibration and Measurement Capability Uncertainty (CMC) is the smallest uncertainty of measurement that a laboratory can achieve within its scope of accreditation when performing more or less routine calibrations of nearly ideal measurement standards or nearly ideal measuring equipment. CMCs represent expanded uncertainties expressed at approximately the 95 % level of confidence, usually using a coverage factor of $k = 2$. The actual measurement uncertainty of a specific calibration performed by the laboratory may be greater than the CMC due to the behavior of the customer's device and to influences from the circumstances of the specific calibration.

³ Field calibration service is available for this calibration. Please note the actual measurement uncertainties achievable on a customer's site can normally be expected to be larger than the CMC found on the A2LA Scope. Allowance must be made for aspects such as the environment at the place of calibration and for other possible adverse effects such as those caused by transportation of the calibration equipment. The usual allowance for the actual uncertainty introduced by the item being calibrated, (e.g., resolution) must also be considered and this, on its own, could result in the actual measurement uncertainty achievable on a customer's site being larger than the CMC.

⁴ In the statement of CMC, L is the numerical value of the nominal length of the device measured in inches. R is the resolution of the unit under test. D is the numerical value of the nominal diameter of the device measured in inches, M represents mismatch, X is mass in gram and W is mass in pounds and F is length in feet.

⁵ This laboratory meets R205 – *Specific Requirements: Calibration Laboratory Accreditation Program* for the types of dimensional tests listed above and is considered equivalent to that of a calibration.

⁶ In the statement of CMC, percentages are of rdg unless otherwise noted.



⁷ The stated measured values are determined using the indicated instrument (see Comments). This capability is suitable for the calibration of the devices intended to measure or generate the measured value in the ranges indicated. CMC's are expressed as either a specific value that covers the full range or as a percentage or fraction of the rdg plus a fixed floor specification.

⁸ This scope meets A2LA's *PI12 Flexible Scope Policy*.

⁹ The type of instrument or material being calibrated is defined by the parameter. This indicates the laboratory is capable of calibrating instruments that measure or generate the values in the ranges indicated for the listed measurement parameter.

¹⁰ The locations of the laboratories that can perform the calibrations are given by a three-letter code with valid to dates given in the table below:

¹¹ The name and contact information under each laboratory's address "below" represents the point-of-contact for that respective laboratory

¹² Due to its corporate scope nature all certificates are issued and shown under 2348.01, but locations perform their work individually.

^{10, 11, 12} Location	Initials	Cert#	Expiration
12530 Telecom Drive, Temple Terrace, FL 33637 Wally Gynn - 813-978-3054 - wally.gynn@tmicalibration.com	TPA	2348.02	September 30, 2027
117 Jetplex Circle Suite C4, Madison, AL 35758 Donny Prax - 256-772-4115 - donny.prax@tmicalibration.com	HSV	2348.03	September 30, 2027
3248 Forest View Road, Rockford, IL 61109 Brian Schickowski - 779-774-3877 - brian.schickowski@tmicalibration.com	RFD	2348.04	September 30, 2027
425 Hayden Station Suite B, Windsor, CT 06095 Jesse Revis - 860-219-0046 - jesse.revis@tmicalibration.com	HRT	2348.05	September 30, 2027
3000 Northwoods Parkway Suite 270, Peachtree Corners, GA 30071 Milt Mosher - 888-497-1448 - milt.mosher@tmicalibration.com	ATL	2348.06	September 30, 2028
4613 Northwest Parkway, Hilliard, OH 43026 Matt Ayres - 614-850-9940 - matt.ayres@tmicalibration.com	HLR	2348.07	September 30, 2028
2100 Park Central Blvd. North Suite 300, Pompano Beach, FL 33064 Wesley Gonzalez - 954-252-2223 - wesley.gonzalez@tmicalibration.com	SFL	2348.08	September 30, 2028
3060 Venture Lane Suite 106, Melbourne, FL 32934 Schuyler Cournoyer - 321-242-0890 - schuyler.cournoyer@tmicalibration.com	MEL	2348.09	September 30, 2028
1355 Garden of the Gods Road, Suite 100, Colorado Springs, CO 80907 Glenn Curtis - 719-424-7068 - glenn.r.curtis@tmicalibration.com	COS	2348.11	September 30, 2027
2200 Gateway Centre Blvd. #208, Morrisville, NC 27560 Taylor Floyd - 919-234-1291 - taylor.floyd@tmicalibration.com	RDU	2348.12	February 29, 2028
1801 Royal Lane, Suite 100, Dallas, TX 75229 Kyle Huitt - 469-779-0107 - kyle.huitt@tmicalibration.com	DFW	2348.13	September 30, 2027

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SCOPE OF ACCREDITATION TO ISO/IEC 17025:2017
& ANSI/NCSL Z540-1-1994 & ANSI/NCSL Z540-3-2006

MICRO QUALITY CALIBRATION LLC A TRUMETRIC FAMILY

9168 De Soto Ave
Chatsworth, CA 91311-4408
Jeff Breidigan Phone: 818 701 4969 ext 241
[Click here to access the Cypress location](#)

CALIBRATION

Valid To: November 30, 2026

Certificate Number: 2348.01

In recognition of the successful completion of the A2LA evaluation process (including an assessment of the organization's compliance with A2LA's – R205 Calibration Program Requirements), accreditation is granted to this laboratory at the location listed above to perform the following calibrations^{1, 7, 10}

I. Acoustical

Parameter/Equipment	Frequency	CMC ² (±)	Comments
Sound Level Meters ³ –			
94 dB	31.5 Hz to 12.5 kHz 16 kHz	0.31 dB 0.32 dB	Briel & Kjaer 4226
104 dB	31.5 Hz to 12.5 kHz 16 kHz	0.30 dB 0.34 dB	
114 dB	31.5 Hz to 12.5 kHz 16 kHz	0.30 dB 0.57 dB	

II. Chemical

Parameter/Equipment	Range	CMC ^{2, 8} (±)	Comments
pH – Measuring Equipment ³	4.00 pH 7.00 pH 10.00 pH	0.012 pH 0.012 pH 0.012 pH	Buffer solutions

Parameter/Equipment	Range	CMC ^{2, 5, 8} ($\pm$)	Comments
Conductivity – Measuring Equipment ³	10 μ S/cm 100 μ S/cm 1410 μ S/cm 10 000 μ S/cm	0.65 μ S/cm 2.2 μ S/cm 6 μ S/cm 41 μ S/cm	Laboratory standard conductivity solution
Aerosol Particle Counters	(0.3 to 10) μ m	2.9 %	TSI electrostatic classifier 3082 TSI condensation particle counter 3772

III. Dimensional

Parameter/Equipment	Range	CMC ^{2, 6} ($\pm$)	Comments
Gage Blocks	Up to 4 in (> 4 to 20) in	(2.9 + 0.7L) μ in (3.1 + 1.3L) μ in	Electronic comparator, master steel gage blocks
Caliper ³	Up to 20 in (> 20 to 40) in	(4.8L + 0.6R) μ in (370 + 6L) μ in	Gage blocks
Micrometer ³	Up to 12 in (> 12 to 36) in	(4.8L + 0.6R) μ in (43 + 8.8L) μ in	Gage blocks
Bench Micrometers	Up to 20 in	(12 + 1.3L) μ in	Gage blocks
Dial, Digital, & Test Indicator ³	Up to 4 in	(4.8L + 0.6R) μ in	Gage blocks
Height Gages ³	Up to 40 in	(4.8L + 0.6R) μ in	Gage blocks
Optical Flats	(1 to 8) in	6.2 μ in	Standard optical flat

Parameter/Equipment	Range	CMC ^{2, 6} (±)	Comments
Measuring Microscopes ³	Up to 12 in	(95 + 3.0L) μin	Glass scale
Cylindrical Gages – Plug & Pin Gages Plain Ring Gages	Up to 1 in (> 1 to 4) in (> 4 to 16) in Up to 1 in (> 1 to 4) in (> 4 to 16) in	(6.8 + 0.7D) μin (5.4 + 2.2D) μin (10 + 1.7D) μin (13 + 0.9D) μin (13 + 1.2D) μin (12 + 2.2D) μin	Universal measuring standard-Supra-500 Universal measuring standard-Supra-500 w/ID probes
Thread Wires	(4 to 20) TPI (> 20 to 80) TPI	17 μin 12 μin	Supermicrometer™ universal measuring standard-Supra-500
Thread Plug Gage Pitch Diameter Major Diameter	(4 to 20) TPI (> 20 to 80) TPI Up to 16 in	(28 + 1.5D) μin (24 + 0.5D) μin (11 + 1.5D) μin	Supermicrometer™ universal measuring standard-Supra-500 w/ thread wires Universal measuring standard-Supra-500
Thread Plug Gage – Minor Lead Angle Major Minor Pitch Flank Angle	(4 to 80) TPI Up to 6 in	(95 + 5.4D) μin (31 + 2.6D) μin 0.054° (80 + 4.5L) μin (84 + 3.8L) μin (50 + 5.5L) μin 0° 6' 32"	Quest thread view machine MicroScanner™
Thread Ring Gage – Major Minor Pitch Flank Angle	(80 to 4.5) TPI Up to 6 in	(67 + 0.5D) μin (83 + 4.2L) μin (81 + 4.9L) μin (51 + 7.7L) μin 0° 6' 32' 3"	Universal measuring standard-Supra-500 w/ probe MicroScanner™



Parameter/Equipment	Range	CMC ^{2, 6} (±)	Comments
Surface Plate ³ – Flatness Repeatability	(18 x 18) in (36 x 72) in	13 µin 28 µin	Autocollimator, repeat-o-meter
Optical Comparator ³ – X Axis Y Axis Angle	Up to 12 in Up to 12 in Up to 360°	(46 + 4L) µin (47 + 3L) µin 2.5 min	Gage blocks, angle blocks
Angle Blocks ³	Up to 45°	2.1 arc sec	Sine plate, gage blocks & electronic indicator
Crimping Tools ³	Up to 1 in diameter	200 µin	Pin gages, optical comparator & pull tester
Precision Levels ³	(2 to 15) in	150 µin	Gage blocks
Protractors/Clinometer ³	Up to 180°	1.3 arc sec + 0.6R	Sine plate w/ angle blocks
Surface Roughness Specimens	Up to 400 µin	0.62 µin	SurfTest w/ reference specimen
Profilometers	Up to 400 µin	0.55 µin	Surface roughness specimen
Rotary Table	(1 to 360) °	4.1 arc sec	Renishaw laser
Steel Rules & Tapes – Steel Rules Measuring Tapes	Up to 72 in Up to 1200 in (In 40 in segments)	0.0027 in (6600 + 16L) µin	Kudale TSCU



IV. Dimensional Testing¹

Parameter/Equipment	Range	CMC ^{2, 6} ($\pm$)	Comments
Length – 1D ⁹	Up to 40 in	5.2 μ in/in	Gage blocks, CMM, Supra 500, etc
	Up to 110 in	(12 + 0.8L) μ in	Renishaw laser

V. Electrical – DC/Low Frequency

Parameter/Equipment	Range	CMC ^{2, 4, 6} ($\pm$)	Comments
DC Voltage – Generate ³	10 V	0.52 μ V/V	Fluke 732B
	Up to 220 mV 220 mV to 2.2V (2.2 to 11) V (11 to 22) V (22 to 220) V (220 to 1100) V	7.5 μ V/V + 0.39 μ V 4.6 μ V/V + 0.62 μ V 3.1 μ V/V + 2.3 μ V 3.2 μ V/V + 3.9 μ V 4.7 μ V/V + 39 μ V 6.2 μ V/V + 0.39 mV	Fluke 5730A
DC Voltage – Measure ³	Up to 100 mV (0.1 to 1) V (1 to 10) V (10 to 100) V (100 to 1000) V	5.7 μ V/V + 0.2 μ V 2.8 μ V/V + 0.3 μ V 2.8 μ V/V + 0.5 μ V 4.1 μ V/V + 30 μ V 4.3 μ V/V + 0.5 mV	FLUKE 8588A
High Voltage	(1000 to 10 000) V (10 000 to 70 000) V	0.042 % + 0.6R 0.048 % + 0.6R	Vitretek 4700/HLV-70
DC Current – Generate ³	20 nA to 220 μ A 220 μ A to 2.2 mA (2.2 to 22) mA (22 to 220) mA 220 mA to 2.2 A (2.2 to 11) A	39 μ A/A + 5.4 nA 31 μ A/A + 6.2 nA 32 μ A/A + 40 nA 46 μ A/A + 0.70 μ A 85 μ A/A + 12 μ A 0.28 mA/A + 0.37 mA	Fluke 5730A, Fluke 5730A, Fluke 5725A
	(11 to 20) A	1.1 mA/A + 0.75 mA	Fluke 5522A
	(20 to 700) A	1.5 mA/A + 0.52 A	Keysight 6680A HP 3458A, current shunts
	(20.5 to 120) A	0.8 mA/A + 5.3 mA	Fluke 5730A, 52120A

Parameter/Equipment	Range	CMC ^{2, 4, 5} (±)	Comments
DC Current – Clamp Meters	(16.5 to 150) A (150 to 1000) A (1 to 5) kA	0.51 % + 0.15 A 0.52 % + 0.54 A 0.6 % + 1 A	Fluke 5522A w/ Fluke 5500 coils Fluke 5730A/52120A/ 6KA coil
DC Current – Measure ³	(10 to 20) pA (20 to 200) pA (0.2 to 2) nA (2 to 20) nA (20 to 100) nA 100 nA to 1 µA (1 to 10) µA (10 to 100) µA 100 µA to 1 mA (1 to 10) mA (10 to 100) mA 100 mA to 1A (1 to 10) A (10 to 30) A (30 to 100) A (100 to 700) A	1.2 % + 3.5 fA 1.2 % + 6 fA 0.27 % + 0.32 pA 0.24 % + 0.6 pA 0.018 % + 60 pA 35 µA/A + 60 pA 27 µA/A + 0.14 nA 31 µA/A + 1 nA 29 µA/A + 7 nA 30 µA/A + 70 nA 48 µA/A + 0.7 µA 0.014 % + 13 µA 0.028 % + 0.43 mA 0.07 % + 4.4 mA 0.026 % 0.038 %	Keithley 6517A HP 3458A, option 002 Fluke 8588A HP 3458A, current shunts
Resistance – Generate	(0 to 10.9999) Ω (11 to 32.9999) Ω (33 to 109.9999) Ω (110 to 329.9999) Ω (0.33 to 1.099 999) kΩ (1.1 to 3.299 999) kΩ (3.3 to 10.999 99) kΩ (11 to 32.999 99) kΩ (33 to 109.9999) kΩ (110 to 329.9999) kΩ (0.33 to 1.099 999) MΩ (1.1 to 3.299 999) MΩ (3.3 to 10.999 99) MΩ (11 to 32.999 99) MΩ (33 to 109.9999) MΩ (110 to 330) MΩ (330 to 1100) MΩ	32 µΩ/Ω + 0.8 mΩ 24 µΩ/Ω + 1.2 mΩ 22 µΩ/Ω + 1.1 mΩ 23 µΩ/Ω + 1.6 mΩ 22 µΩ/Ω + 1.6 mΩ 22 µΩ/Ω + 16 mΩ 22 µΩ/Ω + 16 mΩ 22 µΩ/Ω + 0.16 Ω 22 µΩ/Ω + 0.16 Ω 26 µΩ/Ω + 5.4 Ω 25 µΩ/Ω + 5.4 Ω 47 µΩ/Ω + 39 Ω 0.1 mΩ/Ω + 54 Ω 0.22 mΩ/Ω + 2.1 kΩ 0.39 mΩ/Ω + 2.5 kΩ 2.3 mΩ/Ω + 79 kΩ 12 mΩ/Ω + 0.39 MΩ	Fluke 5522A
Fixed Points	1 Ω 10 kΩ 19 kΩ	10 µΩ/Ω 5 µΩ/Ω 5.2 µΩ/Ω	Fluke 742A

Parameter/Equipment	Range	CMC ^{2, 4} (±)	Comments
Resistance – Generate (cont)			
Fixed Points	0 Ω 1 Ω 1.9 Ω 10 Ω 19 Ω 100 Ω 190 Ω 1 kΩ 1.9 kΩ 10 kΩ 19 kΩ 100 kΩ 190 kΩ 1 MΩ 1.9 MΩ 10 MΩ 19 MΩ 100 MΩ	39 μΩ 85 μΩ/Ω 85 μΩ/Ω 21 μΩ/Ω 21 μΩ/Ω 9.3 μΩ/Ω 9.5 μΩ/Ω 6.3 μΩ/Ω 6.2 μΩ/Ω 6.3 μΩ/Ω 6.3 μΩ/Ω 7.8 μΩ/Ω 10 μΩ/Ω 12 μΩ/Ω 17 μΩ/Ω 36 μΩ/Ω 44 μΩ/Ω 98 μΩ/Ω	Fluke 5730A
High Resistance – Generate, Fixed Points ³	1 MΩ 10 MΩ 100 MΩ 1 GΩ 10 GΩ 100 GΩ 1 TΩ 10 TΩ	11 μΩ/Ω 16 μΩ/Ω 26 μΩ/Ω 46 μΩ/Ω 0.1 mΩ/Ω 0.14 mΩ/Ω 4 mΩ/Ω 12 mΩ/Ω	Ohm-Labs high resistors
Resistance – Measure ³	(0 to 2) Ω (2 to 20) Ω (20 to 200) Ω 200 Ω to 2 kΩ (2 to 20) kΩ (20 to 200) kΩ 200 kΩ to 2 MΩ (2 to 20) MΩ (20 to 200) MΩ 200 MΩ to 2 GΩ (2 to 20) GΩ (0.1 to 2) GΩ (2 to 20) GΩ (20 to 200) GΩ (0.2 to 2) TΩ (2 to 10) TΩ	12 μΩ/Ω + 4 μΩ 8.2 μΩ/Ω + 14 μΩ 7.2 μΩ/Ω + 0.05 mΩ 7.2 μΩ/Ω + 0.5 mΩ 7.2 μΩ/Ω + 5 mΩ 8.9 μΩ/Ω + 1 Ω 17 μΩ/Ω + 10 Ω 68 μΩ/Ω + 1 kΩ 0.02 μΩ/Ω + 0.1 MΩ 0.0053 % + 10 MΩ 0.27 % + 20 kΩ 0.27 % + 0.2 MΩ 0.44 % + 2 MΩ 0.44 % + 20 MΩ 1.3 % + 0.2 GΩ	Fluke 8588A *High voltage mode Keithley 6517A



Parameter/Equipment	Range	CMC ^{2, 4} (±)	Comments
Electrical Simulation of Thermocouple ³ – Type J Type K Type T Type N Type E Type B Type S Type R	 (-210 to 1200) °C (-200 to 1372) °C (-250 to 400) °C (-200 to 1300) °C (-250 to 1000) °C (600 to 1820) °C (0 to 1767) °C (0 to 1767) °C	 0.13 °C 0.13 °C 0.13 °C 0.14 °C 0.14 °C 0.15 °C 0.15 °C 0.15 °C	 Fluke 5522A w/ zero reference junction & SPRT
Capacitance – Measure ³	(0.1 to 1) nF (1 to 10) nF (10 to 100) nF (0.1 to 1) µF (1 to 10) µF (10 to 100) µF (0.1 to 1) mF (1 to 10) mF (10 to 100) mF	0.12 % + 0.1 pF 0.066 % + 2 pF 0.041 % + 10 pF 0.042 % + 0.1 nF 0.044 % + 1 nF 0.062 % + 10 nF 0.063 % + 0.1 µF 0.075 % + 1 µF 0.074 % + 10 µF	Fluke 8588A
Capacitance – Generate ³	(0.22 to 0.4) nF (0.40 to 1.1) nF (1.1 to 3.3) nF (3.3 to 11) nF (11 to 33) nF (33 to 110) nF (0.11 to 0.33) µF (0.33 to 1.1) µF (1.1 to 3.3) µF (3.3 to 11) µF (11 to 33) µF (33 to 110) µF (0.11 to 0.33) mF (0.33 to 1.1) mF (1.1 to 3.3) mF (3.3 to 11) mF (11 to 33) mF (33 to 110) mF	0.45 % + 8 pF 0.39 % + 8 pF 0.46 % + 8 pF 0.2 % + 8 pF 0.2 % + 80 pF 0.2 % + 80 pF 0.2 % + 0.24 nF 0.2 % + 0.8 nF 0.2 % + 2.4 nF 0.2 % + 8 nF 0.31 % + 24 nF 0.35 % + 80 nF 0.35 % + 0.24 µF 0.35 % + 0.8 µF 0.35 % + 2.4 µF 0.35 % + 8 µF 0.58 % + 24 µF 0.85 % + 80 µF	Fluke 5522A



Parameter/Range	Frequency	CMC ^{2, 4, 5} (±)	Comments
Capacitance Generate ³			
Fixed Point:			
1 pF	1 kHz to 1 MHz 2 MHz 3 MHz 4 MHz 5 MHz 10 MHz 13 MHz	0.037 % 0.027 % 0.044 % 0.065 % 0.089 % 0.25 % 0.37 %	Agilent 16380A
10 pF	1 kHz to 1 MHz 2 MHz/3 MHz 4 MHz/5 MHz 10 MHz 13 MHz	0.011 % 0.011 % 0.012 % 0.016 % 0.019 %	
100 pF	1 kHz to 1 MHz 2 MHz/3 MHz 4 MHz 5 MHz 10 MHz 13 MHz	0.011 % 0.012 % 0.014 % 0.017 % 0.035 % 0.050 %	
1000 pF	1 kHz to 1 MHz 2 MHz 3 MHz 4 MHz 5 MHz 10 MHz 13 MHz	0.012 % 0.015 % 0.030 % 0.046 % 0.063 % 0.19 % 0.28 %	
10 nF	(100/120) Hz (1/10/100) kHz	0.014 % 0.014 %	Agilent 16380C
100 nF	(100/120) Hz (1/10/100) kHz	0.014 % 0.014 %	
1000 nF	(100/120) Hz/1 kHz 10 kHz 100 kHz	0.014 % 0.021 % 0.70 %	



Parameter/Range	Frequency	CMC ^{2, 4} ($\pm$)	Comments
AC Voltage – Generate ³			
300 μ V to 2.2 mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1.0) MHz	0.25 mV/V + 4.0 μ V 90 μ V/V + 4.0 μ V 90 μ V/V + 4.0 μ V 0.20 mV/V + 4.0 μ V 0.50 mV/V + 5.0 μ V 1.0 mV/V + 10 μ V 1.4 mV/V + 20 μ V 2.7 mV/V + 20 μ V	Fluke 5730A, Fluke 5725A
(2.2 to 22) mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1.0) MHz	0.24 mV/V + 4.0 μ V 90 μ V/V + 4.0 μ V 80 μ V/V + 4.0 μ V 0.20 mV/V + 4.0 μ V 0.47 mV/V + 4.0 μ V 1.0 mV/V + 10 μ V 1.4 mV/V + 20 μ V 1.4 mV/V + 20 μ V	
(22 to 220) mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1.0) MHz	0.24 mV/V + 12 μ V 90 μ V/V + 6.2 μ V 54 μ V/V + 6.2 μ V 0.12 mV/V + 6.2 μ V 0.31 mV/V + 16 μ V 0.62 mV/V + 20 μ V 1.4 mV/V + 24 μ V 2.7 mV/V + 47 μ V	
220 mV to 2.2 V	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1.0) MHz	0.24 mV/V + 40 μ V 85 μ V/V + 16 μ V 37 μ V/V + 8 μ V 62 μ V/V + 10 μ V 77 μ V/V + 31 μ V 0.31 mV/V + 80 μ V 0.93 mV/V + 0.2 μ V 1.6 mV/V + 0.31 μ V	
(2.2 to 22) V	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1.0) MHz	0.24 mV/V + 0.4 mV 85 μ V/V + 0.16 mV 38 μ V/V + 54 μ V 62 μ V/V + 93 μ V 77 μ V/V + 0.2 mV 0.24 mV/V + 0.62 mV 0.93 mV/V + 2 mV 1.4 mV/V + 3.1 mV	
(22 to 220) V	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz	0.24 mV/V + 4 mV 0.85 mV/V + 1.5 mV 51 μ V/V + 0.5 mV 80 μ V/V + 1 mV 0.15 mV/V + 2.4 mV	

Parameter/Range	Frequency	CMC ^{2, 4} ($\pm$)	Comments
AC Voltage – Generate ³ (cont)			
(220 to 750) V	40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz	72 μ V/V + 3.1 mV 0.13 mV/V + 4.7 mV 0.47 mV/V + 8.5 mV 0.2 % + 35 mV	Fluke 5730A, Fluke 5725A
(750 to 1100) V	40 Hz to 1 kHz (1 to 20) kHz (20 to 30) kHz	70 μ V/V + 3.1 mV 0.13mV/V + 4.7 mV 0.47mV/V + 8.5 mV	
AC Voltage – Measure ³			
Up to 10 mV	1 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz (100 to 300) kHz (300 to 1000) kHz	0.026 % + 1.1 μ V 0.034 % + 1.1 μ V 0.035 % + 1.1 μ V 0.03 % + 0.8 μ V 1 % + 4 μ V 2.1 % + 3.8 μ V	Fluke 8588A
(10 to 100) mV	1 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz (100 to 300) kHz (300 to 1000) kHz	0.007 % + 0.5 μ V 0.012 % + 0.5 μ V 0.024 % + 1 μ V 0.055 % + 5 μ V 0.23 % + 31 μ V 1.2 % + 0.1 mV	
100 mV to 1 V	1 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz (100 to 300) kHz (300 to 1000) kHz	0.0073 % + 5 μ V 0.012 % + 5 μ V 0.022 % + 0.01 mV 0.053 % + 0.05 mV 0.21 % + 0.3 mV 1 % + 1 mV	
(1 to 10) V	1 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz (100 to 300) kHz (300 to 1000) kHz	0.0066 % + 0.05 mV 0.012 % + 0.05 mV 0.022 % + 0.1 mV 0.052 % + 0.5 mV 0.21 % + 3.1 mV 1.1 % + 10 mV	

Parameter/Range	Frequency	CMC ^{2, 4, 6} ($\pm$)	Comments
AC Voltage – Measure ³ (cont)			
(10 to 100) V	1 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz (100 to 300) kHz (300 to 1000) kHz	0.007 % + 0.5 mV 0.0091 % + 0.5 mV 0.022 % + 1 mV 0.052 % + 5 mV 0.35 % + 47 mV 1.1 % + 0.5 V	Fluke 8588A
(100 to 1000) V	1 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz	0.0094 % + 25 mV 0.0093 % + 25 mV 0.023 % + 25 mV 0.054 % + 0.1 V	Fluke 8588A
High Voltage: (1000 to 10 000) V (10 000 to 50 000) V	60 Hz 60 Hz	0.18 % + 0.6R 0.14 % + 0.6R	Vitrek 4700/HLV- 70
2.2 mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1.0) MHz	1.4 mV/V + 1 μ V 0.58 mV/V + 1 μ V 0.33 mV/V + 1 μ V 0.62 mV/V + 1.6 μ V 0.93 mV/V + 2 μ V 1.8 mV/V + 3.1 μ V 1.9 mV/V + 6.2 μ V 2.7 mV/V + 6.2 μ V	Fluke 5790B
(2.2 to 7) mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1.0) MHz	0.66 mV/V + 1 μ V 0.29 mV/V + 1 μ V 0.17 mV/V + 1 μ V 0.32 mV/V + 1.5 μ V 0.48 mV/V + 2 μ V 0.93 mV/V + 3.1 μ V 1 mV/V + 6.2 μ V 1.8 mV/V + 6.2 μ V	
(7 to 22) mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1.0) MHz	0.24 mV/V + 1 μ V 0.15 mV/V + 1 μ V 85 μ V/V + 1 μ V 0.17 mV/V + 1.6 μ V 0.25 mV/V + 2 μ V 0.63 mV/V + 3.1 μ V 0.7 mV/V + 6.2 μ V 1.4 mV/V + 6.2 μ V	
(22 to 70) mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1.0) MHz	0.19 mV/V + 1.2 μ V 93 μ V/V + 1.2 μ V 51 μ V/V + 1.2 μ V 0.17 mV/V + 1.5 μ V 0.25 mV/V + 2 μ V 0.63 mV/V + 3.1 μ V 0.52 mV/V + 6.2 μ V 0.86 mV/V + 6.2 μ V	



Parameter/Range	Frequency	CMC ^{2, 4} (±)	Comments
AC Voltage – Measure ³ (cont)			
(70 to 220) mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1.0) MHz	0.18 mV/V + 1.2 µV 66 µV/V + 1.2 µV 30 µV/V + 1.2 µV 54 µV/V + 1.6 µV 0.13 mV/V + 2 µV 0.2 mV/V + 3.1 µV 0.3 mV/V + 6.2 µV 0.78 mV/V + 6.2 µV	Fluke 5790B
(220 to 700) mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1.0) MHz	0.17 mV/V + 1.2 µV 60 µV/V + 1.2 µV 26 µV/V + 1.2 µV 40 µV/V + 1.5 µV 62 µV/V + 2 µV 0.14 mV/V + 3.1 µV 0.24 mV/V + 6.2 µV 0.75 mV/V + 6.2 µV	
700 mV to 2.2 V	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1.0) MHz	0.16 mV/V 52 µV/V 20 µV/V 36 µV/V 55 µV/V 0.13 mV/V 0.2 mV/V 0.7 mV/V	
(2.2 to 7) V	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1.0) MHz	0.16 mV/V 52 µV/V 19 µV/V 38 µV/V 64 µV/V 0.15 mV/V 0.32 mV/V 0.94 mV/V	
(7 to 22) V	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1.0) MHz	0.16 mV/V 52 µV/V 21 µV/V 37 µV/V 64 µV/V 0.15 mV/V 0.31 mV/V 0.95 mV/V	

Parameter/Range	Frequency	CMC ^{2, 4, 5} ($\pm$)	Comments
AC Voltage – Measure ³ (cont)			
(22 to 70) V	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1.0) MHz	0.16 mV/V 54 μ V/V 26 μ V/V 44 μ V/V 74 μ V/V 0.16 mV/V 1.4 mV/V 1.4 mV/V	Fluke 5790B
(70 to 220) V	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz	0.16 mV/V 55 μ V/V 25 μ V/V 55 μ V/V 80 μ V/V 1.4 mV/V 1.4 mV/V	
(220 to 700) V	(15 to 50) Hz 50 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz	1.6 mV/V 80 μ V/V 32 μ V/V 0.11 mV/V 0.4 mV/V	
(700 to 1000) V	(15 to 50) Hz 50 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz	1.4 mV/V 80 μ V/V 30 μ V/V 1.4 mV/V 1.4 mV/V	
AC Voltage Flatness – Measure ³			
2.2 mV	30 Hz 120 kHz 2 MHz 10 MHz 20 MHz 30 MHz 50 MHz	0.08 % 0.04 % 0.06 % + 0.8 μ V 0.14 % + 0.8 μ V 0.24 % + 0.8 μ V 0.54 % + 1.6 μ V 0.8 % + 1.6 μ V	Fluke 5790B
(2.2 to 7) mV	30 Hz 120 kHz 2 MHz 10 MHz 20 MHz 30 MHz 50 MHz	0.08 % 0.04 % 0.06 % + 0.8 μ V 0.08 % + 0.8 μ V 0.14 % + 0.8 μ V 0.3 % + 0.8 μ V 0.4 % + 0.8 μ V	



Parameter/Range	Frequency	CMC ^{2, 4, 5} (±)	Comments
AC Voltage Flatness – Measure ³ (cont)			
(7 to 22) mV	30 Hz 120 kHz 2 MHz 10 MHz 20 MHz 30 MHz 50 MHz	0.08 % 0.04 % 0.054 % 0.08 % 0.14 % 0.29 % 0.47 %	Fluke 5790B
(22 to 70) mV	30 Hz 2 MHz 10 MHz 20 MHz 30 MHz 50 MHz	0.08 % 0.04 % 0.08 % 0.12 % 0.27 % 0.47 %	
(70 to 220) mV	30 Hz 500 kHz 2 MHz 10 MHz 20 MHz 30 MHz 50 MHz	0.08 % 0.04 % 0.04 % 0.08 % 0.12 % 0.27 % 0.47 %	
(220 to 700) mV	30 Hz 500 kHz 2 MHz 10 MHz 20 MHz 30 MHz 50 MHz	0.08 % 0.03 % 0.04 % 0.08 % 0.12 % 0.27 % 0.47 %	
700 mV to 2.2 V	30 Hz 500 kHz 2 MHz 10 MHz 20 MHz 30 MHz 50 MHz	0.08 % 0.03 % 0.04 % 0.08 % 0.12 % 0.27 % 0.47 %	
(2.2 to 7) V	30 Hz 500 kHz 2 MHz 10 MHz 20 MHz 30 MHz 50 MHz	0.08 % 0.03 % 0.04 % 0.08 % 0.12 % 0.27 % 0.47 %	

Parameter/Range	Frequency	CMC ^{2, 4} (±)	Comments
AC Current – Generate ³			
(29 to 330) µA (0.33 to 3.3) mA (3.3 to 33) mA (33 to 330) mA (0.33 to 1.1) A (1.1 to 3) A (3 to 20.5) A	(10 to 30) kHz (10 to 30) kHz (10 to 30) kHz (10 to 30) kHz (10 to 45) Hz (10 to 45) Hz (45 to 100) Hz 100 Hz to 1 kHz (1 to 5) kHz	1.3 % + 0.31 µA 0.77 % + 0.47 µA 0.31 % + 3.1 µA 0.31 % + 0.16 mA 0.14 % + 77 µA 0.14 % + 77 µA 0.093 % + 5 mA 0.12 % + 5 mA 2.4 % + 5 mA	Fluke 5522A
Up to 220 µA	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.024 % + 16 nA 0.016 % + 10 nA 0.01 % + 8 nA 0.028 % + 12 nA 0.1 % + 62 nA	Fluke 5730A/5725A
220 µA to 2.2 mA	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.024 % + 39 nA 0.016 % + 31 nA 0.01 % + 31 nA 0.019 % + 0.1 µA 0.1 % + 0.62 µA	
(2.2 to 22) mA	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.024 % + 0.39 µA 0.016 % + 0.31 µA 0.01 % + 0.31 µA 0.019 % + 0.54 µA 0.1 % + 4.7 µA	
(22 to 220) mA	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.024 % + 3.8 µA 0.016 % + 3.1 µA 0.01 % + 2.4 µA 0.019 % + 3.1 µA 0.1 % + 9.3 µA	
220 mA to 2.2 A	20 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.024 % + 31 µA 0.039 % + 77 µA 0.62 % + 0.16 mA	
(2.2 to 11) A	20 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.036 % + 0.14 mA 0.078 % + 0.3 mA 0.28 % + 0.6 mA	
Up to 120 A	(10 to 65) Hz (65 to 300) Hz (0.3 to 1) kHz	0.026 % + 29 mA 0.024 % + 46 mA 0.077 % + 0.13 mA	Fluke 5730A /52120A



Parameter/Range	Frequency	CMC ^{2, 4} (±)	Comments
Clamp On Meters			
(16.5 to 150) A	(45 to 65) Hz (65 to 400) Hz	0.31 % + 0.03 A 0.86 % + 0.032 A	Fluke 5522A w/5500 coil
(150 to 1025) A	(45 to 5) Hz (65 to 400) Hz	0.34 % + 0.19 A 1.2 % + 0.35 A	
(1000 to 6000) A	(10 to 1000) Hz	0.58 % + 1 A	Fluke 5730A/ 52120A/6KA coil
AC Current – Measure			
Up to 20 µA	1 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz	0.2 % + 2.5 nA 0.20 % + 2.5 nA 0.23 % + 2.5 nA	Fluke 8588A
(20 to 200) µA	1 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz	0.026 % + 5 nA 0.051 % + 5 nA 0.072 % + 5 nA 0.45 % + 10 nA	
200 µA to 2 mA	1 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz	0.026 % + 50 nA 0.051 % + 50 nA 0.072 % + 50 nA 0.45 % + 0.1 µA	
(2 to 20) mA	1 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz	0.026 % + 0.5 µA 0.051 % + 0.5 µA 0.072 % + 0.5 µA 0.46 % + 1 µA	
(20 to 200) mA	1 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz	0.026 % + 5 µA 0.05 % + 5 µA 0.07 % + 5 µA	
200 mA to 2 A	1 Hz to 2 kHz 2 to 10) kHz (10 to 30) kHz	0.026 % + 0.1 mA 0.051 % + 0.1 mA 0.084 % + 0.1 mA	
(2 to 20) A	10 Hz to 2 kHz (2 to 10) kHz	0.08 % + 0.5 mA 0.08 % + 0.5 mA	
(20 to 30) A	10 Hz to 2 kHz (2 to 5) kHz	0.08 % + 12 mA 0.12 % + 12 mA	



Parameter/Range	Frequency	CMC ^{2, 4, 5} (±)	Comments
AC Current – Measure (cont)			
Up to 1 mA	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 10) kHz (10 to 30) kHz (30 to 50) kHz (50 to 100) kHz	0.017 % 0.0075 % 0.006 % 0.0078 % 0.0083 % 0.016 % 0.017 %	Fluke 8588A
(1 to 10) mA	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz	0.016 % 0.0058 % 0.0033 % 0.0044 % 0.0069 %	
(10 to 200) mA	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz	0.016 % 0.0058 % 0.0033 % 0.0044 % 0.006 %	Fluke 5790B/A40B
(0.2 to 2) A	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 10) kHz (10 to 30) kHz (30 to 50) kHz (50 to 100) kHz	0.016 % 0.0058 % 0.0035 % 0.0038 % 0.0085 % 0.0068 % 0.008 %	
(2 to 20) A	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 10) kHz (10 to 20) kHz (20 to 30) kHz (30 to 100) kHz	0.017 % 0.0068 % 0.0048 % 0.0057 % 0.0079 % 0.0085 % 0.013 %	
(20 to 100) A	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 10) kHz (10 to 20) kHz (20 to 30) kHz (30 to 50) kHz (50 to 100) kHz	0.018 % 0.0085 % 0.0069 % 0.0095 % 0.011 % 0.011 % 0.018 % 0.019 %	



Parameter/Equipment	Range	CMC ^{2, 4, 5} ($\pm$)	Comments
Oscilloscopes ³ –			
Amplitude DC Signal: Into 50 Ω Load Into 1 M Ω Load	(-6.6 to 6.6) V (-130 to 130) V	0.25 % + 40 μ V 0.050 % + 40 μ V	Fluke 5522A/SC1100
Rise Time	< 300 ps	+0 ps/-100 ps	
Leveled Sine Wave Flatness, Relative to 50 kHz, 5 mV(p-p) to 5.5 V(p-p)	50 Hz to 100 MHz (100 to 300) MHz (300 to 600) MHz 600 MHz to 1.1 GHz	1.5 % + 100 μ V 2.0 % + 100 μ V 4.0 % + 100 μ V 5.0 % + 100 μ V	
Time Marker Into 50 Ω Load	(5 to 50) ms 20 ms to 2 ns	(25 + 1000t) parts in 10 ⁶ 2.5 parts in 10 ⁶	t is time in seconds
Bandwidth	(0.1 to 300) MHz (300 to 550) MHz 550 MHz to 1.1 GHz 1.1 GHz to 3.2 GHz	2 % 2.7 % 3.3 % 4.1 %	Fluke 9500B/9530
Time Marker	9.0091 ns to 83 μ s 83 μ s to 55 s	0.22 μ s/s 2.4 μ s/s	
Voltage:			
DC Into 1 M Ω	$\pm$ 1 mV to 200 V	0.024 % + 20 μ V	
DC Into 50 Ω	$\pm$ 1 mV to 5 V	0.024 % + 20 μ V	
Squarewave Into 1 M Ω	40 μ V + 200 Vp-p	0.08 % + 8 μ V	
Squarewave Into 50 Ω	40 μ V + 5 Vp-p	0.08 % + 8 μ V	
Risetime	10 Hz to 2 MHz	22 ps	
Tachometers ³	(6 to 99 999) RPM	0.004 %	Frequency standard w/ LED
Phase – Measure (0 to 360) ^{o 3}	5 Hz to 2 kHz (2 to 5) kHz (5 to 10) kHz (10 to 50) kHz	0.03° 0.04° 0.05° 0.06°	Clark Hess 6000A

VI. Electrical – RF/Microwave

Parameter/Range	Frequency	CMC ^{2, 4, 5} ($\pm$)	Comments
Power Sensor – Calibration Factors (-30 to 20) dBm (-30 to 20) dBm	0.1 MHz to 4.2 GHz 50 MHz to 26.5 GHz	2.8 % CF 3.5 % CF	Agilent power sensors 8482A & 8485A CF is calibration factor
Amplitude Modulation ³ – Carrier: (0.15 to 10) MHz Depth: Up to 99 % Carrier: 10 MHz to 1.3 GHz Depth: Up to 99 %	(20 to 50) Hz 50 Hz to 10 kHz (20 to 50) Hz 50 Hz to 50 kHz (50 to 100) kHz	3.8 % 2.7 % 3.8 % 1.6 % 3.8 %	HP 8902A measuring receiver w/ 11722A power sensor
Frequency Modulation ³ – Carrier: 250 kHz to 10 MHz Dev: Up to 40 kHz Carrier: 10 MHz to 1.3 GHz Dev: Up to 400 kHz	20 Hz to 10 kHz (20 to 50) Hz 50 Hz to 100 kHz (100 to 200) kHz	2.9 % 5.9 % 1.3 % 5.9 %	HP 8902A measuring receiver w/ 11722A power sensor
Phase Modulation ³ – Carrier: 150 kHz to 10 MHz Carrier: 10 MHz to 1.3 GHz	200 Hz to 10 kHz 200 Hz to 20 kHz	4.8 % 3.7 %	HP 8902A measuring receiver w/ 11722A power sensor
Absolute Power – Measure ³ (0 to -10) dBm (-10 to -20) dBm (-20 to -30) dBm (-30 to -40) dBm (-40 to -50) dBm (-50 to -60) dBm (-60 to -70) dBm (-70 to -80) dBm (-80 to -90) dBm (-90 to -100) dBm (-100 to -110) dBm (-110 to -120) dBm	10 MHz to 26.5 GHz	0.08 dB 0.10 dB 0.12 dB 0.13 dB 0.15 dB 0.17 dB 0.20 dB 0.23 dB 0.28 dB 0.33 dB 0.39 dB 0.43 dB	HP 8902A measuring receiver w/ 11722A & 11792A power sensors



VII. Fluid Quantities

Parameter/Equipment	Range ⁷	CMC ^{2, 5, 8} (±)	Comments
Flow – Gas ³	(0.5 to 5) sccm (5 to 50) sccm (0.05 to 0.5) lpm (0.5 to 5) lpm (3 to 30) lpm (30 to 100) lpm (100 to 2500) lpm	1.2 % 1.2 % 0.28 % 0.26 % 0.42 % 0.65 % 1.2 %	DH instruments flow meter calibrator Molbox1 Alicat MCR2500SLM
Flow – Liquid ³	(0.02 to 3) gpm (0.5 to 60.0) gpm (1.5 to 160) gpm (0.1 to 10) gpm (10 to 400) gpm	0.11 % 0.09 % 0.09 % 0.067 % 0.079 %	Flow technology turbine meter Compuflow test stand

VIII. Magnetic Quantities

Parameter/Equipment	Range	CMC ^{2, 5} (±)	Comments
Gauss Meter ³	(1 to 200) Gauss	0.88 %	Helmholtz coil, zero gauss chamber

IX. Optical Quantities

Parameter/Equipment	Range ⁷	CMC ^{2, 5, 8} (±)	Comments
Illuminance – Light Meters	(5 to 200) fc (200 to 2000) fc	2.8 % 3.1 %	Hoffman light source w/ PCS 600 light meter
Optical Wavelength – Measure	(700 to 1650) nm	0.000 48 %	Keysight 86120A
Optical Absolute Power – Measure	-20 dBm @ 850 nm -20 dBm @ 1550 nm	0.091 dBm 0.090 dBm	Agilent 81624A

Parameter/Equipment	Range	CMC ^{2, 8} (±)	Comments
Optical Power Linearity – Measure			
850 nm	0 dBm -10 dBm -20 dBm -30 dBm -40 dBm -50 dBm	0.022 dBm 0.024 dBm 0.023 dBm 0.024 dBm 0.024 dBm 0.029 dBm	Agilent 81624A
1310 nm	0 dBm -10 dBm -20 dBm -30 dBm -40 dBm -50 dBm	0.023 dBm 0.024 dBm 0.025 dBm 0.025 dBm 0.027 dBm 0.030 dBm	
1550 nm	0 dBm -10 dBm -20 dBm -30 dBm -40 dBm -50 dBm	0.022 dBm 0.025 dBm 0.023 dBm 0.024 dBm 0.024 dBm 0.030 dBm	

X. Mechanical

Parameter/Equipment	Range	CMC ^{2, 5} (±)	Comments
Pressure Gauges & Transducer/Vacuum ³			
Vacuum	Up to 1 Torr (1 to 1000) Torr	0.0008 Torr 0.26 Torr	INFICON CDGsci DH Instrument PPC3
Pneumatic	(0 to 17) psia Up to 600 psig Up to 3000 psig Up to 6000 psig Up to 10 000 psig	0.002 % + 0.001 psia 0.010 % + 0.001 psig 0.010 % + 0.01 psig 0.011 % + 0.1 psig 0.021 % + 0.1 psig	Mensor CPC 8000 DH Instruments pressure calibrator, PPCH-G
Hydraulic	(5 to 40 000) psig (725 to 72 500) psi	0.030 % 0.030 %	Ruska Model 2450-701 DH-Budenberg 5306

Parameter/Equipment	Range	CMC ^{2, 5} (±)	Comments
Torque Analyzers ³	(1 to 10) ozf·in (10 to 100) ozf·in (4 to 50) lbf·in (30 to 400) lbf·in (80 to 1000) lbf·in (20 to 250) lbf·ft (200 to 2000) lbf·ft	0.16 % 0.12 % 0.065 % 0.025 % 0.026 % 0.017 % 0.086 %	Torque arms w/ Class F weights
Torque Tools ³	(1 to 10) ozf·in (10 to 100) ozf·in (4 to 50) lbf·in (30 to 400) lbf·in (80 to 1000) lbf·in (20 to 250) lbf·ft (200 to 2000) lbf·ft	0.11 % 0.01 % 0.19 % 0.51 % 0.34 % 0.34 % 0.36 %	Mountz MTX10Z AWS: QC10-100 CDI torque, force & tension calibration system, Model: 200- 400-02
Air Velocity Instruments	(25 to 350) fpm (350 to 1000) fpm (1000 to 9000) fpm	2.6 % 2.4 % 1.3 %	Omega WT4401-D Pitot tube
Fume Hood			
Anemometer	(25 to 500) fpm	4.9 %	Testo anemometer
Air Volume Flow	(200 to 400) cfm	9 cfm	Testo flow hood systems
Force Gages & Transducers ³	Up to 1 lbf (1 to 100) lbf (1 to 1000) lbf (350 to 1000) lbf (1000 to 30 000) lbf (30 000 to 100 000) lbf	0.064 % 0.049 % 0.037 % 0.12 % 0.026 % + 1.5 lbf 0.028 %	Dead weights Morehouse force machine w/ load cell
Durometer Calibrator –			
A Scale	(56.08 to 820.87) g	2.6 g	25 lbf load cell
D Scale	(0 to 4.53) kg	0.012 kg	

Parameter/Equipment	Range	CMC ^{2, 8} (±)	Comments
Pipettes	≤ 1 µL ≤ 10 µL ≤ 100 µL ≤ 1000 µL ≤ 5 mL ≤ 10 mL	0.007 µL 0.008 µL 0.017 µL 0.040 µL 0.045 µL 0.66 µL	Sartorius CC111, Sartorius WZA 225-CW mass comparator
Volumetric – Measure	Up to 5 L	0.094 mL/L	Sartorius mass comparator
Durometers – Type A, B, O Type C, D, DO Indenter Geometry: Length Diameter Angle Radius	(0 to 100) DUROS (0 to 100) DUROS Up to 0.2 in Up to 1 in (0 to 90)° Up to 1 in	0.52 DUROS 0.46 DUROS 0.58 m·in 0.41 m·in 0.049° 0.18 m·in	REX-1 durometer calibrator Optical comparator
Indirect Verification of Rockwell Hardness Testers ³	HRA: Low Mid High HRBW: Low Mid High HRC: Low Mid High HR15N: Low Mid High	0.31 HRA 0.22 HRA 0.19 HRA 0.60 HRBW 0.50 HRBW 0.68 HRBW 0.56 HRC 0.46 HRC 0.40 HRC 0.54 HR15N 0.47 HR15N 0.61 HR15N	ASTM E18



Parameter/Equipment	Range	CMC ^{2, 5} (±)	Comments
Indirect Verification of Rockwell Hardness Testers ³ (cont)	HR15TW: Low Mid High HR30N: Low Mid High HR30TW: Low Mid High HR45N: Low Mid High HR45TW: Low Mid High	0.29 HR15TW 0.29 HR15TW 0.47 HR15TW 0.35 HR30N 0.52 HR30N 0.57 HR30N 0.40 HR30TW 0.38 HR30TW 0.34 HR30TW 0.56 HR45N 0.35 HR45N 0.29 HR45N 0.89 HR45TW 0.62 HR45TW 0.61 HR45TW	ASTM E18
Direct Verification of Rockwell Hardness Testers			
Verification of Test Force	(15 to 150) kgf	0.08 % + 0.01 kgf	Load cell
Verification of Depth Measuring Device	(0 to 260) µm	0.17 µm	Digital indicator system
Accelerometers –			
Vibration: Sensitivity/Frequency Response	(0.5 to 10) Hz (5 to 10 000) Hz (10 000 to 15 000) Hz	1.7 % 1.9 % 2.2 %	Modal shop 9155w/ PCB accelerometers
Shock: Linearity	Up to 10 000 g	2.3 %	
Dynamic Pressure: Linearity	Up to 15 000 psi	3.1 %	



Parameter/Equipment	Range	CMC ^{2, 6, 8} ($\pm$)	Comments
Balances ³	Up to 310 g Up to 4100 g Up to 15 kg	0.3 mg + 0.6R 48 mg + 0.6R 0.52 g + 0.6R	Class 1 master weights
Scales ³	Up to 100 lb Up to 1000 lb Up to 7200 lb	7.7 g + 0.6R 0.12 kg + 0.6R 0.051 % + 0.6R	Class 4 master weights Standard weights
Mass – Measure	30 kg 25 kg 20 kg 10 kg 5 kg 3 kg 2 kg 1 kg 500g 300 g 200 g 100 g 50 g 30 g 20 g 10 g 5 g 3 g 2 g 1 g 500 mg 300 mg 200 mg 100 mg 50 mg 30 mg 20 mg 10 mg 5 mg 3 mg 2 mg 1 mg	15 mg 13 mg 10 mg 5.5 mg 2.5 mg 4.9 mg 2.3 mg 1.6 mg 0.57 mg 0.36 mg 0.19 mg 0.19 mg 73 μ g 64 μ g 9.3 μ g 6.1 μ g 4.6 μ g 4.2 μ g 4.6 μ g 4.6 μ g 3.3 μ g 3.2 μ g 2.9 μ g 2.9 μ g 2.5 μ g 3.0 μ g 2.5 μ g 2.5 μ g 2.5 μ g 2.9 μ g 2.5 μ g 2.5 μ g	Double substitution
Mass – Measure (Avoirdupois)	1 lb 5 lb 10 lb 25 lb 50 lb 500 lb 1000 lb	5.3 μ lb (2.4 mg) 5.3 μ lb (2.4 mg) 2.1 μ lb (9.5 mg) 11 μ lb (4.8 mg) 33 μ lb (15 mg) 0.026 lb (12 g) 0.068 lb (31 g)	Double substitution Load cell



XI. Thermodynamics

Parameter/Equipment	Range	CMC ^{2, 5, 6, 8} (±)	Comments
Temperature – Measure & Measuring Equipment	(-196 to -80) °C (-80 to 100) °C (100 to 660) °C (400 to 1600) °C	0.034 °C 0.021 °C 0.039 °C 0.27 % + 0.6 <i>R</i>	Fluke 1560 w/SPRT, TempSens cal-sys -196/-80 & Fluke 7380 Type R TC w/ Tempsens cal-sys 1700
Infrared / Pyrometers ³	(50 to 500) °C (150 to 1200) °C (-30 to 150) °C	1.4 °C + 0.6 <i>R</i> 0.48 % + 0.6 <i>R</i> 0.8 °C	Fluke 9132 ε = 0.95 (8 to 14) μm IsoTech Pegasus R970 ε = 0.995 (9 to 14) μm Fluke 9133 ε = 0.95 (8 to 14) μm
Humidity – Measuring Equipment, (10 to 30) °C	(5 to 15) % RH (5 to 25) % RH (25 to 35) % RH (35 to 50) % RH (50 to 65) % RH (65 to 80) % RH (80 to 95) % RH	0.40 % RH 0.49 % RH 0.52 % RH 0.59 % RH 0.62 % RH 0.66 % RH 0.83 % RH	Rotronic HC2-SH & GEO 2000
Temperature – Measuring Equipment, Fixed Point	Triple Point of Water Liquid Nitrogen	8.3 mK 7.5 mK	Pond Engineering TPW
Humidity – Measure ³			
(-50 to 90) °C	Frost Point Dew Point	1.1 °C 0.14 °C	Chilled mirror
(10 to 30) °C	(5 to 15) % RH (5 to 25) % RH (25 to 35) % RH	0.20 % RH 0.36 % RH 0.40 % RH	Rotronic HC2-SH
(10 to 30) °C	(35 to 50) % RH (50 to 65) % RH (65 to 80) % RH (80 to 95) % RH	0.47 % RH 0.51 % RH 0.56 % RH 0.77 % RH	Rotronic HC2-SH

Parameter/Equipment	Range	CMC ² ($\pm$)	Comments
Dew Point	(100 to -65) °C	0.35 °C	Edge tech 1500
Environmental Chambers, Ovens, Furnaces, Freezers, Temperature Baths & Dry Wells	(-80 to 1000) °C	2.0 °C	Type K TCs & Vaisala RH probe

XII. Time & Frequency

Parameter/Equipment	Range	CMC ^{2, 8} ($\pm$)	Comments
Frequency –Measuring Equipment	10 MHz Reference Signal	2.0 parts in 10^{10} Hz	Datum 9390-6000 w/ GPS
Frequency – Measure	1 MHz to 40 GHz	9.3 parts in 10^9 Hz 1.4 part in 10^7 Hz	10 MHz signal from Datum 9390- 6000 w/GPS to: 53131 counter 53152A counter
Stopwatches	Up to 24 hrs	0.048 s/day	Timometer 4500



SCOPE OF ACCREDITATION TO ISO/IEC 17025:2017
& ANSI/NCSL Z540-1-1994 & ANSI/NCSL Z540-3-2006

MICRO QUALITY CALIBRATION LLC A TRUMETRIC FAMILY
5770 Warland Drive Suite A
Cypress, CA 90630
Sean Jaimerena Phone: 526-989-2366

CALIBRATION

Valid To: November 30, 2026

Certificate Number: 2348.01

In recognition of the successful completion of the A2LA evaluation process (including an assessment of the organization's compliance with A2LA's – R205 Calibration Program Requirements), accreditation is granted to this laboratory at the location listed above to perform the following calibrations^{1, 7, 10}

I. Acoustical

Parameter/Equipment	Range	CMC ² (±)	Comments
Sound Level Meters ³ – 125 Hz to 4000 Hz	114 dB 104 dB 94 dB 84 dB 74 dB	0.26 dB 0.38 dB 0.39 dB 0.48 dB 0.86 dB	IET Labs 1986 omnical sound level calibrator

II. Chemical

Parameter/Equipment	Range	CMC ^{2, 5, 8} (±)	Comments
Conductivity – Liquid Measuring Equipment ³	84 µS/cm 1413 µS/cm 12 880 µS/cm	0.8 µs/cm 4.0 µs/cm 50 µs/cm	Laboratory standard conductivity solution
Conductivity – Metal Measuring Equipment ³	9.33 % IACS 14.92 % IACS 25.80 % IACS 32.56 % IACS 44.92 % IACS 59.42 % IACS 100.97 % IACS	0.2 % IACS 0.35 % IACS 0.31 % IACS 0.38 % IACS 0.37 % IACS 0.47 % IACS 1.5 % IACS	Metal conductivity standards
Metal Conductivity Standards	Up to 102 % IACS	0.013 % + 0.2 % IACS	Conductivity meter
pH – Measuring Equipment ³	4 pH 7 pH 10 pH	0.01 pH 0.01 pH 0.01 pH	Buffer solutions

III. Dimensional

Parameter/Equipment	Range	CMC ^{2, 6} ($\pm$)	Comments
Angle Blocks	Up to 90°	0.0015°	Angle blocks
Angle Gages	Up to 120°	0.0058°	Video measuring system
Bore Gages/Intramics	(0.150 to 1.000) in (3.810 to 25.400) mm (1.000 to 2.000) in (25.4025 to 50.800) mm (2.000 to 3.000) in (50.8025 to 76.200) mm (3.000 to 4.000) in (76.2025 to 101.600) mm (4.000 to 5.000) in (101.6025 to 127.000) mm (5.000 to 6.000) in (127.0025 to 152.40) mm (6.000 to 7.000) in (152.4025 to 177.800) mm	(4.2 + 1.4D) μ in (110 + 1.4D) nm (3.5 + 2.1D) μ in (89 + 2.1D) nm (3.1 + 2.3D) μ in (79 + 2.3D) nm (4 + 2D) μ in (100 + 2.0D) nm (12 + 6D) μ in (300 + 6.0D) nm (8 + 2D) μ in (200 + 2.0D) nm (8 + 2D) μ in (200 + 2.0D) nm	LabMaster™, gage blocks, cylindrical rings
Calipers ³	Up to 6 in Up to 150 mm (6.0005 to 12) in (150.001 to 300) mm (12.0005 to 18) in (300.001 to 450) mm (18.0005 to 24) in (450.001 to 600) mm (24.0005 to 36) in (600.001 to 900) mm (36.0005 to 48) in (900.001 to 1200) mm (48.0005 to 60) in (1200.001 to 1500) mm (60.005 to 72) in (1500.001 to 1830) mm	(3.7 + 3.6L) μ in (94 + 3.6L) nm (3 + 4L) μ in (76 + 4L) nm (5 + 4.5L) μ in 4.5L nm + 0.13 μ m (20 + 5L) μ in 5.0L nm + 0.51 μ m (15 + 4.6L) μ in 4.6L nm + 0.38 μ m (11 + 4.2L) μ in 4.2L nm + 0.28 μ m (70 + 2.5L) μ in 2.5 nm + 1.8 μ m (270 + 7.5L) μ in 7.5L nm + 6.9 μ m	Gage blocks

Parameter/Equipment	Range	CMC ^{2, 6} ($\pm$)	Comments
Chamfer & Countersink Gages	Up to 3 in Up to 76.2 mm	$(170 + 110D) \mu\text{in}$ $4.3 \mu\text{m} + 110D \text{ nm}$	Chamfer rings
Coating Thickness	Up to 0.060 in thick	$0.022 + 0.0035L$ mils	Comparison to master films
Concentricity Gage	Up to 0.050 in	$8 \mu\text{in}$	LVDT with amplifier master cylinder
Crimpers	Up to 12 in Up to 304.8 mm (0.011 to 0.060) in (0.061 to 0.250) in (0.251 to 0.500) in	$(80 + 3.2L) \mu\text{in}$ $(2.03 + 3.25L) \mu\text{m}$ $(140 + 200L) \mu\text{in}$ $(140 + 160L) \mu\text{in}$ $(130 + 80L) \mu\text{in}$	Video measuring system Pin gages
Depth Measuring Instruments, Gages & Micrometers ³	Up to 6 in Up to 150.0 mm (6.000 to 12) in (150.001 to 300) mm (12.000 to 18) in (300.001 to 450) mm (18.000 to 24) in (450.001 to 600) mm	$(12 + 1.3L) \mu\text{in}$ $1.3L \text{ nm} + 0.30 \mu\text{m}$ $(20 + 2.5L) \mu\text{in}$ $2.5L \text{ nm} + 0.51 \mu\text{m}$ $(14 + 5L) \mu\text{in}$ $5L \text{ nm} + 0.36 \mu\text{m}$ $(15 + 4.8L) \mu\text{in}$ $4.8L \text{ nm} + 0.38 \mu\text{m}$	Gage blocks, surface plate
Flatness ³ – Anvils, Spindles, Gage Stands & Gage Blocks	Up to 3 in diameter Up to 76.2 mm diameter	$2.8 \mu\text{in}$ $0.071 \mu\text{m}$	Comparison to master optical flat under monochromatic light source
Gage Block – Length	(0.01 to 0.21) in (0.031 25 to 4) in 2 in 3 in 4 in (5 to 20) in (125 to 500) mm	$4.7 \mu\text{in}$ $(2.5 + 1.7L) \mu\text{in}$ $5.7 \mu\text{in}$ $7.2 \mu\text{in}$ $8.9 \mu\text{in}$ $(8.8 + 1.2L) \mu\text{in}$ $1.2L \text{ nm} + 0.22 \mu\text{m}$	Gage blocks, gage block comparator LabMaster™ 175

Parameter/Equipment	Range	CMC ^{2, 6} (±)	Comments
Gage Block – Parallelism	Up to 4 in Up to 100 mm (5 to 20) in (125 to 500) mm	2.7 µin 0.069 µm 1.6 µin 0.04 µm	Gage block Comparator LabMaster™ 175
Glass Scale / Stage Micrometer	Up to 12 in Up to 304.8 mm	(80 + 3.2L) µin (2.0 + 3.2L) nm	Video measuring system
Height Gages ³ – Dial, Digital & Vernier	Up to 12 in Up to 300 mm (12.000 to 18) in (300.001 to 450) mm (18.000 to 24) in (450.001 to 600) mm (24.000 to 36) in (600.001 to 900) mm (36.000 to 48) in (900.001 to 1200) mm (48.000 to 60) in (1200.001 to 1500) mm	(17 + 3L) µin 3L nm + 0.43 µm (35 + 3.5L) µin 3.5L nm + 0.86 µm (21 + 6.3L) µin 6.3L nm + 0.53 µm (41 + 3.3L) µin 3.3L nm + 1.0 µm (30 + 5L) µin 5.0L nm + 0.76 µm (60 + 2.5L) µin 2.5L nm + 1.5 µm	Gage blocks surface plate
High Accuracy Height Gages	Up to 12 in Up to 300 mm (12.000 1 to 18) in (300.001 to 450) mm (18.000 1 to 24) in 450.000 1 to 609.6) mm	(23 + 1.7L) µin 0.17L nm + 0.58 µm (8 + 2L) µin 2.0L nm + 0.20 µm (14 + 1.8L) µin 1.8L nm + 0.36 µm	Gage blocks, surface plate
Indicators ³ – Digital, Dial, Bore Gages With Removable Indicator	Up to 4 in Up to 101.6 mm	(6.8 + 2.6L) µin (170 + 2.6L) nm	Gage blocks

Parameter/Equipment	Range	CMC ² (±)	Comments
Indicators Test ³ –	Up to 0.05 in Up to 1.25 mm	15 µin 0.38 µm	Calibration tester, gage blocks
Cylindrical Gages, Protusion Gages & Washer Rings			
Inside Measurements	(0.040 to 0.125) in (1.015 to 3.175) mm	4.4 µin 0.11 µm	LMU-175, gage blocks
	(0.125 to 0.250) in (3.175 to 6.350) mm	4.5 µin 0.14 µm	
	(0.250 to 1.000) in (6.350 to 25.400) mm	5.2 µin 0.13 µm	
	(1.000 to 2.000) in (50.8025 to 76.2000) mm	5.5 µin 0.14 µm	
	(2.0001 to 3.0000) in (50.8025 to 76.2000) mm	5.5 µin 0.14 µm	
	(3.0001 to 4.0000) in (76.2025 to 101.6000) mm	5.5 µin 0.14 µm	
	(4.0001 to 5.0000) in (101.6025 to 127.0000) mm	6.2 µin 0.16 µm	
	(5.0001 to 6.0000) in (127.0025 to 152.4000) mm	6.6 µin 0.17 µm	
	(6.0001 to 7.0000) in (152.4025 to 177.8000) mm	8.8 µin 0.22 µm	
	(7.0001 to 8.0000) in (177.8025 to 203.2000) mm	9.2 µin 0.23 µm	
	(8.0001 to 9.0000) in (203.2025 to 228.6000) mm	9.2 µin 0.23 µm	
	(9.0001 to 10.0000) in (228.6025 to 254.0000) mm	9.2 µin 0.23 µm	
	(10.0001 to 11.0000) in (254.0025 to 279.4000) mm	10 µin 0.25 µm	
	(11.0001 to 12.0000) in (279.4025 to 304.8000) mm	13 µin 0.33 µm	



Parameter/Equipment	Range	CMC ^{2, 6} (±)	Comments
Inside / Outside Measurement			
Non-Contact	Up to 12 in Up to 304.8 mm	$(80 + 3.2L) \mu\text{in}$ $(2.0 + 3.2L) \mu\text{m}$	Video measuring system
Inspection Fixtures			
Parallelism	Up to 72 in Up to 1825 mm	$(37 + 0.4L) \mu\text{in}$ $(0.94 + 0.4L) \text{nm}$	Surface plate, LVDT with amplifier
Perpendicularity / Squareness	Up to 24 in Up to 455 mm	$(37 + 66L) \mu\text{in}$ $(0.94 + 5.5L) \text{nm}$	Surface plate, granite square, LVDT with amplifier
V-Groove Parallelism	Up to 12 in Up to 305 mm	$(37 + 7L) \mu\text{in}$ $(0.94 + 7L) \text{nm}$	Surface plate, master cylinders, LVDT
Laser Micrometer ³	(0.05 to 1.00) in (1.27 to 25.4) mm	$(4.1 + 31L) \mu\text{in}$ $(100 + 31L) \text{nm}$	Master cylinders
Step Height Parallelism	Up to 5000 μin	8.5 μin	LVDT w/ amplifier
Levels	Up to 18 in Up to 455 mm	$(6.4 + 5.6L) \mu\text{in}$ $(160 + 5.6L) \text{nm}$	Gage blocks & surface plate
Micrometers ³			
Inside	Up to 6 in Up to 150 mm (6.0001 to 12) in (150.001 to 300) mm (12.0001 to 32) in (300.001 to 800) mm (32.001 to 60) in (800.001 to 1525) mm	$(7.4 + 2.6L) \mu\text{in}$ $(190 + 2.6L) \text{nm}$ $(13 + 3.2L) \mu\text{in}$ $3.2L \text{nm} + 0.33 \mu\text{m}$ $(21 + 2.8L) \mu\text{in}$ $2.8L \text{nm} + 0.53 \mu\text{m}$ $(27 + 2.9L) \mu\text{in}$ $2.9L \text{nm} + 0.69 \mu\text{m}$	Gage blocks

Parameter/Equipment	Range	CMC ^{2, 6} (±)	Comments
Micrometers ³ (cont)			
Outside	Up to 6 in Up to 150 mm (6.0001 to 12) in (150.001 to 300) mm (12.0001 to 18) in (300.001 to 450) mm (18.0001 to 24) in (450.001 to 600) mm (24.0001 to 30) in (600.001 to 750) mm (30.0001 to 36) in (750.001 to 900) mm (36.0001 to 42) in (900.001 to 1050) mm (42.0001 to 48) in (1050.001 to 1200) mm (48.0001 to 54) in (1200.001 to 1375) mm (54.0001 to 60) in (1375.001 to 1525) mm	(18 + 0.26L) μin (460 + 0.26L) nm (19 + 1L) μin (480 + 1.0L) nm (28 + 0.67L) μin (710 + 0.67L) nm (20 + 3.3L) μin 3.3L nm + 0.51 μm (52 + 0.17L) μin 0.17L nm + 1.3 μm (49 + 2.5L) μin 2.5L nm + 1.2 μm (97 + 3.5L) μin 3.5L nm + 2.5 μm (89 + 2.8L) μin 2.8L nm + 2.3 μm (76 + 2.2L) μin 2.2L nm + 1.8 μm (110 + 2.7L) μin 2.7L nm + 2.8 μm	Gage blocks
Length/Height – Ranged Caliper Checkers Check Master Depth Mic Master Height Master Mic Master Micrometer Standards Rise Blocks Standard Reference Bars	Up to 6 in Up to 155 mm (6.0001 to 12) in (150.001 to 300) mm (12.0001 to 18) in (300.001 to 450) mm (18.0001 to 24) in (450.001 to 600) mm (24.0001 to 36) in (600.001 to 900) mm (36.0001 to 48) in (900.001 to 1200) mm (48.0001 to 60) in (1200.001 to 1500) mm	(12 + 0.2L) μin 0.20L nm + 0.30 μm (12 + 0.33L) μin 0.33L nm + 0.30 μm (17 + 0.33L) μin 0.33L nm + 0.43 μm (14 + 0.67L) μin 0.67L nm + 0.36 μm (19 + 0.58L) μin 0.58L nm + 0.48 μm (21 + 0.17L) μin 0.17L nm + 0.53 μm (22 + 0.17L) μin 0.17L nm + 0.56 μm	Surface plate, gage blocks & LVDT with amplifier
Mu-Checker/Gage Amplifier & Probe ³	Up to 0.05 in Up to 1.25 mm	5 μin 120 nm	Gage blocks

Parameter/Equipment	Range	CMC ^{2, 5, 6} (±)	Comments
Microscope ³			
Linearity X Y	Up to 4 in Up to 101.6 mm	$(8.8 + 1.5L) \mu\text{in}$ $(220 + 1.5L) \text{nm}$	Gage blocks
Angle	(0 to 90) °	0.012°	Angle blocks
Optical Comparator ³ – Stage Movement			
Angularity X Y	(0.5 to 12) in (12.7 to 304.8) mm	$(37 + 12L) \mu\text{in}$ $(940 + 12L) \text{nm}$	Gage blocks
Squareness X Y	(0 to 360)° (12 in of X axis travel maximum, Y axis travel maximum less than 12 in)	0.0013°	True square
Magnification X Y	10X, 20X, 31.25X, 50X, 62.5X, 100X	0.08 %	Gage blocks, glass scales
Optical Flats	Up to 3 in diameter Up to 76.2 mm diameter	2.8 μin 0.071 μm	Comparison to master optical flat
Optical Parallels			
Flatness	Up to 3 in diameter Up to 76.2 mm dia	2.8 μin 0.071 μm	Comparison to master optical flat
Parallelism	Up to 3 in diameter Up to 76.2 mm dia	0.75 μin 0.019 μm	
Protractors ³	Up to 90°	0.023°	Master angle blocks
Radius Length	Up to 6 in Up to 152.4 mm	$(80 + 3.2L) \mu\text{in}$ $3.2L \text{nm} + 2.0 \mu\text{m}$	Video measuring system

Parameter/Equipment	Range	CMC ^{2, 6} (±)	Comments
Outside Measurements Cylindrical Plug Gages, Deltronic Pin Gages, Discs, Master Cylinders, Spheres (Diameter)	Up to 1.0000 in Up to 25.4000 mm (1.0001 to 2.0000) in (25.4025 to 50.8000) mm (2.0001 to 3.0000) in (50.8025 to 76.2000) mm (3.0001 to 4.0000) in (76.2025 to 101.6000) mm (4.0001 to 5.0000) in (101.6025 to 127.0000) mm (5.0001 to 6.0000) in (127.0025 to 152.4000) mm (6.0001 to 7.0000) in (152.4025 to 177.8000) mm (7.0001 to 8.0000) in (177.8025 to 203.2000) mm (8.0001 to 9.0000) in (203.2025 to 228.6000) mm (9.0001 to 10.0000) in (228.6025 to 254.0000) mm	6.0 µin 0.15 µm 6.3 µin 0.16 µm 6.3 µin 0.16 µm 6.3 µin 0.16 µm 6.9 µin 0.18 µm 7.2 µin 0.18 µm 9.5 µin 0.24 µm 9.5 µin 0.24 µm 9.5 µin 0.24 µm 9.5 µin 0.24 µm	LMU-175, gage blocks
Rulers & Tape	Up to 12 in Up to 304.8 mm (12 to 300) in (304.0 to 365.7) mm	(80 + 3.2L) µin 3.2L nm + 2.0 µm (1100 + 8.3L) µin 8.3L nm + 28 µm	Video measuring system Gage blocks

Parameter/Equipment	Range	CMC ^{2, 6} ($\pm$)	Comments
Sine Bars/Plates	Up to 5 in Up to 127 mm	$(23 + 20L) \mu\text{in}$ $20L \text{ nm} + 0.58 \mu\text{m}$	Squares, angle blocks LVDT w/ amplifier, gage blocks
Surface Plates ³			
Flatness	Up to 12 in Up to 300 mm	$20 \mu\text{in}$ $0.51 \mu\text{m}$	LVDT with amplifier
	(12 to 120) in (300 to 3050) mm	$21 \mu\text{in}$ $0.54 \mu\text{m}$	Auto collimator
Repeatability	0.002 in 0.05 mm	$25 \mu\text{in}$ $0.64 \mu\text{m}$	Repeat-o-meter
Surface Roughness – Profilometer	$118.6 \mu\text{in Ra}$ $2.96 \mu\text{m Ra}$ $40 \mu\text{in Ra}$ $1.02 \mu\text{m Ra}$ $20 \mu\text{in Ra}$ $0.508 \mu\text{m Ra}$ $15.9 \mu\text{in Ra}$ $0.378 \mu\text{m Ra}$	$1 \mu\text{in}$ $0.03 \mu\text{m}$ $2.5 \mu\text{in}$ $0.064 \mu\text{m}$ $1.2 \mu\text{in}$ $0.031 \mu\text{m}$ $1 \mu\text{in}$ $0.03 \mu\text{m}$	Roughness specimen
Surface Roughness Patch / Specimens	$(2 \text{ to } 500) \mu\text{in Ra}$ $(0.0508 \text{ to } 127) \mu\text{m Ra}$	$9.2 \text{ nin}/\mu\text{in} + 0.92 \mu\text{in}$ $0.23 \text{ nm}/\mu\text{m} + 0.023 \mu\text{m}$	Profilometer w/ specimens
Tapered Thread Plug			
Major Diameter	Up to 6 in Up to 150 mm	$(100 + 1.3D) \mu\text{in}$ $1.3D \text{ nm} + 2.6 \mu\text{m}$	LabMaster™ 175, thread wires
Pitch Diameter	Up to 6 in Up to 150 mm	$(110 + 1.3D) \mu\text{in}$ $1.3D \text{ nm} + 2.8 \mu\text{m}$	
Tapered Thread Ring - Thickness / Step Height	Up to 6 in Up to 150 mm	$(3.1 + 1.3D) \mu\text{in}$ $1.3D \text{ nm} + 0.13 \mu\text{m}$	Gage blocks, master taper plugs, LabMaster™

Parameter/Equipment	Range	CMC ^{2, 6} ($\pm$)	Comments
Thread Plug Major Diameter Pitch Diameter (127 to 4) TPI (0.35 to 2.50) mm	Up to 10 in Up to 254 mm Up to 10 in Up to 254 mm	$(5.6 + 1.2D) \mu\text{in}$ $1.2D \text{ nm} + 0.14 \mu\text{m}$ $(29 + 1.2D) \mu\text{in}$ $1.2D \text{ nm} + 0.74 \mu\text{m}$	LabMaster™ 175, gage blocks, thread wires
Thread Rings Pitch Diameter Taper	Up to 4.5000 in Up to 115.000 mm Up to 6 in Up to 150 mm	$(29 + 1.3D) \mu\text{in}$ $1.3D \text{ nm} + 0.74 \mu\text{m}$ $(110 + 1.3D) \mu\text{in}$ $1.3D \text{ nm} + 2.8 \mu\text{m}$	Setting plug gages Gage blocks, master taper plugs, LabMaster™ 175
Thread & Gear Wires	Up to 1.0000 in Dia Up to 25.400 mm Dia	$7.9 \mu\text{in}$ $0.22 \mu\text{m}$	LabMaster™ 175, gage blocks, master cylinders
Video Measuring System Keyence ³	Up to 12 in	$(6.6 + 16L) \mu\text{in}$	Master cylinders

IV. Electrical – DC/Low Frequency

Parameter/Equipment	Frequency	CMC ^{2, 4} ($\pm$)	Comments
AC Current – Generate ³			
Up to 220 μ A	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	700 μ A/A + 25 nA 350 μ A/A + 20 nA 140 μ A/A + 16 nA 600 μ A/A + 40 nA 1.6 mA/A + 80 nA	Fluke 5700A, Fluke 5725A
220 μ A to 2.02 mA	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	700 μ A/A + 40 nA 350 μ A/A + 35 nA 140 μ A/A + 35 nA 600 μ A/A + 400 nA 1.6 mA/A + 800 nA	
(2.2 to 22) mA	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	700 μ A/A + 400 nA 350 μ A/A + 350 nA 140 μ A/A + 350 nA 600 μ A/A + 4 μ A 1.6 mA/A + 8 μ A	
(22 to 220) mA	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	700 μ A/A + 4 μ A 350 μ A/A + 3.5 μ A 140 μ A/A + 3.5 μ A 600 μ A/A + 40 μ A 1.6 mA/A + 80 μ A	
220 mA to 2.2 A	20 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	650 μ A/A + 35 μ A 750 μ A/A + 80 μ A 8.5 mA/A + 160 μ A	
(2.2 to 11) A	40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	460 μ A/A + 170 μ A 950 μ A/A + 380 μ A 3.6 mA/A + 760 μ A	
(29 to 330) μ A	(10 to 20) Hz (20 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz	0.44 nA/A + 160 nA 0.22 nA/A + 98 nA 0.16 nA/A + 49 nA 1.1 nA/A + 18 nA 0.99 nA/A + 43 nA 9.5 nA/A + 220 nA	Fluke 5522A
330 μ A to 3.3 mA	10 to 20) Hz (20 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz	3.4 μ A/A + 0.31 μ A 2.5 μ A/A + 0.27 μ A 0.14 μ A/A + 54 nA 0.14 μ A/A + 46 nA 0.77 μ A/A + 140 nA 0.44 μ A/A + 1.1 μ A	

Parameter/Equipment	Frequency	CMC ^{2, 4} (±)	Comments
AC Current – Generate ³ (cont)			Fluke 5522A
(3.3 to 33) mA	10 to 20) Hz (20 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz	0.81 µA/A + 2.3 µA 0.3 µA/A + 4 µA 90 nA/A + 330 nA 90 nA/A + 330 nA 210 nA/A + 1 µA 74 nA/A + 9.8 µA	
(33 to 330) mA	10 to 20) Hz (20 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz	0.71 µA/A + 27 µA 47 nA/A + 48 µA 98 nA/A + 2.8 µA 160 nA/A + 0.82 µA 190 nA/A + 9.7 µA 0.44 µA/A + 66 µA	
(330 mA to 1.1 A	(10 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.79 mA/A + 0.45 mA 61 µA/A + 54 µA 1.6 mA/A + 0.45 mA 5.1 mA/A + 0.017 mA	
(1.1 to 3) A	(10 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	37 µA/A + 0.65 mA 270 µA/A + 180 µA 0.57 mA/A + 0.51 mA 6.2 mA/A + 5.5 mA	
(3 to 11) A	(45 to 100) Hz 100 Hz to 1 kHz (1 to 5) kHz	0.17 mA/A + 3.5 mA 0.29 mA/A + 0.16 mA 22 mA/A + 72 mA	
(11 to 20.5) A	(45 to 100) Hz 100 to 1 kHz (1 to 5) kHz	0.64 mA/A + 4.2 mA 0.82 mA/A + 6.4 mA 29 mA/A + 310 mA	
Clamp Meters (20 to 150) A (150 to 1050) A	(50 to 400) Hz (50 to 400) Hz	0.057 % + 0.14 A 0.026 % + 0.45 A	Fluke 5522A/ with 5500A COIL
AC Current – Measure ³			
Up to 100 µA	(10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz	4 mA/A + 30 nA 1.5 mA/A + 30 nA 600 µA/A + 30 nA 600 µA/A + 30 nA	Keysight 3458A, option 002

Parameter/Equipment	Frequency	CMC ^{2, 4} ($\pm$)	Comments
AC Current – Measure ³ (cont)			
100 μ A to 1 mA	(10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz (5 to 20) kHz (20 to 50) kHz (50 to 100) kHz	4 mA/A + 200 nA 1.5 mA/A + 200 nA 600 μ A/A + 200 nA 300 μ A/A + 200 nA 600 μ A/A + 200 nA 4 mA/A + 400 nA 5.5 mA/A + 1.5 μ A	Keysight 3458A, option 002
(1 to 10) mA	(10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz (5 to 20) kHz (20 to 50) kHz (50 to 100) kHz	4 mA/A + 2 μ A 1.5 mA/A + 2 μ A 600 μ A/A + 2 μ A 300 μ A/A + 2 μ A 600 μ A/A + 2 μ A 4 mA/A + 4 μ A 5.5 mA/A + 15 μ A	
(10 to 100) mA	(10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz (5 to 20) kHz (20 to 50) kHz (50 to 100) kHz	4 mA/A + 20 μ A 1.5 mA/A + 20 μ A 600 μ A/A + 20 μ A 300 μ A/A + 20 μ A 600 μ A/A + 20 μ A 4 mA/A + 40 μ A 5.5 mA/A + 150 μ A	
100 mA to 1 A	(10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz (5 to 20) kHz (20 to 50) kHz	4 mA/A + 200 μ A 1.6 mA/A + 200 μ A 800 μ A/A + 200 μ A 1 mA/A + 200 μ A 3 mA/A + 200 μ A 10 mA/A + 400 μ A	
(1 to 3) A	3 Hz to 5 kHz (5 to 10) kHz	20 μ A/A + 0.1 mA 0.9 mA/A + 0.2 mA	Keysight 34465A
(3 to 10) A	33 Hz to 5 kHz (5 to 10) kHz	0.43 mA/A + 0.72 mA 0.2 mA/A + 1.6 mA	
(1 to 50) A	10 Hz to 1 kHz	0.59 mA/A + 2 mA	Keysight 34465A current shunt
(1 to 100) A	10 Hz to 1 kHz	0.42 mA/A + 0.27 mA	



Parameter/Equipment	Frequency	CMC ^{2, 4} (±)	Comments
AC Voltage – Generate ³			
Up to 2.2 mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (500 to 1000) kHz	550 μ V/V + 4.5 μ V 210 μ V/V + 4.5 μ V 110 μ V/V + 4.5 μ V 370 μ V/V + 4.5 μ V 850 μ V/V + 7 μ V 1.1 mV/V + 13 μ V 1.7 mV/V + 25 μ V 3.4 mV/V + 25 μ V	Fluke 5700A with 5725A
(2.2 to 22) mV	10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (500 to 1000) kHz	550 μ V/V + 5 μ V 210 μ V/V + 5 μ V 105 μ V/V + 5 μ V 370 μ V/V + 5 μ V 850 μ V/V + 7 μ V 1.1 mV/V + 12 μ V 1.7 mV/V + 25 μ V 3.4 mV/V + 25 μ V	
(22 to 220) mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (500 to 1000) kHz	550 μ V/V + 13 μ V 210 μ V/V + 8 μ V 105 μ V/V + 8 μ V 370 μ V/V + 8 μ V 850 μ V/V + 25 μ V 1.1 mV/V + 25 μ V 1.7 mV/V + 35 μ V 3.4 mV/V + 80 μ V	
220 mV to 2.2 V	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (500 to 1000) kHz	500 μ V/V + 80 μ V 160 μ V/V + 25 μ V 75 μ V/V + 6 μ V 120 μ V/V + 16 μ V 250 μ V/V + 70 μ V 430 μ V/V + 130 μ V 1.1 mV/V + 350 μ V 2.2 mV/V + 850 μ V	
(2.2 to 22) V	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (500 to 1000) kHz	500 μ V/V + 800 μ V 160 μ V/V + 250 μ V 75 μ V/V + 60 μ V 120 μ V/V + 160 μ V 250 μ V/V + 350 μ V 500 μ V/V + 1.5 mV 1.3 mV/V + 4.3 mV 2.7 mV/V + 85 mV	



Parameter/Equipment	Frequency	CMC ^{2, 4} (±)	Comments
AC Voltage – Generate ³ (cont)			
(22 to 220) V	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (500 to 1000) kHz	500 $\mu\text{V/V} + 8 \text{ mV}$ 160 $\mu\text{V/V} + 2.5 \text{ mV}$ 80 $\mu\text{V/V} + 0.8 \text{ mV}$ 220 $\mu\text{V/V} + 3.5 \text{ mV}$ 500 $\mu\text{V/V} + 8 \text{ mV}$ 1.5 $\text{mV/V} + 90 \text{ mV}$ 4.7 $\text{mV/V} + 90 \text{ mV}$ 12 $\text{mV/V} + 190 \text{ mV}$	Fluke 5700A with 5725A
(220 to 750) V	30 to 50) kHz (50 to 100) kHz	600 $\mu\text{V/V} + 11 \text{ mV}$ 2.3 $\text{mV/V} + 45 \text{ mV}$	
(220 to 1100) V	(15 to 50) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 30) kHz	400 $\mu\text{V/V} + 16 \text{ mV}$ 90 $\mu\text{V/V} + 4 \text{ mV}$ 170 $\mu\text{V/V} + 6 \text{ mV}$ 600 $\mu\text{V/V} + 11 \text{ mV}$	Fluke 5522A
(33 to 330) V	45 Hz to 1 kHz (1 to 10) kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz	160 $\mu\text{V/V} + 0.82 \text{ mV}$ 140 $\mu\text{V/V} + 3.9 \text{ mV}$ 230 $\mu\text{V/V} + 0.91 \text{ mV}$ 350 $\mu\text{V/V} + 27 \text{ mV}$ 1.1 $\text{mV/V} + 30 \text{ mV}$	
(330 to 1020) V	45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	66 $\mu\text{V/V} + 11 \text{ mV}$ 67 $\mu\text{V/V} + 3.1 \text{ mV}$ 91 $\mu\text{V/V} + 6 \text{ mV}$	
AC Voltage – Measure ³			Keysight 3458A
Up to 10 mV	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz 100 kHz to 1 MHz	300 $\mu\text{V/V} + 3 \mu\text{V}$ 200 $\mu\text{V/V} + 1.1 \mu\text{V}$ 300 $\mu\text{V/V} + 1.1 \mu\text{V}$ 1 $\text{mV/V} + 1.1 \mu\text{V}$ 5 $\text{mV/V} + 1.1 \mu\text{V}$ 40 $\text{mV/V} + 2 \mu\text{V}$ 12 $\text{mV/V} + 5 \mu\text{V}$	AC Band $\leq 2 \text{ MHz}$
Up to 10 mV	(1 to 4) MHz (4 to 8) MHz	70 $\text{mV/V} + 7 \mu\text{V}$ 200 $\text{mV/V} + 8 \mu\text{V}$	AC Band $> 2 \text{ MHz}$

Parameter/Equipment	Frequency	CMC ^{2, 4} (±)	Comments
AC Voltage – Measure ³ (cont)			
(10 to 100) mV	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz (1 to 2) MHz 100 kHz to 1 MHz (1 to 4) MHz (4 to 8) MHz (8 to 10) MHz	70 $\mu\text{V/V} + 4 \mu\text{V}$ 70 $\mu\text{V/V} + 2 \mu\text{V}$ 140 $\mu\text{V/V} + 2 \mu\text{V}$ 300 $\mu\text{V/V} + 2 \mu\text{V}$ 800 $\mu\text{V/V} + 2 \mu\text{V}$ 3 mV/V + 10 μV 10 mV/V + 10 μV 15 mV/V + 10 μV 20 mV/V + 50 μV 40 mV/V + 70 μV 40 mV/V + 80 μV 150 mV/V + 100 μV	Keysight 3458A AC Band ≤ 2 MHz Keysight 3458A AC Band > 2 MHz
100 mV to 1 V	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz (1 to 2) MHz 100kHz to 1 MHz (1 to 4) MHz (4 to 8) MHz (8 to 10) MHz	70 $\mu\text{V/V} + 40 \mu\text{V}$ 70 $\mu\text{V/V} + 20 \mu\text{V}$ 140 $\mu\text{V/V} + 20 \mu\text{V}$ 300 $\mu\text{V/V} + 20 \mu\text{V}$ 800 $\mu\text{V/V} + 20 \mu\text{V}$ 3 mV/V + 100 μV 10 mV/V + 100 μV 15 mV/V + 100 μV 20 mV/V + 500 μV 40 mV/V + 700 μV 40 mV/V + 800 μV 150 mV/V + 1mV	Keysight 3458A AC Band ≤ 2 MHz Keysight 3458A AC Band > 2 MHz
(1 to 10) V	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz (1 to 2) MHz 300 kHz to 1 MHz (2 to 4) MHz (4 to 8) MHz (8 to 10) MHz	70 $\mu\text{V/V} + 400 \mu\text{V}$ 70 $\mu\text{V/V} + 200 \mu\text{V}$ 140 $\mu\text{V/V} + 200 \mu\text{V}$ 300 $\mu\text{V/V} + 200 \mu\text{V}$ 800 $\mu\text{V/V} + 200 \mu\text{V}$ 3 mV/V + 1 mV 10 mV/V + 1 mV 15 mV/V + 1 mV 20 mV/V + 5 mV 40 mV/V + 7 mV 40 mV/V + 8 mV 150 mV/V + 10 mV	Keysight 3458A AC Band ≤ 2 MHz Keysight 3458A AC Band > 2 MHz
(10 to 100) V	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz	200 $\mu\text{V/V} + 4 \text{ mV}$ 200 $\mu\text{V/V} + 2 \text{ mV}$ 200 $\mu\text{V/V} + 2 \text{ mV}$ 350 $\mu\text{V/V} + 2 \text{ mV}$ 1.2 mV/V + 2 mV 4 mV/V + 10 mV 15 mV/V + 10 mV	Keysight 3458A AC Band ≤ 2 MHz
(100 to 1000) V	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz	400 $\mu\text{V/V} + 40 \text{ mV}$ 400 $\mu\text{V/V} + 20 \text{ mV}$ 600 $\mu\text{V/V} + 20 \text{ mV}$ 1.2 mV/V + 20 mV 3 mV/V + 20 mV	



Parameter/Equipment	Frequency	CMC ^{2, 4} (±)	Comments
AC Voltage – Measure ³ (cont) (100 to 1000) V (1000 to 50 000) V	50 Hz to 400 Hz 50 Hz to 400 Hz	820 μ V/V + 480 mV 0.72 mV/V + 170 mV	Vitrek 4700 Vitrek HVL-70
Capacitance – Generate ³ (220 to 399.9) pF (0.4 to 1.0999) nF (1.1 to 3.2999) nF (3.3 to 10.9999) nF (11 to 32.9999) nF (33 to 109.999) nF (110 to 329.999) nF (0.33 to 1.099 99) μ F (1.1 to 3.299 99) μ F (3.3 to 10.9999) μ F (11 to 32.9999) μ F (33 to 109.999) μ F (110 to 329.999) μ F (0.33 to 1.0999) mF (1.1 to 3.299 99) mF (3.3 to 10.9999) mF (11 to 32.9999) mF (33 to 110) mF	10 Hz to 10 kHz 10 Hz to 10 kHz 10 Hz to 3 kHz 10 Hz to 1 kHz 10 Hz to 1 kHz 10 Hz to 1 kHz 10 Hz to 1 kHz 10 Hz to 1 kHz (10 to 600) Hz (10 to 300) Hz (10 to 150) Hz (10 to 120) Hz (10 to 80) Hz (0 to 50) Hz (0 to 20) Hz (0 to 6) Hz (0 to 2) Hz (0 to 0.6) Hz (0 to 0.2) Hz	0.12 % + 1.6 pF 0.19 pF/F + 2.2 pF 2.8 pF/F + 7.6 pF 1.3 pF/F + 11 pF 1.3 pF/F + 7.6 pF 1.8 pF/F + 6 pF 1.3 pF/F + 50 pF 1.8 nF/F + 0.04 nF 1.4 nF/F + 0.6 nF 2.1 nF/F + 4.7 nF 3 nF/F + 26 nF 2.8 nF/F + 86 nF 1.7 nF/F + 10 nF 1.7 μ F/F + 0.38 μ F 1.8 μ F/F + 0.52 μ F 2.1 μ F/F + 0.87 μ F 5.3 μ F/F + 49 μ F 1.9 μ F/F + 130 μ F	Fluke 5522A
Capacitance – Measure ³ 1 pF to 1 mF	20 Hz to 300 kHz	0.11 % + 3.6 fF	Keysight E4980AL

Parameter/Equipment	Range	CMC ^{2, 4} (±)	Comments
DC Current – Generate ³	Up to 220 μ A 220 μ A to 2.2 mA (2.2 to 22) mA (22 to 220) mA 220 mA to 2.2 A (2.2 to 11) A	50 μ A/A + 8 nA 50 μ A/A + 8 nA 50 μ A/A + 80 nA 60 μ A/A + 0.8 μ A 80 μ A/A + 25 μ A 360 μ A/A + 480 μ A	Fluke 5700A w/ 5725A

Parameter/Equipment	Range	CMC ^{2, 4} (±)	Comments
DC Current – Generate ³ (cont)	Up to 330 µA 330 µA to 3.3 mA (3.3 to 33) mA (33 to 330) mA 330 mA to 1.1 A (1.1 to 3) A (3 to 11) A (11 to 20.5) A	32 pA/A + 2.4 nA 47 nA/A + 24 nA 40 nA/A + 190 nA 35 nA/A + 1.4 µA 20 µA/A + 22 µA 66 µA/A + 34 µA 90 µA/A + 220 µA 270 µA/A + 1.2 mA	Fluke 5522A
Clamp Meters	(20 to 150) A (150 to 1050) A	0.26 % + 40 mA 0.25 % + 100 mA	Fluke 5522A/ with 5500A COIL
DC Current – Measure ³	Up to 100 nA 100 nA to 1 µA (1 to 10) µA (10 to 100) µA 100 µA to 1 mA (1 to 10) mA (10 to 100) mA 100 mA to 1 A (1 to 50) A (1 to 100) A (1 to 500) A (1 to 3) A (3 to 10) A (1 to 50) A (1 to 100) A (1 to 500) A	30 µA/A + 40 pA 20 µA/A + 40 pA 20 µA/A + 100 pA 20 µA/A + 800 pA 20 µA/A + 5 nA 20 µA/A + 50 nA 35 µA/A + 500 nA 110 µA/A + 10 µA 0.59 mA/A + 60 mA 0.42 mA/A + 42 mA 0.28 mA/A + 28 mA 390 µA/A + 190 µA 240 µA/A + 1.4 mA 0.59 mA/A + 62 mA 0.42 mA/A + 45 mA 0.28 mA/A + 31 mA	Keysight 3458A option 2 Keysight 3458A current shunts Keysight 34465A Keysight 34465A current shunts
DC Voltage – Generate ³	Up to 220 mV 220 mV to 2.2 V (2.2 to 11) V (11 to 22) V (22 to 220) V (220 to 1100) V Up to 330 mV 330 mV to 3.3 V (3.3 to 33) V (33 to 330) V (330 V to 1020) V	8 µV/V + 0.6 µV 7 µV/V + 1 µV 7 µV/V + 3.5 µV 7 µV/V + 6.5 µV 8 µV/V + 80 µV 9 µV/V + 500 µV 5.8 µV/V + 1.2 µV 4.5 µV/V + 5.3 µV 4.5 µV/V + 61 µV 3.3 µV/V + 720 µV 2.8 µV/V + 4.4 mV	Fluke 5700A Fluke 5522A

Parameter/Equipment	Range	CMC ^{2, 4} ($\pm$)	Comments
DC Voltage – Measure ³	Up to 100 mV 100 mV to 1 V (1 to 10) V (10 to 100) V (100 to 1000) V (100 to 10 000) V (1000 to 70 000)	5 μ V/V + 300 nV 4 μ V/V + 300 nV 4 μ V/V + 500 nV 6 μ V/V + 30 μ V 6 μ V/V + 100 μ V 160 μ V/V + 55 mV 0.22 mV/V + 5.7 V	Keysight 3458A, option 002 Vitrek 4700, Vitrek HVL-70
Inductance – Generate ³	100 mH	0.13 mH	Standard inductor
Oscilloscopes ³			Fluke 5522A/SC1100
AC Square Wave Signal Into 1 M Ω Into 50 Ω	1.0 mVpp to 130 Vpp 1.0 mVpp to 6.6 Vpp	0.1 % of output + 40 μ V 0.25 % of output + 40 μ V	
AC Square Wave Frequency	10 Hz to 10 kHz	2.5 μ Hz/Hz	
DC Signal Into 1 M Ω Into 50 Ω	Up to $\pm$ 130 V Up to $\pm$ 6.6 V	0.05 % of output + 40 μ V 0.25 % of output + 40 μ V	
Edge – Aberrations	Within 2 ns from 50 % of Rising Edge (2 to 5) ns (5 to 15) ns After 15 ns	<(3 % of output + 2 mV) <(2 % of output + 2 mV) <(1 % of output + 2 mV) <(0.5 % of output + 2 mV)	
Edge - Amplitude Range	5 mVpp to 2.5 Vpp	2 % of output + 200 μ V	
Edge - Frequency Range	1 kHz to 10 MHz	2.5 μ Hz/Hz	
Edge - Rise Time	24 ps to 350 ps	23 ps	
Level Sine Wave – Amplitude			
(5 mV to 5.5 V)	50 kHz Reference 50 kHz to 100 MHz (100 to 300) MHz (300 to 600) MHz	2.0 % of output + 0.3 mV 3.5 % of output + 0.3 mV 4.0 % of output + 0.3 mV 6.0 % of output + 0.3 mV	
(5 mV to 3.5 V)	(600 to 1100) MHz	7.0 % of output + 0.3 mV	



Parameter/Equipment	Range	CMC ^{2, 4} (±)	Comments
Oscilloscopes ³ (cont)			
Level Sine Wave – Flatness			
(5 mV to 5.5 V)	50 kHz to 100 MHz (100 to 300) MHz (300 to 600) MHz	1.5 % + 100 µV 2 % + 100 µV 4 % + 100 µV	Fluke 5522A/SC1100
(5 mV to 3.5 V)	600 to 1100) MHz	5 % + 100 µV	
Frequency Range	50 kHz to 1100 MHz	2.5 µHz/Hz	
Time Marker	(1 to 5) ns 10 ns (20 to 50) ns 100 ns to 20 ms 50 ms to 5 s	1.2 ps 12 ps 12 ps 460 ps/s + 46 ps 42 µs/s + 108 ns	
Resistance – Generate ³ , Fixed Points 4-Wire	0.001 Ω 0.01 Ω 0.1 Ω 1 Ω 10 Ω 100 Ω 1 kΩ 10 kΩ 100 kΩ 1 MΩ 10 MΩ	30 µΩ 33 µΩ 36 µΩ 75 µΩ 87 µΩ 550 µΩ 3.7 mΩ 90 mΩ 620 mΩ 9.9 Ω 310 Ω	Standard resistors & Keysight 3458A, option 002
Fixed Points	0 Ω 1 Ω 1.9 Ω 10 Ω 19 Ω 100 Ω 190 Ω 1 kΩ 1.9 kΩ 10 kΩ 19 kΩ 100 kΩ 190 kΩ 1 MΩ 1.9 MΩ 10 MΩ 19 MΩ 100 MΩ	50 µΩ 95 µΩ/Ω 95 µΩ/Ω 28 µΩ/Ω 27 µΩ/Ω 17 µΩ/Ω 17 µΩ/Ω 13 µΩ/Ω 13 µΩ/Ω 12 µΩ/Ω 12 µΩ/Ω 14 µΩ/Ω 14 µΩ/Ω 20 µΩ/Ω 21 µΩ/Ω 40 µΩ/Ω 47 µΩ/Ω 110 µΩ/Ω	Fluke 5700A



Parameter/Equipment	Range	CMC ^{2, 4} ($\pm$)	Comments
Resistance – Generate ³ (cont)			
(1 to 10) k Ω Decade	1 k Ω	150 m Ω	IET HRRS-F-9-1k-5kV-WT high voltage resistors
	2 k Ω	270 m Ω	
	3 k Ω	400 m Ω	
	4 k Ω	510 m Ω	
	5 k Ω	660 m Ω	
	6 k Ω	800 m Ω	
	7 k Ω	930 m Ω	
	8 k Ω	1 Ω	
	9 k Ω	1 Ω	
	10 k Ω	1 Ω	
(10 to 100) k Ω Decade	10 k Ω	46 m Ω	
	20 k Ω	1.5 Ω	
	30 k Ω	2.9 Ω	
	40 k Ω	3.9 Ω	
	50 k Ω	3.1 Ω	
	60 k Ω	4.4 Ω	
	70 k Ω	5.4 Ω	
	80 k Ω	6.4 Ω	
	90 k Ω	7.5 Ω	
	100 k Ω	7.2 Ω	
(100 to 1000) k Ω Decade	100 k Ω	1.9 Ω	
	200 k Ω	91 Ω	
	300 k Ω	90 Ω	
	400 k Ω	91 Ω	
	500 k Ω	85 Ω	
	600 k Ω	86 Ω	
	700 k Ω	75 Ω	
	800 k Ω	79 Ω	
	900 k Ω	78 Ω	
	1000 k Ω	74 Ω	
(1 to 10) M Ω Decade	1 M Ω	190 Ω	
	2 M Ω	140 Ω	
	3 M Ω	180 Ω	
	4 M Ω	230 Ω	
	5 M Ω	310 Ω	
	6 M Ω	340 Ω	
	7 M Ω	420 Ω	
	8 M Ω	500 Ω	
	9 M Ω	530 Ω	
	10 M Ω	590 Ω	



Parameter/Equipment	Range	CMC ^{2, 4} ($\pm$)	Comments
Resistance – Generate ³ (cont)			
(10 to 100) M Ω Decade	10 M Ω	2.4 k Ω	IET HRRS-F-9-1k-5kV-WT high voltage resistors
	20 M Ω	17 k Ω	
	30 M Ω	34 k Ω	
	40 M Ω	57 k Ω	
	50 M Ω	80 k Ω	
	60 M Ω	100 k Ω	
	70 M Ω	130 k Ω	
	80 M Ω	120 k Ω	
	90 M Ω	130 k Ω	
	100 M Ω	78 k Ω	
(100 to 1000) M Ω Decade	100 M Ω	37 k Ω	
	200 M Ω	80 k Ω	
	300 M Ω	290 k Ω	
	400 M Ω	480 k Ω	
	500 M Ω	600 k Ω	
	600 M Ω	910 k Ω	
	700 M Ω	1.1 M Ω	
	800 M Ω	1.3 M Ω	
	900 M Ω	1.6 M Ω	
	1000 M Ω	1.8 M Ω	
(1 to 10) G Ω Decade	1 G Ω	0.72 M Ω	
	2 G Ω	1 M Ω	
	3 G Ω	1.7 M Ω	
	4 G Ω	4 M Ω	
	5 G Ω	6.4 M Ω	
	6 G Ω	8.7 M Ω	
	7 G Ω	21 M Ω	
	8 G Ω	22 M Ω	
	9 G Ω	28 M Ω	
	10 G Ω	35 M Ω	
(10 to 100) G Ω Decade	10 G Ω	60 M Ω	
	20 G Ω	140 M Ω	
	30 G Ω	290 M Ω	
	40 G Ω	510 M Ω	
	50 G Ω	750 M Ω	
	60 G Ω	990 M Ω	
	70 G Ω	1.4 G Ω	
	80 G Ω	1.9 G Ω	
	90 G Ω	2.1 G Ω	
	100 G Ω	1.3 G Ω	

Parameter/Equipment	Range	CMC ^{2, 4} (±)	Comments
Resistance – Generate ³ (cont)			
(100 to 1000) GΩ Decade	100 GΩ 200 GΩ 300 GΩ 400 GΩ 500 GΩ 600 GΩ 700 GΩ 800 GΩ 900 GΩ 1000 GΩ	1.2 GΩ 2.4 GΩ 3.5 GΩ 7.2 GΩ 8.2 GΩ 9.7 GΩ 12 GΩ 16 GΩ 18 GΩ 20 GΩ	IET HRRS-F-9-1k-5kV-WT high voltage resistors
Variable Points	Up to 11 Ω (10 to 33) Ω (33 to 110) Ω (110 to 330) Ω 330 to 1.1 kΩ (1.1 to 3.3) kΩ (3.3 to 11) kΩ (11 to 33) kΩ (33 to 110) kΩ (110 to 330) kΩ 330 kΩ to 1.1 MΩ (1.1 to 3.3) MΩ (3.3 to 11) MΩ (1 to 33) MΩ (33 to 110) MΩ (110 to 330) MΩ (330 to 1100) MΩ	18 μΩ/Ω + 270 μΩ 32 μΩ/Ω + 340 μΩ 9.2 μΩ/Ω + 1.1 mΩ 11 μΩ/Ω + 110 μΩ 15 μΩ/Ω + 0.45 mΩ 29 μΩ/Ω + 17 mΩ 5.3 μΩ/Ω + 120 mΩ 10 μΩ/Ω + 31 mΩ 9.3 μΩ/Ω + 180 mΩ 30 μΩ/Ω + 12 Ω 1.3 μΩ/Ω + 14 Ω 23 μΩ/Ω + 51 Ω 100 μΩ/Ω + 150 Ω 100 μΩ/Ω + 10 Ω 150 μΩ/Ω + 4.7 kΩ 860 μΩ/Ω + 79 kΩ 8.2 mΩ/Ω + 2.6 MΩ	Fluke 5522A
Resistance – Measure ³	Up to 10 Ω (10 to 100) Ω 100 Ω to 1 kΩ (1 to 10) kΩ (10 to 100) kΩ (100 to 1) MΩ (1 to 10) MΩ (10 to 100) MΩ 100 MΩ to 1 GΩ	15 μΩ/Ω + 50 μΩ 12 μΩ/Ω + 500 μΩ 10 μΩ/Ω + 500 μΩ 10 μΩ/Ω + 5 mΩ 10 μΩ/Ω + 50 mΩ 10 μΩ/Ω + 2 Ω 50 μΩ/Ω + 100 Ω 500 μΩ/Ω + 1 kΩ 0.5 % + 10 kΩ	Keysight 3458A option 002

Parameter/Equipment	Range	CMC ² (±)	Comments
Electrical Calibration of Thermocouples – Generate			
Type E	(-175 to 950) °C (-283 to 1742) °F	0.077 °C 0.14 °F	Ectron 1140A SPRT with readout & ice bath
Type K	(-200 to 1200) °C (-328 to 2192) °F	0.096 °C 0.17 °F	
Type J	(-105 to 1100) °C (-157 to 2012) °F	0.10 °C 0.18 °F	
Type N	(-175 to 1000) °C (-283 to 1832) °F	0.13 °C 0.24 °F	
Type T	(-135 to 300) °C (-211 to 572) °F	0.19 °C 0.34 °F	
Electrical Calibration of Thermocouples – Measure			
Type E	(-175 to 950) °C (-283 to 1742) °F	0.052 °C 0.093 °F	Ectron 1140A SPRT with readout & ice bath
Type K	(-200 to 1200) °C (-328 to 2192) °F	0.099 °C 0.18 °F	
Type J	(-105 to 1100) °C (-157 to 2012) °F	0.068 °C 0.12 °F	
Type N	(-175 to 1000) °C (-283 to 1832) °F	0.13 °C 0.23 °F	
Type T	(-135 to 300) °C (-211 to 572) °F	0.12 °C 0.21 °F	

Parameter/Equipment	Range	CMC ² (±)	Comments
Temperature Calibrations Electrical Indication & Control ³			
Type B	(250 to 350) °C (350 to 445) °C (450 to 580) °C (580 to 750) °C (750 to 1000) °C (1000 to 1820) °C	0.95 °C 0.74 °C 0.58 °C 0.45 °C 0.37 °C 0.29 °C	Ectron 1140A
Type C	(0 to 250) °C (250 to 1000) °C (1000 to 1500) °C (1500 to 1800) °C (1800 to 2000) °C (2000 to 2250) °C (2250 to 2315) °C	0.20 °C 0.16 °C 0.18 °C 0.21 °C 0.23 °C 0.29 °C 0.32 °C	
Type E	(-270 to -245) °C (-245 to -195) °C (-195 to -155) °C (-155 to -90) °C (-90 to 15) °C (15 to 890) °C (890 to 1000) °C	1.2 °C 0.18 °C 0.10 °C 0.08 °C 0.07 °C 0.06 °C 0.07 °C	
Type J	(-210 to -180) °C (-180 to -120) °C (-120 to -50) °C (-50 to 990) °C (990 to 1200) °C	0.12 °C 0.10 °C 0.08 °C 0.07 °C 0.07 °C	
Type K	(-270 to -255) °C (-255 to -195) °C (-195 to -115) °C (-115 to -55) °C (-55 to 1000) °C (1000 to 1372) °C	2.2 °C 0.70 °C 0.12 °C 0.09 °C 0.07 °C 0.08 °C	
Type N	(-270 to -260) °C (-260 to -200) °C (-200 to -140) °C (-140 to -70) °C (-70 to 25) °C (25 to 160) °C (160 to 1300) °C	5 °C 1 °C 0.23 °C 0.15 °C 0.12 °C 0.10 °C 0.09 °C	



Parameter/Equipment	Range	CMC ² (±)	Comments
Temperature Calibrations Electrical Indication & Control ³ (cont)			
Type R	(-50 to -30) °C (-30 to 45) °C (45 to 160) °C (160 to 380) °C (380 to 775) °C (775 to 1768) °C	0.65 °C 0.55 °C 0.40 °C 0.30 °C 0.26 °C 0.22 °C	Ectron 1140A
Type S	(-50 to -30) °C (-30 to 45) °C (45 to 105) °C (105 to 310) °C (310 to 615) °C (615 to 1768) °C	0.62 °C 0.56 °C 0.40 °C 0.33 °C 0.29 °C 0.26 °C	
Type T	(-270 to -255) °C (-255 to -240) °C (-240 to -210) °C (-210 to -150) °C (-150 to -40) °C (-40 to 100) °C (100 to 400) °C	1.8 °C 0.49 °C 0.30 °C 0.18 °C 0.12 °C 0.08 °C 0.07 °C	
Type L	(-200 to -100) °C (-100 to 800) °C (800 to 900) °C	0.37 °C 0.26 °C 0.17 °C	
Type U	(-200 to 0) °C (0 to 600) °C	0.56 °C 0.27 °C	
Electrical Calibration of RTD			
Pt 385, 100 Ω	(-200 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 300) °C (300 to 400) °C (400 to 630) °C (630 to 800) °C	0.05 °C 0.05 °C 0.07 °C 0.09 °C 0.10 °C 0.12 °C 0.23 °C	



Parameter/Equipment	Range	CMC ² (±)	Comments
Electrical Calibration of RTD (cont)			
Pt 3916, 100 Ω	(-200 to -190) °C (-190 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 260) °C (260 to 300) °C (300 to 400) °C (400 to 600) °C (600 to 630) °C	0.25 °C 0.04 °C 0.05 °C 0.06 °C 0.07 °C 0.08 °C 0.09 °C 0.10 °C 0.23 °C	Fluke 5522A
Pt 3926, 100 Ω	(-200 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 300) °C (300 to 400) °C (400 to 630) °C	0.05 °C 0.05 °C 0.07 °C 0.09 °C 0.10 °C 0.12 °C	
Pt 385, 200 Ω	(-200 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 260) °C (260 to 300) °C (300 to 400) °C (400 to 600) °C (600 to 630) °C	0.04 °C 0.04 °C 0.04 °C 0.05 °C 0.12 °C 0.13 °C 0.14 °C 0.16 °C	
Pt 385, 500 Ω	(-200 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 260) °C (260 to 300) °C (300 to 400) °C (400 to 600) °C (600 to 630) °C	0.04 °C 0.05 °C 0.05 °C 0.06 °C 0.08 °C 0.08 °C 0.09 °C 0.11 °C	
Pt 385, 1000 Ω	(-200 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 260) °C (260 to 300) °C (300 to 400) °C (400 to 600) °C (600 TO 630) °C	0.03 °C 0.03 °C 0.04 °C 0.05 °C 0.06 °C 0.07 °C 0.07 °C 0.23 °C	
PtNi, 120 Ω	(-80 to 0) °C (0 to 100) °C (100 to 260) °C	0.08 °C 0.08 °C 0.14 °C	
Cu 42 710 Ω	(-120 to 260) °C	0.30 °C	



Parameter/Equipment	Range	CMC ² (±)	Comments
Welders ³ – AC Voltage 10 Hz to 20 kHz AC Current 10 Hz to 20 kHz DC Voltage DC Current	Up to 750 V Up to 100 A Up to 1000 V Up to 500 A	0.43 mV/V + 330 mV 0.42 mA/A + 24 mA 6.7 µV/V + 14 mV 0.28 mA/A + 31 mA	Keysight 34465A current shunt
Wrist Strap/Footwear & Workstation Monitors ³	675 kΩ 825 kΩ 8.5 MΩ 11.5 MΩ 35 MΩ 40 MΩ 80 MΩ 120 MΩ	5.6 kΩ 2.2 kΩ 2.2 kΩ 22 kΩ 140 kΩ 140 kΩ 610 kΩ 1.9 MΩ	Calibration Unit Desco 07010 & Charleswater 99090

V. Mechanical

Parameter/Equipment	Range	CMC ^{2, 5, 8} (±)	Comments
Durometers – Types: A, B, O Types: C, D Types: CF Types: OO, OOO Types: M Indenter Length	Up to 750 gf Up to 4100 gf Up to 10 000 gf Up to 2610 gf Up to 2610 gf Up to 1 in	0.016 % + 0.17 gf 0.003 % + 0.3 gf 0.023 % + 0.39 gf 0.01 % + 0.18 gf 0.01 % + 0.18 gf (80 + 3.2L) µin	Weight scale ASTM D2240 Video Measuring System ASTM D2240
Force ³ – Measuring & Sourcing Devices	Up to 10 gf (10 to 100) gf (100 to 500) gf (1 to 10) lbf (10 to 50) lbf Up to 300 lbf Up to 1000 lbf Up to 5000 lbf Up to 15 000 lbf	0.29 mgf/gf + 2.7 mgf 0.027 mgf/gf + 5.3 mgf 0.018 mgf/gf + 10 mgf 0.038 % + 0.013 ozf 0.0058 % + 0.064 ozf 0.0015 % + 0.0018 lbf 0.0016 % + 0.0059 lbf 0.0014 % + 0.015 lbf 0.05 %	Class 3 standard weights NIST Class F weights Load cell with indicator

Parameter/Equipment	Range	CMC ² (±)	Comments
Indirect Verification of Rockwell Hardness Testers ³	(170 to 960) HLD	9.7 HLD	Leeb hardness test blocks ASTM A956
	HRA (20 to 70) (70.01 to 79) (79.01 to 84)	0.55 HRA 0.48 HRA 0.41 HRA	Rockwell hardness test blocks ASTM E18
	HRB (40 to 60) (60.01 to 88) (88.01 to 100)	1.6 HRB 1.1 HRB 1.1 HRB	
	HRC (20 to 35) (35.01 to 60) (60.01 to 71)	0.77 HRC 0.53 HRC 0.43 HRC	
	HRE (70 to 84) (84.01 to 93) (93.01 to 150)	1.0 HRE 1.0 HRE 1.0 HRE	
	HR15N (70 to 78) (78.01 to 90) (90.01 to 92)	0.63 HR15N 0.61 HR15N 0.61 HR15N	
	HRN30 (40 to 55) (55.01 to 77) (77.01 to 82)	1.0 HR30N 0.75 HR30N 0.62 HR30N	
	HRN45N (20 to 37) (37.01 to 66) (66.01 to 72)	1.0 HR45N 1.0 HR45N 0.65 HR45N	
	HR15T (74 to 79) (79.01 to 85) (85.01 to 93)	1.0 HR15T 1.0 HR15T 1.1 HR15T	
	HR30T (42 to 57) (57.01 to 70) (70.01 to 87)	1.0 HR30T 1.0 HR30T 1.0 HR30T	
	HR45T (13 to 33) (33.01 to 53) (53.01 to 73)	1.0 HR45T 1.1 HR45T 1.0 HR45T	



Parameter/Equipment	Range	CMC ^{2, 5, 8} (±)	Comments
Pressure Measuring & Sourcing Devices ³	(- 60 to 60) inH ₂ O Up to 300 psi	0.0025 % + 0.000 48 inH ₂ O 0.0051 % + 0.0007 psi	Ruska 7252i
	(0.2 to 25) psi Up to 1000 psi	0.0011 % + 0.000 01 psi 0.0017 % + 0.000 06 psi	Ruska 2465
	(8 to 17) psia (14.5 to 1014) psia Up to 1000 psi Up to 10 000 psi	0.003 % + 0.000 02 psia 0.011 % + 0.011 psia 0.0021 % + 0.018 psi 0.0029 % + 0.32 psi	Mensor CPG2500 with CPR2550
	(100 to 3000) psi	0.0036 % + 0.000 02 psi	Ruska 2470
	(90 to 40 000) psi	0.0055 %	DH-Budenberg CPB3800HP
	(-10 to 10) inH ₂ O	0.0053 % + 0.017 in.H ₂ O	Fluke 700G01
	(-15 to 30) psi (-30 to 60) inHg	0.001 % + 0.0057 psi 0.001 % + 0.012 inHg	Additel ADT681
	Up to 100 psi	0.0012 % + 0.027 psi	Additel ADT681
	(-12 to 300) psi (-24.4 to 610 inHg)	0.0031 % + 0.044 psi 0.0031 % + 0.09 inHg	Fluke 2700G
	(-15 to 500) psi (-30 to 1018) inHg	0.027 % + 0.043 psi 0.027 % + 0.088 inHg	Omega DPG4000
	Up to 1000 psi Up to 3000 psi Up to 5000 psi Up to 10 000 psi	0.0024 % + 0.15 psi 0.009 % + 0.23 psi 0.002 % + 0.91 psi 0.017 % + 0.36 psi	Additel ADT681 Fluke 2700G Additel ADT681 Fluke 2700G
	Up to 30 000 psi	0.0035 % + 2.8 psi	Additel ADT681
Transducers, Tester & Analyzer	Up to 10 lbf·in (5 to 100) lbf·in (100 to 3000) lbf·in (200 to 2000) lbf·ft	0.016 % + 0.0018 lbf·in 0.01 % + 0.0049 lbf·in 0.01 % + 0.011 lbf·in 0.031 % + 0.039 lbf·ft	Torque wheel arm 2.5, 5, 10 & 40 in with weights

Parameter/Equipment	Range	CMC ^{2,5} (±)	Comments
Scales ³ – Analytical & Precision	1 mg 10 mg 20 mg 50 mg 100 mg 200 mg 500 mg 1 g 2 g 3 g 5 g 10 g 20 g 30 g 50 g 100 g 200 g 300 g 500 g 1 kg 2 kg 4 kg 5 kg 10 kg 20 kg	2.9 µg 17 µg 4.4 µg 8.3 µg 3.4 µg 3.9 µg 4.3 µg 7 µg 6.1 µg 7.1 µg 8.1 µg 14 µg 18 µg 46 µg 27 µg 63 µg 0.19 mg 0.16 mg 0.3 mg 0.57 mg 1 mg 2.2 mg 2.7 mg 5.3 mg 10 mg	Ultra & Class 1 standard weight
Floor & Bench Scales	(0.001 to 1) lb (1 to 10) lb (10 to 50) lb (50 to 100) lb (100 to 200) lb (200 to 500) lb (500 to 1000) lb (1000 to 1500) lb (1500 to 2000) lb	(1.9 x 10 ⁻⁶ + 1.5 x 10 ⁻⁴ Wt) lb (1.4 x 10 ⁻⁴ + 8.9 x 10 ⁻⁶ Wt) lb (8.5 x 10 ⁻⁴ + 1.5 x 10 ⁻⁵ Wt) lb (2.0 x 10 ⁻⁴ + 1.8 x 10 ⁻⁵ Wt) lb (6.0 x 10 ⁻⁴ + 2.5 x 10 ⁻⁵ Wt) lb (1.0 x 10 ⁻² + 1.3 x 10 ⁻⁴ Wt) lb (1.1 x 10 ⁻² + 3.6 x 10 ⁻⁵ Wt) lb (3.3 x 10 ⁻² + 1.4 x 10 ⁻⁵ Wt) lb (1.0 x 10 ⁻² + 2.0 x 10 ⁻⁵ Wt) lb	NIST Class F weights
Torque Tools ³ –	(2 to 20) ozf·in (10 to 100) ozf·in (2 to 20) lbf·in (24 to 240) lbf·in (20 to 200) lbf·ft (100 to 1000) lbf·ft (200 to 2000) lbf·ft	00.022 % + 0.0056 ozf·in 0.026 % + 0.022 ozf·in 0.022 % + 0.0039 lbf·in 0.013 % + 0.029 lbf·in 0.013 % + 0.029 lbf·ft 0.15 % + 0.1 lbf·ft 0.35 % + 0.02 lbf·ft	AKO TSD6500 with transducers AWS QCMF-2000

VI. Thermodynamics

Parameter/Equipment	Range	CMC ^{2,5,8} (±)	Comments
Humidity – Measuring Equipment			
0 °C	10 % RH (10 to 30) % RH (30 to 50) % RH (50 to 70) % RH (70 to 95) % RH	0.03 % RH 0.08 % RH 0.13 % RH 0.19 % RH 0.25 % RH	RH Systems CGS-240 , humidity generator By primary realization in accordance to RISP-5
25 °C	10 % RH (10 to 30) % RH (30 to 50) % RH (50 to 70) % RH (70 to 95) % RH	0.02 % RH 0.06 % RH 0.10 % RH 0.14 % RH 0.19 % RH	
50 °C	10 % RH (10 to 30) % RH (30 to 50) % RH (50 to 70) % RH (70 to 95) % RH	0.02 % RH 0.05 % RH 0.08 % RH 0.12 % RH 0.16 % RH	
70 °C	10 % RH (10 to 30) % RH (30 to 50) % RH (50 to 70) % RH (70 to 95) % RH	0.02 % RH 0.05 % RH 0.07 % RH 0.10 % RH 0.14 % RH	
Temperature – Measuring Equipment	(0 to 70) °C (32 to 158) °F	0.018 °C 0.032 °F	RH Systems CGS-240 humidity generator
Infrared Temperature – Measuring Equipment	(-15 to 120) °C (35 to 500) °C (50 to 749) °C (601 to 1100) °C (1101 to 1200) °C	0.13 % + 0.85 °C 0.25 % + 0.33 °C 2.8 °C 4.9 °C 0.7 °C	Fluke 4180 $\epsilon = 0.95$ Fluke 4181 $\epsilon = 0.95$ IR-564 IR-300
Ovens, Autoclaves, Freezers, Refrigerators, Environmental Chambers, Liquid Baths ³			
Type K	(-87.2 to 1204.4) °C TUS	1.2 °C	Thermocouples AMS 2750 customer specific specifications
Type N	TUS	1.3 °C	
Type K	SAT	1.4 °C	
Type N	SAT	1.2 °C	

Parameter/Equipment	Range	CMC ^{2, 5, 8} ($\pm$)	Comments
Oven/Chamber Temperature Uniformity – Measure ³	(32 to 1800) °F	0.073 % + 0.59 °F	Fluke 1586A Type K thermocouple, AMS2750
	(32 to 1400) °F	0.11 % + 0.26 °F	Fluke 1586A Type J thermocouple
Temperature – Measuring Equipment, Resistance Thermometers Fixed Point Calibrations			
Liquid Nitrogen	-196 °C	6.2 mK	Triple, melting, & freezing point cells with MicroK thermometry bridge
Mercury	-38.8344 °C	1.4 mK	
Triple Point Water	0.010 °C	0.5 mK	
Gallium	29.7646 °C	0.9 mK	
Indium	156.5985 °C	2.1 mK	
Tin	231.928 °C	2.3 mK	
Zinc	419.527 °C	2.3 mK	
Aluminum	660.323 °C	6.0 mK	
Comparison	-196 °C	0.012 °C	Calibration baths and furnaces, SPRT, Super thermometer
	(-80 to 0) °C	0.009 °C	
	(0 to 150) °C	0.017 °C	
	(150 to 300) °C	0.032 °C	
	(300 to 550) °C	0.06 °C	
	(550 to 1100) °C	0.9 °C	Type S thermocouple
Thermocouple Probes & Wire Types E, J, K, N, T	(-80 to 0) °C (0 to 150) °C (25 to 250) °C (50 to 660) °C	0.16 °C 0.12 °C 0.11 °C 0.015 % + 0.13 °C	Temperature baths, Ectron 1140A Fluke 1594A w/SPRT & field metrology well

VII. Time & Frequency

Parameter/Equipment	Range	CMC ^{2, 8} ($\pm$)	Comments
Frequency – Measuring Equipment ³	1 μ Hz to 30 MHz	56 nHz/Hz + 0.055 μ Hz	Keysight 33519B
	0.1 Hz to 225 MHz	50 pHz/Hz + 1.2 mHz	Agilent 53181A counter
	100 MHz to 3 GHz	340 pHz/Hz + 19 mHz	

Parameter/Equipment	Range	CMC ^{2, 5} ($\pm$)	Comments
Stop Watches/ Timer ³	Up to 24 hr Up to 86 400 s Up to 86 400 s	0.063 s / 24 hr 0.08 s 0.001 s/hr + 0.47 s	Timometer 4500 photo totalize method direct comparison
Tachometer – Contact Non-Contact	 (10 to 50 000) RPM Up to 99 999 RPM	 0.000 12 % + 0.021 RPM 0.001 % + 0.003 RPM	 Ideal Aerosmith Generator with LED



SCOPE OF ACCREDITATION TO ISO/IEC 17025:2017
& ANSI/NCSL Z540-1-1994

INTERNATIONAL PROCESS SOLUTIONS, A TRUMETRIC FAMILY
1300 Industrial Road, Suite 22
San Carlos, CA 94070
Thomas Main Phone: 650-595-7890

CALIBRATION

Valid To: March 31, 2027

Certificate Number: 2348.01

In recognition of the successful completion of the A2LA evaluation (including an assessment of the organization's compliance with A2LA's – R205 Calibration Program Requirements), accreditation is granted to this laboratory at the locations listed above as well as the satellite laboratory location listed below to perform the following calibrations^{1, 7, 10}

I. Dimensional

Parameter/Equipment	Range	CMC ² (±)	Comment
Outside Diameter (Pin & Plug Gages)	(0.01 to 0.25) in	30 µin	Comparison to plug gage using Mitutoyo LSM-6100 laser scan micrometer
	(0.25 to 1) in	78 µin	Measurement heads

II. Electrical – DC/Low Frequency

Parameter/Equipment	Range	CMC ^{2, 4} (±)	Comment
DC Voltage – Generate	(0 to 3 299 999) mV (0.33 to 3 299 999) V (3.3 to 3 299 999) V (33 to 3 299 999) V (330 to 1020) V	64 µV/V + 5.8 µV 54 µV/V + 27 µV 55 µV/V + 0.24 mV 69 µV/V + 3.4 mV 71 µV/V + 11 mV	Comparison to Fluke 5502A multiproduct calibrator

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Parameter/Range	Frequency	CMC ^{2,4} (±)	Comment
DC Voltage – Measure	(10 to 100) mV 100 mV to 1 V (1 to 10) V (10 to 100) V 100 V to 1 kV	23 $\mu\text{V/V} + 0.3 \mu\text{V}$ 5.6 $\mu\text{V/V} + 0.4 \mu\text{V}$ 5.6 $\mu\text{V/V} + 0.8 \mu\text{V}$ 8.5 $\mu\text{V/V} + 45 \mu\text{V}$ 9.9 $\mu\text{V/V} + 1.7 \text{ mV}$	Comparison to Fluke 8558A, 8.5-digit multimeter
AC Voltage – Generate (Sine)			
(1 to 32.999) mV	(10 to 45) Hz 45 Hz to 10 kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 500) kHz	1.5 mV/V + 31 μV 1 mV/V + 25 μV 1.6 mV/V + 25 μV 2.1 mV/V + 30 μV 3.7 mV/V + 45 μV 11 mV/V + 94 μV	Comparison to Fluke 5502A, multiproduct calibrator
(33 to 329.999) mV	(10 to 45) Hz 45 Hz to 10 kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 500) kHz	0.4 mV/V + 97 μV 0.31 mV/V + 35 μV 0.8 mV/V + 35 μV 1.1 mV/V + 63 μV 2.6 mV/V + 0.21 mV 5.5 mV/V + 0.45 mV	
(0.33 to 3.29999) V	(10 to 45) Hz 45 Hz to 10 kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 500) kHz	0.4 mV/V + 0.8 mV 0.31 mV/V + 0.21 mV 0.77 mV/V + 0.2 mV 1.1 mV/V + 0.23 mV 2.6 mV/V + 0.49 mV 5.4 mV/V + 2.3 mV	
(3.3 to 32.9999) V	(10 to 45) Hz 45 Hz to 10 kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz	0.4 mV/V + 8 mV 0.31 mV/V + 2 mV 0.77 mV/V + 2 mV 1.1 mV/V + 2.6 mV 2.6 mV/V + 5.4 mV	
(33 to 329.999) V	45 Hz to 1 kHz (1 to 10) kHz (10 to 20) kHz (20 to 50) kHz (20 to 50) kHz	0.53 mV/V + 21 mV 0.88 mV/V + 27 mV 1 mV/V + 27 mV 1.2 mV/V + 55 mV 2.7 mV/V + 0.13 V	
(330 to 1020) V	45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.39 mV/V + 0.26 V 0.88 mV/V + 68 mV 1 mV/V + 73 mV	



Parameter/Range	Frequency	CMC ^{2, 4} (±)	Comment
AC Voltage – Measure			
(1 to 10) mV	1 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz	0.86 mV/V + 2.6 µV 0.64 mV/V + 2.6 µV 0.65 mV/V + 2.6 µV 6.3 mV/V + 2.6 µV 24 mV/V + 7.7 µV 38 mV/V + 7.7 µV	Comparison to Fluke 8558A, 8.5 digit multimeter
(10 to 100) mV	1 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz (1 to 2) MHz (2 to 4) MHz (4 to 8) MHz (8 to 10) MHz	0.14 mV/V + 1.3 µV 0.19 mV/V + 1.3 µV 0.35 mV/V + 2.6 µV 0.85 mV/V + 26 µV 4.5 mV/V + 65 µV 21 mV/V + 0.26 mV 24 mV/V + 0.9 mV 69 mV/V + 1.5 mV 0.14 mV/V + 1.6 mV 0.26 mV/V + 1.6 mV	
(0.1 to 1) V	1 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz (1 to 2) MHz (2 to 4) MHz (4 to 8) MHz (8 to 10) MHz	0.14 mV/V + 13 µV 0.2 mV/V + 13 µV 0.35 mV/V + 26 µV 0.85 mV/V + 0.26 mV 3.9 mV/V + 0.65 mV 21 mV/V + 2.6 mV 24 mV/V + 9 mV 70 mV/V + 16 mV 0.14 V/V + 16 mV 0.26 V/V + 16 mV	
(1 to 10) V	1 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz (1 to 2) MHz (2 to 4) MHz (4 to 8) MHz (8 to 10) MHz	0.14 mV/V + 0.13 mV 0.19 mV/V + 0.13 mV 0.35 mV/V + 0.26 mV 0.85 mV/V + 2.6 mV 3.9 mV/V + 6.5 mV 21 mV/V + 26 mV 24 mV/V + 90 mV 69 mV/V + 0.16 V 0.13 V/V + 0.16 V 0.26 V/V + 0.16 V	
(10 to 100) V	1 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz	0.13 mV/V + 1.3 mV 0.19 mV/V + 1.3 mV 0.35 mV/V + 2.6 mV 0.85 mV/V + 26 mV 6.3 mV/V + 0.13 V 23 mV/V + 0.9 V	
(100 to 1000) V	1 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz	0.21 mV/V + 39 mV 0.24 mV/V + 39 mV 0.47 mV/V + 39 mV 0.85 mV/V + 0.26 V	



Parameter/Equipment	Range	CMC ^{2, 4} ($\pm$)	Comment
Resistance – Generate (Simulation)	Up to 10.999 Ω (11 to 32.999) Ω (33 to 109.999) Ω (110 to 329.999) Ω (0.33 to 1.1) k Ω (1.1 to 3.3) k Ω (3.3 to 11) k Ω (11 to 33) k Ω (33 to 110) k Ω (110 to 330) k Ω (0.33 to 1.1) M Ω (1.1 to 3.3) M Ω (3.3 to 11) M Ω (11 to 33) M Ω (33 to 110) M Ω (110 to 330) M Ω (0.33 to 1.1) G Ω	58 $\mu\Omega/\Omega$ + 2.7 m Ω 70 $\mu\Omega/\Omega$ + 5.2 m Ω 90 $\mu\Omega/\Omega$ + 3.4 m Ω 96 $\mu\Omega/\Omega$ + 5.3 m Ω 88 $\mu\Omega/\Omega$ + 22 m Ω 93 $\mu\Omega/\Omega$ + 41 m Ω 89 $\mu\Omega/\Omega$ + 0.22 Ω 78 $\mu\Omega/\Omega$ + 0.6 Ω 0.11 m Ω/Ω + 2.2 Ω 0.13 m Ω/Ω + 6.6 Ω 0.16 m Ω/Ω + 20 Ω 0.13 m Ω/Ω + 22 Ω 0.67 m Ω/Ω + 0.4 k Ω 1.1 m Ω/Ω + 6.1 k Ω 5.2 m Ω/Ω + 7.6 k Ω 5.5 m Ω/Ω + 0.24 M Ω 7.5 m Ω/Ω + 19 M Ω	Comparison to Fluke 5502A multiproduct calibrator Millivolt/resistance simulation using Fluke 5502A, multiproduct calibrator
Resistance – Measure (4-Wire Configuration)	Up to 1 Ω (1 to 10) Ω (10 to 100) Ω (0.1 to 1) k Ω (1 to 10) k Ω (10 to 100) k Ω (0.1 to 1) M Ω (1 to 10) M Ω (10 to 100) M Ω (0.1 to 1) G Ω	26 $\mu\Omega/\Omega$ + 6.3 $\mu\Omega$ 19 $\mu\Omega/\Omega$ + 31 $\mu\Omega$ 14 $\mu\Omega/\Omega$ + 0.12 m Ω 14 $\mu\Omega/\Omega$ + 1.2 m Ω 14 $\mu\Omega/\Omega$ + 12 m Ω 13 $\mu\Omega/\Omega$ + 0.12 Ω 17 $\mu\Omega/\Omega$ + 2.4 Ω 29 $\mu\Omega/\Omega$ + 0.2 k Ω 74 $\mu\Omega/\Omega$ + 20 k Ω 0.8 m Ω/Ω + 1.9 M Ω	Comparison to Fluke 8558A, 8.5 digit multimeter
DC Current – Generate	(0 to 329.999) μ A (0 to 3.299 99) mA (0 to 32.9999) mA (0 to 329.999) mA (0 to 2.999 99) A (0 to 20.5) A	0.16 mA/A + 28 nA 0.14 mA/A + 0.11 μ A 0.1 mA/A + 0.86 μ A 0.9 mA/A + 14 μ A 0.13 mA/A + 2.1 mA 1 mA/A + 4.6 mA	Comparison to Fluke 5502A, multiproduct calibrator
DC Current – Measure	(0.001 to 10) μ A (10 to 100) μ A (0.1 to 1) mA (1 to 10) mA (10 to 100) mA (0.1 to 1) A	48 μ A/A + 0.52 nA 16 μ A/A + 0.6 nA 16 μ A/A + 6 nA 16 μ A/A + 60 nA 53 μ A/A + 1.9 μ A 0.18 mA/A + 0.19 mA	Comparison to Fluke 8558A, 8.5 digit multimeter

Parameter/Range	Frequency	CMC ^{2, 4} (±)	Comment
AC Current – Generate			
(29 to 329.99) µA	(10 to 20) Hz (20 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz	2 mA/A + 0.22 µA 1.6 mA/A + 0.13 µA 1.4 mA/A + 0.12 µA 3.4 mA/A + 0.18 µA 9.2 mA/A + 0.23 µA 18 mA/A + 0.49 µA	Comparison to Fluke 5502A, multiproduct calibrator
(0.33 to 3.299 99) mA	(10 to 20) Hz (20 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz	2.3 mA/A + 0.27 µA 1.4 mA/A + 0.3 µA 1.2 mA/A + 0.16 µA 2.3 mA/A + 0.21 µA 3.91 mA/A + 8.1 µA 7.4 mA/A + 19 µA	
(3.3 to 32.999 9) mA	(10 to 20) Hz (20 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz	1.8 mA/A + 14 µA 1 mA/A + 3.5 µA 0.42 mA/A + 3.5 µA 0.93 mA/A + 2.1 µA 2.3 mA/A + 5.4 µA 4.6 mA/A + 6.6 µA	
(33 to 329.999) mA	(10 to 20) Hz (20 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz	1.8 mA/A + 0.11 mA 1 mA/A + 35 µA 0.46 mA/A + 22 µA 1.1 mA/A + 70 µA 2.3 mA/A + 0.12 mA 4.5 mA/A + 0.26 mA	
(0.33 to 1.099 99) A	(10 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	2.1 µA/A + 0.11 mA 0.4 µA/A + 0.34 mA 6.8 mA/A + 1.2 mA 29 mA/A + 5.2 mA	
(1.1 to 2.999 99) A	(10 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	2 mA/A + 0.25 mA 0.61 mA/A + 0.4 mA 6.9 mA/A + 1.2 mA 29 mA/A + 5.3 mA	
(3 to 11) A	(45 to 100) Hz 100 Hz to 1 kHz (1 to 5) kHz	0.46 mA/A + 5.4 mA 0.97 mA/A + 4.3 mA 35 mA/A + 4 mA	
(11 to 20.5) A	(45 to 100) Hz 100 Hz to 1 kHz (1 to 5) kHz	0.63 mA/A + 30 mA 1.6 mA/A + 7.3 mA 34 mA/A + 25 mA	

Parameter/Range	Frequency	CMC ^{2, 4} (±)	Comment
AC Current – Measure			
(10 to 100) µA	1 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz	6 mA/A + 13 nA 1 mA/A + 13 nA 1.4 mA/A + 13 nA 7.8 mA/A + 19 nA	Comparison to Fluke 8558A, 8.5 digit multimeter
(0.1 to 1) mA	1 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz	0.7 mA/A + 0.13 µA 1.1 mA/A + 0.13 µA 1.5 mA/A + 0.13 µA 7.8 mA/A + 0.19 µA	
(1 to 10) mA	1 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz	0.6 mA/A + 1.3 µA 1 mA/A + 1.3 µA 1.3 mA/A + 1.3 µA 7.8 mA/A + 1.9 µA	
(10 to 100) mA	1 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz	0.58 mA/A + 13 µA 1 mA/A + 13 µA 1.3 mA/A + 13 µA	
(0.1 to 1) A	1 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz	0.75 mA/A + 0.19 mA 1.3 mA/A + 0.19 mA 1.5 mA/A + 0.19 mA	

Parameter/Frequency	Range	CMC ^{2, 4} (±)	Comment
DC Voltage – Measure ³	(-1 to 1) V (1 to 25) V (25 to 60) V	0.21 mV/V + 6 µV 0.22 mV/V + 60 µV 0.23 mV/V + 52 µV	Comparison to Beamex MC2, documenting process calibrator
DC Voltage – Genearte ³	(-3 to 0.25) V (0.25 to 12) V	0.15 mA/A + 12 µV 0.22 mV/V + 85 µV	Comparison to Beamex MC2, documenting process calibrator



Parameter/Equipment	Range	CMC ^{2, 4} (±)	Comment
Capacitance – Generate	(220 to 399.9) pF (0.4 to 1.0999) nF (1.1 to 3.2999) nF (3.3 to 10.999) nF (11 to 32.999) nF (33 to 109.99) nF (110 to 329.99) nF (0.33 to 1.0999) μF (1.1 to 3.2999) μF (3.3 to 10.999) μF (11 to 32.999) μF (33 to 109.99) μF (110 to 329.99) μF (0.33 to 1.0999) mF (1.1 to 3.2999) mF (3.3 to 10.999) mF (11 to 32.999) mF (33 to 110) mF	3.3 mF/F + 14 pF 3.8 mF/F + 14 pF 3.5 mF/F + 20 pF 2.1 mF/F + 22 pF 2.2 mF/F + 0.14 nF 2.1 mF/F + 0.22 nF 2.1 mF/F + 0.67 nF 2.1 mF/F + 2.2 nF 2 mF/F + 7 nF 1.9 mF/F + 26 nF 3.5 mF/F + 78 nF 3.7 mF/F + 0.32 μF 3.9 mF/F + 0.89 μF 4.7 mF/F + 1.8 μF 4.7 mF/F + 5.2 μ 4.4 mF/F + 21 μF 7.7 mF/F + 71 μF 12 mF/F + 0.17 mF	Comparison to Fluke 5502A, multiproduct calibrator
Electrical Simulation of Thermocouple Indicating Devices – Generate			
Type J	(-210 to -100) °C (-100 to -30) °C (-30 to 150) °C (150 to 760) °C (760 to 1200) °C	0.32 °C 0.19 °C 0.17 °C 0.27 °C 0.32 °C	Comparison to Fluke 5502A, multiproduct calibrator
Type K	(-210 to -100) °C (-100 to -25) °C (-25 to 120) °C (120 to 1000) °C (1000 to 1372) °C	0.39 °C 0.22 °C 0.19 °C 0.35 °C 0.5 °C	
Type T	(-250 to -150) °C (-150 to 0) °C (0 to 120) °C (120 to 400) °C	0.73 °C 0.28 °C 0.19 °C 0.16 °C	
DC Current – Measure ³	(-100 to 100) Ma	0.19 mA/A + 2 μV	Comparison to Beamex MC2, documenting process calibrator



Parameter/Equipment	Range	CMC ^{2, 4} (±)	Comment
DC Current – Generate ³	(-100 to 100) mA	0.15 mA/A + 3 µA	Comparison to Beamex MC2, documenting process calibrator
Resistance – Measure ³	Up to 250 Ω (0.25 to 4) kΩ	0.21 µΩ/Ω + 4 mΩ 0.23 µΩ/Ω + 4 mΩ	Comparison to Beamex MC2, documenting process calibrator
Resistance – Generate ³ (Simulation)	Up to 2650 Ω (2650 to 4000) Ω	0.4 mΩ/Ω + 20 mΩ 0.46 mΩ/Ω + 3 mΩ	Comparison to Beamex MC2, documenting process calibrator
Electrical Simulation of RTD Indicating Devices – Generate/Measure ³	(-200 to 200) °C (200 to 600) °C (600 to 800) °C	0.18 °C 0.29 °C 0.53 °C	Comparison to Beamex MC2, documenting process calibrator

III. Mechanical

Parameter/Equipment	Range	CMC ^{2, 8} (±)	Comment
Pressure – Measure ³	(-14.5 to 300) psig	0.18 psi	Comparison to Beamex MC2, documenting process calibrator, Beamex IPM20C pressure module with pressure sources
Pressure – Measuring Equipment (Gages, Transducers, etc.)	Up to 9.999 kPa (10 to 15) kPa Up to 59.999 kPa (60 to 100) kPa (-100 to 250) kPa (70 to 699) kPa 700 kPa to 2 MPa	1 Pa 0.11 Pa/kPa 5.8 kPa 0.11 Pa/kPa 30 Pa 180 Pa 87 Pa/MPa + 130 Pa	Comparison to Fluke 6270A, pressure controller; Fluke PM600 A2M/BG15k, Fluke PM500 G100k/BG250k pressure modules
Pipettes ³	(1 to 10) µL (10 to 100) µL (100 to 1000) µL	0.09 µL 0.12 µL 1.8 µL	Comparison to balance using gravimetric method per ISO 8655-2:2000/2022 ISO 8655-6:2000/2022 & ISO 20461:2023

IV. Thermodynamics

Parameter/Equipment	Range	CMC ^{2, 8} (±)	Comment
Temperature – Measuring Equipment	(50 to 650) °C	0.076 % rdg + 0.0079 °C	Comparison to Fluke 5628 PRT, Fluke 1560, black stack thermometer, Fluke 9144 metrology well
Temperature – Measure	(-196 to 0) °C (0 to 300) °C	0.0009 % rdg + 0.027 °C 0.007 % rdg + 0.027 °C	Comparison to Intelligent RTD temperature probe w/ bath/dry wells. The actual value from the reference probe will be utilized at the setpoint.
Relative Humidity – Measuring Equipment			
10 °C	10 % RH 30 % RH 50 % RH 70 % RH 80 % RH	0.08 % RH 0.21 % RH 0.32 % RH 0.43 % RH 0.54 % RH	Comparison to Thunder Scientific 2500 RH/temp chamber
21.11 °C	10 % RH 30 % RH 50 % RH 70 % RH 80 % RH	0.08 % RH 0.26 % RH 0.30 % RH 0.40 % RH 0.49 % RH	
70 °C	10 % RH 30 % RH 50 % RH 70 % RH 80 % RH	0.07 % RH 0.23 % RH 0.23 % RH 0.29 % RH 0.35 % RH	

V. Time & Frequency

Parameter/Equipment	Range	CMC ^{2, 8} (±)	Comment
Frequency – Measure	(1 to 10) Hz 10 Hz to 1 kHz (1 to 10) kHz (10 to 100) kHz 100 kHz to 1 MHz (1 to 100) MHz (10 to 100) MHz	2.6 µHz/Hz 1 mHz/kHz 1 mHz/kHz 1 mHz/kHz 1 Hz/MHz 1 Hz/MHz 1 Hz/MHz	Comparison to Fluke 8558A, 8.5 digit multimeter
Frequency – Measure ³	(5 to 50) Hz (50 to 500) Hz 500 Hz to 5 kHz (5 to 50) kHz	0.11 mHz/Hz + 1 mHz 0.12 mHz/Hz + 0.22 mHz 0.12 mHz/Hz + 0.35 mHz 0.12 mHz/Hz + 3 mHz	Comparison to Beamex MC2, documenting process calibrator

¹ This laboratory offers commercial calibration service and field calibration service, where noted.

² Calibration and Measurement Capability Uncertainty (CMC) is the smallest uncertainty of measurement that a laboratory can achieve within its scope of accreditation when performing more or less routine calibrations of nearly ideal measurement standards or nearly ideal measuring equipment. CMCs represent expanded uncertainties expressed at approximately the 95 % level of confidence, usually using a coverage factor of $k = 2$. The actual measurement uncertainty of a specific calibration performed by the laboratory may be greater than the CMC due to the behavior of the customer's device and to influences from the circumstances of the specific calibration.

³ Field calibration service is available for these calibrations. Please note the actual measurement uncertainties achievable on a customer's site can normally be expected to be larger than the CMC found on the A2LA Scope. Allowance must be made for aspects such as the environment at the place of calibration and for other possible adverse effects such as those caused by transportation of the calibration equipment. The usual allowance for the actual uncertainty introduced by the item being calibrated, (e.g., resolution) must also be considered and this, on its own, could result in the actual measurement uncertainty achievable on a customer's site being larger than the CMC.

⁴ The stated measured values are determined using the indicated instrument (see Comments). This capability is suitable for the calibration of the devices intended to measure or generate the measured value in the ranges indicated. CMCs are expressed as either a specific value that covers the full range or as a percent or fraction of the reading plus a fixed floor specification.

⁵ In the statement of CMC, percentages are to be read as percent of reading, unless noted otherwise.

⁶ In the statement of CMC, L is the numerical value of the nominal length of the device measured in inches, R is the numerical value of the resolution of the device under test in microinches, D is the numerical value of the nominal diameter of the device measured in inches.

⁷ This scope meets A2LA's *P112 Flexible Scope Policy*.

⁸ The type of instrument or material being calibrated is defined by the parameter. This indicates the laboratory is capable of calibrating instruments that measure or generate the values in the ranges indicated for the listed measurement parameter.

⁹ This laboratory meets *R205 – Specific Requirements: Calibration Laboratory Accreditation Program* for the types of dimensional tests listed above and is considered equivalent to that of a calibration.



¹⁰ Due to its corporate scope nature all certificates are issued and shown under 2348.01, but locations perform their work individually.



Accredited Laboratory

A2LA has accredited

TECHNICAL MAINTENANCE, INC. A TRUMETRIC FAMILY

for technical competence in the field of

Calibration

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017 *General requirements for the competence of testing and calibration laboratories*. This laboratory also meets the requirements of ANSI/NCSL Z540-1-1994 and the requirements of ANSI/NCSL Z540.3-2006 and R205 – Specific Requirements: Calibration Laboratory Accreditation Program. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated April 2017).



Presented this 31st of August, 2026.

A blue ink signature of Mr. Trace McInturff.

Mr. Trace McInturff, Vice President, Accreditation Services
For the Accreditation Council
Certificate Number 2348.01
Valid to see scope of accreditation

For the calibrations to which this accreditation applies, please refer to the laboratory's Calibration Scope of Accreditation.



Accredited Laboratory

A2LA has accredited

MICRO QUALITY CALIBRATION, INC. A TRUMETRIC FAMILY

Chatsworth, CA

for technical competence in the field of

Calibration

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017 *General requirements for the competence of testing and calibration laboratories*. This laboratory also meets the requirements of ANSI/NCSL Z540-1-1994 and the requirements of ANSI/NCSL Z540.3-2006 and R205 – Specific Requirements: Calibration Laboratory Accreditation Program. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated April 2017).



Presented this 30th day of January 2023.

A blue ink signature of Mr. Trace McInturff.

Mr. Trace McInturff, Vice President, Accreditation Services
For the Accreditation Council
Certificate Number 2348.01
Valid to November 30, 2026
Revised January 6, 2026

For the calibrations to which this accreditation applies, please refer to the laboratory's Calibration Scope of Accreditation.



Accredited Laboratory

A2LA has accredited

INTERNATIONAL PROCESS SOLUTIONS A TRUMETRIC FAMILY

for technical competence in the field of

Calibration

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017 *General requirements for the competence of testing and calibration laboratories*. This laboratory also meets the requirements of ANSI/NCSL Z540-1-1994 and R205 – Specific Requirements: Calibration Laboratory Accreditation Program. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (*refer to joint ISO-ILAC-IAF Communiqué dated April 2017*).



Presented this 2nd of February 2026.

A blue ink signature of Mr. Trace McInturff.

Mr. Trace McInturff, Vice President, Accreditation Services
For the Accreditation Council
Certificate Number 2348.01
Valid to see scope of accreditation

For the calibrations to which this accreditation applies, please refer to the laboratory's Calibration Scope of Accreditation.